MC56F8006 Reference Manual

16-Bit Digital Signal Controllers (DSC)

MC56F8006RM Rev. 0 03/2009





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Chapter 1 Device Overview

1.1 The MC56F8006 Series

1.1.1 Introduction

The 56F8006/56F8002 is a member of the 56800E core-based family of digital signal controllers (DSCs). It combines, on a single chip, the processing power of a DSP and the functionality of a microcontroller with a flexible set of peripherals to create an extremely cost-effective solution. Because of its low cost, configuration flexibility, and compact program code, the 56F8006/56F8002 is well-suited for many applications. The 56F8006/56F8002 includes many peripherals that are especially useful for cost-sensitive applications, including:

- Industrial control
- Home appliances
- Smart sensors
- Fire and security systems
- Switched-mode power supply and power management
- Power metering
- Motor control (ACIM, BLDC, PMSM, SR, and stepper)
- Handheld power tools
- Arc detection
- Medical device/equipment
- Instrumentation
- Lighting ballast

The 56800E core is based on a dual Harvard-style architecture consisting of three execution units operating in parallel, allowing as many as six operations per instruction cycle. The MCU-style programming model and optimized instruction set allow straightforward generation of efficient, compact DSP and control code. The instruction set is also highly efficient for C compilers to enable rapid development of optimized control applications.

The 56F8006/56F8002 supports program execution from internal memories. Two data operands can be accessed from the on-chip data RAM per instruction cycle. The 56F8006/56F8002 also offers up to 40 general-purpose input/output (GPIO) lines, depending on peripheral configuration.

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NOTE

In this manual, a reference to a register name such as PWM_VAL*n* means that there are multiple related registers named PWM_VAL1, PWM_VAL2, etc.

1.1.2 MC56F8006 Series Device Comparison

This table compares the devices in the MC56F8006 series. The pinout configuration in these devices is highly multiplexed – each signal pin can be programmed to perform one of several functions. See the data sheet for details.

Table 1. MC56F8006 Series Device Comparison

Factions		MC56F8006			
Feature	28-pin	32-pin	48-pin	28-pin	
Flash memory size (Kbytes)		16	l	12	
RAM size (Kbytes)	2		•		
Analog comparators (ACMP)		,	3		
Analog-to-digital converters (ADC)			2		
Unshielded ADC inputs	6	7	7	6	
Shielded ADC inputs	9	11	17	9	
Total number of ADC input pins ¹	15	18	24	15	
Programmable gain amplifiers (PGA)		2			
Pulse-width modulator (PWM) outputs	6				
PWM fault inputs	3	4	4	3	
Inter-integrated circuit (IIC)	1				
Serial peripheral interface (SPI)	1				
High speed serial communications interface (SCI)	1				
Programmable interrupt timer (PIT)	1				
Programmable delay block (PDB)	1				
16-bit multi-purpose timers (TMR)	2				
Real-time counter (RTC)	1				
Computer operating properly (COP) timer	Yes				
Phase-locked loop (PLL)	Yes				
1 kHz on-chip oscillator	Yes				
8 MHz (400 kHz at standby mode) on-chip ROSC	Yes				

Table 1. MC56F8006 Series Device Comparison

Feature	MC56F8006			MC56F8002
reature	28-pin	32-pin	48-pin	28-pin
Crystal oscillator	Yes			
Power management controller (PMC)	Yes			
IEEE 1149.1 Joint Test Action Group (JTAG) interface	Yes			
Enhanced on-chip emulator (EOnCE) IEEE 1149.1 Joint Test Action Group (JTAG) interface	Yes			

¹ Some ADC inputs share the same pin.

1.2 MC56F8006 Series Block Diagram

Figure 1-1 shows block diagrams of the 56800E system buses, their communication with internal memories and the IP bus interface, and the internal connections to each unit of the 56800E core. Figure 1-2 shows the peripherals and control blocks connected to the IP bus bridge.

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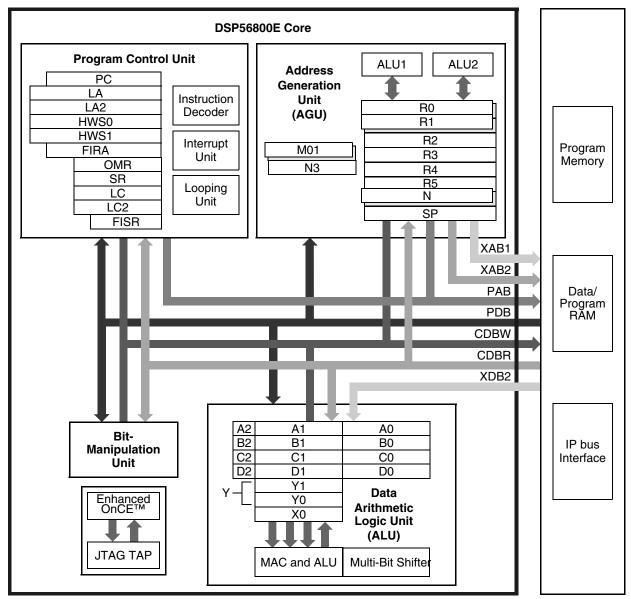


Figure 1-1. 56800E Core Block Diagram

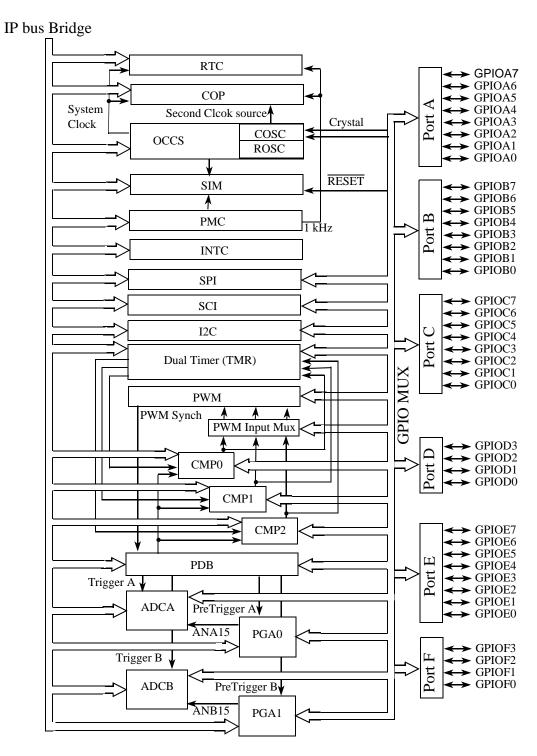


Figure 1-2. Peripheral Subsystem

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1.3 High Performance Core

- Efficient 16-bit 56800E family Digital Signal Controller (DSC) engine with dual Harvard architecture
- Up to 32 Million Instructions Per Second (MIPS) at 32 MHz core frequency
- 155 Basic Instructions in conjunction with up to 20 address modes
- Single-cycle 16 × 16-bit parallel Multiplier-Accumulator (MAC)
- Four 36-bit accumulators, including extension bits
- 32-bit arithmetic and logic multi-bit shifter
- Parallel instruction set with unique DSP addressing modes
- Hardware DO and REP loops
- Three internal address buses
- Four internal data buses
- Instruction set supports both DSP and controller functions
- Controller-style addressing modes and instructions for compact code
- Efficient C compiler and local variable support
- Software subroutine and interrupt stack with depth limited only by memory
- JTAG/Enhanced On-Chip Emulation (OnCE) for unobtrusive, processor speed-independent, real-time debugging

1.4 Operation Range

- From power-on-reset: Approximately 1.9 V to 3.6 V
- Operating: 1.8 V to 3.6 V (power supplies and input/output)
- Ambient temperature operating range: -40 °C to 105 °C

1.5 Memory Configuration

- Up to 16 Kbytes program flash memory with flash security protection
- 2 Kbytes unified program/data RAM

1.6 Module Configuration

- One 6-channel PWM module
 - Up to 96 MHz PWM operating clock
 - 15 bits of resolution
 - Center-Aligned and edge-aligned PWM signal mode
 - Four programmable fault inputs with programmable digital filter
 - Double-Buffered PWM registers
- Each complementary PWM signal pair allows selection of a PWM supply source from:
 - PWM generator

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- Internal timers
- Analog comparator outputs
- Two independent 12-bit analog-to-digital converters (ADCs)
 - 3.042 μs for first 10- or 12-bit ADC conversion
 - 2.5 μs for subsequent 10- or 12-bit ADC conversions
 - Up to 28 analog inputs (internal and external) per ADC
 - Output formatted in 12-, 10-, or 8-bit right-justified unsigned format
 - Single or continuous conversion (automatic return to idle after single conversion)
 - Configurable sample time and conversion speed/power
 - Conversion complete flag and interrupt
 - Input clock selectable from up to four sources
 - Operation in wait or stop modes for lower noise operation
 - Asynchronous clock source for lower noise operation
 - Can be configured to take two samples (with no software reconfiguration required) based on hardware triggers during ping-pong mode
 - Support simultaneous and software-triggering conversions
 - Automatic compare with interrupt for less-than, or greater-than or equal-to, programmable value
 - Temperature sensor
- Two differential programmable gain amplifiers (PGA)
 - Sampled PGA architecture
 - Common mode noise and offset are automatically cancelled out (2–4 consecutive samples required for noise/offset cancellation)
 - Sample is able to be synchronized with PWM operation by using the PWM sync output and programmable delay block
 - Sampling time can be precisely controlled (to less than 0.1 μs)
 - Several programmable gains $(1\times, 2\times, 4\times, 8\times, 16\times, \text{ and } 32\times)$
 - 0.14 MSPS maximum
 - Selectable tradeoff for slower/low power versus faster/more power
 - Rail-to-rail input voltage range
 - Single-ended output routed directly to on-chip ADCs ANA15 and ANB15
- Available software and hardware triggers
- Includes additional calibration features:
 - Offset calibration eliminates any errors in the internal reference used to generate the VDDA/2 output center point
 - Gain calibration can be used to verify the gain of the overall data path
 - Both features require software correction of the ADC result
- One high-speed serial communication interface (SCI) with LIN slave functionality

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Device Overview

- Max baud rate of 6 Mbit/s when using 3× system clock at up to 96 MHz.
- Full-duplex or single-wire operation
- Two receiver wake-up methods:
 - Idle line
 - Address mark
- One serial peripheral interface (SPI)
 - Full-duplex operation
 - Master and slave modes
 - Programmable Length Transactions (2 to 16 bits)
 - Programmable transmit and receive shift order (MSB as first or last bit transmitted)
 - Maximum slave module frequency = module clock frequency/2
- One dual-channel 16-bit multi-purpose timer module (TMR)
 - Up to 96 MHz operating clock
 - Two independent 16-bit counter/timers with cascading capability
 - Each timer has capture and compare capability
 - Up to 12 operating modes
 - Four external inputs and two external outputs
- One programmable interval timer (PIT)
 - 16-bit counter with programmable counter modulo
 - Interrupt capability
- Real-time counter (RTC) which can be used to implement a real-time clock
 - 8-Bit up-counter
 - Three software-selectable clock sources for input to prescaler with selectable binary-based and decimal-based divider values
 - 1 kHz internal low-power oscillator
 - External crystal oscillator/external clock source
 - System bus (IPBus up to 32 MHz)
- One 16-bit programmable delay block (PDB)
 - 16-bit counter with programmable counter modulo and delay time
 - Counter is initiated by positive transition of internal or external trigger pulse
 - Supports two independently controlled delay pulses used to synchronize PGA and ADC conversions with input
 - trigger event
 - Two PDB outputs can be ORed together to schedule two conversions from one input trigger event
 - PDB outputs can be used to schedule precise edge placement for a pulsed output that generates the control signal for the CMP windowing comparison
 - Supports continuous or single-shot mode

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- Supports Bypass mode
- One inter-integrated circuit (I²C) port
 - Operates up to 400 kbps
 - Supports both master and slave operation
 - Supports both 10-bit address mode and broadcasting mode
 - Supports System Management Bus (SMBus) version 2
- Computer operating properly (COP)/watchdog timer capable of selecting different clock sources
 - Programmable prescaler and timeout period
 - Programmable wait, stop, and partial power-down mode operation
 - Causes a loss of reference reset 128 cycles after a loss of the reference clock to the PLL is detected
 - Choice of clock sources from four sources in support of EN60730 and IEC61508:
 - On-chip relaxation oscillator
 - External crystal oscillator/external clock source
 - System clock (IPBus)
 - On-chip low-power 1 kHz oscillator
- Clock sources
 - On-chip 8 MHz relaxation oscillator
 - On-chip 1 kHz clock
 - External clock (32 kHz or 8 MHz): crystal oscillator, ceramic resonator, and external clock source
- Phase lock loop (PLL) provides a high-speed clock to the core and peripherals
 - Provides 3x system clock to PWM, dual timer, and SCI
 - Loss of lock interrupt
 - Loss of reference clock interrupt
- Three analog comparators (CMPs)
 - Selectable input source includes external pins, internal DACs
 - Programmable output polarity
 - Output can drive timer input, PWM fault input, PWM source, external pin output, and trigger ADCs
 - Output falling- and rising-edge detection able to generate interrupts
- Up to 40 general-purpose I/O (GPIO) pins
 - Individual setting of each pin in peripheral or GPIO mode
 - Individual input/output direction control for each pin in GPIO mode
 - Hysteresis and configurable pullup device on all input pins
 - Configurable slew rate and drive strength and optional input low-pass filters on all output pins
 - 20 mA sink/source current
- Power management controller (PMC)

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Device Overview

- On-chip regulator for digital and analog circuitry to lower cost and reduce noise
- Integrated power-on reset (POR)
- Low-voltage interrupt with a user-selectable trip voltage of 1.81 V or 2.31 V
- Selectable brown-out reset
- RUN, WAIT, and STOP modes
- Low-power RUN, WAIT, and STOP modes
- Partial Power Down mode
 - RAM, PMC, and COP remain powered
 - Rest of the chip is shut down for extreme power savings
- Each peripheral can be individually disabled to save power
- Integrated 1 kHz oscillator
- JTAG/EOnCE debug programming interface for real-time debugging
 - IEEE 1149.1 Joint Test Action Group (JTAG) interface
 - EOnCE interface for real-time debugging

1.7 System Clock Generation and Distribution

1.7.1 Clock Generation

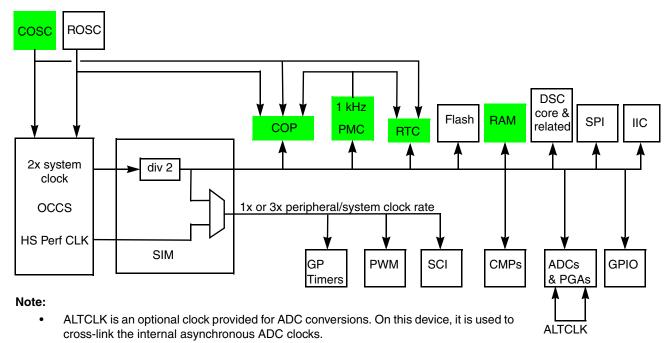
The MC56F8006 has numerous options for clock generation:

- On-chip relaxation oscillator (ROSC). This module nominally generates an 8 MHz clock signal. It is also capable of operating at 400 kHz when the device is in low-power mode.
- Very low power (VLP) crystal oscillator (COSC). This VLP module is designed for use with a 32 kHz crystal (low range mode), or a crystal or resonator in the 1 to 16 MHz range (high range mode). When used with the on-chip PLL, the maximum crystal/resonator frequency is 10 MHz.
- Off-chip external oscillator.
- 1 kHz low-power oscillator. This clock may be used by the COP module to wake the device from partial power down mode.
- Asynchronous ADC clock sources. There are two, one for each ADC hard block. They may be used to schedule ADC conversions asynchronously from the system clocks to reduce noise.
- The JTAG port is clocked asynchronously from the rest of the chip using the TCK signal supplied from off-chip.

1.7.2 Clock Distribution

Figure 1-3 illustrates how the various clock frequencies are used on the device.

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- All peripheral clocks can be individually gated off within the SIM
- The COSC, COP, PMC and RTC all continue to operate in partial power down mode. Both COP and RTC can signal the PMC to exit PPD mode.

Figure 1-3. System Clock Distribution Diagram

The external oscillator, COSC, and ROSC can all be used as the PLL reference clock to generate 2x system clock. This signal runs at 2× the DSC core frequency. It is divided by two within the SIM to ensure a 50% duty cycle for clocks distributed across the chip. The external oscillator, COSC, and ROSC can also be used as 2x system clock directly.

1.7.3 Communication Between Peripherals

Peripherals are optimized for specific applications, and in many cases, their integration on-chip is optimized as well. This section outlines the communication between various peripherals on this device.

The two general-purpose timers can access the outputs of the three comparators (CMP0_OUT, CMP1_OUT, and CMP2_OUT) as T0, T1, and TIN2 respectively. The muxing is controlled via the peripheral pin enable registers in the SIM. T0 and T1 timer pins can operate as either timer input or output pins. TIN2 and TIN3 are input pins only.

The HSCMP WINDOW/SAMPLE input can be supplied from PDB TriggerA/B or Timer 0/1 outputs. Muxing is controlled via internal peripheral select registers in the SIM.

The SCI, SPI, IIC are stand alone communications peripherals and do not communicate with other blocks on chip.

Each ADC contains a temperature sensor. Outputs of temperature sensors, PGAs, on-chip regulators, and VDDA are internally routed to the ADC inputs.

• Internal PGA0 output is available on ANA15

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Device Overview

- Internal PGA0 positive input calibration voltage is available on ANA16
- Internal PGA0 negative input calibration voltage is available on ANA17
- Internal PGA1 output is available on ANB15
- Internal PGA1 positive input calibration voltage is available on ANB16
- Internal PGA1 negative input calibration voltage is available on ANB17
- ADCA temperature sensor is available on ANA26
- ADCB temperature sensor is available on ANB26
- Output of on-chip digital voltage regulator is routed to ANA24 and ANB24
- Output of on-chip analog voltage regulator is routed to ANA25 and ANB25
- VDDA is routed to ANA27 and ANB27

The comparators, timers, and PWM_reload_sync output can be connected to the programmable delay block (PDB) trigger input. The PDB pre-trigger A and trigger A outputs are connected to the ADCA and PGA0 hardware trigger inputs. The PDB pre-trigger B and trigger B outputs are connected to the ADCB and PGA1 hardware trigger inputs. When the input trigger of PDB is asserted, PDB trigger and pre-trigger outputs are asserted after a delay of a pre-programmed period.

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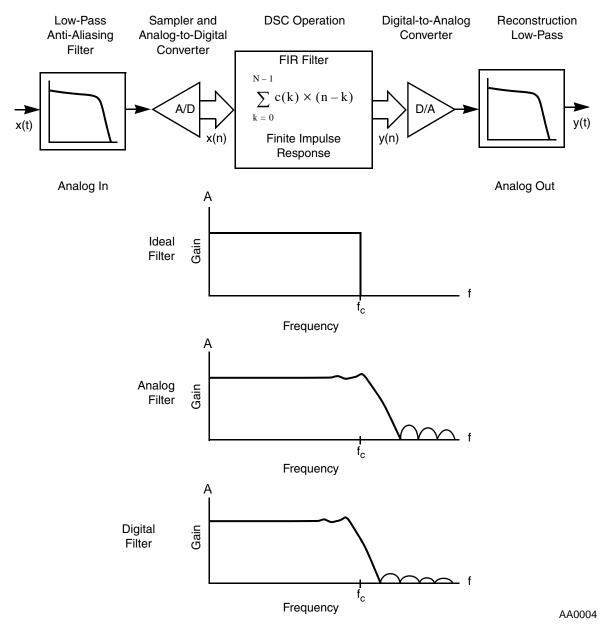


Figure 1-4. Digital Signal Processing

Processing in this circuit begins by band-limiting the input signal with an anti-alias filter, eliminating out-of-band signals that can be aliased back into the pass band due to the sampling process. The signal is then sampled, digitized with an ADC, and sent to the DSC. The filter implemented by the DSC is strictly a matter of software. The DSC can directly employ any filter that can also be implemented using analog techniques. Also, adaptive filters can be easily put into practice using DSC, whereas these filters are extremely difficult to implement using analog techniques. Similarly, compression can also be implemented on a DSC. The DSC output is processed by a DAC and is low-pass filtered to remove the effects of digitizing.

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1.7.4 **Key DSC Attributes**

The key attributes of a DSC are:

- Multiply-accumulate (MAC) operations sustained at one cycle per MAC, including memory accesses
- Fetching up to two operands per instruction cycle for the MAC
- Program control to provide versatile operation and zero overhead looping
- Input/output to move data in and out of the DSC

These are shown schematically in Figure 1-5.

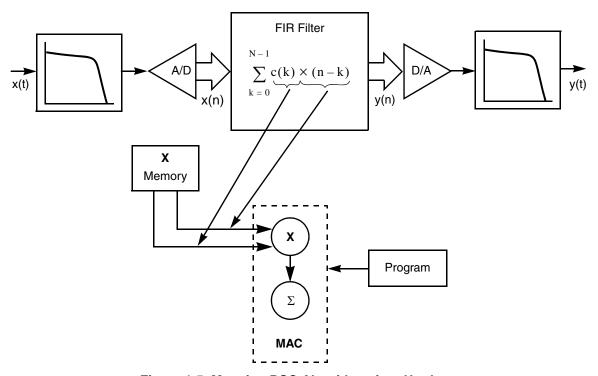


Figure 1-5. Mapping DSC Algorithms into Hardware

The multiply-accumulation (MAC) operation is the fundamental operation used in DSP. The core of the MC56F8006 series has a dual Harvard architecture optimized for MAC operations. The two operands shown in Figure 1-5, c() and x(), are directed to a multiply operation, and the result is summed. This process is built into the chip by allowing two separate data-memory accesses to feed a single-cycle MAC. The entire process must occur under program control to direct the correct operands to the multiplier and save the accumulated result as needed. Because the memory and the MAC are independent, the DSC can perform two memory moves, a multiply and an accumulate, and two address updates in a single operation cycle. As a result, DSP and MCU benchmarks execute very efficiently.

1.7.5 Advantages of DSC

The advantages of using the DSC include the following:

Fewer components

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- Stable, deterministic performance
- No analog filter adjustments
- Wide range of applications
- Filters with much closer tolerances
- High noise immunity
- Adaptive filters easily implemented
- Self-test can be built in
- Better power-supply rejection

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Device Overview

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Chapter 2 Analog-to-Digital Converter (ADC)

2.1 Introduction

The 12-bit analog-to-digital converter (ADC) is designed for operation with a DSC.

2.1.1 Features

Features of the ADC module include:

- Input voltage values may range from V_{SSA} to V_{DDA}.
- Up to 28 analog inputs.
- Output formatted in 12-, 10- or 8-bit right-justified format.
- Single or continuous conversion (automatic return to idle after single conversion).
- Configurable sample time and conversion speed/power.
- Conversion complete flag and interrupt.
- Input clock selectable from up to four sources.
- Operation in wait or stop modes for lower noise operation.
- Asynchronous clock source for lower noise operation.
- Support of simultaneous and software triggering conversions.
- Temperature sensors that are routed to ANA26 and ANB26.
- Can be configured to take two samples (with no software reconfiguration required) based on hardware triggers during ping-pong mode.

2.1.2 Related Material

This block interfaces directly with the programmable gain amplifier and programmable delay block. See Chapter 5, "Programmable Delay Block (PDB)," for additional information.

2.1.3 Block Diagram

Figure 2-1 provides a block diagram of the ADC module.

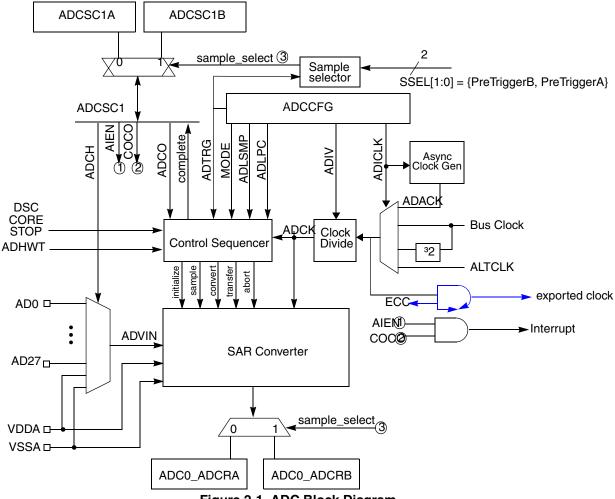


Figure 2-1. ADC Block Diagram

2.2 External Signal Description

The ADC module supports up to 28 separate analog inputs.

Table 2-1. Signal Properties

Name	Function
AD27–AD0	Analog Channel inputs

2.2.1 Analog Channel Inputs (ADn)

The ADC module supports up to 28 separate analog inputs. An input is selected for conversion through the ADCH channel select bits.

2.3 Register Definition

Memory mapped registers shown in Table 2-2 control and monitor operation of the ADC.

Address Register Name Description Offset ADC0_ADCSC1A 0x0Status and control register 1A Status and control register ADC0 ADCSC2 0x1Reserved 0x2 Reserved 0x3 Reserved 0x4 Reserved 0x5 ADC0_ADCCFG Configuration register 0x6 Reserved 0x7 Reserved 0x8 Reserved 0x9 ADC0_ADCSC1B Status and control register 1B 0xA ADC0 ADCRA Data result register A 0xB ADC0_ADCRB 0xC Data result register B Reserved 0xD Reserved 0xE

Table 2-2. ADC Registers

2.3.1 Status and Control Register 1A and 1B (ADC0_ADCSC1A and ADC0_ADCSC1B)

This section describes the function of the ADC status and control registers, ADC0_ADCSC1A and ADC0_ADCSC1B. These registers have identical fields, and are used in a "ping-pong" approach to control ADC operation. At any one point in time, only one of ADC0_ADCSC1A and ADC0_ADCSC1B is actively controlling the ADC analog core. It is possible to write to ADC0_ADCSC1A while ADC0_ADCSC1B is driving a conversion, and vice-versa. Writing ADC0_ADCSC1A while it is actively controlling a conversion aborts the current conversion and initiates a new conversion (if the ADCH bits are equal to a value other than all 1s). The same applies to ADC0_ADCSC1B.

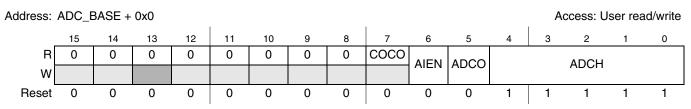


Figure 2-2. Status and Control Register 1A (ADC0_ADCSC1A)

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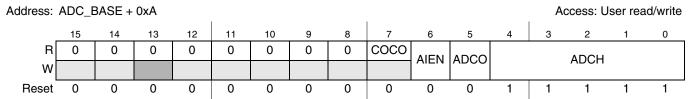


Figure 2-3. Status and Control Register 1B (ADC0_ADCSC1B)

Table 2-3. ADC0_ADCSC1A/B Register Field Descriptions

Field	Description
15–8	Reserved. Read and write as zero
7 COCO	Conversion Complete Flag. The COCO flag is a read-only bit that is set each time a conversion is completed when the compare function is disabled (ACFE = 0). When the compare function is enabled (ACFE = 1) the COCO flag is set upon completion of a conversion only if the compare result is true. This bit is cleared whenever ADCSC1 is written or whenever ADCRL is read. 0 Conversion not completed 1 Conversion completed
6 AIEN	Interrupt Enable. AIEN is used to enable conversion complete interrupts. When COCO becomes set while AIEN is high, an interrupt is asserted. O Conversion complete interrupt disabled Conversion complete interrupt enabled
5 ADCO	Continuous Conversion Enable. ADCO is used to enable continuous conversions. O One conversion following a write to the ADCSC1 when software triggered operation is selected, or one conversion following assertion of ADHWT when hardware triggered operation is selected. Continuous conversions initiated following a write to ADCSC1 when software triggered operation is selected. Continuous conversions are initiated by an ADHWT event when hardware triggered operation is selected.
4–0 ADCH	Input Channel Select. The ADCH bits form a 5-bit field that is used to select one of the input channels. The input channels are detailed in Figure 2-4. The analog-to-digital converter subsystem is turned off when the channel select bits are all set to 1. This feature allows for explicit disabling of the ADC and isolation of the input channel from all sources. Terminating continuous conversions this way prevents an additional, single conversion from being performed. It is not necessary to set the channel select bits to all 1s to place the ADC in a low-power state when continuous conversions are not enabled because the module automatically enters a low-power state when a conversion completes.

Table 2-4. Input Channel Select

ADCH	Input Select
00000	AD0
00001	AD1
00010	AD2
00011	AD3
00100	AD4
00101	AD5
00110	AD6

ADCH	Input Select
10000	AD16
10001	AD17
10010	AD18
10011	AD19
10100	AD20
10101	AD21
10110	AD22

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ADCH	Input Select
00111	AD7
01000	AD8
01001	AD9
01010	AD10
01011	AD11
01100	AD12
01101	AD13
01110	AD14
01111	AD15

ADCH	Input Select
10111	AD23
11000	AD24
11001	AD25
11010	AD26
11011	AD27
11100	Reserved
11101	V _{REFH}
11110	V _{REFL}
11111	Module disabled

2.3.2 Status and Control Register 2 (ADC0_ADCSC2)

The ADC0_ADCSC2 register is used to control the conversion trigger and conversion active of the ADC module

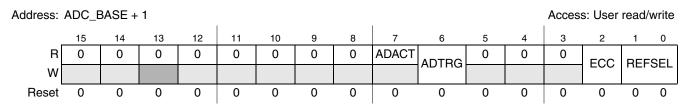


Figure 2-4. Status and Control Register 2 (ADC0_ADCSC2)

Table 2-5. ADC0_ADCSC2 Register Field Descriptions

Field	Description
15–0	Reserved. Read and write as zero
7 ADACT	Conversion Active. ADACT indicates that a conversion is in progress. ADACT is set when a conversion is initiated and cleared when a conversion is completed or aborted. O Conversion not in progress Conversion in progress
6 ADTRG	Conversion Trigger Select. ADTRG is used to select the type of trigger to be used for initiating a conversion. Two types of trigger are selectable: software trigger and hardware trigger. When software trigger is selected, a conversion is initiated following a write to ADCSC1. When hardware trigger is selected, a conversion is initiated following the assertion of the ADHWT input. O Software trigger selected Hardware trigger selected

Table 2-5. ADC0_ADCSC2 Register Field Descriptions (continued)

Field	Description
5–3	Reserved. Read and write as zero
2 ECC	Enable Continuous Clock output. This bit gates the exported clock output of the ADC module. Set to zero to conserve power if the ADC clock output is not required by other on-chip devices. Output clock is forced inactive Output clock is enabled

2.3.3 Data Result Registers A and B (ADC0_ADCRA and ADC0_ADCRB)

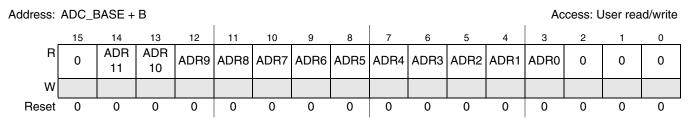


Figure 2-5. Data Result Register (ADC0_ADCRA)



Figure 2-6. Data Result Register (ADC0 ADCRB)

In 12-bit operation, ADCR[14:3] contains the full 12-bit conversion result. In 10-bit mode, ADCR[12:3] contains the 10-bit conversion result and ADR[14:13] are both zero. Likewise, when configured for 8-bit mode, the result is in ADR[10:3] and ADR[14:11] are zero.

ADCR is updated each time a conversion completes.

In the case that the MODE bits are changed, any data in ADCR becomes invalid.

2.3.4 Configuration Register (ADC0_ADCCFG)

ADCCFG is used to select the mode of operation, clock source, clock divide, and configure for low power or long sample time.

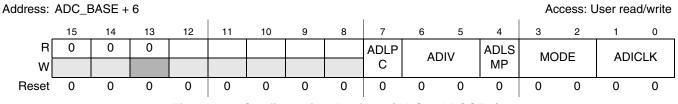


Figure 2-7. Configuration Register (ADC0_ADCCFG)

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Table 2-6. ADC0_ADCCFG Register Field Descriptions

Field	Description
7 ADLPC	Low Power Configuration. ADLPC controls the speed and power configuration of the analog-to-digital converter. This is used to optimize power consumption when higher sample rates are not required. O High speed configuration Low power configuration: The power is reduced at the expense of maximum clock speed.
6, 5 ADIV	Clock Divide Select. ADIV select the divide ratio used by the ADC to generate the internal clock ADCK. Table 2-7 shows the available clock configurations.
4 ADLSMP	Long Sample Time Configuration. ADLSMP selects between long and short sample time. This adjusts the sample period to allow higher impedance inputs to be accurately sampled or to maximize conversion speed for lower impedance inputs. Longer sample times can also be used to lower overall power consumption when continuous conversions are enabled if high conversion rates are not required. O Short sample time Long sample time
3, 2 MODE	Conversion Mode Selection. MODE bits are used to select between 12-, 10- or 8-bit operation. See Table 2-8.
1, 0 ADICLK	Input Clock Select. ADICLK bits select the input clock source to generate the internal clock ADCK. See Table 2-9.

Table 2-7. Clock Divide Select

ADIV	Divide Ratio	Clock Rate
00	1	Input clock
01	2	Input clock ÷ 2
10	4	Input clock ÷ 4
11	8	Input clock ÷ 8

Table 2-8. Conversion Modes

MODE	Mode Description
00	8-bit conversion (N=8)
01	12-bit conversion (N=12)
10	10-bit conversion (N=10)
11	Reserved

Table 2-9. Input Clock Select

ADICLK	Selected Clock Source
00	Bus clock
01	Bus clock divided by 2
10	Alternate clock (ALTCLK)
11	Asynchronous clock (ADACK)

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2.4 Functional Description

The ADC module is disabled during reset or when the ADCH bits are all high. The module is idle when a conversion has completed and another conversion has not been initiated. When idle, the module is in its lowest power state.

The ADC can perform an analog-to-digital conversion on any of the software selectable channels. In 12-bit and 10-bit mode, the selected channel voltage is converted into a 12-bit digital result. In 8-bit mode, the selected channel voltage is converted into a 9-bit digital result.

When the conversion is completed, the result is placed in the data register. In 10-bit mode, the result is rounded to 10 bits and placed in the data register. In 8-bit mode, the result is rounded to 8 bits and placed in ADCR. The conversion complete flag (COCO) is then set and an interrupt is generated if the conversion complete interrupt has been enabled (AIEN = 1).

2.4.1 Clock Select and Divide Control

One of four clock sources can be selected as the clock source for the ADC module. This clock source is then divided by a configurable value to generate the input clock to the converter (ADCK). The clock is selected from one of the following sources by means of the ADICLK bits.

- The bus clock, which is equal to the frequency at which software is executed. This is the default selection following reset.
- The bus clock divided by 2. For higher bus clock rates, this allows a maximum divide by 16 of the bus clock.
- The asynchronous clock (ADACK) This clock is generated from a clock source within the ADC module. When selected as the clock source this clock remains active while the DSC core is in wait or LPstop mode and allows conversions in these modes for lower noise operation.

Whichever clock is selected, its frequency must fall within the specified frequency range for ADCK. If the available clocks are too slow, the ADC does not perform according to specifications. If the available clocks are too fast, then the clock must be divided to the appropriate frequency. This divider is specified by the ADIV bits and can be divide-by 1, 2, 4, or 8.

2.4.2 Hardware Trigger

The ADC module has a selectable asynchronous hardware conversion trigger, ADHWT, that is enabled when the ADTRG bit is set. See Figure 3-10 for how ADHWT is used to interface to the PGA.

When hardware trigger is enabled (ADTRG=1), a conversion is initiated on the rising edge of ADHWT. If a conversion is in progress when a rising edge occurs, the rising edge is ignored. In continuous convert configuration, only the initial rising edge to launch continuous conversions is observed. The hardware trigger function operates in conjunction with any of the conversion modes and configurations.

Figure 2-1 includes the following code segment to describe the operation of the sample select function:

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This implies that ADC0_ADSCS1A and ADC0_ADCRA are used whenever hardware triggering is not in use. When hardware triggering IS used, then edges on SSEL[1:0] determine which set of control/result registers is used. A positive edge on SSEL[0] but not on SSEL[1] selects ADC0_ADSCS1A / ADC0_ADCRA. A positive edge on SSEL[1] but not on SSEL[0] selects ADC0_ADSCS1B / ADC0_ADCRB. Simultaneous changes on both SSEL[1] and SSEL[0] result in no change to the currently selected control/register set.

In essence, SSEL[1:0] act as control bits to pre-specify the control/result registers to use for the next conversion.

2.4.3 Conversion Control

Conversions can be performed in 12-bit mode, 10-bit mode, or 8-bit mode as determined by the MODE bits. Conversions can be initiated by either a software or hardware trigger. In addition, the ADC module can be configured for low power operation, long sample time, and continuous conversion.

2.4.3.1 Initiating Conversions

A conversion is initiated:

- Following a write to ADCSC1 (with ADCH bits not all 1s) if software triggered operation is selected.
- Following a hardware trigger (ADHWT) event if hardware triggered operation is selected.
- Following the transfer of the result to the data registers when continuous conversion is enabled.

If continuous conversions are enabled a new conversion is automatically initiated after the completion of the current conversion. In software triggered operation, continuous conversions begin after ADCSC1 is written and continue until aborted. In hardware triggered operation, continuous conversions begin after a hardware trigger event and continue until aborted.

2.4.3.2 Completing Conversions

A conversion is completed when the result of the conversion is transferred into the data result register, ADCRADC. This is indicated by the setting of COCO. An interrupt is generated if AIEN is high at the time that COCO is set.

2.4.3.3 Aborting Conversions

Any conversion in progress is aborted when:

- A write to ADCSC1 occurs (the current conversion is aborted and a new conversion is initiated if ADCH are not all 1s).
- A write to ADCSC2, ADCCFG, or ADCCV occurs. This indicates a mode of operation change has occurred and the current conversion is therefore invalid. No new conversion is initiated.
- The DSC core is reset.

Analog-to-Digital Converter (ADC)

• The DSC core enters stop mode with ADACK not enabled.

When a conversion is aborted, the contents of the data registers, ADC0_ADCRA/B, are not altered but continue to be the values transferred after the completion of the last successful conversion. In the case that the conversion was aborted by a reset, ADCR returns to its reset state.

2.4.3.4 Power Control

The ADC module remains in its idle state until a conversion is initiated. If ADACK is selected as the conversion clock source, the ADACK clock generator is also enabled.

Power consumption can be reduced by setting ADLPC. This results in a lower maximum value for f_{ADCK}.

2.4.3.5 Sample Time and Total Conversion Time

The total conversion time depends on the sample time (as determined by ADLSMP), the IP bus frequency, the conversion mode (8-bit, 10-bit or 12-bit), and the frequency of the conversion clock (f_{ADCK}). After the module becomes active, sampling of the input begins. ADLSMP is used to select between short (3.5 ADCK cycles) and long (23.5 ADCK cycles) sample times. When sampling is complete, the converter is isolated from the input channel and conversion is performed to determine the digital value of the analog signal. The result of the conversion is transferred to ADCR upon completion of the conversion.

If the bus frequency is less than the f_{ADCK} frequency, precise sample time for continuous conversions cannot be guaranteed when short sampling is enabled (ADLSMP=0). If the bus frequency is less than 1/11th of the f_{ADCK} frequency, precise sample time for continuous conversions cannot be guaranteed when long sampling is enabled (ADLSMP=1).

The maximum total conversion time for different conditions is summarized in Table 2-10.

Conversion Type ADICLK ADLSMP Max Total Conversion Time Single or first continuous 8-bit 0x, 10 0 20 ADCK cycles + 5 bus clock cycles Single or first continuous 10-bit or 12-bit 0x, 10 0 23 ADCK cycles + 5 bus clock cycles Single or first continuous 8-bit 0x, 10 1 40 ADCK cycles + 5 bus clock cycles 43 ADCK cycles + 5 bus clock cycles Single or first continuous 10-bit or 12-bit 0x, 10 1 Single or first continuous 8-bit 11 0 5 μs + 20 ADCK + 5 bus clock cycles 0 5 μs + 23 ADCK + 5 bus clock cycles Single or first continuous 10-bit or 12-bit 11 Single or first continuous 8-bit 11 1 $5 \mu s + 40 ADCK + 5 bus clock cycles$ Single or first continuous 10-bit or 12-bit 5 μs + 43 ADCK + 5 bus clock cycles 11 1 Subsequent continuous 8-bit; 0 17 ADCK cycles ХX $f_{BUS} \ge f_{ADCK}$ Subsequent continuous 10-bit or 12-bit; XX 0 20 ADCK cycles $f_{BUS} \ge f_{ADCK}$

Table 2-10. Total Conversion Time vs. Control Conditions

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Conversion Type	ADICLK	ADLSMP	Max Total Conversion Time
Subsequent continuous 8-bit; $f_{BUS} \ge f_{ADCK}/11$	xx	1	37 ADCK cycles
Subsequent continuous 10-bit or 12-bit; $f_{BUS} \ge f_{ADCK}/11$	XX	1	40 ADCK cycles

Table 2-10. Total Conversion Time vs. Control Conditions (continued)

The maximum total conversion time is determined by the clock source chosen and the divide ratio selected. The clock source is selectable by the ADICLK bits, and the divide ratio is specified by the ADIV bits. For example, in 10-bit mode, with the bus clock selected as the input clock source, the input clock divide-by-1 ratio selected, and a bus frequency of 8 MHz, then the conversion time for a single conversion is:

Eqn. 2-1

Conversion time =
$$\frac{23 \text{ ADCK Cyc}}{8 \text{ MHz/1}} + \frac{5 \text{ bus Cyc}}{8 \text{ MHz}} = 3.5 \text{ ms}$$

Number of bus cycles = 3.5 ms x 8 MHz = 28 cycles

NOTE

The ADCK frequency must be between f_{ADCK} minimum and f_{ADCK} maximum to meet ADC specifications.

2.4.4 Temperature Sensor

Each ADC module includes a temperature sensor whose output is connected to one of the ADC analog channel inputs. Equation 2-2 provides an approximate transfer function of the temperature sensor.

Temp = 25 -
$$((V_{TEMP} - V_{TEMP25}) \div m)$$
 Eqn. 2-2

where:

V_{TEMP} is the voltage of the temperature sensor channel at the ambient temperature.

 V_{TEMP25} is the voltage of the temperature sensor channel at 25°C.

m is the hot or cold voltage versus temperature slope in V/°C.

For temperature calculations, use the V_{TEMP25} and m values from the ADC Electricals table in the data sheet.

In application code, the user reads the temperature sensor channel, calculates V_{TEMP} and compares to V_{TEMP25} . If V_{TEMP} is greater than V_{TEMP25} the cold slope value is applied in Equation 2-2. If V_{TEMP} is less than V_{TEMP25} the hot slope value is applied in Equation 2-2.

For more information on using the temperature sensor, consult AN3031.

2.4.5 DSC Core Wait Mode Operation

The WAIT instruction puts the DSC core in a lower power-consumption standby mode from which recovery is very fast because the clock sources remain active. If a conversion is in progress when the DSC core enters wait mode, it continues until completion. Conversions can be initiated while the DSC core is in wait mode by means of the hardware trigger or if continuous conversions are enabled.

The bus clock, bus clock divided by two, and ADACK are available as conversion clock sources while in wait mode.

A conversion complete event sets the COCO and generates an ADC interrupt to wake the DSC core from wait mode if the ADC interrupt is enabled (AIEN = 1).

2.4.6 DSC Core LPstop Mode Operation

The STOP instruction is used to put the DSC core in a low power-consumption standby mode during which most or all clock sources on the DSC core are disabled.

2.4.6.1 Stop Mode with ADACK Disabled

If the asynchronous clock, ADACK, is not selected as the conversion clock, executing a STOP instruction during an ADC conversion could result in unexpected behavior. Do not enter stop mode until all conversions have completed when using any clock other than ADACK.

The contents of ADCR are unaffected by stop mode. After exiting from stop mode, a software or hardware trigger is required to resume conversions.

2.4.6.2 Stop Mode with ADACK Enabled

If ADACK is selected as the conversion clock, the ADC continues operation during stop mode. The DSC's voltage regulator remains active during stop mode.

If a conversion is in progress when the DSC core enters stop mode, it continues until completion. Conversions can be initiated while the DSC core is in stop mode by means of the hardware trigger or if continuous conversions are enabled.

A conversion complete event sets the COCO and generates an ADC interrupt to wake the DSC core from stop mode if the ADC interrupt is enabled (AIEN = 1).

2.4.7 DSC Partial Power Down Mode Operation

The ADC module is automatically disabled when the DSC core enters PPD mode. All module registers contain their reset values following exit from PPD mode. Therefore, the module must be re-enabled and reconfigured following exit from PPD.

2.5 Initialization Information

This section gives an example that provides some basic direction on how a user would initialize and configure the ADC module. The user has the flexibility of choosing between configuring the module for

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8-, 10-, or 12-bit resolution, single or continuous conversion, and a polled or interrupt approach, among many other options. Refer to Table 2-7, Table 2-8, and Table 2-9 for information used in this example.

NOTE

Hexadecimal values designated by a preceding 0x, binary values designated by a preceding %, and decimal values have no preceding character.

2.5.1 ADC Module Initialization Example

2.5.1.1 Initialization Sequence

Before the ADC module can be used to complete conversions, an initialization procedure must be performed. A typical sequence is as follows:

- 1. Update the configuration register (ADC0_ADCCFG) to select the input clock source and the divide ratio used to generate the internal clock, ADCK. This register is also used for selecting sample time and low-power configuration.
- 2. Update status and control register 2 (ADC0_ADCSC2) to select the conversion trigger (hardware or software).
- 3. Update status and control register 1 (ADC0_ADCSC1) to select whether conversions are continuous or completed only once, and to enable or disable conversion complete interrupts. The input channel on which conversions are performed is also selected here.

2.5.1.2 Pseudo-code Example

In this example, the ADC module is set up with interrupts enabled to perform a single 10-bit conversion at low power with a long sample time on input channel 1, where the internal ADCK clock is derived from the bus clock divided by 1.

ADC Module Enabled Interrupts ADC0_ADCCFG = 0x98 (%10011000) Configures for low power (lowers Bit 7 **ADLPC** 1 maximum clock speed) Sets the ADCK to the input clock/1 Bit 6, 5 **ADIV** 00 Bit 4 **ADLSMP** 1 Configures for long sample time Bit 3. 2 MODE 10 Sets mode at 10-bit conversions Bit 1, 0 **ADICLK** 00 Selects bus clock as input clock source

Table 2-11. ADC Module Pseudo-code Example

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Table 2-11	ADC Module	Pseudo-code	Example	(continued)
Iabic 2-11.	ADC MOGUIC	r seudo-code		i Continu c a <i>r</i>

ADC Module	Enabled Interrupts			d Interrupts
ADC0_ADCSC2 = 0x00 (%00000000)	_	ADACT	0	Flag indicates if a conversion is in progress
	Bit 6	ADTRG	0	Software trigger selected
	Bit 5	_	0	Unimplemented or reserved, always reads zero
	Bit 4	_	0	Unimplemented or reserved, always reads zero
	Bit 3, 2	_	00	Unimplemented or reserved, always reads zero
	Bit 1, 0	_	00	Reserved for Freescale's internal use; always write zero
ADC0_ADCSC1A = 0x41 (%01000001)	Bit 7	coco	0	Read-only flag that is set when a conversion completes
	Bit 6	AIEN	1	Conversion complete interrupt enabled
	Bit 5	ADCO	0	One conversion only (continuous conversions disabled)
	Bit 4-0	ADCH	00001	Input channel 1 selected as ADC input channel
ADC0_ADCRA = xxxx	_	_	_	Holds results of conversion.

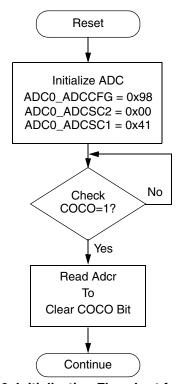


Figure 2-8. Initialization Flowchart for Example

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2.6 Application Information

This section contains information for using the ADC module in applications. The ADC has been designed to be integrated into a DSC for use in embedded control applications.

2.6.1 External Pins and Routing

The following sections discuss the external pins associated with the ADC module and how they should be used for best results.

2.6.1.1 Analog Input Pins

Conversions can be performed on inputs even when the pins are not configured for the ADC normal usage. (For example, they might be configured for GPIO.) It is recommended that the pin control register bit always be set up to use the pin as an ADC input when using a pin as an analog input. This avoids problems with contention because the output buffer is in its high impedance state and the pullup is disabled. Also, the input buffer draws DC current when its input is not at either V_{DD} or V_{SS} . Setting the pin control register bits for all pins used as analog inputs should be done to achieve lowest operating current.

Empirical data shows that capacitors on the analog inputs improve performance in the presence of noise or when the source impedance is high. Use of $0.01~\mu F$ capacitors with good high-frequency characteristics is sufficient. These capacitors are not necessary in all cases, but when used they must be placed as near as possible to the package pins and be referenced to V_{SSA} .

For proper conversion, the input voltage must fall between V_{DDA} and V_{SSA} . If the input is equal to or exceeds V_{REFH} , the converter circuit converts the signal to 0xFFF (full scale 12-bit representation), 0x3FF (full scale 10-bit representation) or 0xFF (full scale 8-bit representation). If the input is equal to or less than V_{REFL} , the converter circuit converts it to 0x000. Input voltages between V_{REFH} and V_{REFL} are straight-line linear conversions. There is a brief current associated with V_{REFL} when the sampling capacitor is charging. The input is sampled for 3.5 cycles of the ADCK source when ADLSMP is low, or 23.5 cycles when ADLSMP is high.

For minimal loss of accuracy due to current injection, pins adjacent to the analog input pins should not be transitioning during conversions.

2.6.2 Sources of Error

Several sources of error exist for A/D conversions. These are discussed in the following sections.

2.6.2.1 Sampling Error

For proper conversions, the input must be sampled long enough to achieve the proper accuracy. Given the maximum input resistance of approximately 7 k Ω and input capacitance of approximately 5.5 pF, sampling to within 1/4LSB (at 12-bit resolution) can be achieved within the minimum sample window (3.5 cycles @ 8 MHz maximum ADCK frequency) provided the resistance of the external analog source (R_{AS}) is kept below 2 k Ω .

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Higher source resistances or higher-accuracy sampling is possible by setting ADLSMP (to increase the sample window to 23.5 cycles) or decreasing ADCK frequency to increase sample time.

2.6.2.2 Pin Leakage Error

Leakage on the I/O pins can cause conversion error if the external analog source resistance (R_{AS}) is high. If this error cannot be tolerated by the application, keep R_{AS} lower than V_{DDAD} / ($2^{N*}I_{LEAK}$) for less than 1/4LSB leakage error (N=8 in 8-bit, 10 in 10-bit or 12 in 12-bit mode).

2.6.2.3 Noise-Induced Errors

System noise that occurs during the sample or conversion process can affect the accuracy of the conversion. The ADC accuracy numbers are guaranteed as specified only if the following conditions are met:

- There is a 0.1 μF low-ESR capacitor from V_{REFH} to V_{REFL}.
- There is a 0.1 μ F low-ESR capacitor from V_{DDAD} to V_{SSAD} .
- If inductive isolation is used from the primary supply, an additional 1 μF capacitor is placed from V_{DDAD} to V_{SSAD}.
- V_{SSAD} (and V_{REFL}, if connected) is connected to V_{SS} at a quiet point in the ground plane.
- Operate the DSC core in wait or LPstop mode before initiating (hardware triggered conversions) or immediately after initiating (hardware or software triggered conversions) the ADC conversion.
 - For software triggered conversions, immediately follow the write to the ADCSC1 with a WAIT instruction or STOP instruction.
 - For LPstop mode operation, select ADACK as the clock source. Operation in LPstop reduces
 V_{DD} noise but increases effective conversion time due to stop recovery.
- There is no I/O switching, input or output, on the DSC core during the conversion.

There are some situations where external system activity causes radiated or conducted noise emissions or excessive V_{DD} noise is coupled into the ADC. In these situations, or when the DSC core cannot be placed in wait or LPstop or I/O activity cannot be halted, these recommended actions may reduce the effect of noise on the accuracy:

- Place a 0.01 μ F capacitor (C_{AS}) on the selected input channel to V_{REFL} or V_{SSAD} (this improves noise issues but affects sample rate based on the external analog source resistance).
- Average the result by converting the analog input many times in succession and dividing the sum of the results. Four samples are required to eliminate the effect of a 1 LSB, one-time error.
- Reduce the effect of synchronous noise by operating off the asynchronous clock (ADACK) and averaging. Noise that is synchronous to ADCK cannot be averaged out.

2.6.2.4 Code Width and Quantization Error

The ADC quantizes the ideal straight-line transfer function into 4096 steps (in 12-bit mode). Each step ideally has the same height (1 code) and width. The width is defined as the delta between the transition points to one code and the next. The ideal code width for an N bit converter (in this case N can be 8, 10 or 12), defined as 1 LSB, is:

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Egn. 2-3

$$1LSB = (V_{REFH} - V_{REFL}) / 2^{N}$$

There is an inherent quantization error due to the digitization of the result. For 8-bit or 10-bit conversions the code transitions when the voltage is at the midpoint between the points where the straight line transfer function is exactly represented by the actual transfer function. Therefore, the quantization error is $\pm 1/2$ LSB in 8- or 10-bit mode. As a consequence, however, the code width of the first (0x000) conversion is only 1/2 LSB and the code width of the last (0xFF or 0x3FF) is 1.5 LSB.

For 12-bit conversions the code transitions only after the full code width is present, so the quantization error is -1LSB to 0LSB and the code width of each step is 1LSB.

2.6.2.5 Linearity Errors

The ADC may also exhibit non-linearity of several forms. Every effort has been made to reduce these errors but the system should be aware of them because they affect overall accuracy. These errors are:

- Zero-scale error (E_{ZS}) (sometimes called offset) This error is defined as the difference between the actual code width of the first conversion and the ideal code width (1/2 LSB in 8-bit or 10-bit modes and 1 LSB in 12-bit mode). Note, if the first conversion is 0x001, then the difference between the actual 0x001 code width and its ideal (1 LSB) is used.
- Full-scale error (E_{FS}) This error is defined as the difference between the actual code width of
 the last conversion and the ideal code width (1.5 LSB in 8-bit or 10-bit modes and 1 LSB in 12-bit
 mode). Note, if the last conversion is 0x3FE, then the difference between the actual 0x3FE code
 width and its ideal (1LSB) is used.
- Differential non-linearity (DNL) This error is defined as the worst-case difference between the actual code width and the ideal code width for all conversions.
- Integral non-linearity (INL) This error is defined as the highest-value the (absolute value of the) running sum of DNL achieves. More simply, this is the worst-case difference of the actual transition voltage to a given code and its corresponding ideal transition voltage, for all codes.
- Total unadjusted error (TUE) This error is defined as the difference between the actual transfer function and the ideal straight-line transfer function, and therefore includes all forms of error.

2.6.2.6 Code Jitter, Non-Monotonicity and Missing Codes

Analog-to-digital converters are susceptible to three special forms of error. These are code jitter, non-monotonicity, and missing codes.

Code jitter is when, at certain points, a given input voltage converts to one of two values when sampled repeatedly. Ideally, when the input voltage is infinitesimally smaller than the transition voltage, the converter yields the lower code (and vice-versa). However, even very small amounts of system noise can cause the converter to be indeterminate (between two codes) for a range of input voltages around the transition voltage. This range is normally around $\pm 1/2$ LSB in 8-bit or 10-bit mode, or around 2 LSB in 12-bit mode, and increases with noise.

This error may be reduced by repeatedly sampling the input and averaging the result. Additionally the techniques discussed in Section 2.6.2.3, "Noise-Induced Errors," reduce this error.

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Chapter 3 Programmable Gain Amplifier (PGA)

3.1 Introduction

3.1.1 Overview

The programmable gain amplifier, or PGA, is intended to operate in conjuction with the on-chip analog-to-digital converter (ADC). By itself, the PGA has no useful function. When used to pre-process ADC inputs, it amplifies and converts differential signals to a single-ended value, which is passed on to the ADC for conversion to digital format.

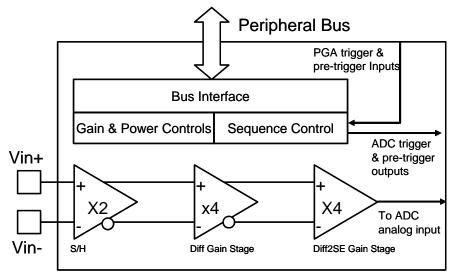


Figure 3-1. Programmable Gain Amplifier Block Diagram

Features:

- Sampled PGA architecture
- Common mode noise and offset are automatically cancelled out (2–4 consecutive samples required for noise/offset cancellation)
- Sample is able to be synchronized with PWM operation using the PWM sync output and programmable delay block
- Sampling time can be precisely controlled (to less than 0.1 µs)
- Several programmable gains $(1\times, 2\times, 4\times, 8\times, 16\times, \text{ and } 32\times)$
- 0.14 MSPS maximum
- Selectable tradeoff for slower/low power versus faster/more power

- Rail-to-rail input voltage range
- Single-ended output routed directly to on-chip ADCs ANA15 and ANB15
- Software and hardware triggers are available
- Includes additional calibration features:
 - Offset calibration eliminates any errors in the internal reference used to generate the $V_{DDA}/2$ output center point
 - Gain calibration can be used to verify the gain of the overall datapath
 - Both features require software correction of the ADC result

3.2 Definitions

Table 3-1. Definitions

Terms	Definitions
ADC	Analog-to-digital converter
PDB	Programmable delay block
PGA	Programmable gain amplifier
S/H	Sample/hold

3.3 Transfer Function

The PGA differential amplifier is a switched-capacitor (SC) circuit that amplifies a differential input signal and converts it to single-ended output. The mathematical description of the output voltage is given by:

$$V_{out} = GAIN(Vin+-Vin-) + \left(\frac{V_{DDA}}{2}\right)$$
 Eqn. 3-1

where $(V_{in+} - V_{in-})$ is the differential input voltage, V_{DDA} is the power supply voltage, and GAIN defines the amplifier gain. Also, differential stages have high immunity to both virtual ground (or differential ground) variations, and to finite gain and offset operational amplifier non-idealities.

3.4 Options for On-Chip Analog Conversions

The PGA is designed to operate as part of a larger system designed for precise conversion of analog values. Some possible configurations of on-chip components are shown in Figure 3-2.

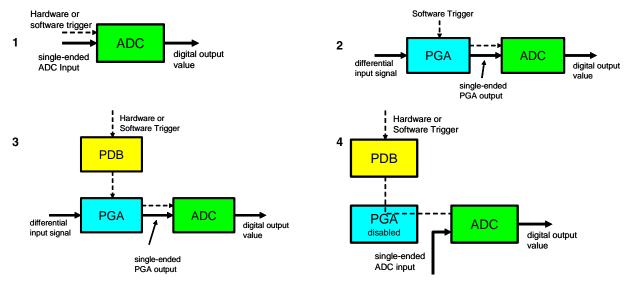


Figure 3-2. Analog Sub-System Configuration Options

Descriptions of the options listed in Figure 3-2:

- 1. ADC operating on single-ended values in isolation.
- 2. PGA preprocesses differential signal. Conversion initiated via software.
- 3. PGA preprocesses differential signal. PGA sample time is timed to either hardware or software trigger into the programmable delay counter (PDB).
- 4. The PGA analog circuitry is not used. The PDB provides timing control for ADC conversions, which the PGA passes unchanged.

In Figure 3-2, PDB stands for programmable delay block. This is a digital function designed to generate precisely timed hardware triggers for the ADC and PGA blocks.

3.5 PGA Prerequisites

When using the PGA, you must:

- Use long ADC sample times: ADCCFG[ADLSMP] = 1.
- Configure the ADC to use hardware triggering: ADCSC2[ADTRG] = 1.
- Configure the ADC to export a continuous clock source for use by the PGA: ADCSC2[ECC] = 1.
- Configure the PGA: CNTL2[ADIV] = ADC ADCCFG[ADIV]
- Not exceed sampling intervals, as specified in Table 3-2 later in this chapter.

3.6 Analog Block Diagram

Figure 3-3 illustrates the structure of the PGA analog block. A differential voltage is presented for conversion across V_{in+} and V_{in-} . During mission mode operation, these arrive at the sample/hold of the PGA. The sampling window of the PGA can be precisely placed, and has a minimum sampling aperture of 1 μ s.

Figure 3-3 shows the maximum allowable gain for each stage of the PGA. Each stage also supports lower values. The S/H stage can be programmed for gains of $1\times$ and $2\times$. The differential and differential-to-single-ended gain stages can be programmed for $1\times$, $2\times$, $3\times$, or $4\times$ gain.

Clock details are provided in Section 3.8, "PGA Clocking."

The input muxes can be used to place 0 V across ($V_{in+} - V_{in-}$), which allows measurement of offset errors associated with the S/H and virtual ground. Software can compensate for offset errors.

The charge pump is used to manage bias levels in the PGA. It is enabled automatically whenever the PGA is enabled. The recommended frequency for the charge pump is PGA/ADC clock ÷ 4. Higher frequencies tend to inject noise into PGA output, while lower frequencies tend to slow down PGA response time and corrupt its output. As shown in Figure 3-3, the charge pump clock source is divided down based on the value of CNTL1[CPD].

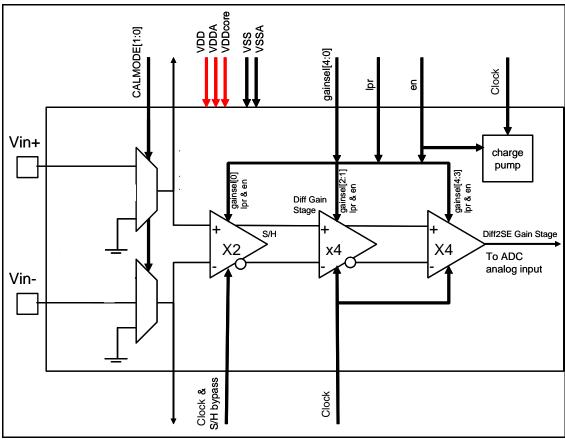


Figure 3-3. Analog Block Diagram of the PGA

The charge pump clock source is the 8 MHz oscillator reference frequency into the phase-locked loop (master clock). This frequency is divided by 2^{CPD} ; therefore CNTL1[CPD] should be programmed to 0x2.

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3.7 Dual PGA Options

This device includes two PGAs that share a common set of charge pumps and bias generators. If either PGA is enabled, those circuits are enabled. The charge pump requires a 2 MHz input clock whenever either PGA is enabled. The oscillator clock source is divided down to generate the charge pump clock based on the value of the charge pump divisor. The divisor is specified as either PGA0_CNTL1[CPD] or PGA1_CTRL1, based on the following criteria:

- PGA0_CTNL1[CPT] if only PGA0 is enabled.
- PGA1_CTNL1[CPT] if only PGA1 is enabled.
- PGA0_CTNL1[CPT] if both PGAs are enabled.

3.8 PGA Clocking

The clocks to the PGA sample/hold and gain stage both operate at a nominal duty cycle of 8/18, as shown in Figure 3-4. If high, they are high for a minimum of eight PGA clocks. When low, they are low for a minimum of ten PGA clocks. Only one of the two clocks is ever high at any one time.

The maximum PGA clock rate is 8 MHz; therefore the minimum pulse width high is 1 µs.

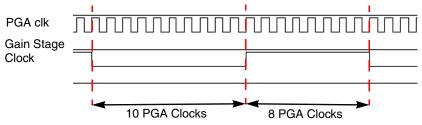


Figure 3-4. PGA Clock Generation

The sample/hold stage of the PGA is sampling when the PGA sample/hold stage clock is high. A high transition on the PGA sample/hold stage clock is initiated via either a hardware or software trigger into the PGA. The latency between the hardware trigger and the beginning of the sampling window is typically only a few clock periods. This is minimized when the system is running at 32 MHz, and the peripheral clock is used as the basis for the ADC/PGA clocks. In this case, latency is less than 0.1 µs between trigger event and the start of the sampling window. This allows precise placement of the sampling window.

Figure 3-5 shows one possible PGA conversion sequence. From top to bottom, waveforms are:

- Running indicates that the PGA is converting a signal.
- PGA trigger this is the signal to the PGA that an analog value needs to be processed. This pulse can be the result of either hardware or software triggers.
- PGA clk the PGA clock is restarted from the off condition when a trigger event is detected. PGA
 clk is derived from the same clock source used by the corresponding ADC channel. This may be
 asynchronous to the standard peripheral clock.
- PGA sample/hold stage clock is high only during the sample interval for the S/H stage.
- Gain stage clock when operating with short, non-periodic signals, there are offset and noise benefits in clocking the gain and differential to single-ended stages of the PGA multiple times for

each sample taken by the S/H stage. In the case shown, these stages are clocked four times. During the fourth period, the gain stage clock is held high for a total of 36 PGA clock cycles.

- ADC trigger issued at the beginning of the last gain stage clock high phase, this signal is used as a hardware trigger to the ADC, which must sample the PGA output while the gain stage clock remains high.
- Done signifies that the PGA has completed operation. The output of the PGA is no longer guaranteed to be valid, and the PGA clock is shut back down.

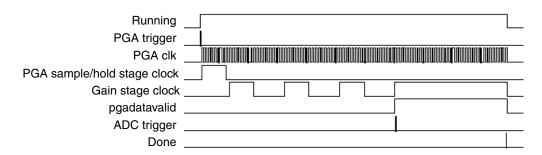


Figure 3-5. PGA Clock Sequencing 4:1

When operated in conjunction with the PGA, the ADC must be programmed to use its "long sampling time." This is 23.5 ADC clock periods long. Because the PGA and ADC clocks operate at the same frequency (although out of phase), there is more than sufficient time for the ADC to sample the PGA output during the final PGA gain stage clock high phase, which is 36 PGA clock periods long.

CNTL2[NUM_CLK_GS] specifies how many times the gain and differential to single-ended stages are clocked per conversion. Overclocking these stages results in improved offset and noise performance when sampling waveforms such as that shown in Figure 3-6. This is an example of a non-periodic waveform of short duration. In this case, the S/H stage can obtain a valid sample which is centered within the 2 µs signal being sampled. Clocking the gain and differential to single-ended multiple times allows those stages to use correlated-double-sampling techniques on the output of the S/H to reduce their offset error.

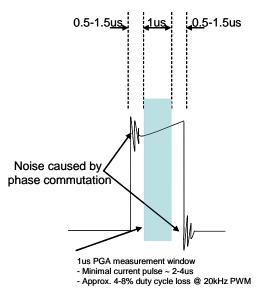


Figure 3-6. Targeted Sample Window

Overclocking is not required when using the PGA/ADC to perform continuous conversions of signals that meet the bandwidth limitations listed in the device data sheet.

A minimum of 2× overclocking should be used if not continuously sampling the input signal. This is because two clocks are required to propagate the signal through both the gain and differential to single-ended stages. This restriction applies even for low bandwidth signals.

Figure 3-5 illustrates the case where CNTL2[NUM_CLK_GS] has a value of 0x3, which corresponds to four assertions of the gain stage clock per conversion.

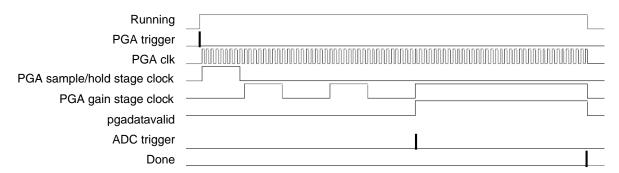


Figure 3-7. PGA Clock Sequencing 3:1

Figure 3-7 illustrates the case where CNTL2[NUM_CLK_GS] has a value of 0x2, which corresponds to three assertions of the PGA gain stage clock per conversion.

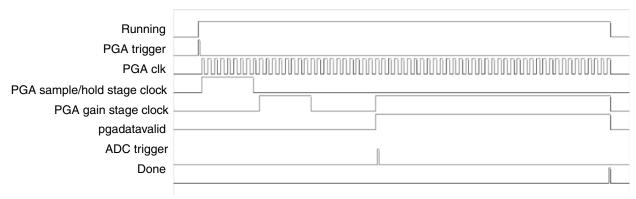


Figure 3-8. PGA Clock Sequencing 2:1

Figure 3-8 illustrates the case where CNTL2[NUM_CLK_GS] has a value of 0x1, which corresponds to two assertions of clk_gs per conversion.



Figure 3-9. PGA Clock Sequencing 1:1

Figure 3-9 illustrates the case where CNTL2[NUM_CLK_GS] has a value of 0x0, which corresponds to one assertion of PGA gain stage clock per conversion.

3.9 Effects on ADC Latency

Inspection of Figure 3-5, Figure 3-7, Figure 3-8, and Figure 3-9 shows that the PGA adds approximately

ADC/PGA clock periods to the latency of the ADC by itself. So, at a default value of NUM_CLK_GS=3, with an 8 MHz ADC clock rate, we have

$$[12 + (18 \times 3)] \times 125 \text{ ns} = 8.25 \,\mu\text{s}$$
 additional latency Eqn. 3-3

Assuming a 12-bit conversion with long sample times by the ADC (required), the ADC conversion time is 43 ADC clock cycles + 5 pclk cycles. With 8 MHz ADC clock and 32 MHz pclk, this is 5.531 µs. So the total conversion time from triggerIn of the PGA to ADC conversion complete is 13.78 µs.

If NUM_CLK_GS is set to zero (OK when continuously sampling bandwidth limited signals), then the additional latency is only 12 ADC/PGA clock periods, or 1.5 µs. The total conversion time from triggerIn of the PGA to ADC conversion complete is only 7 µs.

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To minimize conversion latency, NUM_CLK_GS should be set to the minimum value that yields the accuracy required for a given application. To maximize conversion accuracy, set NUM_CLK_GS to the maximum value allowed by the required conversion rate. Table 3-2 below summarizes latency effects and conversion rates as a function of NUM_CLK_GS for the case when the peripheral clock rate is 32 MHz and the ADC/PGA clock rate is 8 MHz.

#	NUM_ CLK_GS	ADC Conversion Time in μs	Additional PGA clocks required	Latency Adder Due to PGA in μs	Total Conversion Time	Max PGA/ADC Conversions/Sec
1	N/A	5.53125	0	0	5.53125	180790
2	0	5.53125	12	1.5	7.03125	142222
3	1	5.53125	30	3.75	9.28125	107744
4	2	5.53125	48	6	11.53125	86721
5	3	5.53125	66	8.25	13.78125	72562
6	4	5.53125	84	10.5	16.03125	62378
7	5	5.53125	102	12.75	18.28125	54701
8	6	5.53125	120	15	20.53125	48706
9	7	5.53125	138	17.25	22.78125	43896

Table 3-2. PGA/ADC Conversion Times and Rates (32 MHz DSC Core & 8 MHz ADC/PGA)

Conversion accuracy depends on a combination of input bandwidth and NUM_CLK_GS. Higher bandwidth signals result in the higher variation in S/H output from one sample to another, and more clocks are required by GS and differential to single-ended to output an accurate signal.

3.10 ADC Triggers

The PGA is designed to operate in conjunction with the programmable delay block and analog-to-digital converter. This version of the ADC has been enhanced to allow two different conversions to be pre-programmed into the ADC, using duplicate copies of the ADC status and control register 1. Conversions specified by ADC0_ADCSC1A and ADC0_ADCSC1B can be executed one after the other as a result of two sequential trigger events. Prior to each conversion, a pre-trigger input into the ADC specifies whether ADC0_ADCSC1A or ADC0_ADCSC1B should control the next conversion. These pre-triggers occur one peripheral clock prior to the actual hardware trigger into the ADC.

Because the PGA adds latency to each analog-to-digital conversion, ADC trigger and pre-trigger timing must be adjusted accordingly. Figure 3-10 shows the PDB block and the two PGAs, each of which is associated with a separate ADC module. Notice that both ADCs get both pre-triggers. This allows simultaneous conversions on ADC 0 and ADC 1. If a PGA is not enabled for use, the associated PDB-generated pre-trigger and trigger are passed unchanged. Likewise, use of a PGA software trigger frees up the associated PDB pre-trigger for use by the other ADC. When the PGA is enabled for use with hardware triggering, it consumes the PDB-generated trigger and pre-trigger, and generates new ones for use by the ADCs.

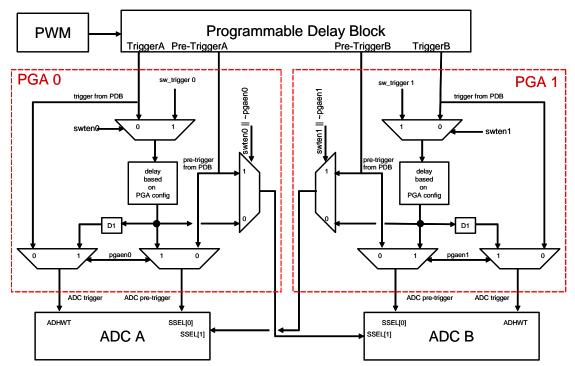


Figure 3-10. ADC Trigger/Pre-Trigger Generation

3.11 Modes of Operation

There are several modes of operation:

- Power down
- Startup
- Calibration
- Mission mode: low power
- Mission mode: high power

These, as well as implications of chip power modes on the PGA, are described in the following sections.

3.11.1 PGA Power Down

In this mode of operation, the analog block is powered down. Trigger and pre-trigger inputs are passed unchanged to the digital outputs of the PGA. Configuration one and configuration four in Figure 3-2 are consistent with this mode of operation.

3.11.2 PGA Startup

There is a delay from the time the PGA is first enabled to when it is available for conversions. During the 16 PGA (PGA sample/hold stage clock)/(PGA gain stage clock) periods immediately after setting CNTL0[EN] to 1, the PGA samples differential ground. This is equivalent to the case where CNTL1[CALMODE] = 10.

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At the end of this period, STS[STCOMP] is set, and the PGA is available for use.

3.11.3 PGA Calibration

The PGA supports these calibration methods:

- Internal offset calibration by setting CNTL1[CALMODE] to 10
- External offset calibration by connecting the PGA input pins together to the same low-noise external DC voltage reference while setting CNTL1[CALMODE] to 00
- External gain calibration by connecting the PGA input pins to a differential voltage, derived from low-noise high-accuracy external DC voltage references, while setting CNTL1[CALMODE] to 00

Operation of the PGA/ADC is otherwise unchanged. For best performance, offset and gain calibrations should be performed just after PGA startup. If PGA is disabled, or if any of its operating conditions are changed (V_{DDA}, gain, power mode, first-stage bypass, ADIV, CPD, NUM_CLK_GS, and so on), offset and gain calibrations should be repeated.

3.11.3.1 Offset Calibration — V_{Offset}

Offset calibration is enabled by setting CNTL1[CALMODE] to 10. In this mode, both PGA inputs sample differential ground (nominally $V_{DDA}/2$). From Equation 3-1 we can see that this should yield a PGA output voltage of $V_{DDA}/2$. When sampled and converted to a 12-bit value by the ADC, this should result in a binary value of 0x7FF. Any variance above or below that value represents the amount of offset present in the PGA/ADC conversion datapath.

The value of V_{Offset} , coupled with V_{Gain} (described in the next section), can be used in conjunction with Equation 3-9 to cancel gain and offset errors via a simple software calculation, described in Section 3.11.3.3, "Software Calibration."

External offset calibration is another method for measuring PGA offset errors. In this method, both PGA input pins are shorted together and connected to a common low-noise DC voltage reference, external to the chip. In this method — external offset calibration — the PGA should operate in mission mode.

3.11.3.2 Gain Calibration — V_{Gain}

Gain calibration is enabled by using the PGA/ADC to measure the resulting value, V_{Gain} . In this mode, a reference voltage of $V_{DDA}/3$ is placed between the PGA inputs.

The PGA gain must be set to $1\times$, CNTL1[GAINSEL] = 00000, to use this particular feature. The reason for this limitation becomes obvious after once again evaluating Equation 3-1:

$$V_{Out} = GAIN \times (V_{in+} - V_{in-}) + V_{DDA}/2$$

 $V_{Out} = (V_{DDA}/3) + (V_{DDA}/2)$
 $V_{Out} = (5/6) \times V_{DDA} = 0.83333 V_{DDA}$

If we used 2× PGA gain, the desired PGA output voltage would exceed the supply limits.

At this ADC input voltage, an ideal device, with zero offset and zero gain error, would yield 0xD54 as a result of a 12-bit conversion.

The value of V_{Gain} , coupled with V_{Offset} (described in the previous section), can be used in conjunction with Equation 3-9 to cancel gain and offset errors via a simple software calculation, described in Section 3.11.3.3, "Software Calibration."

3.11.3.3 Software Calibration

If we take measurements for both gain and offset errors as outlined in the previous sections, we can correct for inaccuracies in our measurement using basic interpolation.

Specific Example

Figure 3-11 illustrates both the ideal PGA/ADC transfer function, as well as a grossly exaggerated non-ideal transfer function.

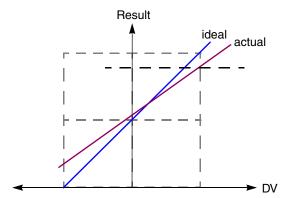


Figure 3-11. Overall ADC/PGA Transfer Function

Assuming $\Delta V = (V_{in+} - V_{in-})$, the ideal transfer function for the PGA is:

$$V_{out} = GAIN \times \Delta V + V_{DDA}/2$$
 Eqn. 3-4

The transfer function for the ADC in 12-bit mode is:

Digital Result =
$$0xFFF \times V_{Out}/V_{DD\Delta}$$
 Eqn. 3-5

Setting GAIN = 1, and combining these for the overall datapath:

Result =
$$(0xFFF/V_{DDA}) \times [GAIN \times \Delta V + V_{DDA}/2]$$
 Eqn. 3-6

Result =
$$0xFFF \times (\Delta V/V_{DDA}) + 0x7FF$$
 Eqn. 3-7

Re-arranging the terms gives us:

$$\Delta V = V_{DDA} \times (Result - 0x7FF)/0xFFF$$
 Eqn. 3-8

Now consider the "actual" case where we define:

$$\Delta V = A \times Result - B$$
 Eqn. 3-9

Given

V_{Offset} = measurement resulting from offset calibration

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V_{Gain} = measurement resulting from gain calibration

we can solve for A and B in Equation 3-9.

$$0 = A \times V_{Offset} - B$$
 Eqn. 3-10

$$V_{DDA}/3 = A \times V_{Gain} - B$$
 Eqn. 3-11

Solving for A and B:

$$A = V_{DDA} / [3 \times (V_{Gain} - V_{Offset})]$$
 Eqn. 3-12

$$B = V_{DDA} \times V_{Offset} / [3 \times (V_{Gain} - V_{Offset})]$$
 Eqn. 3-13

Generalized Example

Here is a more general calibration routine, suitable for all gain settings and external gain calibration.

For a given V_{DDA}, any analog input voltage can be derived from:

3.11.3.4 Calibration

The PGA calibration features are intended for run-time use. Values for V_{Gain} and V_{Offset} should be measured via the ADC during device startup. Then A and B parameters for Equation 3-9 should be pre-calculated and stored in RAM for use during operation. If the device is intended to be used in varying environmental conditions, it may be advisable to recalibrate the coefficients on a regular basis.

3.11.4 PGA Mission Mode

The two mission modes differ as shown in Table 3-3.

Table 3-3. PGA Features: Low Power versus Full Power

Feature	Low Power	Full Power	
Voltage Supply	1.8 V to 3.6 V	$V_{LVDH} < V_{DD} <= 3.6 V$	
Max Power Consumption	650 μΑ ^{1,2} 340 μΑ ^{1,3} 490 μΑ ^{2,4} 260 μΑ ^{3,4}	1 mA ^{1,2} 520 μA ^{1,3} 750 μA ^{2,4} 390 μA ^{3,4}	
Max PGA/ADC Clock Rate	4 MHz	8 MHz	
Recommended Charge Pump Clock	PGA Cl	ock ÷ 4	
PGA Sampling Rate ⁵	1 ÷ [(12 + 18 × NUM_C 43 ADC Clocks + 5	,	
Max Input Bandwidth	PGA Samplir PGA Samplir		

¹ Motor Control Mode (BP = 0)

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- ² Two PGAs enabled
- ³ One PGA enabled
- ⁴ General Purpose Mode (BP = 1)
- ⁵ ADC in 12-bit mode, long sampling time

Mission mode encompasses a number of options. These include:

- Optional use of the sample/hold: CNTL1[BP])
- Number of gain stage clocks per conversion: CNTL2[NUM_CLK_GS]
- Low/full power: CNTL0[LP]
- Choice of hardware or software trigger: CNTL1[TM]
- Any gain setting: CNTL0[GAINSEL]

3.12 Operation in Various Chip Operating Modes

3.12.1 Power Modes

Power modes are described in Table 3-4, which summarizes the terms that apply for each family. These terms are used throughout the discussion.

Power Mode	Comments
Run	Normal operating mode
Wait	Processor halted, peripherals continue to run.
LPrun	Low power run. clock frequencies are reduced, regulation is looser.
LPwait	Processor halted, peripherals continue to run. Clock frequencies are reduced, regulation is looser.
Stop	Processor and peripheral clocks halted. Regulator is fully engaged.
LPstop	Processor and peripheral clocks halted. Regulator is loosely regulating.
PPD (Partial Power Down)	Most of the chip is powered down. RAM continues to be powered to retain state. Outputs are frozen at the value they had upon entering this mode.
N/A	Full power down.

Table 3-4. Power Modes

3.12.2 Operation During Run, Wait, and Stop

The PGA operates normally in wait and run modes. It can also be configured to work in stop mode (you must set the appropriate bit in the SIM stop disable register, if applicable for the given chip).

3.12.3 Operation During LPRun, LPWait, and LPStop

Operation is the same as run, wait and stop, with the exception that frequency of peripheral clocks is limited to a maximum of 1 MHz.

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3.12.4 Operation During Partial Power Down (PPD)

The PGA must be disabled prior to entering partial power down (PPD). Failure to do so results in increased power dissipation in that mode.

3.13 Interrupts

The PGA does not generate any interrupts to the DSC core. ADC conversion complete interrupts can be used to process converted values. In the case where both ADC0_ADCSC1A and ADC0_ADCSC1B are used to control two conversions, one after the other, it is recommended that only the second ADC conversion should be configured to generate an interrupt. The ISR routine would then read both result registers in one pass.

3.14 Reset Considerations

The PGA is inactive during device reset. All PGA registers are reset to their default values.

3.15 Register Definitions

Register Name	Address Offset	Description
PGA0_CNTL0	0x0	Control Register 0
PGA0_CNTL1	0x1	Control Register 1
PGA0_CNTL2	0x2	Control Register 2
PGA0_STS	0x3	Status Register

Table 3-5. Module Memory Map

Address offsets are in terms of 16-bit words. The eight bits of the register descriptions shown are zero-extended to sixteen bits; bits 15 to 8 are added to the left. The resulting registers are 16-bit, with the content of bits seven to zero shown.

3.15.1 Control Register 0 (PGA0_CNTL0)

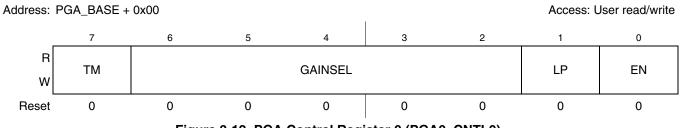


Figure 3-12. PGA Control Register 0 (PGA0_CNTL0)

Table 3-6. PGA Control Register 0 (PGA0_CNTL0) Descriptions

Field	Description
7 TM	Trigger Mode 1 Software trigger mode: Writing a 1 to PGA0_CNTL2[SWTRIG] initiates a PGA conversion. 0 Hardware trigger mode: Conversions are initiated on the positive edge of the hardware trigger.
6–2 GAINSEL	Gain Select GAINSEL[0] selects the gain for the S/H stage of the PGA GAINSEL[2:1] selects the gain for the differential gain stage of the PGA GAINSEL[4:3] selects the gain for the differential-to-single-ended stage of the PGA Between them, these bits select the overall gain of the PGA. Table 3-7 outlines the effects of each possible setting of the GAINSEL field.
1 LP	Power Mode 1 Low power (performance limited) 0 High power (maximum performance) Note: Power consideration: these blocks share common circuitry that must remain biased if either of the two PGAs remain in high power mode.
0 EN	Enable 1 PGA is powered and enabled 0 PGA disabled and powered down (output shorted to V _{SSA})

Table 3-7. PGA Gain Selection

#	GAIN	GAINSEL[4]	GAINSEL[3]	GAINSEL[2]	GAINSEL[1]	GAINSEL[0]	DSE Gain	DIFF Gain	S/H Gain
1	1x ¹	0	0	0	0	0	1	1	1
2	2x ²	0	0	0	0	1	1	1	2
3	2x ³	0	0	0	1	0	1	2	1
4	4x ²	0	0	0	1	1	1	2	2
5	3x ¹	0	0	1	0	0	1	3	1
6	6x ²	0	0	1	0	1	1	3	2
7	4x ³	0	0	1	1	0	1	4	1
8	8x ²	0	0	1	1	1	1	4	2
9	2x	0	1	0	0	0	2	1	1
10	4x	0	1	0	0	1	2	1	2
11	4x	0	1	0	1	0	2	2	1
12	8x	0	1	0	1	1	2	2	2
13	6x ³	0	1	1	0	0	2	3	1
14	12x ²	0	1	1	0	1	2	3	2
15	8x ³	0	1	1	1	0	2	4	1
16	16x ²	0	1	1	1	1	2	4	2
17	3x	1	0	0	0	0	3	1	1
18	6x	1	0	0	0	1	3	1	2

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Table 3-7. PGA Gain Selection (continued)

#	GAIN	GAINSEL[4]	GAINSEL[3]	GAINSEL[2]	GAINSEL[1]	GAINSEL[0]	DSE Gain	DIFF Gain	S/H Gain
19	6x	1	0	0	1	0	3	2	1
20	12x	1	0	0	1	1	3	2	2
21	9x ¹	1	0	1	0	0	3	3	1
22	18x ²	1	0	1	0	1	3	3	2
23	12x ³	1	0	1	1	0	3	4	1
24	24x ²	1	0	1	1	1	3	4	2
25	4x	1	1	0	0	0	4	1	1
26	8x	1	1	0	0	1	4	1	2
27	8x	1	1	0	1	0	4	2	1
28	16x	1	1	0	1	1	4	2	2
29	12x	1	1	1	0	0	4	3	1
30	24x	1	1	1	0	1	4	3	2
31	16x ³	1	1	1	1	0	4	4	1
32	32x ²	1	1	1	1	1	4	4	2

¹ Recommended setting, where both BP = 0 and BP = 1

3.15.2 Control Register 1 (PGA0_CNTL1)

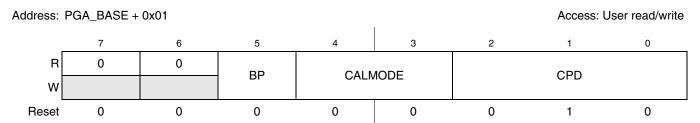


Figure 3-13. PGA Control Register 1 (PGA0_CNTL1)

Table 3-8. GA Control Register 1 (PGA0_CNTL1) Descriptions

Field	Description						
7, 6	Reserved						
5 BP	S/H Bypass Enable. This bit is currently reserved for factory use only. It should always be written as zero. 1 S/H bypass is enabled. 0 S/H bypass is not enabled						

 $^{^{2}}$ Recommended setting, where BP = 0

 $^{^{3}}$ Recommended setting, where BP = 1

Table 3-8. GA Control Register 1 (PGA0_CNTL1) Descriptions (continued)

Field	Description
4, 3 CALMOD E	Calibration Mode. 00 Mission Mode 01 Reserved 10 Offset calibration — inputs sample differential ground 11 Reserved
2–0 CPD	Charge Pump Divisor. The programmable gain amplifier utilizes an internal charge pump for bias purposes. The clock to that charge pump has a frequency equal to the chip oscillator frequency (nominally 8 MHz), divided by 2 raised to the CPD power. The default value of this field is 0x2, resulting in a charge pump frequency of 2 MHz when based off an 8 MHz oscillator.

3.15.3 Control Register 2 (PGA0_CNTL2)

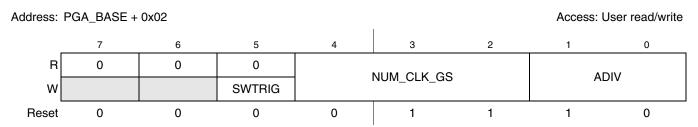


Figure 3-14. PGA Control Register 2 (PGA0_CNTL2)

Table 3-9. PGA Control Register 2 (PGA0_CNTL2) Descriptions

Field	Description							
7, 6	Reserved.							
5 SWTRIG	Software Trigger. When software triggering has been abled by writing PGA0_CNTL0[TM] = 1, writing a one to this bit initiates a conversion. Note NUM_CLK_SEL must be set to a minimum value of 001 when using software triggers. This is required in order for the signal to propagate through both gain stages of the PGA. This bit always reads as zero.							
4-2 NUM_CL K_GS	Number of PGA gain clock pulses per conversion. This parameter controls how many times the gain and differential to single-ended stages of the PGA are clocked per conversion (NUM_CLK_GS+1). The default value of this field is 0x3. Refer to Section 3.8, "PGA Clocking," and Section 3.9, "Effects on ADC Latency," for additional details.							
1, 0 ADIV	Clock Divide Select. These two bits must be set to the same value as ADC0_ADCCFG[ADIV] within the associated ADC module. It determines the baud rate for the PGA clk. This clock runs at the same rate as the ADC clock, and is derived from the same source (exported by the ADC module for this use). Table 3-6 shows the available clock configurations.							
		ADIV	Divide Ratio	Clock Rate				
	00 1 Input Clock							
		01	2	Input Clock / 2				
		10	4	Input Clock / 4				
	11 8 Input Clock / 8							
		1	1	1				

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3.15.4 Status Register (PGA0_STS)

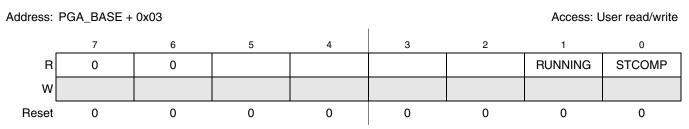


Figure 3-15. PGA Status Register (PGA0_STS)

Table 3-10. PGA Status Register (PGA0_STS) Descriptions

Field	Description						
7–2	Reserved.						
1 RUNNING	PGA RUN Sequence Underway. 0 = The PGA state machine is inactive 1 = The PGA is performing a differential-to-single-ended conversion. If the system bus rate is much slower than the PGA clock rate (which can occur when the PGA is clocked from the ADC asynchronous clock), it is possible that a "1" is not seen in this bit location after initiating a conversion. The bit is resynchronized when crossing clock domains, and may be missed due to the differences in clock rates.						
0 STCOMP	Startup Complete. 0 = The PGA is disabled, or the PGA startup sequence is incomplete. The PGA is not available for conversions. 1 = The PGA is enabled and has completed its startup sequence.						

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Chapter 4 High Speed Comparator (HSCMP)

4.1 Introduction

The high-speed comparator module (HSCMP) provides a circuit for comparing two analog input voltages. The comparator circuit is designed to operate across the full range of the supply voltage (rail-to-rail operation).

4.2 Features

The HSCMP has the following features:

- Operates over the entire supply range.
- Inputs may range from rail to rail.
- Less than 40 mV of input offset.
- Less than 15 mV of hysteresis.
- Selectable interrupt on rising edge, falling edge, or either rising or falling edges of comparator output.
- Selectable inversion on comparator output.
- Comparator output may be:
 - Sampled.
 - Windowed (ideal for certain PWM zero-crossing-detection applications).
 - Digitally Filtered.
 - Filter can be bypassed.
 - May be clocked via external SAMPLE signal or scaled peripheral clock.
- External hysteresis can be used at the same time that the output filter is used for internal functions.
- The positive and minus inputs of the comparator are both driven from 4-to-1 muxes that allow additional flexibility in assigning IO as comparator inputs during PCB design.
- Two software selectable performance levels:
 - Shorter propagation delay at the expense of higher power. This mode can be used only when the VDDA rail is above the low voltage interrupt trip point.
 - Low power, with longer propagation delay.

4.3 Block Diagram

The block diagram for the high speed comparator module is shown in Figure 4-1.

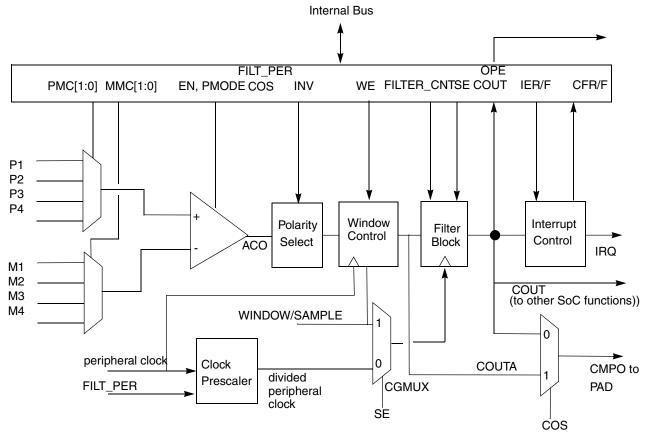


Figure 4-1. High Speed Comparator Module Block Diagram

In Figure 4-1:

- The window control block is completely bypassed when WE = 0
- If WE = 1, the comparator output is sampled on every peripheral clock when WINDOW=1 to generate COUTA. Sampling does NOT occur when WINDOW = 0.
- The filter block is bypassed when not in use.

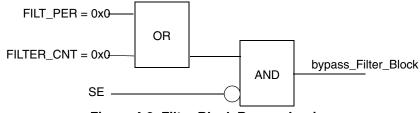


Figure 4-2. Filter Block Bypass Logic

- The filter block acts as a simple sampler if bypass_Filter_Block && FILTER_CNT = 0x1.
- The filter block filters based on multiple samples when bypass_Filter_Block && FILTER_CNT > 0x1
 - If SE = 1, the external SAMPLE input is used as sampling clock
 - If SE = 0, the divided peripheral clock is used as sampling clock

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- If enabled, the filter block incurs up to 1 IP bus additional latency penalty on COUT because COUT (which is crossing clock domain boundaries) must be resynchronized to the peripheral clock.
- WE and SE are mutually exclusive.

4.4 Pin Descriptions

4.4.1 External Pins

Each HSCMP has up to eight external analog input pins and one external output pin. Each input pin can accept an input voltage that varies across the full operating voltage range of the DSC.

Consult the data sheet to determine what functions are shared with analog inputs. As shown in the block diagram, the Pn pins are connected to the comparator non-inverting input. Mn pins are connected to the inverting input of the comparator.

The user can select either filtered or unfiltered comparator outputs for use on an external IO pad.

Operation of CMP0 CR1[OPE] simplified examples are shown in Figure 4-3.

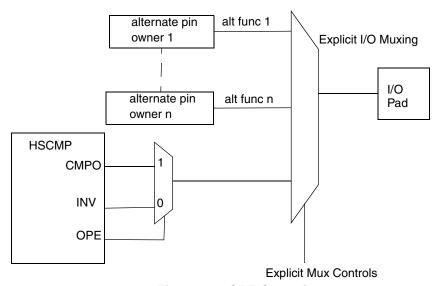


Figure 4-3. OPE Operation

4.5 Functional Description

The high-speed comparator can be used to compare two analog input voltages applied to Pn and Mn. The analog comparator output (ACO) is high when the non-inverting input is greater than the inverting input, and is low when the non-inverting input is less than the inverting input. This signal can be selectively inverted by setting CMP0_CR1[INV] = 1.

The CMP0_SCR[IER] and CMP0_SCR[IEF] bits are used to select the condition that causes the comparator module to assert an interrupt to the processor. CMP0_SCR[CFR] bit is set on a rising edge of

High Speed Comparator (HSCMP)

the comparator output. CMP0_SCR[CFF] is set on a falling edge of the comparator output. The (optionally filtered) comparator output can be read directly through the CMP0_SCR[COUT] bit.

4.5.1 HSCMP Functional Modes

There are three main sub-blocks to the comparator module: the comparator itself, the window function, and the filter function. The filter can be clocked from an internally generated clock, or via an external sample input. Additionally, the filter is programmable with respect to how many samples must agree before a change on the output is registered. In the simplest case, only one sample must agree. In this case, the filter acts as a simple sampler.

The external sample input is enabled using CMP0_CR1[SE]. When set, the output of the comparator is sampled only on rising edges of the sample input.

The windowing mode is enabled by setting CMP0_CR1[WE]. When set, the comparator output is sampled only when the WINDOW input signal is equal to one. This feature can be used to ignore the comparator output during time periods in which the input voltages are not valid. This is especially useful when implementing zero-crossing-detection for certain PWM applications.

The comparator filter and sampling features can be combined as shown in Table 4-1. Individual modes are discussed below.

Mode #	EN	WE	SE	FILT_CNT	FILT_PER	Operation
1	0	Х	Х	Х	Х	Disabled See "Disabled Mode (# 1)" on page 5
2A	1	0	0	0x0	Х	Continuous Mode
2B	1	0	0	Х	0x00	See "Continuous Mode (#s 2A & 2B)" on page 6
ЗА	1	0	1	0x1	Х	Sampled, Non-Filtered mode
3B	1	0	0	0x1	> 0x0	See "Sampled, Non-Filtered Mode (#s 3A & 3B)" on page 7
4A	1	0	1	> 0x1	Х	Sampled, Filtered mode
4B	1	0	0	> 0x1	> 0x0	See "Sampled, Filtered Mode (#s 4A & 4B)" on page 8
5A	1	1	0	0x0	Х	Windowed mode
5B	1	1	0	Х	0x00	Comparator output is sampled on every rising peripheral clock edge when SAMPLE=1 to generate COUTA See "Windowed Mode (#s 5A & 5B)" on page 10
6	1	1	0	0x1	0x01 - 0xFF	Windowed/Resampled mode Comparator output is sampled on every rising peripheral clock edge when SAMPLE=1 to generate COUTA, which is then resampled on an interval determined by FILT_PER to generate COUT. See "Windowed/Resampled Mode (# 6)" on page 12

Table 4-1. Comparator Sample/Filter Controls

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Table 4-1. Comparator Sample/Filter Controls (continued)

Mode #	EN	WE	SE	FILT_CNT	FILT_PER	Operation
7	1	1	0	> 0x1	0x01 - 0xFF	Windowed/Filtered mode Comparator output is sampled on every rising peripheral clock edge when SAMPLE=1 to generate COUTA, which is then resampled and filtered to generate COUT. Section 4.5.1.7, "Windowed/Filtered Mode (#7)"
	All other combinations of EN, WE, SE, FILT_CNT and FILT_PER are illegal.					

For cases where a comparator is used to drive a fault input of the PWM, it should generally be configured to operate in continuous mode, so that an external fault can immediately pass through the comparator to the PWM fault circuitry.

CAUTION

Filtering and sampling settings should be changed only after setting SE=0 and FILTER_CNT=0x0. This has the effect of resetting the filter to a known state.

4.5.1.1 Disabled Mode (# 1)

In disabled mode, the analog comparator is non-functional and consumes no power. The output of the analog comparator block (ACO) is zero in this mode. It is possible to further reduce power consumed by disabling the peripheral clock to the comparator logic. This is a function of the system integration module, or SIM.

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4.5.1.2 Continuous Mode (#s 2A & 2B)

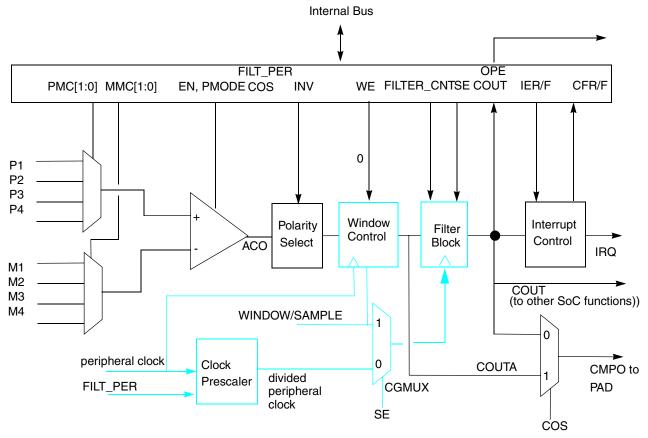


Figure 4-4. Comparator Operation in Continuous Mode

The analog comparator block is powered and active. ACO may be optionally inverted, but is not subject to external sampling or filtering. Both window control and filter blocks are completely bypassed. CMP0_SCR[COUT] is updated continuously. The path from comparator input pins to output pin is operating in combinational (unclocked) mode. COUT and COUTA are identical.

See Figure 4-2 for control configurations that result in disabling the filter block.

4.5.1.3 Sampled, Non-Filtered Mode (#s 3A & 3B)

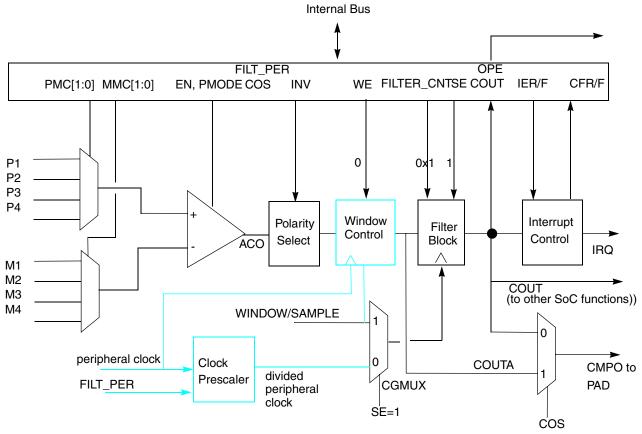


Figure 4-5. Sampled, Non-Filtered (# 3A): Sampling Point Externally Driven

In sampled, non-filtered mode, the analog comparator block is powered and active. The path from analog inputs to COUTA is combinational (unclocked). Windowing control is completely bypassed. COUTA is sampled whenever a rising edge is detected on the filter block clock input.

The only difference in operation between Figure 4-5 and Figure 4-6 is in how the clock to the filter block is derived.

The comparator filter has no other function than sample/hold of the comparator output in this mode.

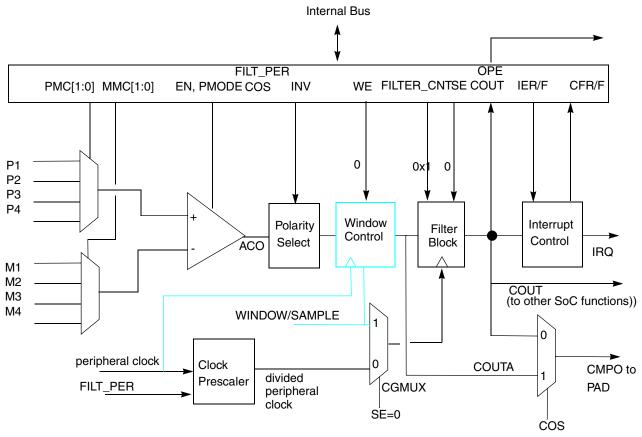


Figure 4-6. Sampled, Non-Filtered (# 3B): Sampling interval internally derived

4.5.1.4 Sampled, Filtered Mode (#s 4A & 4B)

In sampled, filtered mode, the analog comparator block is powered and active. The path from analog inputs to COUTA is combinational (unclocked). Windowing control is completely bypassed. COUTA is sampled whenever a rising edge is detected on the filter block clock input.

The only difference in operation between Figure 4-5 (Sampled, Non-Filtered # 3A) and Figure 4-8 (Sampled, Filtered # 4A) is that FILTER_CNT is now greater than 1, which activates filter operation.

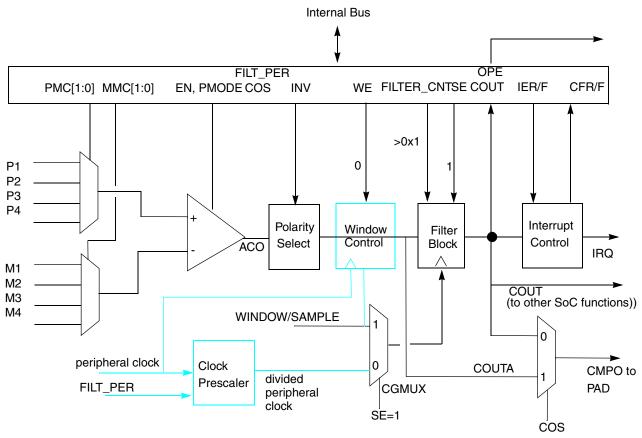


Figure 4-7. Sampled, Filtered (# 4A): Sampling Point Externally Driven

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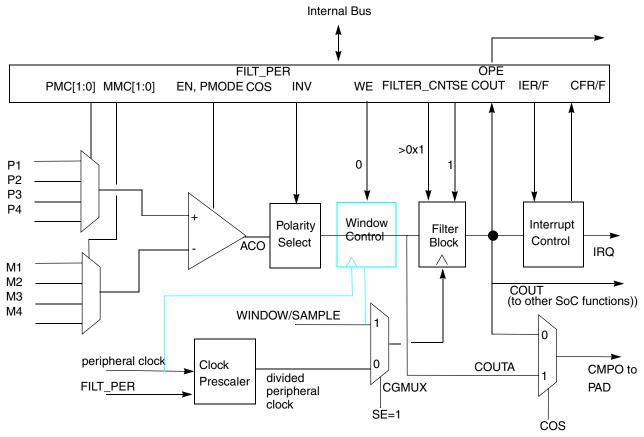


Figure 4-8. Sampled, Filtered (# 4B): Sampling Point Internally Derived

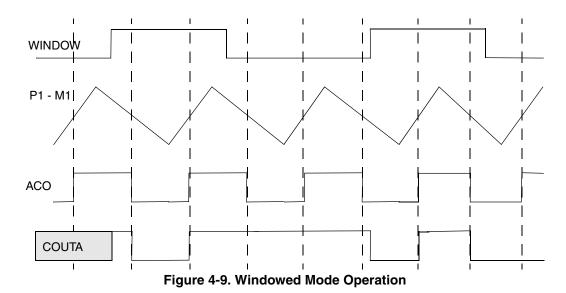
The only difference in operation between Figure 4-7 (Sampled, Non-Filtered # 3B) and Figure 4-8 (Sampled, Filtered # 4B) is that FILTER_CNT is now greater than 1, which activates filter operation.

4.5.1.5 Windowed Mode (#s 5A & 5B)

Figure 4-9 illustrates comparator operation in the windowed mode, ignoring latency of the analog comparator, polarity select and window control block. It also assumes that the polarity select is set to non-inverting. Note that the analog comparator output is passed to COUTA only when the WINDOW signal is high.

In actual operation, COUTA may lag the analog inputs by up to one peripheral clock cycle plus the combinational path delay through the comparator and polarity select logic.

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Internal Bus FILT_PER OPE PMC[1:0] MMC[1:0] EN, PMODE COS WE FILTER_CNTSE COUT IER/F CFR/F 0x P1 P2 P3 P4 Window Interrupt Polarity Filter Control Control Select Block ACO **IRQ** М1 M2 COUT (to other SoC functions)) М3 M4 WINDOW/SAMPLE 0 peripheral clock Clock 0 **COUTA** CMPO to divided Prescaler FILT_PER CGMUX PAD peripheral clock SE=0 COS

Figure 4-10. Windowed Mode

See Figure 4-2 for control configurations that result in disabling the filter block.

When any windowed mode is active, COUTA is clocked by the peripheral clock whenever WINDOW = 1. The last latched value is held when WINDOW = 0.

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4.5.1.6 Windowed/Resampled Mode (# 6)

Figure 4-11 uses the same input stimulus shown in Figure 4-9, and adds resampling of COUTA to generate COUT. Samples are taken at the time points indicated by the arrows. Again, prop delays and latency are ignored for clarity's sake. This example was generated solely to demonstrate operation of the comparator in windowing / resampled mode, and does not reflect any specific application. Depending upon the sampling rate and window placement, COUT may not see zero-crossing events detected by the analog comparator. Sampling period and/or window placement must be carefully considered for a given application.

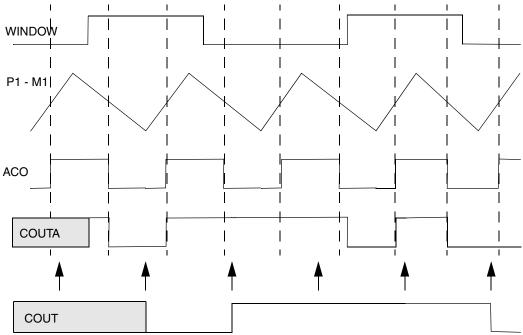


Figure 4-11. Windowed/Resampled Mode Operation

This mode of operation results in an unfiltered string of comparator samples where the interval between the samples is determined by FILT_PER and the peripheral clock rate. Configuration for this mode is virtually identical to that for the windowed/filtered mode shown in the next section. The only difference is that the value of FILTER CNT must be exactly one.

4.5.1.7 Windowed/Filtered Mode (#7)

This is the most complex mode of operation for the comparator block, as it uses both windowing and filtering features. It also has the highest latency of any of the modes. This can be approximated: up to 1 peripheral clock synchronization in the window function + ((FILT_CNT X FILT_PER) + 1) X peripheral clock for the filter function.

When any windowed mode is active, COUTA is clocked by the peripheral clock whenever WINDOW = 1. The last latched value is held when WINDOW = 0.

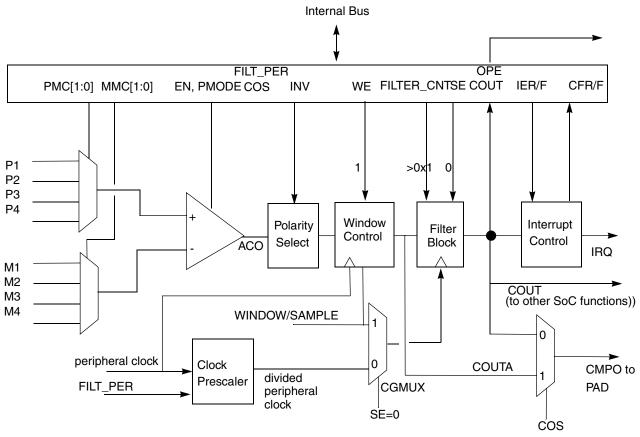


Figure 4-12. Windowed/Filtered Mode

4.5.2 Power Modes

Table 4-2 summarizes the terms that apply for each power mode.

Table 4-2. Power Modes

Power Mode	Comments
Run	Normal operating mode
Wait	Processor halted, peripherals continue to run.
LPrun	Low power run. Clock frequencies are reduced, regulation is looser.
LPwait	Processor halted, peripherals continue to run. Clock frequencies are reduced, regulation is looser.
Stop	Processor and peripheral clocks halted. Regulator is fully engaged.
LPstop	Processor and peripheral clocks halted. Regulator is loosely regulating.
PPN (Partial Power Down)	Most of the chip is powered down. RAM continues to be powered to retain state. Outputs are frozen at the value they had upon entering this mode.

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High Speed Comparator (HSCMP)

4.5.2.1 Wait Mode Operation

During wait and LPwait modes, the HSCMP, if enabled, continues to operate normally. Also, if enabled, the interrupt can wake the DSC core.

4.5.2.2 Stop Mode Operation

4.5.2.2.1 LPstop and Stop Mode Operation

Subject to platform-specific clock restrictions outlined below, the DSC core is brought out of stop when a compare event occurs and corresponding interrupt is enabled. Similarly, if CMP0_CR1[OPE] is enabled, the comparator output operates as in the normal operating mode and comparator output is placed onto the external pin.

If stop is exited with a reset, all comparator registers are put into their reset state.

Windowed, sampled, and filtered modes of operation continue to operate in stop and LPstop modes if the clock to the peripheral is enabled for stop. Edge detection for compare events also requires a peripheral clock. None of these features function correctly unless the clock to the HSCMP has been enabled for stop (via the SIM stop disable registers).

4.5.2.2.2 Partial Power Down (PPD) and Stop1 Mode Operation

During either partial power down (PPD) or stop1 mode, the HSCMP module is fully powered down. Upon waking from partial power down (PPD) or stop1 mode, the HSCMP module is in the reset state.

4.5.2.3 Debug Mode Operation

When the DSC is in debug mode, the HSCMP continues to operate normally.

4.5.3 Hysteresis

The following diagram illustrates implementation of an external hysteresis resistor bridge between the asynchronous comparator output and the positive (+) input of the comparator. Because positive feedback is required, INV must be set to 0 when the hysteresis resistor bridge is added to the positive (+) input of the comparator. INV must be set to 1 when the hysteresis resistor bridge is added to the negative (–) input of the comparator.

The option of adding an external resistor bridge for the purpose of adding hysteresis to the comparator and the amount of hysteresis depends on the user's individual requirements. Hysteresis can be important in some system designs. In the absence of hysteresis, the continuous comparison of nearly identical analog inputs may add noise and waste power by generating high-frequency oscillations at CMPO.

If external hysteresis is added to the comparator, the bridge must be designed to consider other issues than how much hysteresis is needed. The resistor values must be sufficiently high so that they do not cause the drive strength of the digital output driver in the CMPO IO circuitry to be exceeded. Also, if any digital function other than CMPO must operate on the CMPO pad in the presence of such a bridge, the resistor values must be sufficiently high so that the IO circuitry can function appropriately in its digital role.

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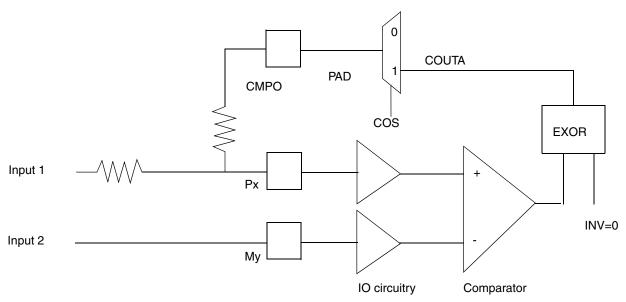


Figure 4-13. External Hysteresis Circuit

4.5.4 Startup and Operation

A typical startup sequence is as follows.

The time required to stabilize COUT is the power-on delay of the comparators plus the largest propagation delay from a selected analog source through the analog comparator, windowing function, and filter. The windowing function has a maximum of 1 peripheral bus clock period delay. Filter delay is specified in Section 4.5.5, "Low Pass Filter."

Interrupts should be disabled during power up, recovery from partial-power-down, and while re-enabling the module. Failure to do so could result in spurious interrupts.

During operation, the propagation delay of the selected data paths must always be considered. It can take many peripheral bus clock cycles for COUT and the CFR/CFF status bits to reflect an input change or a configuration change to one of the components involved in the data path.

When programmed for filtering modes, COUT is initially equal to zero until sufficient clock cycles have elapsed to fill all stages of the filter. This occurs even if COUTA is at a one.

4.5.5 Low Pass Filter

4.5.5.1 Introduction

The low-pass filter operates on the unfiltered, unsynchronized, and optionally-inverted comparator output COUTA and generates the filtered and synchronized output COUT. Both COUTA and COUT can be configured as module outputs and are used for different purposes within the system.

Synchronization and edge detection are always used to determine status register bit values. They also apply to COUT for all sampling and windowed modes. Filtering can be performed using an internal timebase defined by CMP0_FPR[FILT_PER], or by using an external SAMPLE input to determine sample time.

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High Speed Comparator (HSCMP)

The need for digital filtering and the amount of filtering is dependent on user requirements. Filtering can become more useful in the absence of an external hysteresis circuit. Without external hysteresis, high frequency oscillations can be generated at COUTA when the selected N and P input voltages differ by less than the offset voltage of the differential comparator.

4.5.5.2 Enabling Filter Modes

Filter modes are enabled by setting CMP0_CR0[FILTER_CNT] greater than 0x1 and setting CMP0_FPR[FILT_PER] to a non-zero value OR setting SE=1. If using the divided peripheral clock to drive the filter, it takes samples of COUTA every FILT_PER peripheral bus cycles.

The filter output is at zero when first initialized and subsequently changes when FILT_CNT consecutive samples all agree that the output value has changed. Said another way, COUT is zero for some initial period, even when COUTA is at one.

Setting both SE and FILT_PER to 0 disables the filter and eliminates switching current associated with the filtering process. Always switch to this setting prior to making any changes in filter parameters. This resets the filter to a known state. Switching FILTER_CNT on the fly without this intermediate step can result in unexpected behavior.

If SE=1, the filter takes samples of COUTA on each positive transition of the SAMPLE input. The output state of the filter changes when FILT_CNT consecutive samples all agree that the output value has changed.

4.5.5.3 Latency Issues

The FILT_PER value (or SAMPLE period) should be set such that the sampling period is just larger the period of the expected noise. This way a noise spike corrupts only one sample. The FILT_CNT value should be chosen to reduce the probability of noisy samples causing an incorrect transition to be recognized. The probability of an incorrect transition is defined as the probability of an incorrect sample raised to the FILT_CNT power.

Table 4-1 summarizes maximum latency values for the various modes of operation in the absence of noise. Filtering latency restarts each time noise masks an actual output transition.

The values of FILT_PER (or SAMPLE period) and FILT_CNT must also be traded off against the desire for minimal latency in recognizing actual comparator output transitions. The probability of detecting an actual output change within the nominal latency is the probability of a correct sample raised to the FILT_CNT power.

Mode #	EN	WE	SE	FILT_CNT	FILT_PER	Operation	Maximum Latency ¹
1	0	Х	Х	Х	Х	Disabled	N/A
2A	1	0	0	0x0	Х	Continuous Mode t _{PD}	t
2B	1	0	0	Х	0x00		чPD

Table 4-1. Comparator Sample/Filter Maximum Latencies

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Mode # ΕN WE SE **FILT CNT FILT PER** Operation Maximum Latency¹ ЗА 1 0 1 0x1 Χ t_{PD} + t_{SAMPLE} + t_{per} Sampled, Non-Filtered mode 3B 1 0 0 0x1 > 0x0 $t_{PD} + (FILT_PER X t_{per}) + t_{per}$ 1 0 1 > 0x1 Χ t_{PD} + (FILT_CNT X t_{Sample}) + t_{per} Sampled, Filtered t_{PD} + (FILT_CNT X FILT_PER X t_{per}) + mode 4B 1 0 0 > 0x1 > 0x0 t_{per} 5A 1 1 0 0x0 Х $t_{PD} + t_{per}$ Windowed mode 5B 1 1 0 Χ 0x00 $t_{PD} + t_{per}$ Windowed / 6 1 1 0 0x01-0xFF t_{PD} + (FILT_PER X t_{per}) + $2t_{per}$ 0x1 Resampled mode t_{PD} + (FILT_CNT X FILT_PER X t_{per}) + Windowed / Filtered 7 1 1 0 > 0x10x01-0xFF mode 2t_{per}

Table 4-1. Comparator Sample/Filter Maximum Latencies

4.6 Interrupts

The HSCMP module is capable of generating an interrupt on either the rising or falling edge of the comparator output (or both). The interrupt request is asserted when both CMP0_SCR[IER] bit and CMP0_SCR[CFR] are set. It is also asserted when both CMP0_SCR[IEF] bit and CMP0_SCR[CFF] are set. The interrupt is deasserted by clearing either CMP0_SCR[IER] or CMP0_SCR[CFR] for a rising-edge interrupt, or CMP0_SCR[IEF] and CMP0_SCR[CFF] for a falling-edge interrupt.

4.7 Memory Map and Register Definition

Table 4-2. Module Memory Map

Address	Use	Access
Base + 0x00	HSCMP Control Register 0 (CMP0_CR0)	Read/Write
Base + 0x01	HSCMP Control Register 1 (CMP0_CR1)	Read/Write
Base + 0x02	HSCMP Filter Period Register (CMP0_FPR)	Read/Write
Base + 0x03	HSCMP Status & Control Register (CMP0_SCR)	Read/Write
Base + 0x04	Reserved ¹	Reserved

¹ The PCR is not present.

Address offsets are in terms of 16-bit words. The 8-bit register descriptions shown are zero-extended to 16 bits.

t_{PD} represents the intrinsic delay of the analog component plus the polarity select logic. t_{Sample} is the clock period of the external sample clock. t_{per} is the period of the peripheral bus clock.

4.7.1 Control Register 0 (CMP0_CR0)

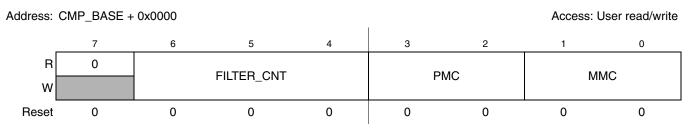


Figure 4-14. HSCMP Control Register 0 (CMP0_CR0)

Figure 4-15. HSCMP Control Register 0 (CMP0_CR0) Descriptions

Field	Description
7	Reserved.
6–4 FILT_CNT	Filter Sample Count. These bits represent the number of consecutive samples that must agree prior to the comparator output filter accepting a new output state. Filter programming and latency details are described in Section 4.5.5, "Low Pass Filter." 000 = Filter is disabled. If SE = 1, Then COUT is a zero (this is not a legal state in Table 4-1, and is not recommended). If SE = 0, COUT = COUTA. 001 = 1 consecutive samples must agree (comparator output is simply sampled) 010 = 2 consecutive samples must agree 011 = 3 consecutive samples must agree 100 = 4 consecutive samples must agree 101 = 5 consecutive samples must agree 110 = 6 consecutive samples must agree 111 = 7 consecutive samples must agree
3, 2 PMC	Positive Input Mux Control. Determines which input is selected for the positive input of the comparator. 00 = P1 01 = P2 10 = P3 11 = P4
1, 0 MMC	Minus Input Mux Control. Determines which input is selected for the negative input of the comparator. 00 = M1 01 = M2 10 = M3 11 = M4

4.7.2 Control Register 1 (CMP0_CR1)

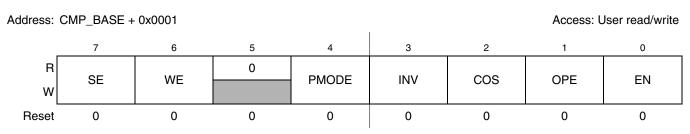


Figure 4-16. HSCMP Control Register 1 (CMP0_CR1)

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Figure 4-17. HSCMP Control Register 0 (CMP0_CR1) Descriptions

Field	Description
7 SE	Sample Enable. 1 = Sampling mode selected 0 = Sampling mode not selected At most, one of SE and WE can be set at a time. If a write to this register attempts to set both, then SE is set and WE is cleared. However, writing ones to both bit locations should be avoided, as the "11" case is reserved and may change in future implementations.
6 WE	Windowing Enable. 1 = Windowing mode selected 0 = Windowing mode not selected At most, one of SE and WE can be set at a time. If a write to this register attempts to set both, then SE is set and WE is cleared. However, writing ones to both bit locations should be avoided, as the "11" case is reserved and may change in future implementations.
5	Reserved.
4 PMODE	Power Mode Select. 1 = High speed comparison mode selected 0 = Power savings mode selected
3 INV	Comparator Invert. This bit allows you to select the polarity of the comparator function. It is also driven to the COUT output (on both the device pin and as CMP0_SCR[COUT]) when OPE=0. 1 = Invert the output of the analog comparator 0 = Do not invert the comparator output
2 COS	Comparator Output Select. 0 = Set CMPO to equal COUT (filtered comparator output) 1 = Set CMPO to equal COUTA (unfiltered comparator output)
1 OPE	Comparator Output Pin Enable. OPE is used to enable the comparator output to be placed onto the external pin, CMPO. 0 = The comparator output (CMPO) is not available on associated CMPO output pin. Instead, the INV bit is driven IF the comparator owns the pin in question (usually a result of properly setting pin mux controls at the SoC level). If the comparator does not own the pin, this bit has no effect. 1 = The comparator output (CMPO) is driven out on associated CMPO output pin if the comparator owns the pin. Again, if the comparator does not own the pin, this bit has no effect.
0 EN	Comparator Module Enable. The EN bit enables the analog comparator module. When the module is not enabled, it remains in the off state, and consumes no power. 1 = Analog comparator enabled 0 = Analog comparator disabled

NOTE

Interrupts should be disabled during power up, recovery from partial-power-down, and while re-enabling the module. Failure to do so could result in spurious interrupts. Refer to the device data sheet for comparator enable times.

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High Speed Comparator (HSCMP)

4.7.3 Filter Period Register (CMP0_FPR)

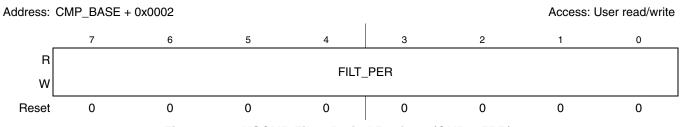


Figure 4-18. HSCMP Filter Period Register (CMP0_FPR)

Figure 4-19. HSCMP Control Register 0 (CMP0_FPR) Descriptions

Field	Description
FILT_PER	Filter Sample Period. When CMP0_CR1[SE] is equal to zero, this field specifies the sampling period, in peripheral clock cycles, of the comparator output filter. Setting FILT_PER to 0x0 disables the filter. Filter programming and latency details are described in Section 4.5.5, "Low Pass Filter." This field has no effect when CMP0_CR1[SE] is equal to one. In that case, the external SAMPLE signal is used to determine the sampling period.

4.7.4 Status and Control Register (CMP0_SCR)

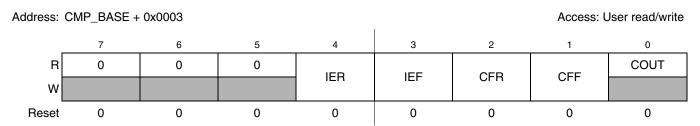


Figure 4-20. HSCMP Status and Control Register (CMP0_SCR)

Figure 4-21. HSCMP Control Register 0 (CMP0_SCR) Descriptions

Field	Description
7, 6, 5	Reserved.
4 IER	Comparator Interrupt Enable Rising. The IER bit enables the CFR interrupt from the ACM. When this bit is set, an interrupt is asserted when the CFR bit is set. 1 = Interrupt enabled 0 = Interrupt disabled
3 IEF	Comparator Interrupt Enable Falling. The IEF bit enables the CFF interrupt from the ACM. When this bit is set, an interrupt is asserted when the CFF bit is set. 1 = Interrupt enabled 0 = Interrupt disabled
2 CFR	Analog Comparator Flag Rising. During normal operation, the CFR bit is set when a rising edge on COUT has been detected. The CFR bit is cleared by writing a one to the bit. During stop mode, CFR can be programmed as either edge- or level-sensitive via the SMELB bit. 1 = Rising edge on COUT has occurred. 0 = Rising edge on COMPO has not been detected.

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Figure 4-21. HSCMP Control Register 0 (CMP0_SCR) Descriptions (continued)

Field	Description
1 CFF	Analog Comparator Flag Falling. During normal operation, the CFF bit is set when a falling edge on COUT has been detected. The CFF bit is cleared by writing a one to the bit. During stop mode, CFF can be programmed as either edge- or level-sensitive via the SMELB bit. 1 = A falling edge on COUT has occurred. 0 = A falling edge on COUT has not been detected.
0 COUT	Analog Comparator Output. Reading the COUT bit returns the current value of the analog comparator output. The register bit is reset to zero and reads as CMP0_CR1[INV] when the analog comparator module is disabled (CMP0_CR1[EN] = 0). Writes to this bit are ignored.

Edge detection during stop is supported only on platforms that allow peripherals to be clocked during stop modes. If the CFF and CFR flags are to be active during stop, then SMELB must be set to "0" for cases where the it is not receiving a clock during stop.

NOTE

Interrupts must be disabled during power up, recovery from partial-power-down and module enable sequences. The comparator output is not guaranteed to be stable until the module has had time to reach its stable operating point. See the t_{ONEN}, t_{ONPOR} and t_{ONPPD} electrical specifications in the data sheet.

High Speed Comparator (HSCMP)

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Chapter 5 Programmable Delay Block (PDB)

5.1 Introduction

5.1.1 Overview

Motor control applications often need to synchronize the time at which ADC samples are taken with respect to the PWM period. The PWM has a SYNC output specifically for that purpose. The primary function of the programmable delay block is simply to provide a controllable delay from the PWM SYNC output to the sample trigger input of the programmable gain amplifiers and ADCs.

An alternate function of the PDB is to generate timing for comparator sampling windows, or to generate a sampling/filter clock that can be used by the comparator.

5.1.2 Features

- Positive transition of trigger_in initiates the counter.
- Supports two trigger_out signals. Each has an independently controlled delay from sync_in.
- Trigger outputs can be ORed together to schedule two conversions from one input trigger event.
- Trigger outputs can be can be used to schedule precise edge placement for a pulsed output. This feature is used to generate the control signal for the HSCMP windowing feature (see Section 5.1.3, "Modes of Operation").
- Continuous trigger or single-shot mode supported.
- Bypass mode supported.
- Each trigger output is independently enabled.

5.1.3 Modes of Operation

Modes of operation include:

- Disabled: counter is off and both TriggerA and TriggerB are low.
- Enabled OneShot: counter is enabled & restarted at count zero upon receiving a positive edge on the trigger input. TriggerA and TriggerB only have one output trigger per input trigger.
- Enabled Continuous: counter is enabled and restarted at count zero. The counter is rolled over to zero again when the count reaches the value specified in the PDB_MOD register, and counting restarted. This enables a continuous stream of triggers out as a result of a single trigger input.
- Bypassed: input trigger bypasses the PDB logic entirely. It is possible to bypass only one of the two trigger outputs; therefore this mode can be used in conjunction with any of the above.

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Programmable Delay Block (PDB)

- In Enabled OneShot and Enabled Continuous, the outputs of the Delay A and Delay B comparators can be combined in such a way that two ADC events can be triggered from a single input event. These are referred to as TwoShot and Continuous TwoShot modes.
- In Enabled OneShot and Enabled Continuous, the outputs of the Delay A and Delay B comparators can be combined in such a way that an output pulse(s) can be generated with precisely controlled rising and falling times. These are referred to as single pulse and continuous pulse modes.

5.1.4 Block Diagram

Figure 5-4 illustrates the basic structure of the PDB block. It contains a single counter whose output is compared against three different digital values. delayA and delayB determine the time between assertion of the trigger input to the point at which changes in the trigger output signals are initiated. These times are defined as:

- trigger input to Pre-TriggerA = $(prescaler \times delayA) + 1$ peripheral bus clock cycle
- trigger input to Pre-TriggerB = (prescaler × delayB) + 1 peripheral bus clock cycle Add one additional peripheral bus clock cycle to determine the time at which the trigger outputs change.

Pre-TriggerA and Pre-TriggerB are used to precondition the PGA/ADC blocks one peripheral bus clock period prior to the actual measurement trigger. The ADC blocks on this device contain duplicate control and result registers, allowing them to operate in a ping-pong fashion, alternating conversions between two different analog sources (per converter). The Pre-Trigger signals are used to specify which signal is sampled next.

The signals shown in Figure 5-1 would be used to operate both ADC A and ADC B in one-shot mode. The trigger delays for the ADCs are independently set via the DELAYA and DELAYB parameters.

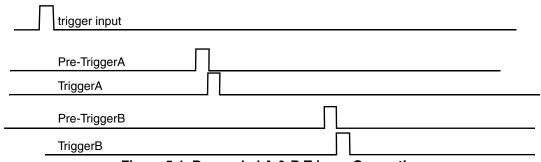


Figure 5-1. Decoupled A & B Trigger Generation

The two-shot mode is shown in Figure 5-2. In this case, both ADC A and ADC B are given the same trigger. This results in a total of 4 ADC conversions (two on ADC A, and two on ADC B).

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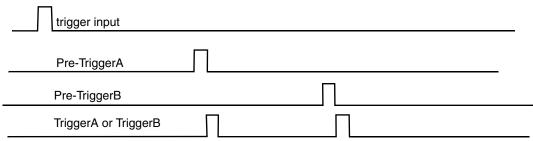


Figure 5-2. Trigger Configured for Simultaneous Sampling / Ping-Pong Operation

The third digital value, modulus, is used to reset the counter back to zero at the end of the count. If PDB_SCR[CONT] is set, the counter then resumes a new count. Otherwise, the timer operation ceases until the next trigger input event occurs.

The pulsed modes are shown in Figure 5-3. In this case, Pre-Trigger A and Pre-Trigger B are used to precisely schedule the rising and falling edges for the output waveform.

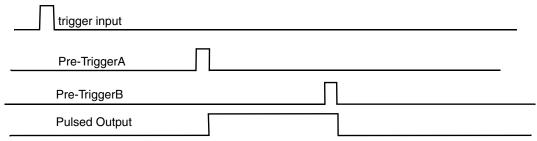


Figure 5-3. Trigger Pulsed Output Operation

The third digital value, modulus, is used to reset the counter back to zero at the end of the count. If PDB_SCR[CONT] is set, the counter then resumes a new count. Otherwise, the timer operation ceases until the next trigger input event occurs.

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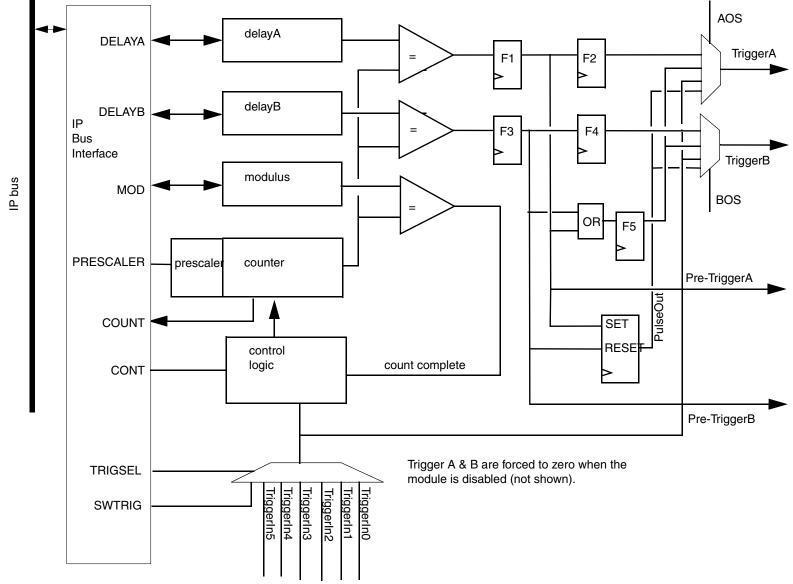


Figure 5-4. PDB Block Diagram

5.2 Memory Map and Registers

5.2.1 Memory Map

Table 5-1. PDB Memory Map

Offset	Register	Description
0x00	PDB_SCR	PDB Status and Control Register
0x01	PDB_DELAYA	PDB Delay A Register
0x02	PDB_DELAYB	PDB Delay B Register
0x03	PDB_MOD	PDB Counter Modulus Register
0x04	PDB_COUNT	Counter Value (READ ONLY)

5.2.2 Register Descriptions

5.2.2.1 PDB Status and Control Register (PDB_SCR)

This register contains status and control bits for the programmable delay block. The counter is enabled if either ENA or ENB have been set to one.

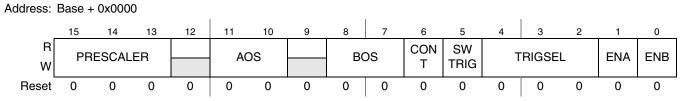


Figure 5-5. Programmable Delay Block Status and Control Register (PDB_SCR)

Table 5-2. PDB_SCR Register Field Descriptions

Field	Description
15–13 PRESCALER	Clock Prescaler Select 000 = timer uses peripheral clock 001 = timer uses peripheral clock / 2 010 = timer uses peripheral clock / 4 011 = timer uses peripheral clock / 8 100 = timer uses peripheral clock / 16 101 = timer uses peripheral clock / 32 110 = timer uses peripheral clock / 64 111 = timer uses peripheral clock / 128
12	Reserved
11, 10 AOS	Trigger A Output Select 00 = counter delay is bypassed 01 = Trigger A is function of Delay A only 10 = Trigger A is function of both Delay A and Delay B 11 = Trigger A = PulseOut

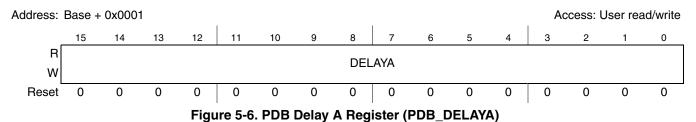
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Table 5-2. PDB_SCR Register Field Descriptions (continued)

Field	Description
9	Reserved
8, 7 BOS	Trigger B Output Select 00 = counter delay is bypassed 01 = Trigger B is function of Delay A only 10 = Trigger B is function of both Delay A and Delay B 11 = Trigger B = PulseOut
6 CONT	Continuous Mode Enable 0 = Module is in OneShot mode 1 = Module is in continuous mode
5 SWTRIG	Software Trigger When TRIGSEL = 7 and the module is enabled, writing a one to this field triggers a reset and restart of the counter. Alternately, if TriggerA or TriggerB are bypassed, it propagates there immediately. This bit always reads as zero. If passed to output triggers via the bypass mode, it has a one cycle pulse width.
4–2 TRIGSEL	Input Trigger Select 000 = TriggerIn0 is selected. This is CMP0_OUT. 001 = TriggerIn1 is selected. This is CMP1_OUT. 010 = TriggerIn2 is selected. This is CMP2_OUT. 011 = TriggerIn3 is selected. This is the PWM SYNC signal. 100 = TriggerIn4 is selected. This is ExtTrigger. 101 = TriggerIn5 is selected. This is the output of General Purpose Timer 0 (T0). 110 = TriggerIn6 is selected. This is the output of General Purpose Timer 1 (T1). 111 = SWTRIG is selected.
1 ENA	Trigger A Enable 0 = Trigger A is disabled (and forced to zero) 1 = Trigger A is enabled ENA and ENB must be enabled during pulsed output mode. The ENA/B also enable/disable the associated comparator, both of which are required for this mode of operation.
0 ENB	Trigger B Enable 0 = Trigger B is disabled (and forced to zero) 1 = Trigger B is enabled Both ENA and ENB must be enabled during pulsed output mode. The enables also enable/disable the associated comparator, both of which are required for this mode of operation.

5.2.2.2 PDB Delay A & Delay B Registers (PDB_DELAYA & PDB_DELAYB)

These registers are used to specify the delay from assertion of TriggerIn to assertion of TriggerA and TriggerB out. This delay is only applicable if the module is enabled and the output trigger in question has not been bypassed. In each case, the delay is in terms of peripheral clock cycles.



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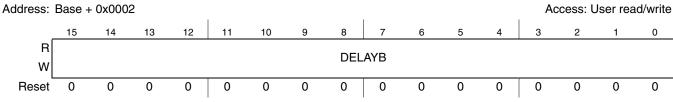
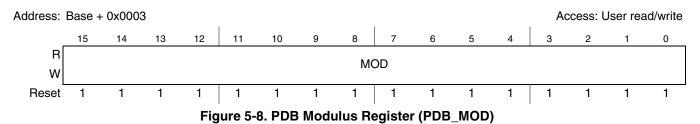


Figure 5-7. PDB Delay B Register (PDB_DELAYB)

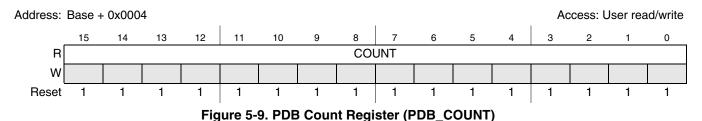
5.2.2.3 PDB Modulus Register (PDB_MOD)

This register specifies the period of the counter in terms of peripheral bus cycles. When the counter reaches this value, it is reset back to all zeros. If PDB_SCR[CONT] is set to one, the count begins anew.



5.2.2.4 PDB COUNT Register (PDB_COUNT)

This register can be used to read the current value of the counter. It is READ ONLY.



5.2.3 Functional Description

5.2.3.1 Miscellaneous Concerns and SoC Integration

- Figure 5-10 illustrates how the PDB is integrated on-chip. The sole purpose of this block is to manage the delay between an external event and the time at which comparator, ADC, or PGA samples are taken.
- Trigger A and Trigger B are defined to be glitch free.
- The PDB correctly responds to an external trigger, even if that trigger is the result of a SYNC output on the PWM running at 3X bus speed.
- Additional trigger events, after the first, but before the timer times out, cause the counter to restart.

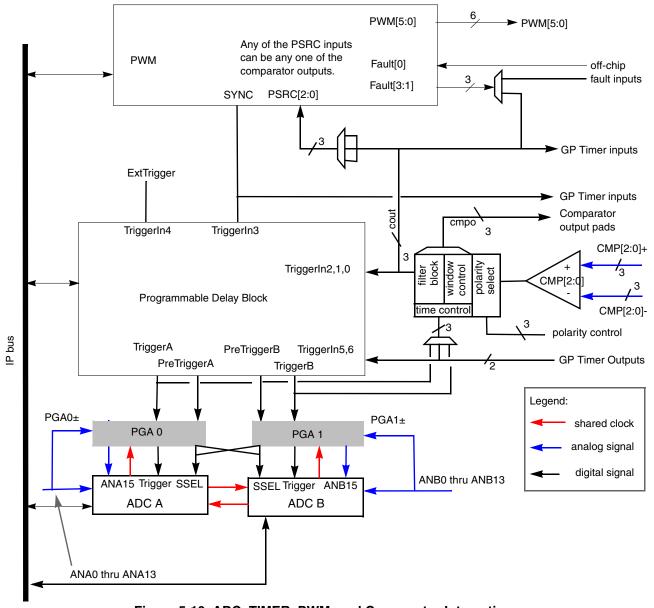


Figure 5-10. ADC, TIMER, PWM, and Comparator Interactions

5.2.3.2 Impacts of Using the Prescaler on Timing Resolution

Use of prescalers (div) greater than 1 limits the count/delay accuracy in units of peripheral clocks to the modulus of the prescaler value. If the prescaler is set to divide by two then the only values of total peripheral clocks that can be detected are even values, if the prescaler is set to divide by four then the only values of total peripheral clocks that can be decoded as detected are modulo four and so forth. If the user wanted to set a really long delay value and used a prescaler divisor of 128 then he would be limited to an resolution of 128 bus clocks.

Therefore, use the lowest possible prescaler for a given application.

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5.3 Resets

This module has a single reset input, corresponding to the device reset.

5.4 Interrupts

This module has no interrupts.

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Chapter 6 Dual Timer (DTMR)

6.1 Introduction

6.1.1 Overview

Each timer module (TMR) contains four identical counter/timer groups. Each 16-bit counter/timer group contains a prescaler, a counter, a load register, a hold register, a capture register, two compare registers, two status-and-control registers, and one control register. All of the registers except the prescaler are read/writable. NOTE: This document uses the terms "timer" and "counter" interchangeably because the counter/timers may perform either or both tasks.

The load register provides the initialization value to the counter when the counter's terminal value has been reached.

The hold register captures the counter's value when other counters are being read. This feature supports the reading of cascaded counters.

The capture register enables an external signal to take a "snapshot" of the counter's current value.

The TMRn_COMP1 and TMRn_COMP2 registers provide the values to which the counter is compared. If a match occurs, the OFLAG signal can be set, cleared, or toggled. At match time, an interrupt is generated if enabled, and the new compare value is loaded into the TMRn_COMP1 or TMRn_COMP2 registers from TMRn_CMPLD1 and TMRn_CMPLD2, if enabled.

The prescaler provides different time bases useful for clocking the counter/timer.

The counter provides the ability to count internal or external events.

Within a timer module (set of four timer/counters) the input pins are shareable.

6.1.2 Features

The TMR module design includes these distinctive features:

- Four 16-bit counters/timers
- Count up/down
- Counters cascadable
- Programmable count modulo
- Max count rate equals peripheral clock/2 for external clocks
- Max count rate equals peripheral clock for internal clocks
- Count once or repeatedly

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Dual Timer (DTMR)

- Counters preloadable
- Compare registers preloadable (available with compare load feature)
- Counters can share available input pins
- Separate prescaler for each counter
- Each counter has capture and compare capability
- Programmable operation during debug mode
- Inputs may act as fault inputs
- Programmable input filter
- Counting start can be synchronized across counters
- Clock Rate: this device can be clocked at two or three times the IP bus clock rate.
- Compare preload registers: this device includes the compare preload registers.
- Timer and stop mode: the timer can get the processor out of stop by selectively enabling timer channels to operate in stop mode.
- General-purpose timers: the general purpose timers (there are two) can access the outputs of the three comparators (CMP0_OUT, CMP1_OUT, and CMP2_OUT) as T0, T1, and TIN2, respectively. The peripheral pin-enable registers in the SIM control the muxing.
- TMRn_ENBL: this device supports the TMRn_ENBL function that allows simultaneously starting both timer channels. TMRn ENBL has two enable bits.
- Timer filter registers: because this device associates two channels with four inputs, the following construct applies:
 - Timer T0 filter registers also control the TIN2 filter.
 - Timer T1 filter registers also control the TIN3 filter.

6.1.3 Mode of Operation

The TMR module design operates in only a single mode of operation: functional mode. The various counting modes are detailed in Section 6.3.2, "Functional Modes."

6.1.4 Block Diagram

Each of the timer/counter groups within the quad timer are shown in Figure 6-1.

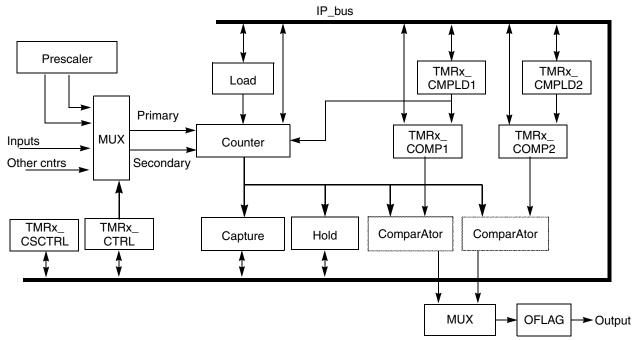


Figure 6-1. Quad Timer Block Diagram

6.2 Memory Map and Registers

6.2.1 Overview

The base address of the TMR module is specified in the data sheet. All memory-mapped registers described below have their location described in relation to the base address.

6.2.2 Module Memory Map

Table 6-1. Timer Memory Map

Address	Reg Name	Access
Base + 0x0	Timer Channel 0 Compare Register 1 (TMR0_COMP1)	Read/Write
Base + 0x1	Timer Channel 0 Compare Register 2 (TMR0_COMP2)	Read/Write
Base + 0x2	Timer Channel 0 Capture Register (TMR0_CAPT)	Read/Write
Base + 0x3	Timer Channel 0 Load Register (TMR0_LOAD)	Read/Write
Base + 0x4	Timer Channel 0 Hold Register (TMR0_HOLD)	Read/Write
Base + 0x5	Timer Channel 0 Counter Register (TMR0_CNTR)	Read/Write
Base + 0x6	Timer Channel 0 Control Register (TMR0_CTRL)	Read/Write
Base + 0x7	Timer Channel 0 Status and Control Register (TMR0_SCTRL)	Read/Write
Base + 0x8	Timer Channel 0 Comparator Load Register 1 (TMR0_CMPLD1)	Read/Write
Base + 0x9	Timer Channel 0 Comparator Load Register 2 (TMR0_CMPLD2)	Read/Write

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Dual Timer (DTMR)

Table 6-1. Timer Memory Map (continued)

Address	Reg Name	Access	
Base + 0xA	Timer Channel 0 Comparator Status and Control Register (TMR0_CSCTRL)	Read/Write	
Base + 0xB	Timer Channel 0 Input Filter Register (TMR0_FILT)	Read/Write	
Base + 0xC- Base + 0xE	Reserved	N/A	
Base + 0xF	Timer Channel Enable Register (TMR0_ENBL)	Read/Write	
Base + 0x10	Timer Channel 1 Compare Register 1 (TMR1_COMP1)	Read/Write	
Base + 0x11	Timer Channel 1 Compare Register 2 (TMR1_COMP2)	Read/Write	
Base + 0x12	Timer Channel 1 Capture Register (TMR1_CAPT)	Read/Write	
Base + 0x13	Timer Channel 1 Load Register (TMR1_LOAD)	Read/Write	
Base + 0x14	Timer Channel 1 Hold Register (TMR1_HOLD)	Read/Write	
Base + 0x15	Timer Channel 1 Counter Register (TMR1_CNTR)	Read/Write	
Base + 0x16	Timer Channel 1 Control Register (TMR1_CTRL)	Read/Write	
Base + 0x17	Timer Channel 1 Status and Control Register (TMR1_SCTRL)	Read/Write	
Base + 0x18	Timer Channel 1 Comparator Load Register 1 (TMR1_CMPLD1)	Read/Write	
Base + 0x19	Timer Channel 1 Comparator Load Register 2 (TMR1_CMPLD2)	Read/Write	
Base + 0x1A	Timer Channel 1 Comparator Status and Control Register (TMR1_CSCTRL)	Read/Write	
Base + 0x1B	Timer Channel 1 Input Filter Register (TMR1_FILT)	Read/Write	
Base + 0x1C- Base + 0x1F	Reserved N/A		
Base + 0x20	Timer Channel 2 Compare Register 1 (TMR2_COMP1)	Read/Write	
Base + 0x21	Timer Channel 2 Compare Register 2 (TMR2_COMP2) Read/Wi		
Base + 0x22	Timer Channel 2 Capture Register (TMR2_CAPT)	Read/Write	
Base + 0x23	Timer Channel 2 Load Register (TMR2_LOAD)	Read/Write	
Base + 0x24	Timer Channel 2 Hold Register (TMR2_HOLD)	Read/Write	
Base + 0x25	Timer Channel 2 Counter Register (TMR2_CNTR)	Read/Write	
Base + 0x26	Timer Channel 2 Control Register (TMR2_CTRL)	Read/Write	
Base + 0x27	Timer Channel 2 Status and Control Register (TMR2_SCTRL)	Read/Write	
Base + 0x28	Timer Channel 2 Comparator Load Register 1 (TMR2_CMPLD1) Rea		
Base + 0x29	Timer Channel 2 Comparator Load Register 2 (TMR2_CMPLD2) Read/Wr		
Base + 0x2A	Timer Channel 2 Comparator Status and Control Register (TMR2_CSCTRL) Read/Wri		
Base + 0x2B	Timer Channel 2 Input Filter Register (TMR2_FILT) Read/Write		
Base + 0x2C- Base + 0x2F	Reserved N/A		
Base + 0x30	Timer Channel 3 Compare Register 1 (TMR3_COMP1)	Read/Write	

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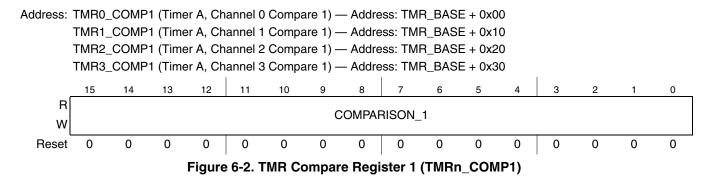
Table 6-1. Timer Memory Map (continued)

Address	Reg Name	Access
Base + 0x31	Timer Channel 3 Compare Register 2 (TMR3_COMP2)	Read/Write
Base + 0x32	Timer Channel 3 Capture Register (TMR3_CAPT) Read/Write	
Base + 0x33	Timer Channel 3 Load Register (TMR3_LOAD)	Read/Write
Base + 0x34	Timer Channel 3 Hold Register (TMR3_HOLD)	Read/Write
Base + 0x35	Timer Channel 3 Counter Register (TMR3_CNTR)	Read/Write
Base + 0x36	Timer Channel 3 Control Register (TMR3_CTRL)	Read/Write
Base + 0x37	Timer Channel 3 Status and Control Register (TMR3_SCTRL)	Read/Write
Base + 0x38	Timer Channel 3 Comparator Load Register 1 (TMR3_CMPLD1)	Read/Write
Base + 0x39	Timer Channel 3 Comparator Load Register 2 (TMR3_CMPLD2)	Read/Write
Base + 0x3A	Timer Channel 3 Comparator Status and Control Register (TMR3_CSCTRL)	Read/Write
Base + 0x3B	Timer Channel 3 Input Filter Register (TMR3_FILT)	Read/Write
Base + 0x3C- Base + 0x3F	Reserved	N/A

6.2.3 Register Descriptions

The address of a register is the sum of a base address and an address offset. The base address is defined in the data sheet and the address offset is defined here. The base address given for each register is TMRn_BASE.

6.2.3.1 TMR Compare Register 1 (TMRn_COMP1)



This read/write register stores the value used for comparison with the counter value. More explanation on the use of TMRn_COMP1 can be found in Section 6.3.2.14, "Usage of Compare Registers."

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6.2.3.2 TMR Compare Register 2 (TMRn_COMP2)

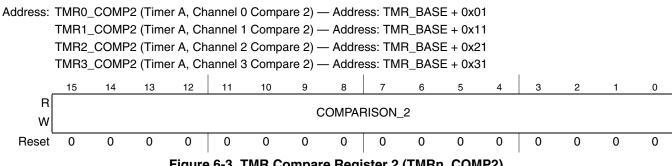
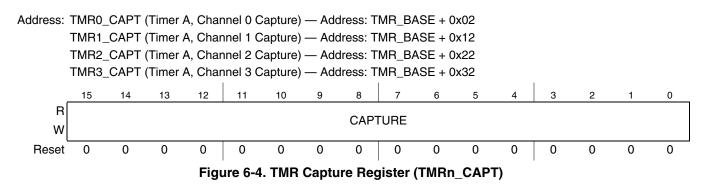


Figure 6-3. TMR Compare Register 2 (TMRn COMP2)

This read/write register stores the value used for comparison with the counter value. More explanation on the use of TMRn_COMP2 can be found in Section 6.3.2.14, "Usage of Compare Registers."

6.2.3.3 TMR Capture Register (TMRn_CAPT)



This read/write register stores the value captured from the counter.

6.2.3.4 TMR Load Register (TMRn LOAD)

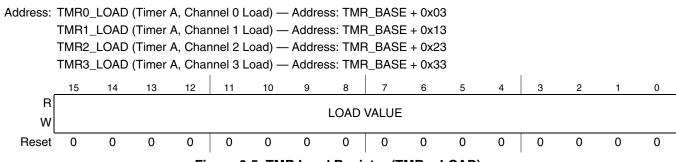
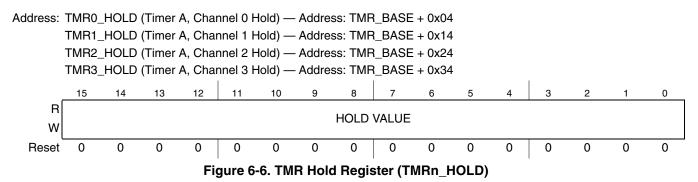


Figure 6-5. TMR Load Register (TMRn_LOAD)

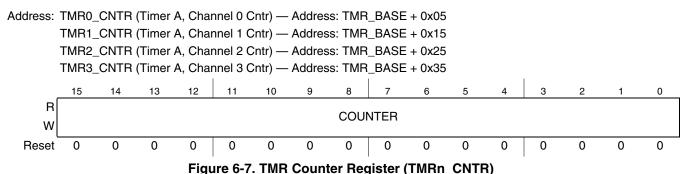
This read/write register stores the value used to initialize the counter.

6.2.3.5 TMR Hold Register (TMRn_HOLD)



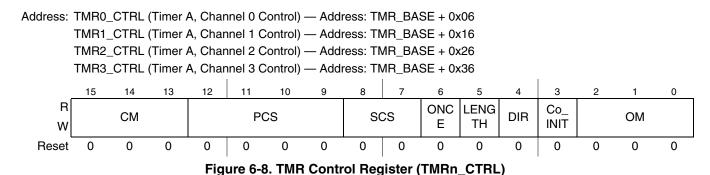
This read/write register stores the counter's values of specific channels whenever any of the four counters within a module is read.

6.2.3.6 TMR Counter Register (TMRn_CNTR)



This read/write register is the counter for the corresponding channel in a timer module.

6.2.3.7 TMR Control Registers (TMRn_CTRL)



Dual Timer (DTMR)

Table 6-2. TMR Control Register (TMRn_CTRL) Descriptions

Field	Description					
15–13 CM	Count Mode. These bits control the basic counting and behavior of the counter.					
	Value	Meaning Meaning				
	000	No operation				
	001	Count rising edges of primary source ¹				
	010	Count rising and falling edges of primary source ²				
	011	Count rising edges of primary source while secondary input high active				
	100	Quadrature count mode, uses primary and secondary sources				
	101	Count primary source rising edges, secondary source specifies direction (1 = minus) ³				
	110	Edge of secondary source triggers primary count till compare				
	111	Cascaded counter mode, up/down ⁴				
	Rising edges counted only when TMRx_SCTRL[IPS] = 0. Falling edges counted when TMRx_SCTRL[IPS] = 1. If primary count source is IP bus clock divide by 1, only rising edge counted regardless of TMRx_SCTRL[IPS] value.					
	_	us clock divide by 1 cannot be used as a primary count source in edge count mode.				
	³ Rising edges counted only when TMRx_SCTRL[IPS] = 0. Falling edges counted when TMRx_SCTRL[IPS] = 1.					
		nary count source must be set to one of the counter outputs.				

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Table 6-2. TMR Control Register (TMRn_CTRL) Descriptions (continued)

Field	Description					
12–9	Primary Count Source. Thes	e bits select t	the p	rimary count source.		
PCS		Value		Meaning		
		0000		Counter 0 input pin		
		0001		Counter 1 input pin		
		0010		Counter 2 input pin		
		0011		Counter 3 input pin		
		0100		Counter 0 output		
		0101		Counter 1 output		
		0110		Counter 2 output		
		0111		Counter 3 output		
		1000		IP bus clock divide by 1 pre	escaler	
		1001		IP bus clock divide by 2 pre	escaler	
		1010		IP bus clock divide by 4 pre	escaler	
		1011		IP bus clock divide by 8 pre	escaler	
		1100		IP bus clock divide by 16 pr	escaler	
		1101		IP bus clock divide by 32 pr	escaler	
		1110		IP bus clock divide by 64 pr	escaler	
		1111		IP bus clock divide by 128 p	rescaler	
	Note: A timer selecting its ov	vn output for	input	is not a legal choice. The resu	ult is no counting.	
8, 7 SCS	Secondary Count Source. These bits identify the external input pin to be used as a count command or timer command. The selected input can trigger the timer to capture the current value of TMRn_CNTR. The selected input can also be used to specify the count direction. The selected signal can also be used as a fault input when TMRn_CSCTRL[FAULT] is set. The polarity of the signal can be inverted by TMRn_SCTRL[IPS].				nput	
		Va	alue	Meaning		
			00	Counter 0 input pin		
			01	Counter 1 input pin		
			10	Counter 2 input pin		
			11	Counter 3 input pin		
6 ONCE	TMRn_COMP1 value. If c	then stop. If counting dowr 0x4 is used	coun n, suc l, the	ting up, successful compare of cessful compare occurs when counter re-initializes after reac	ocurs when the counter reaches a the counter reaches a TMRn_COI hing the TMRn_COMP1 value an	MP2

Table 6-2. TMR Control Register (TMRn_CTRL) Descriptions (continued)

Field	Description				
5 LENGTH	Count Length. This bit determines whether the counter counts to the compare value and then re-initializes itself to the value specified in the TMRn_LOAD (or TMRn_CMPLD2) register, or the counter continues counting past the compare value, to the binary rollover. 1 Count until compare, then reinitialize. If counting up, successful compare occurs when counter reaches TMRn_COMP1 value. If counting down, successful compare occurs when counter reaches TMRn_COMP2 value. When output mode 0x4 is used, alternating values of TMRn_COMP1 and TMRn_COMP2 are used to generate successful comparisons. For example, the counter counts until TMRn_COMP1 value is reached, reinitializes, then counts until TMRn_COMP1 value is reached, etc. 0 Roll Over				
4 DIR	Count Direction. This bit selects either the normal count direction — up — or the reverse direction — down. 1 Count down 0 Count up				
3 Co_INIT	counter/timer will 1 Co-Channel	Co-Channel Initialization. This bit enables another counter/timer within the module to force the reinitialization of this counter/timer when it has an active compare event. 1 Co-Channel counter/timers may force a reinitialization of this counter/timer. 2 Co-Channel counter/timers cannot force a reinitialization of this counter/timer.			
2–0 OM	Output Mode. These bits determine the mode of operation for the OFLAG output signal.				
Olvi		Value	Meaning		
		000	Asserted while counter is active		
		001	Clear OFLAG output on successful compare		
		010	Set OFLAG output on successful compare		
		011	Toggle OFLAG output on successful compare		
	100 Toggle OFLAG output using alternating compare registers				
		101 Set on compare, cleared on secondary source input edge			
		110 Set on compare, cleared on counter rollover			
		111	Enable gated clock output while counter is active		

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6.2.3.8 TMR Status and Control Registers (TMRn_SCTRL)

Reset

0

0

0

Address: TMR0_SCTRL (Timer A, Channel 0 Status and Control) — Address: TMR_BASE + 0x07 TMR1_SCTRL (Timer A, Channel 1 Status and Control) — Address: TMR_BASE + 0x17 TMR2_SCTRL (Timer A, Channel 2 Status and Control) — Address: TMR_BASE + 0x27 TMR3_SCTRL (Timer A, Channel 3 Status and Control) — Address: TMR_BASE + 0x37 **INPU** 0 **TCFI** Т CAPTURE_ TOFI **MST TCF** TOF **IEF IEFIE IPS EEOF** VAL **OPS** OEN Ε **MODE** FOR W CE

Figure 6-9. TMR Status and Control Register (TMRn_SCTRL)

Table 6-3. TMR Status and Control Register (TMRn_SCTRL) Descriptions

Field	Description
15 TCF	Timer Compare Flag. This bit is set when a successful compare occurs. This bit is cleared by writing a zero to this bit location.
14 TCFIE	Timer Compare Flag Interrupt Enable. This bit (when set) enables interrupts when TMRn_SCTRL[TCF] is set.
13 TOF	Timer Overflow Flag. This bit is set when the counter rolls over its maximum value 0xFFFF or 0x0000 (depending on count direction). This bit is cleared by writing a zero to this bit location.
12 TOFIE	Timer Overflow Flag Interrupt Enable. This bit (when set) enables interrupts when TMRn_SCTRL[TOF] is set.
11 IEF	Input Edge Flag. This bit is set when a positive input transition occurs (on an input selected as a secondary count source) while the count mode does not equal 000. This bit is cleared by writing a zero to this bit position. Note: Setting the input polarity select bit, (TMRn_SCTRL[IPS]), enables the detection of negative input edge transitions. Also, the control register's secondary count source determines which external input pin is monitored by the detection circuitry.
10 IEFIE	Input Edge Flag Interrupt Enable. This bit (when set) enables interrupts when TMRn_SCTRL[IEF] is set.
9 IPS	Input Polarity Select. This bit (when set) inverts the input signal polarity.
8 INPUT	External input signal. This read-only bit reflects the current state of the external input pin selected via the secondary count source after application of TMRn_SCTRL[IPS] and filtering.

Table 6-3. TMR Status and Control Register (TMRn_SCTRL) Descriptions (continued)

Field	Description					
7, 6 CAPTURE_ MODE	Input Capture Mode. These bits specify the operation of the capture register as well as the operation of the input edge flag. The input source is the secondary count source.					
WODE		Capture Mode	IPS	Meaning		
		00	Х	Capture function is disabled.		
		01	0	Load Capture register on rising edge of input.		
			1	Load Capture register on falling edge of input.		
		10	0	Load Capture register on falling edge of input.		
			1	Load Capture register on rising edge of input.		
		11	Х	Load Capture register on both edges of input.		
5 MSTR	Master Mode. This bit (when set) enables the compare function's output to be broadcast to the other counter/timers in the module. This signal then can be used to reinitialize the other counters and/or force their OFLAG signal outputs.					
EEOF	Enable External OFLAG Force. This bit (when set) enables the compare from another counter/timer within the same module to force the state of this counter's OFLAG output signal.					
3 VAL	Forced OFLAG Value. This bit determines the value of the OFLAG output signal when software sets TMRn_SCTRL[FORCE].					
2 FORCE	Force the OFLAG output. This write-only bit forces the current value of TMRn_SCTRL[VAL] to be written to the OFLAG output. This bit always reads as a zero. TMRn_SCTRL[VAL] and TMRn_SCTRL[FORCE] can be written simultaneously in a single write operation. Write to TMRn_SCTRL[FORCE] only if the counter is disabled. Setting this bit while the counter is enabled may yield unpredictable results.					
1 OPS	Output Polarity Select. This bit determines the polarity of the OFLAG output signal. O True polarity. 1 Inverted polarity.					
0 OEN	Output Enable. This bit determines the direction of the external pin. OFLAG output signal is driven on the external pin. Other timer groups using this external pin as their input see the driven value. The polarity of the signal is determined by TMRn_SCTRL[OPS]. The external pin is configured as an input.					

6.2.3.9 TMR Comparator Load Register 1 (TMRn_CMPLD1)

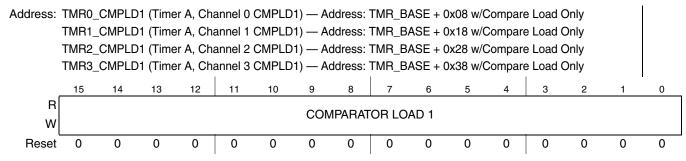
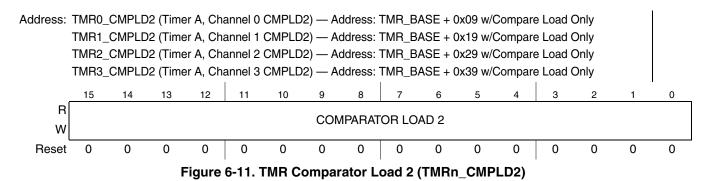


Figure 6-10. TMR Comparator Load 1 (TMRn_CMPLD1)

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This read/write register is the comparator one preload value for the TMRn_COMP1 register for the corresponding channel in a timer module. More information on the use of this register can be found in Section 6.3.2.15, "Usage of Compare Load Registers."

6.2.3.10 TMR Comparator Load Register 2 (TMRn_CMPLD2)



This read/write register is the comparator two preload value for the TMRn_COMP2 register for the corresponding channel in a timer module. More information on the use of this register can be found in Section 6.3.2.15, "Usage of Compare Load Registers."

6.2.3.11 TMR Comparator Status and Control Register (TMRn_CSCTRL)

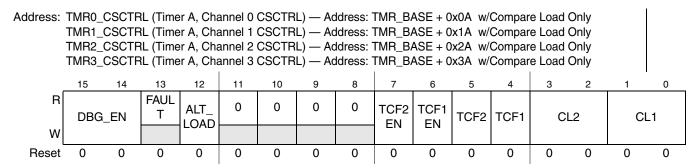


Figure 6-12. TMR Comparator Status and Control Register (TMRn_CSCTRL)

Table 6-4. TMR Comparator Status and Control Register (TMRn_CSCTRL) Descriptions

Field	Description					
15, 14 DBG_EN	Debug Actions Enable. These bits allow the TMR module to perform certain actions in response to the chip ento debug mode.					
	Value Meaning					
	00	Continue with normal operation during debug mode (default).				
	01	Halt TMR counter during debug mode.				
	10	Force TMR output to zero (prior to consideration of TMRx_SCTRL[OPS]).				
	11	Both halt counter and force output to 0 during debug mode.				
13 FAULT	Fault Enable. The selected secondary input acts as a fault signal so that the timer OFLAG is cleared when the secondary input is set. 1 Fault function enabled. 0 Fault function disabled.					
12 ALT_ LOAD	Alternative Load Enable. This bit allows for an alternative method for loading the counter during modulo counting. Normally, the counter can only be loaded with the value from the TMRn_LOAD register. When this bit is set, the counter is loaded from the TMRn_LOAD register when counting up and a match with TMRn_COMP1 occurs, and the counter is loaded from the TMRn_CMPLD2 register when counting down and a match with TMRn_COMP2 occurs. 1 Counter can be reinitialized with the TMRn_LOAD or TMRn_CMPLD2 registers, depending on count direction. 0 Counter can only be reinitialized with the TMRn_LOAD register.					
11–8	Reserved.					
7 TCF2EN	Timer Compare 2 Interrupt Enable. An interrupt is issued when both this bit and TMRn_CSCTRL[TCF2] are set.					
6 TCF1EN	Timer Compare 1 Interrupt Enable. An interrupt is issued when both this bit and TMRn_CSCTRL[TCF1] are set.					
5 TCF2	Timer Compare 2 Interrupt Flag. When set, this bit indicates a successful comparison of the timer and TMRn_COMP2 register has occurred. This bit is sticky and remains set until explicitly cleared by writing a zero to this bit location.					
4 TCF1	Timer Compare 1 Interrupt Flag. When set, this bit indicates a successful comparison of the timer and the TMRn_COMP1 register has occurred. This bit is sticky and remains set until explicitly cleared by writing a zero to this bit location.					

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Table 6-4. TMR Comparator Status and Control Register (TMRn_CSCTRL) Descriptions (continued)

Field	Description				
3, 2 CL2	Compare Load Control 2. These bits control when TMRn_COMP2 is preloaded with the value from TMRn_CMPLD2.				
		Value Meaning			
		00	Never preload		
		01	Load upon successful compare with the value in TMRx_COMP1		
		10	Load upon successful compare with the value in TMRx_COMP2		
		Reserved			
1, 0 Compare Load Control 1. These bits control when TMRn_COMP1 is preloaded with the value			hese bits control when TMRn_COMP1 is preloaded with the value froi 	m TMRn_CMPLD1.	
02.			Meaning		
		00	Never preload		
		01	Load upon successful compare with the value in TMRx_COMP1		
		10	Load upon successful compare with the value in TMRx_COMP2		
11 Reserved		Reserved			

6.2.3.12 TMR Input Filter Register (TMRn_FILT)

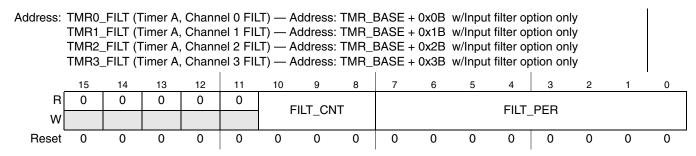


Figure 6-13. TMR Input Filter Register (TMRn_FILT)

Table 6-5. TMR Input Filter Register (TMRn_FILT) Descriptions

Field	Description
15–11	Reserved.
10–8 FILT_ CNT	Input Filter Sample Count. These bits represent the number of consecutive samples that must agree prior to the input filter accepting an input transition. A value of 0x0 represents 3 samples. A value of 0x7 represents 10 samples. The value of TMRn_FILT[FILT_CNT] affects the input latency, as described in "Input Filter Considerations."
7–0 FILT_ PER	Input Filter Sample Period. These bits represent the sampling period (in IP bus clock cycles) of the TMR input signals. Each input is sampled multiple times at the rate specified by this field. If TMRn_FILT[FILT_PER] is 0x00 (default), then the input filter is bypassed. The value of TMRn_FILT[FILT_PER] affects the input latency, as described in "Input Filter Considerations."

Input Filter Considerations

The TMRn_FILT[FILT_PER] value should be set such that the sampling period is larger than the period of the expected noise. This way a noise spike only corrupts one sample. The TMRn_FILT[FILT_CNT] value should be chosen to reduce the probability of noisy samples causing an incorrect transition to be recognized. The probability of an incorrect transition is defined as the probability of an incorrect sample raised to the TMRn_FILT[FILT_CNT] + 3 power.

The values of TMRn_FILT[FILT_PER] and TMRn_FILT[FILT_CNT] must also be traded off against the desire for minimal latency in recognizing input transitions. Turning on the input filter (setting TMRn_FILT[FILT_PER] to a non-zero value) introduces a latency of: (((TMRn_FILT[FILT_CNT] + 3) x TMRn_FILT[FILT_PER]) + 2) IP bus clock periods.

6.2.3.13 TMR Channel Enable Register (TMRn_ENBL)

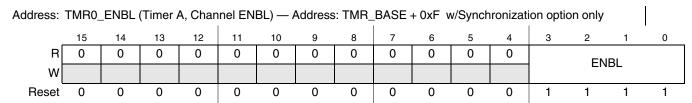


Figure 6-14. TMR Channel Enable Register (TMRn_ENBL)

Table 6-6. TMR Channel Enable Register (TMRn ENBL) Descriptions

Field	Description
15–4	Reserved
3–0 ENBL	Timer Channel Enable. These bits enable the prescaler (if it is being used) and counter in each channel. Multiple ENBL bits can be set at the same time to synchronize the start of separate counters. If an ENBL bit is set, then the corresponding channel starts the counter as soon as the TMRn_CTRL[CM] field has a value other than 0. When an ENBL bit is clear, the corresponding counter maintains its current value. 1 Timer channel is enabled (default) 0 Timer channel is disabled

6.3 Functional Description

6.3.1 General

The counter/timer has two basic modes of operation: it can count internal or external events, or it can count an internal clock source while an external input signal is asserted, thus timing the width of the external input signal.

- The counter can count the rising, falling, or both edges of the selected input pin.
- The counter can decode and count quadrature encoded input signals.
- The counter can count up and down using dual inputs in a "count with direction" format.
- The counter's terminal count value (modulo) is programmable.
 - The value that is loaded into the counter after reaching its terminal count is programmable.

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- The counter can count repeatedly, or it can stop after completing one count cycle.
- The counter can be programmed to count to a programmed value and then immediately reinitialize, or it can count through the compare value until the count rolls over to zero.

The external inputs to each counter/timer are shareable among each of the four counter/timers within the module. The external inputs can be used:

- As count commands
- As timer commands
- To trigger the current counter value to be captured
- To generate interrupt requests

The polarity of the external inputs is selectable.

The primary output of each timer/counter is the output signal OFLAG. The OFLAG output signal can be:

- Set, cleared, or toggled when the counter reaches the programmed value.
- The OFLAG output signal may be output to an external pin instead of having that pin serve as a timer input.
- The OFLAG output signal enables each counter to generate square waves, PWM, or pulse stream outputs.
- The polarity of the OFLAG output signal is selectable.

Any counter/timer can be assigned as a master. A master's compare signal can be broadcast to the other counter/timers within the module. The other counters can be configured to reinitialize their counters and/or force their OFLAG output signals to predetermined values when a master's counter/timer compare event occurs.

6.3.2 Functional Modes

The selected external count signals are sampled at the TMR's base clock rate and then run through a transition detector. The maximum count rate is one-half of the TMR's base clock rate. Internal clock sources can be used to clock the counters at the TMR's base clock rate.

If a counter is programmed to count to a specific value and then stop, the TMRn_CTRL[CM] field is cleared when the count terminates.

6.3.2.1 Stop Mode

If TMRn_CTRL[CM] is set to 000, the counter is inert. No counting occurs. Stop mode also disables the interrupts caused by input transitions on a selected input pin.

6.3.2.2 Count Mode

If TMRn_CTRL[CM] is set to 001, the counter counts the rising edges of the selected clock source. This mode is useful for generating periodic interrupts for timing purposes, or counting external events such as items on a conveyor belt passing a sensor. If the selected input is inverted by setting TMRn_SCTRL[IPS] (input polarity select), then the negative edge of the selected external input signal is counted.

See Section 6.3.2.10, "Cascade Count Mode," through Section 6.3.2.13, "Variable-Frequency PWM Mode" for additional capabilities of this operating mode.

Example 6-1. Count Pulses from External Source

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRA1 to count pulse (actually counts rising edges of the pulse)
// from an external source (TA3).
//
void Pulse_Init(void)
 /* TMRA1_CTRL: CM=0,PCS=3,SCS=0,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA1_CTRL,0x0600);
                                /* Set up mode */
 /* TMRA1_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
        Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
setReg(TMRA1_SCTRL,0x00);
setReg(TMRA1_CNTR,0x00);
                                /* Reset counter register */
                           /* Reset load register */
setReg(TMRA1_LOAD,0x00);
setRegBitGroup(TMRA1_CTRL,CM,0x01); /* Run counter */
```

Example 6-2. Generate Periodic Interrupt By Counting Internal Clocks

```
//
      (See Processor Expert TimerInt bean.)
// This example generates an interrupt every 100ms,
   assuming the chip is operating at 60 MHz.
// It does this by using the IP_bus_clk divided by 128 as the counter clock source.
// The counter then counts to 46874 where it matches the COMP1 value.
// At that time an interrupt is generated, the counter is reloaded and
// the next COMP1 value is loaded from CMPLD1.
//
void TimerInt_Init(void)
 /* TMRAO_CTRL: CM=0,PCS=0,SCS=0,ONCE=0,LENGTH=1,DIR=0,CO_INIT=0,OM=0 */
setReg(TMRA0_CTRL,0x20);
                               /* Stop all functions of the timer */
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
        Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=0,OPS=0,OEN=0 */
 setReg(TMRA0_SCTRL,0x00);
 setReg(TMRA0_LOAD,0x00);
                                /* Reset load register */
 setReg(TMRA0_COMP1,46874);
                                /* Set up compare 1 register */
 setReg(TMRA0_CMPLD1,46874);
                                /* Also set the compare preload register */
 /* TMRAO_CSCTRL: ??=0,??=0,??=0,??=0,??=0,??=0,??=0,TCF2EN=0,TCF1EN=1,
          TCF2=0,TCF1=0,CL2=0,CL1=1 */
 setReg(TMRA0_CSCTRL,0x41);
                                /* Enable compare 1 interrupt and */
                    /* compare 1 preload
                                               * /
 setRegBitGroup(TMRA0_CTRL,PCS,0xF); /* Primary Count Source to IP_bus_clk / 128 */
```

6.3.2.3 Edge Count Mode

If TMRn_CTRL[CM] is set to 010, the counter counts both edges of the selected external clock source. This mode is useful for counting changes in the external environment, such as a simple encoder wheel.

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Example 6-3. Count Both Edges of External Source Signal

6.3.2.4 Gated Count Mode

If TMRn_CTRL[CM] is set to 011, the counter counts while the selected secondary input signal is high. This mode is used to time the duration of external events. If the selected input is inverted by setting TMRn_SCTRL[IPS] (input polarity select), then the counter counts while the selected secondary input is low.

Example 6-4. Capture Duration of External Pulse

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRA1 to determine the duration of an external pulse.
//
// The IP_bus clock is used as the primary counter. If the duration of the
// external pulse is longer than 0.001 seconds one of the other IP bus clock
   dividers can be used. If the pulse duration is longer than 0.128 seconds
   an external clock source will have to be used as the primary clock source.
//
void Pulse1_Init(void)
 /* TMRA1_CTRL: CM=0,PCS=8,SCS=1,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA1_CTRL, 0x1080);
                                  /* Set up mode */
 /* TMRA1_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
        Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
setReg(TMRA1_SCTRL,0x00);
 setReg(TMRA1_CNTR,0x00);
                                /* Reset counter register */
 setReg(TMRA1_LOAD,0x00);
                                /* Reset load register */
```

6.3.2.5 Quadrature Count Mode

If TMRn_CTRL[CM] is set to 100, the counter decodes the primary and secondary external inputs as quadrature encoded signals. Quadrature signals are usually generated by rotary or linear sensors used to monitor movement of motor shafts or mechanical equipment. The quadrature signals are square waves that

are ninety degrees out of phase. Decoding the quadrature signal provides both count and direction information.

Figure 6-15 shows a timing diagram illustrating the basic operation of a quadrature incremental position encoder.

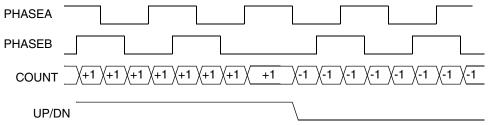


Figure 6-15. Quadrature Incremental Position Encoder

Example 6-5. Quadrature Count Mode Example

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRAO for counting states of a quadrature position encoder.
//
// Timer input 0 is used as the primary count source (PHASEA).
// Timer input 1 is used as the secondary count source (PHASEB).
//
void Pulse_Init(void)
 /* TMRA0_CTRL: CM=0,PCS=0,SCS=1,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRC0_CTRL,0x80);
                                /* Set up mode */
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
        Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
 setReg(TMRA0_SCTRL,0x00);
setReg(TMRA0_CNTR,0x00);
                                /* Reset counter register */
setReg(TMRA0_LOAD,0x00);
                                /* Reset load register */
setReg(TMRA0_COMP1,0xFFFF);
                                  /* Set up compare 1 register */
setReg(TMRA0_COMP2,0x00);
                                 /* Set up compare 2 register */
 /* TMRA0_CSCTRL: ??=0,??=0,??=0,??=0,??=0,??=0,??=0,
          TCF2EN=0, TCF1EN=0, TCF2=0, TCF1=0, CL2=0, CL1=0 */
setReg(TMRA0_CSCTRL,0x00);
```

6.3.2.6 Quadrature Count Mode with Index Input

As an extension to the quadrature count mode discussed in the previous section, some rotary shafts have a HOME or INDEX indicator. This would be a third input to the timer that is used to reset the timer's counter.

In this example, channel 0 is used to decode the quadrature inputs, but it doesn't actually count. Because its upper and lower limits are both set to zero, it outputs its cascaded count up and count down signals each time the quadrature inputs indicate a change in count. Channel 1 works in cascaded count mode receiving

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its counting instructions from channel 0. When an input capture event occurs, channel 1 is programmed to reset its counter value. The channel 1 counter contains the position value for the shaft.

Example 6-6. Quadrature Count Mode with Index Input Example

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRA0and TMRA1 for counting states of a quadrature position encoder.
//
// Timer input 0 is used as the primary count source (PHASEA).
// Timer input 1 is used as the secondary count source (PHASEB).
// Timer input 2 is used as the index input source (INDEX).
//
void Pulse_Init(void)
 /* TMRAO_CTRL: CM=0,PCS=0,SCS=1,ONCE=0,LENGTH=1,DIR=0,CO_INIT=0,OM=0 */
setReg(TMRA0_CTRL,0xA0);
                              /* Set up mode */
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=0,OPS=0,OEN=0 */
setReg(TMRA0_SCTRL,0x00);
setReg(TMRA0_CNTR,0x00);
                              /* Reset counter register */
setReg(TMRA0_LOAD,0x00);
                              /* Reset load register */
setReg(TMRA0_COMP1,0x00);
                              /* Set up compare 1 register */
setReg(TMRA0_COMP2,0x00);
                               /* Set up compare 2 register */
 TCF2EN=0,TCF1EN=0,TCF2=0,TCF1=0,CL2=0,CL1=0 */
setReg(TMRA0_CSCTRL,0x00);
/* TMRA1_CTRL: CM=7,PCS=100,SCS=2,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA1_CTRL,0xEA00);
                                /* Set up capture edge */
/* TMRA1_SCTRL: Capture_Mode=10 */
setReg(TMRA1_SCTRL,0x0080);
/* TMRA1_CSTRL: ROC=1 */
setReg(TMRA1_CTRL,0x0800);
                                /* Set up reload on capture */
setRegBitGroup(TMRA0_CTRL,CM,0x04); /* Run counter */
```

6.3.2.7 Signed Count Mode

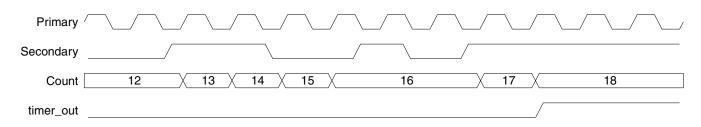
If TMRn_CTRL[CM] is set to 101, the counter counts the primary clock source while the selected secondary source provides the selected count direction (up/down).

Example 6-7. Signed Count Mode Example

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRAO for signed mode counting.
//
// Timer input 2 is used as the primary count source.
// Timer input 1 is used to determine the count direction.
void Pulse_Init(void)
 /* TMRAO_CTRL: CM=0,PCS=2,SCS=1,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA0 CTRL, 0x0480);
                                   /* Set up mode */
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=1,IEF=0,IEFIE=0,IPS=0,INPUT=0,
        Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
 setReg(TMRA0_SCTRL, 0x1000);
 setReg(TMRA0 CNTR, 0x00);
                                 /* Reset counter register */
 setReg(TMRA0_LOAD,0x00);
                                 /* Reset load register */
```

6.3.2.8 Triggered Count Mode

If TMRn_CTRL[CM] is set to 110, the counter begins counting the primary clock source after a positive transition (negative edge if TMRn_SCTRL[IPS] = 1) of the secondary input occurs. The counting continues until a compare event occurs or another positive input transition is detected. If a second input transition occurs before a terminal count was reached, counting stops and TMRn_SCTRL[TCF] (timer compare flag) is set. Subsequent secondary input transitions continue to restart and stop the counting until a compare event occurs. If TMRn_CSCTRL[TCI] is set, then a second input transition won't cause the counting to stop or set TMRn_SCTRL[TCF]. Instead, the counter reloads and continues counting. When TMRn_CSCTRL[TCI] is set, the OFLAG output mode, TMRn_CTRL[OUTMODE], should probably be set to 101 (cleared on init, set on compare) to ensure that the output is in a known state after the second input transition and subsequent reload takes place.



TMRx_COMP1 = 18

Figure 6-16. Triggered Count Mode (TMRn_CTRL[LENGTH]=0)

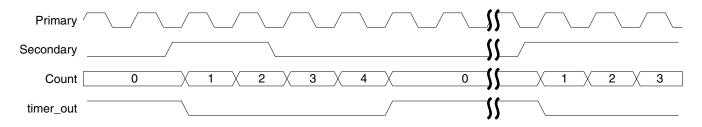
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Example 6-8. Triggered Count Mode Example

```
(See Processor Expert PulseAccumulator bean.)
// This example uses TMRA1 for triggered mode counting.
//
// Timer input 3 is used as the primary count source.
// Timer input 2 is used for the trigger input.
void Pulse_Init(void)
 /* TMRA1_CTRL: CM=0,PCS=3,SCS=2,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA1_CTRL,0x0700);
                               /* Set up mode */
 /* TMRA1_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=1,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
 setReg(TMRA1_SCTRL, 0x1000);
setReg(TMRA1 CNTR, 0x00);
                              /* Reset counter register */
setReg(TMRA1_LOAD,0x00);
                              /* Reset load register */
setReg(TMRA1_COMP1,0x0012);
                                /* Set up compare 1 register */
 TCF2EN=0, TCF1EN=0, TCF2=0, TCF1=0, CL2=0, CL1=0 */
setReg(TMRA1_CSCTRL,0x00);
```

6.3.2.9 One-Shot Mode

If TMRn_CTRL[CM] is set to 110, and the counter is set to reinitialize at a compare event (TMRn_CTRL[LENGTH]=1), and TMRn_CTRL[OUTMODE] is set to 101 (cleared on init, set on compare), the counter works in one-shot mode. An external event causes the counter to count — when terminal count is reached, the output is asserted. This delayed output can be used to provide timing delays.



TMRx_LOAD = 0, TMRx_COMP1 = 4
Figure 6-17. One-Shot Mode (TMRn_CTRL[LENGTH]=1)

Example 6-9. One-Shot Mode Example

```
// (See Processor Expert PulseAccumulator bean.)
// This example uses TMRA1 for one-shot mode counting.
//
// Timer input 3 is used as the primary count source.
// Timer input 2 is used for the trigger input.
void Pulse_Init(void)
 /* TMRA1_CTRL: CM=0,PCS=3,SCS=2,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=5 */
setReg(TMRA1 CTRL, 0x0725);
                             /* Set up mode */
 /* TMRA1_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=1,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=0 */
 setReg(TMRA1_SCTRL, 0x1000);
setReg(TMRA1 CNTR, 0x00);
                             /* Reset counter register */
setReg(TMRA1_LOAD,0x00);
                             /* Reset load register */
setReg(TMRA1_COMP1,0x0004);
                               /* Set up compare 1 register */
 TCF2EN=0, TCF1EN=0, TCF2=0, TCF1=0, CL2=0, CL1=0 */
setReg(TMRA1_CSCTRL,0x00);
```

6.3.2.10 Cascade Count Mode

If TMRn_CTRL[CM] is set to 111, the counter's input is connected to the output of another selected counter. The counter counts up and down as compare events occur in the selected source counter. This cascade or daisy-chained mode enables multiple counters to be cascaded to yield longer counter lengths. When operating in cascade mode, a special high-speed signal path is used between modules rather than the OFLAG output signal. If the selected source counter is counting up and it experiences a compare event, the counter is incremented. If the selected source counter is counting down and it experiences a compare event, the counter is decremented.

Up to four counters may be cascaded to create a 64-bit wide synchronous counter. Check the data sheet to see whether there are any frequency limits for cascaded counting mode.

Whenever any counter is read within a counter module, all of the counters' values within the module are captured in their respective hold registers. This action supports the reading of a cascaded counter chain. First read any counter of a cascaded counter chain, then read the hold registers of the other counters in the chain. The cascaded counter mode is synchronous.

NOTE

It is possible to connect counters together by using the other (non-cascade) counter modes and selecting the outputs of other counters as a clock source. In this case, the counters are operating in a ripple mode, where higher order counters transition a clock later than a purely synchronous design.

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Example 6-10. Generate Periodic Interrupt Cascading Two Counters

```
(See Processor Expert TimerInt bean.)
// This example generates an interrupt every 30 seconds,
// assuming the chip is operating at 60 MHz.
//
// To do this, counter 2 is used to count 60,000 IP_bus clocks, which means it
// will compare and reload every 0.001 seconds.
// Counter 3 is cascaded and used to count the 0.001 second ticks and
// generate the desired interrupt interval.
//
void TimerInt_Init(void)
// Set counter 2 to count IP_bus clocks
/* TMRA2_CTRL: CM=0,PCS=8,SCS=0,ONCE=0,LENGTH=1,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA2_CTRL, 0x1020);
                              /* Stop all functions of the timer */
// Set counter 3 as cascaded and to count counter 2 outputs
 /* TMRA3_CTRL: CM=7,PCS=6,SCS=0,ONCE=0,LENGTH=1,DIR=0,Co_INIT=0,OM=0 */
setReg(TMRA3_CTRL,0xEC20);
                               /* Set up cascade counter mode */
 /* TMRA3_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=0,OPS=0,OEN=0 */
setReg(TMRA3_SCTRL,0x00);
 /* TMRA2_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=0,OPS=0,OEN=0 */
 setReg(TMRA2_SCTRL,0x00);
setReg(TMRA3_CNTR,0x00);
                               /* Reset counter register */
setReg(TMRA2_CNTR,0x00);
setReg(TMRA3_LOAD,0x00);
                               /* Reset load register */
setReg(TMRA2_LOAD,0x00);
setReg(TMRA3_COMP1, 30000);
                                /* milliseconds in 30 seconds */
setReg(TMRA3_CMPLD1,30000);
setReg(TMRA2_COMP1, 60000);
                                // Set to cycle every milisecond
setReg(TMRA2_CMPLD1,60000);
 /* TMRA3_CSCTRL: ??=0,??=0,??=0,??=0,??=0,??=0,??=0,
         TCF2EN=0, TCF1EN=1, TCF2=0, TCF1=0, CL2=0, CL1=1 */
setReg(TMRA3_CSCTRL, 0x41);
                               /* Enable compare 1 interrupt and */
                   /* compare 1 preload
                                              * /
 TCF2EN=0, TCF1EN=0, TCF2=0, TCF1=0, CL2=0, CL1=1 */
```

6.3.2.11 Pulse Output Mode

If TMRn_CTRL[CM] = 001, and TMRn_CTRL[OUTMODE] is set to 111 (gated clock output), and TMRn_CTRL[ONCE] is set, then the counter outputs a stream of pulses that has the same frequency as the selected clock source. The number of output pulses is equal to the compare value minus the init value. This mode is useful for driving step motor systems.

NOTE

This does not work if TMRn_CTRL[PCS] is set to 1000 (IP_bus/1).

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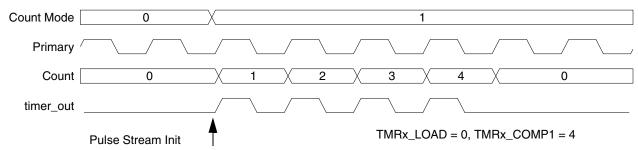


Figure 6-18. Pulse Output Mode

Example 6-11. Pulse Outputs Using Two Counters

```
(See Processor Expert PulseStream bean.)
// This example generates six 10ms pulses, from TA1 output.
// Assuming the chip is operating at 60 MHz.
//
// To do this, timer 3 is used to generate a clock with a period of 10ms.
//
// Timer 1 is used to gate these clocks and count the number of pulses that have
// been generated.
//
void PulseStream Init(void)
// Select IP_bus_clk/16 as the clock source for Timer A3
/* TMRA3_CTRL: CM=0,PCS=0x0C,SCS=0,ONCE=0,LENGTH=1,DIR=0,Co_INIT=0,OM=3 */
 setReg(TMRA3_CTRL, 0x1823);
                                 /* Set up mode */
 /* TMRA3_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=0,OPS=0,OEN=0 */
 setReg(TMRA3_SCTRL,0x00);
 setReg(TMRA3_LOAD,0x00);
                                /* Reset load register */
                                /* (16 * 37500 ) / 60e6 = 0.01 sec */
 setReg(TMRA3_COMP1,37500);
 TCF2EN=0, TCF1EN=0, TCF2=0, TCF1=0, CL2=0, CL1=0 */
setReg(TMRA3_CSCTRL,0x00);
                              /* Set up comparator control register */
// Timer 3 output is the clock source for this timer.
 /* TMRA1_CTRL: CM=0,PCS=7,SCS=0,ONCE=1,LENGTH=1,DIR=0,Co_INIT=0,OM=7 */
setReg(TMRA1_CTRL, 0x0E67);
                               /* Set up mode */
 /* TMRA1 SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=0, OPS=0, OEN=1 */
setReg(TMRA1_SCTRL,0x01);
setReg(TMRA1_CNTR,0x00);
                               /* Reset counter register */
setReg(TMRA1_LOAD,0x00);
                              /* Reset load register */
setReg(TMRA1_COMP1,0x04);
                               /* Set up compare 1 register */
// set to interrupt after the last pulse
 /* TMRA1_CSCTRL: ??=0,??=0,??=0,??=0,??=0,??=0,??=0,
         TCF2EN=0, TCF1EN=1, TCF2=0, TCF1=0, CL2=0, CL1=0 */
setReg(TMRA1_CSCTRL, 0x40);
                               /* Set up comparator control register */
// Finally, start the counters running
setReg(TMRA3_CNTR,0);
                           /* Reset counter */
```

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6.3.2.12 Fixed-Frequency PWM Mode

If TMRn_CTRL[CM] = 001, count through roll-over (TMRn_CTRL[LENGTH]) = 0, continuous count (TMRn_CTRL[ONCE]) = 0 and TMRn_CTRL[OUTMODE] is 110 (set on compare, cleared on counter roll-over), then the counter output yields a pulse-width modulated (PWM) signal with a frequency equal to the count clock frequency divided by 65,536 and a pulse-width duty cycle equal to the compare value divided by 65,536. This mode of operation is often used to drive PWM amplifiers that power motors and inverters.

Example 6-12. Fixed-Frequency PWM Mode Example

```
(See Processor Expert PWM bean.)
// This example uses TMRAO for Fixed-Frequency PWM mode timing.
//
// The timer will count IP bus clocks continuously until it rolls over.
// This results in a PWM period of 65536 / 60e6 = 1092.267 usec
//
// Initially, an output pulse width of 25 usec is generated ( 1500 / 60e6 )
// giving a PWM ratio of 1500 / 65536 = 2.289%
// This pulse width can be changed by changing the COMP1 register value (using CMPLD1).
void PWM1_Init(void)
                              /* Reset counter */
setReg(TMRA0_CNTR,0);
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0, MSTR=0, EEOF=0, VAL=0, FORCE=1, OPS=0, OEN=1 */
setReg(TMRA0 SCTRL, 0x05);
                            /* Enable output */
setReg(TMRA0_COMP1,1500);
                               /* Store initial value to the duty-compare register */
 /* TMRAO_CTRL: CM=1,PCS=8,SCS=0,ONCE=0,LENGTH=0,DIR=0,Co_INIT=0,OM=6 */
```

6.3.2.13 Variable-Frequency PWM Mode

If TMRn_CTRL[CM] = 001, count till compare (TMRn_CTRL[LENGTH]) = 1, continuous count (TMRn_CTRL[ONCE]) = 0 and TMRn_CTRL[OUTMODE] is 100 (toggle OFLAG and alternate compare registers), then the counter output yields a pulse-width modulated (PWM) signal whose frequency and pulse width is determined by the values programmed into the TMRn_COMP1 and TMRn_COMP2 registers, and by the input clock frequency. This method of PWM generation has the advantage of allowing almost any desired PWM frequency and/or constant on or off periods. This mode of operation is often used to drive PWM amplifiers that power motors and inverters. The TMRn_CMPLD1 and TMRn_CMPLD2 registers are especially useful for this mode, as they allow the programmer enough time to calculate values for the next PWM cycle while the PWM current cycle is underway.

To set up the TMR to run in variable frequency PWM mode with compare preload, please use the following setup for the specific counter you would like to use. When performing the setup it is suggested that the TMRn_CTRL register be updated last, as the counter starts counting if the count mode is changed to any value other than 3'b000 (assuming the primary count source is already active).

- Timer Control Register (TMRn_CTRL)
 - CM = 3'b001 (count rising edges of primary source)

- PCS = 4'b1000 (IP bus clock for best granularity for waveform timing)
- SCS = Any (ignored in this mode)
- ONCE = 1'b0 (want to count repeatedly)
- LENGTH = 1'b1 (want to count until compare value is reached and reinitialize counter register)
- DIR = Any (user's choice compare register values need to be chosen carefully to account for things like roll-under, etc.)
- COINIT = 1'b0 (user can set it if this function is needed)
- OUTMODE = 3'b100 (Toggle OFLAG output using alternating compare registers)
- Timer Status and Control Register (TMRn SCTRL)
 - OEN = 1'b1 (Output enable to allow OFLAG output to be put on an external pin set this bit as needed)
 - OPS = Any (user's choice)
 - Make sure the rest of the bits are cleared for this register enable interrupts in the comparator status and control register instead of in this register
- Comparator Status and Control Register (TMRn_CSCTRL)
 - TCF2EN = 1'b1 (allow interrupt to be issued when TMRn_CSCTRL[TCF2] is set)
 - TCF1EN = 1'b0 (do not allow interrupt to be issued when TMRn_CSCTRL[TCF1] is set)
 - TCF1 = 1'b0 (clear timer compare 1 interrupt source flag this is set when counter register equals compare register 1 value and OFLAG is low)
 - TCF2 = 1'b0 (clear timer compare 2 interrupt source flag this is set when counter register equals compare register 2 value and OFLAG is high)
 - CL1 = 2'b10 (load compare register when TMRn_CSCTRL[TCF2] is asserted)
 - CL2 = 2'b01 (load compare register when TMRn_CSCTRL[TCF1] is asserted)
- Interrupt Service Routines

To service the TMRn_CSCTRL[TCF2] interrupts generated by the timer, the interrupt controller must be configured to enable the interrupts for the particular timer being used. Additionally the user needs to write an interrupt service routine to do at a minimum:

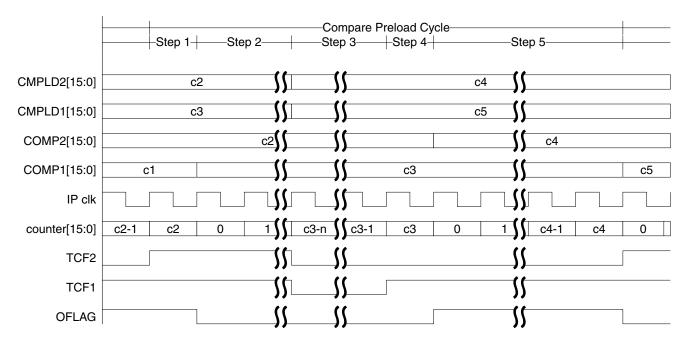
- Clear TMRn_CSCTRL[TCF2] and TMRn_CSCTRL[TCF1] flags.
- Calculate and write new values for both TMRn CMPLD1 and TMRn CMPLD2.

Timing

Figure 6-19 contains the timing for using the compare preload feature. The compare preload cycle begins with a compare event on TMRn_COMP2 causing TMRn_CSCTRL[TCF2] to be asserted. TMRn_COMP1 is loaded with the value in the TMRn_CMPLD1 (c3) one IP bus clock later. In addition, an interrupt is asserted by the timer and the interrupt service routine is executed, during which both comparator load registers are updated with new values (c4 and c5). When TMRn_CSCTRL[TCF1] is asserted, TMRn_COMP2 is loaded with the value in TMRn_CMPLD2 (c4). And on the subsequent TMRn_CSCTRL[TCF2] event, TMRn_COMP1 is loaded with the value in TMRn_CMPLD1 (c5). The cycle starts over again as an interrupt is asserted and the interrupt service routine clears TMRn_CSCTRL[TCF1] and TMRn_CSCTRL[TCF2], then calculates new values for TMRn_CMPLD1 and TMRn_CMPLD2.

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- 1. TMRx_CNTR matches TMRx_COMP2 value. TMRx_CSCTRL[TCF2] is asserted and an interrupt request is generated.
- One clock later, OFLAG toggles, TMRx_CMPLD1 is copied to TMRx_COMP1, TMRx_LOAD is copied to TMRx_CNTR, the counter starts counting.
- The interrupt service routine clears TMRx_CSCTRL[TCF1] and TMRx_CSCTRL[TCF2], and the ISR loads TMRx_CMPLD1 and TMRx_CMPLD2 with the values for the next cycle. The counter continues counting until TMRx_CNTR matches TMRx_COMP1.
- 4. TMRx_CSCTRL[TCF1] is asserted. One clock later, OFLAG toggles, TMRx_CMPLD2 is copied to TMRx_COMP2, TMRx_LOAD is copied to TMRx_CNTR, and the counter starts counting.
- 5. The counter continues counting until TMRx_CNTR matches TMRx_COMP2.

Figure 6-19. Compare Load Timing

Example 6-13. Variable Frequency PWM Mode

```
(See Processor Expert PPG [Programmable Pulse Generator] bean.)
// This example starts with an 11 msec with a 31 msec cycle.
// Assuming the chip is operating at 60 MHz, the timer use IP_bus_clk/32 as its
//
   clock source.
//
// Initial pulse period: 60e6/32 clocks/sec * 31 ms = 58125 total clocks in period
// Initial pulse width: 60e6/32 clocks/sec * 11 ms = 20625 clocks in pulse
//
//
// Once the initial values of COMP1/CMPLD1 and COMP2/CMPLD2 are set the pulse width
// can be varied by load new values of CMPLD1 and CMPLD2 on each compare interrupt.
// (See <link>Section 6.3.2.15, Usage of Compare Load Registers,.)
//
void PPG1_Init(void)
setReg(TMRA0_LOAD,0);
                           /* Clear load register */
setReg(TMRA0_CNTR,0);
                            /* Clear counter */
 /* TMRA0_SCTRL: TCF=0,TCFIE=0,TOF=0,TOFIE=0,IEF=0,IEFIE=0,IPS=0,INPUT=0,
       Capture_Mode=0,MSTR=0,EEOF=0,VAL=0,FORCE=1,OPS=0,OEN=1 */
setReg(TMRA0_SCTRL,5);
                              /* Set Status and Control Register */
// Set compare preload operation and enable an interrupt on compare2 events.
 /* TMRA0_CSCTRL: TCF2EN=1,TCF1EN=0,TCF2=0,TCF1=0,CL21=0,CL20=1,CL11=1,CL10=0 */
setReg(TMRA0_CSCTRL,0x86);
                             /* Set Comparator Status and Control Register */
setReg(TMRA0_COMP2,58125-20625); /* Set the pulse width of the on time */
setReg(TMRA0_CMPLD2,58125-20625); /* Set the pulse width of the on time */
```

6.3.2.14 Usage of Compare Registers

The dual compare registers (TMRn_COMP1 and TMRn_COMP2) provide a bidirectional modulo count capability. The TMRn_COMP1 register is used when the counter is counting up, and the TMRn_COMP2 register is used when the counter is counting down. Alternating compare mode is the only exception.

The TMRn_COMP1 register should be set to the desired maximum count value or 0xFFFF to indicate the maximum unsigned value prior to roll-over, and the TMRn_COMP2 register should be set to the minimum count value or 0x0000 to indicate the minimum unsigned value prior to roll-under.

If TMRn_CTRL[OUTMODE] is set to 100, the OFLAG toggles while using alternating compare registers. In this variable frequency PWM mode, the TMRn_COMP2 value defines the desired pulse width of the on time, and the TMRn_COMP1 register defines the off time. The variable frequency PWM mode is defined for positive counting only.

Use caution when changing TMRn_COMP1 and TMRn_COMP2 while the counter is active. If the counter has already passed the new value, it counts to 0xFFFF or 0x0000, rolls over, then begins counting toward the new value. The check is: Count = CMPn, not Count > TMRn_COMP1 or Count < TMRn_COMP2.

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Comparing values with the use of the TMRn_CMPLD1 and TMRn_CMPLD2 helps minimize this problem.

6.3.2.15 Usage of Compare Load Registers

The TMRn_CMPLD1, TMRn_CMPLD2, and TMRn_CSCTRL registers offer a high degree of flexibility for loading compare registers with user-defined values on different compare events. To ensure correct functionality while using these registers, we strongly suggest using the method described here.

The purpose of the compare load feature is to allow quicker updating of the compare registers. In the past, a compare register could be updated using interrupts. However, because of the latency between an interrupt event occurring and the service of that interrupt, there was the possibility that the counter might have already counted past the new compare value by the time the compare register is updated by the interrupt service routine. The counter would then continue counting until it rolled over and reached the new compare value.

To address this problem, the compare registers are now updated in hardware in the same way the counter register is reinitialized to the value stored in the load register. The compare load feature allows the user to calculate new compare values and store them in the comparator load registers. When a compare event occurs, the new compare values in the comparator load registers are written to the compare registers, therefore eliminating the use of software to perform this operation.

The compare load feature is intended to be used in variable frequency PWM mode. The TMRn_COMP1 register determines the pulse width for the logic-low part of OFLAG, and TMRn_COMP2 determines the pulse width for the logic-high part of OFLAG. The period of the waveform is determined by the TMRn_COMP1 and TMRn_COMP2 values and the frequency of the primary clock source. See Figure 6-20.

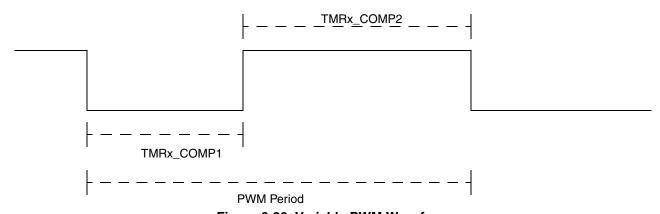


Figure 6-20. Variable PWM Waveform

Should we want to update the duty cycle or period of the above waveform, we would need to update the TMRn_COMP1 and TMRn_COMP2 values, using the compare load feature.

6.3.2.16 Use of Capture Register

The capture register stores a copy of the counter's value when an input edge (positive, negative, or both) is detected. After a capture event occurs, no further updating of the capture register occurs until the TMRn_SCTRL[IEF] (input edge flag) is cleared by writing a zero to TMRn_SCTRL[IEF].

6.4 Resets

6.4.1 General

The TMR module can be reset only by a system reset. This forces all registers to their reset state and clears the OFLAG signal if it is asserted. The counter is turned off until the settings in the control register are changed.

Table 6-7. Reset Summary

Reset	Priority	Source	Characteristics
RESET	n/a	Hardware Reset	Full System Reset

6.5 Interrupts

6.5.1 General

The TMR module can generate 20 interrupts, five for each of the four counters/channels. See Table 6-8.

Table 6-8. Interrupt Summary

Core Interrupt	Interrupt	Description	
	TMR0_COMP_IRQ_B	Compare Interrupt Request for Timer Channel 0	
	TMR0_COMP1_IRQ_B	Compare 1 Interrupt Request for Timer Channel 0	
TMR Channel 0	TMR0_COMP2_IRQ_B	Compare 2 Interrupt Request for Timer Channel 0	
	TMR0_OVF_IRQ_B	Overflow Interrupt Request for Timer Channel 0	
	TMR0_EDGE_IRQ_B	Input Edge Interrupt Request for Timer Channel 0	
	TMR1_COMP_IRQ_B	Compare Interrupt Request for Timer Channel 1	
	TMR1_COMP1_IRQ_B	Compare 1 Interrupt Request for Timer Channel 1	
TMR Channel 1	TMR1_COMP2_IRQ_B	Compare 2 Interrupt Request for Timer Channel 1	
	TMR1_OVF_IRQ_B	Overflow Interrupt Request for Timer Channel 1	
	TMR1_EDGE_IRQ_B	Input Edge Interrupt Request for Timer Channel 1	

Core Interrupt Interrupt		Description	
	TMR2_COMP_IRQ_B	Compare Interrupt Request for Timer Channel 2	
	TMR2_COMP1_IRQ_B	Compare 1 Interrupt Request for Timer Channel 2	
TMR Channel 2	TMR2_COMP2_IRQ_B	Compare 2 Interrupt Request for Timer Channel 2	
	TMR2_OVF_IRQ_B	Overflow Interrupt Request for Timer Channel 2	
	TMR2_EDGE_IRQ_B	Input Edge Interrupt Request for Timer Channel 2	
	TMR3_COMP_IRQ_B	Compare Interrupt Request for Timer Channel 3	
	TMR3_COMP1_IRQ_B	Compare 1 Interrupt Request for Timer Channel 3	
TMR Channel 3	TMR3_COMP2_IRQ_B	Compare 2 Interrupt Request for Timer Channel 3	
	TMR3_OVF_IRQ_B	Overflow Interrupt Request for Timer Channel 3	
	TMR3_EDGE_IRQ_B	Input Edge Interrupt Request for Timer Channel 3	

6.5.2 Description of Interrupt Operation

6.5.2.1 Timer Compare Interrupts

These interrupts are generated when

- A successful compare occurs between a counter and its compare registers.
- TMRn_SCTRL[TCFIE] is set.

These interrupts are cleared by writing a zero to the appropriate TMRn_SCTRL[TCF].

When a timer compare interrupt is set in TMRn_SCTRL and the compare load registers are available, one of the following two interrupts is also asserted.

Timer Compare 1 Interrupts (Available with Compare Load Feature)

These interrupts are generated when a successful compare occurs between a counter and its TMRn_COMP1 register while TMRn_CSCTRL[TCF1EN] is set. These interrupts are cleared by writing a zero to the appropriate TMRn_CSCTRL[TCF1].

Timer Compare 2 Interrupts (Available with Compare Load Feature)

These interrupts are generated when a successful compare occurs between a counter and its TMRn_COMP2 register while TMRn_CSCTRL[TCF2EN] is set. These interrupts are cleared by writing a zero to the appropriate TMRn_CSCTRL[TCF2].

6.5.2.2 Timer Overflow Interrupts

These interrupts are generated when a counter rolls over its maximum value while TMRn_SCTRL[TOFIE] is set. These interrupts are cleared by writing zero to the appropriate TMRn_SCTRL[TOF].

6.5.2.3 Timer Input Edge Interrupts

These interrupts are generated by a transition of the input signal (either positive or negative depending on IPS setting) while TMRn_SCTRL[IEFIE] is set. These interrupts are cleared by writing a zero to the appropriate TMRn_SCTRL[IEF].

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Chapter 7 Pulse Width Modulator (PWM)

7.1 Introduction

7.1.1 Overview

This chapter describes the pulse width modulator (PWM) module. The PWM can be configured as three complementary pairs, six independent PWM signals, or their combinations (such as one complementary pair and four independent signals). Both edge- and center-aligned synchronous pulse-width control, from zero to 100 percent modulation, are supported.

A 15-bit common PWM counter is applied to all six channels. PWM resolution is one clock period for edge-aligned operation and two clock periods for center-aligned operation. The clock period is dependent on clock-source frequency at either system clock or 3× system clock and a programmable prescaler.

When generating complementary PWM signals, the module features automatic deadtime insertion to PWM output pairs. Each PWM output can be controlled manually by a PWM generator, a timer, conversion results of the ADC, GPIO pins, or software, and separate top and bottom output-polarity control. Asymmetric PWM output is able to change the PWM duty cycle alternatively at every half cycle without software involvement.

7.1.2 Features

- PWM operation clock runs at either system clock or 3× system clock
- Six PWM signals
 - all independent
 - complementary pairs
 - mix independent and complementary
- Features of complementary channel operation
 - separate deadtime insertions for rising and falling edges
 - separate top and bottom pulse-width correction via software
 - asymmetric PWM output within center align operation
 - separate top and bottom polarity control
- Edge- or center-aligned PWM signals
- 15 bits of resolution
- Half-cycle reload capability
- Integral reload rates from 1 to 16

Pulse Width Modulator (PWM)

- Individual software controlled PWM output
- Programmable fault protection
- PWM compare output polarity control
- PWM output polarity control
- Push-pull and open drain modes are available on PWM pins
- Write-protected registers
- Selectable PWM supply source for each complementary PWM signal pair
 - PWM generator
 - external GPIO pin
 - internal timer channel
 - ADC conversion result, taking into account values set in ADC high and low limit registers

If all three PWM pairs are driven by any one of the above sources, the following features are disabled:

- PWM sync pulse is not applicable
- PWM reload registers will have no effect

7.1.3 Modes of Operation

Care must be exercised when using this module in operating modes. Some applications require regular software updates for proper operation. Failure to do so could result in destroying the hardware setup. Because of this, PWM outputs are placed in their inactive states in stop mode, and optionally under wait and EOnCE modes. PWM outputs are reactivated (assuming they were active to begin with) when these modes are exited.

Table 7-1. Modes When PWM Operation is Restricted

Mode	Description
Stop	PWM outputs are disabled
Wait	PWM outputs disabled as a function of PWCFG WAIT_EN bit.
EOnCE	PWM outputs are disabled as a function of the PWCFG DBG_EN bit.

7.1.4 Block Diagrams

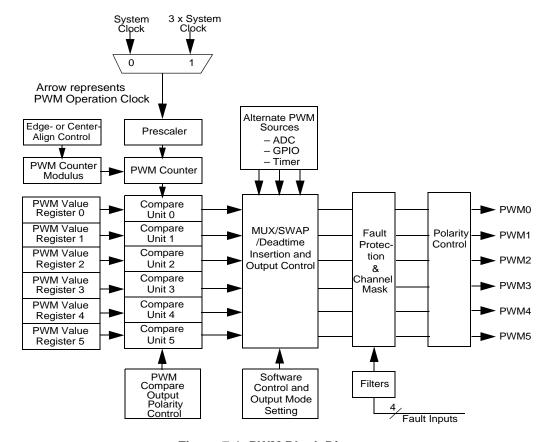


Figure 7-1. PWM Block Diagram

7.2 Functional Description

7.2.1 Prescaler

To permit lower PWM frequencies, the prescaler produces the PWM clock frequency by dividing the PWM operation clock frequency by one, two, four, or eight. The prescaler bits, PRSC0 and PRSC1 in the control (PWM_CTRL) register, select the prescaler divisor. This prescaler is buffered and will not be used by the PWM generator until the LDOK bit is set and a new PWM reload cycle begins.

7.2.2 Generator

The PWM generator contains a 15-bit up/down PWM counter producing output signals with software selectable alignment, period, duty cycle, and the inversion of PWM signal generation.

7.2.2.1 Alignment and Compare Output Polarity

The edge-align (EDG) bit in the configure (PWM_CNFG) register selects either center-aligned or edge-aligned PWM generator outputs.

Pulse Width Modulator (PWM)

PWM compare output polarity is selected by the CINV*n* bit field in the source control (PWM_SCTRL) register. Please see the output operations in Figure 7-2 and Figure 7-3.

The PWM compare output is driven to high state when the value of PWM value (PWM_VALn) register is greater than the value of PWM counter, and PWM compare is counting downwards if the corresponding channel CINVn=0. Or, the PWM compare output is driven to low state if the corresponding channel CINVn=1.

The PWM compare output is driven to low state when the value of PWM value (PWM_VALn) register matches the value of PWM counter, and PWM counter is counting upwards if the corresponding channel CINVn=0. Or, the PWM compare output is driven to high state if the corresponding channel CINVn=1.

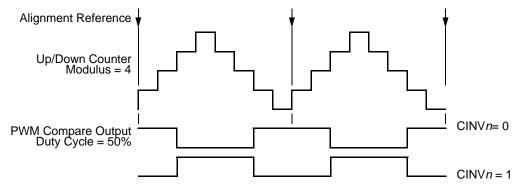


Figure 7-2. Center-Aligned PWM Output

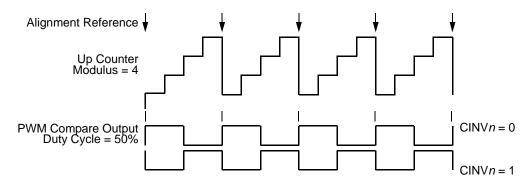


Figure 7-3. Edge-Aligned PWM Output

NOTE

Because of the equals-comparator architecture of this PWM, the modulus=0 case is considered illegal. However, the deadtime constraints and fault conditions will still be guaranteed.

7.2.2.2 Period

The PWM period is determined by the value written to the counter modulo (PWM_CMOD) register. The PWM counter is an up/down counter in a center-aligned operation. In this mode the PWM highest output resolution is two 3× system clock cycles if the PWM clock inputs from 3× system clock. The modulus is one-half of the PWM output period in PWM clock cycles.

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PWM period = (PWM modulus) \times (PWM clock period) \times 2

Eqn. 7-1

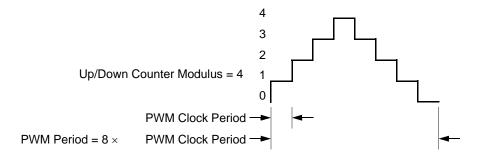


Figure 7-4. Center-Aligned PWM Period

The PWM counter is an up-counter during an edge-aligned operation. In this mode, the PWM highest output resolution is one 3× system clock cycle if the PWM clock inputs from 3× system clock. The modulus is the period of the PWM output in PWM clock cycles.

PWM period = (PWM modulus) × (PWM clock period)

Eqn. 7-2

7-5

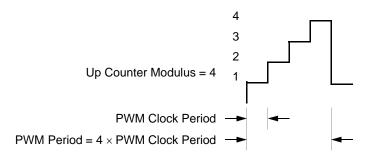


Figure 7-5. Edge-Aligned PWM Period

7.2.2.3 Pulse Width Duty Cycle

The signed 16-bit number written to the PWM value registers is the pulse width in PWM clock periods of the PWM prescaler output (or period minus the pulse width if CINVn=1).

Duty Cycle =
$$\frac{PWM \text{ value}}{Modulus} \times 100$$

NOTE

A PWM value less than, or equal to zero deactivates the PWM output for the entire PWM period. A PWM value greater than, or equal to the modulus activates the PWM output for the entire PWM period when CINVn=0, and vice versa if CINVn=1.

Table 7-2. PWM Value and Underflow Conditions

PWMVAL <i>n</i>	Condition	PWM Value Used
\$0000-\$7FFF	Normal	Value in registers
\$8000-\$FFFF	Underflow	\$0000

A center-aligned operation is illustrated in Figure 7-6. The pulse width is twice the value written to the PWM value register with center-aligned output in PWM clock cycles.

PWM pulse width = (PWM value) \times (PWM clock period) \times 2

Eqn. 7-3

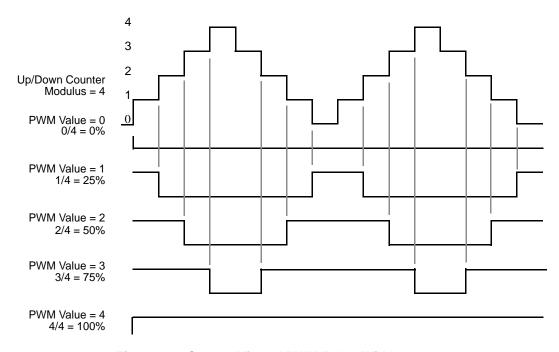


Figure 7-6. Center-Aligned PWM Pulse Width

An edge-aligned operation is illustrated in Figure 7-7. The pulse width is the value written to the PWM value register with edge-aligned output in PWM clock cycles.

PWM pulse width = (PWM value) \times (PWM clock period)

Eqn. 7-4

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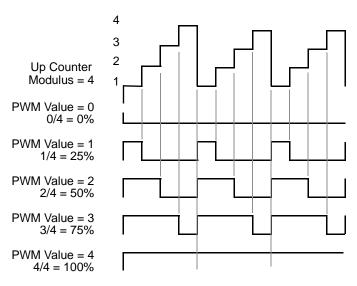


Figure 7-7. Edge-Aligned PWM Pulse Width

7.2.3 Independent or Complementary Channel Operation

In the PWM_CNFG register, writing 1 to the independent (INDEPnn) or complement pair operation bit configures a pair of the PWM outputs as two independent PWM channels. Each PWM output has its own PWM value register operating independently of the other channels in independent channel operation.

Writing 0 to the INDEP*nn* bit configures the PWM output as a pair of complementary channels. The PWM pins are paired in complementary channel operation, illustrated in Figure 7-8.

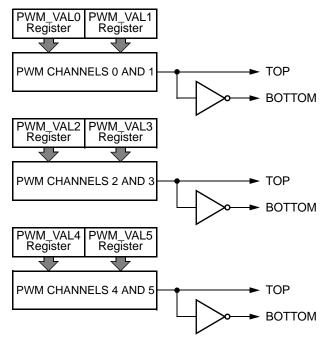


Figure 7-8. Complementary Channel Pairs

Pulse Width Modulator (PWM)

The complementary channel operation drives top and bottom transistors in an inverter circuit, such as the one in Figure 7-9.

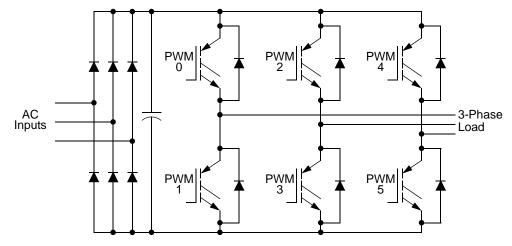


Figure 7-9. Typical 3-Phase Inverter

In complementary channel operation, there are three additional features:

- Deadtime insertion
- Separate top and bottom pulse width correction for distortions caused by deadtime inserted and reactive load characteristics
- Separate top and bottom output polarity control

7.2.4 Deadtime Generators

While in the complementary mode, each PWM pair can be used to drive top/bottom transistors, illustrated in Figure 7-8 and Figure 7-9. Ideally, the PWM pairs are an inversion of each other. When the top PWM channel is active, the bottom PWM channel is inactive and vice versa.

To avoid short circuiting between top and bottom transistor, there must be no overlap of conducting intervals between top and bottom transistor. But the transistor's characteristics make its switching-off time longer than switching-on time. To avoid the conducting overlap of top and bottom transistors, deadtime may be operationally inserted in the switching period.

Deadtime generators automatically insert software-selectable activation delays into each pair of PWM outputs during switching. The PWM deadtime (PWM_DTIM1) register specifies the number of PWM clock cycles to use for deadtime delay. Every time the PWM generator output changes state, deadtime is inserted. PWM_DTIM0 controls deadtime during low state to high state transitions, while PWM_DTIM1 controls deadtime during high state to low state transitions. Deadtime forces both PWM outputs in the pair to the inactive state. A method of correcting this inserted deadtime, adding to or subtracting from the PWM value used, is discussed subsequently.

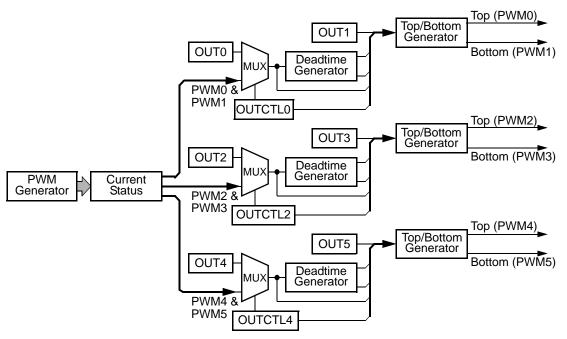


Figure 7-10. Deadtime Generators

Figure 7-10, Figure 7-11, and Figure 7-12 illustrate deadtime insertion in different operation conditions.

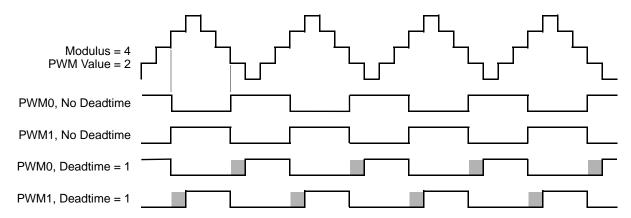


Figure 7-11. Deadtime Insertion, Center Alignment

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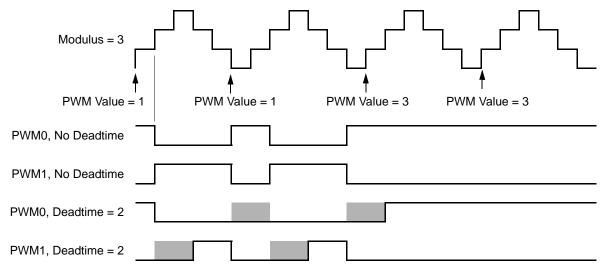


Figure 7-12. Deadtime at Duty Cycle Boundaries

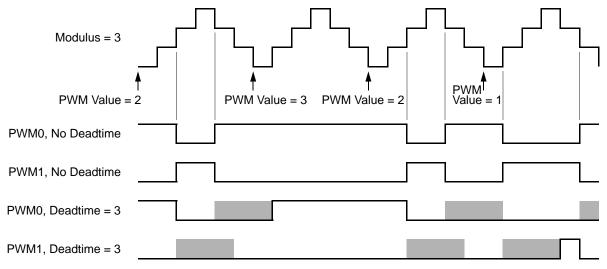


Figure 7-13. Deadtime and Small Pulse Widths

NOTE

The waveform at the output pin is delayed by two PWM Operation Clock cycles for deadtime insertion.

7.2.4.1 Top/Bottom Deadtime Correction

In the complementary mode, either the top or the bottom transistor controls the output voltage. However, deadtime has to be inserted to avoid overlap of conducting interval between the top and bottom transitions. Both transistors in complementary mode are off during deadtime inserted, allowing the output voltage to be determined by the current direction of load and introduce distortion in the output voltage. Please refer to Figure 7-14. The distortion typically manifests itself as poor output waveforms with visible glitches and harmonics.

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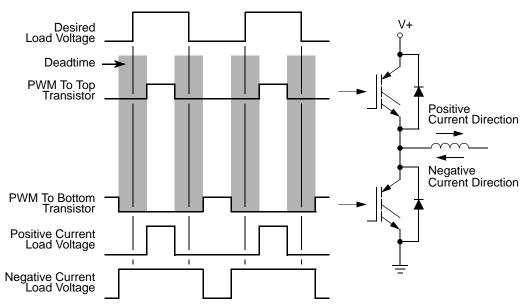


Figure 7-14. Deadtime Distortion

Load inductance distorts output voltage by keeping current flowing through the anti-body diode of transistor during deadtime. This deadtime current flow creates a output voltage varying with current direction. With a positive current flow, the output voltage during deadtime is equal to the bottom supply voltage, putting the top transistor in control. With a negative current flow, the output voltage during deadtime is equal to the top supply voltage, putting the bottom transistor in control. This results in the original pulse widths shortened by deadtime insertion, the averaged output will be less than desired value. However, when deadtime is inserted, it creates a distortion in load current waveform. This distortion is aggravated by dissimilar turn-on and turn-off delays of each of the transistors. By giving the PWM information regarding which transistor is controlling at a given time, distortion can be corrected.

For a typical circuit in complementary channel operation, only one of the transistors will be effective in controlling the output voltage at any given time. This depends on the direction of the load current for that pair. Please see Figure 7-14. To correct distortion one of two different factors must be added to the desired PWM value, depending on whether the top or bottom transistor is controlling the output voltage. Therefore, the software is responsible for calculating both compensated PWM values prior to placing them in an odd/even numbered PWM register pair. Either the odd or the even PWM value (PWM_VAL*n*) registers control the pulse width at any given time. For a given PWM pair, whether the odd or even PWM_VAL*n* register is active depends on either:

- The state of the odd/even correction bit (IPOL*n*) if ICC bits in the PWM_ICCTRL register are set to zeros
- The direction of PWM counter if ICC bits in the PWM_ICCTRL register are set to ones

To correct deadtime distortion, software can decrease or increase the value in the appropriate PWM_VAL*n* register.

• In edge-aligned operation, decreasing or increasing the PWM value by a correction value equal to the deadtime typically compensates for deadtime distortion.

In center-aligned operation, decreasing or increasing the PWM value by a correction value equal to one-half the deadtime typically compensates for deadtime distortion.

NOTE

Assumes the user will provide current sensing circuitry to detect the current direction.

The IPOL0-IPOL2 bits in control (PWM_CTRL) register select either the odd or the even PWM value registers to use in the next PWM cycle in complementary mode if corresponding ICCn bit is 0.

Bit	Logic State	Output Control
IPOL0	0	PWM_VAL0 Controls PWM0/PWM1 Pair
	1	PWM_VAL1 Controls PWM0/PWM1 Pair
IPOL1	0	PWM_VAL2 Controls PWM2/PWM3 Pair
	1	PWM_VAL3 Controls PWM2/PWM3 Pair
IPOL2	0	PWM_VAL4 Controls PWM4/PWM5 Pair
	1	PWM_VAL5 Controls PWM4/PWM5 Pair

Table 7-3. Top/Bottom Manual Correction

NOTE

IPOLn bits are buffered allowing only one PWM register to be used per PWM cycle. If an IPOL*n* bit changes during a PWM period, the new value does not take effect until the next PWM period. IPOLn bits take effect at the end of each PWM cycle regardless of the state of the load okay (LDOK) bit.

Corrected local voltage waveforms are illustrated in Figure 7-15 and Figure 7-16.

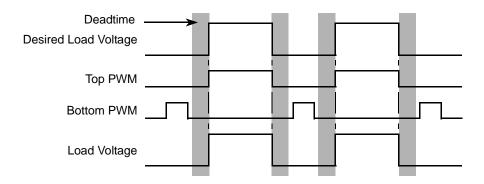


Figure 7-15. Correction with Positive Current

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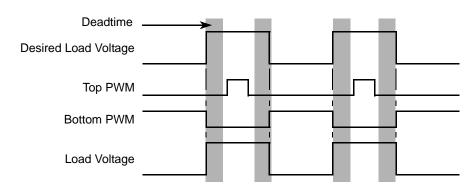


Figure 7-16. Correction with Negative Current

7.2.5 Asymmetric PWM Output

In complementary mode with center-align operation, the PWM duty cycle is able to change alternatively at every half cycle. The count direction of the PWM counter selects either the odd or the even PWM value registers to use in the PWM cycle. For counting up, select even PWM value registers to use in the PWM cycle. For counting down, select odd PWM value registers to use in the PWM cycle.

Bit	Logic State	Output Control
ICC0	0	IPOL0 Controls PWM0/PWM1 Pair
	1	PWM Count Direction Controls PWM0/PWM1 Pair
ICC1	0	IPOL1 Controls PWM2/PWM3 Pair
	1	PWM Count Direction Controls PWM2/PWM3 Pair
ICC2	0	IPOL2 Controls PWM4/PWM5 Pair
	1	PWM Count Direction Controls PWM4/PWM5 Pair

Table 7-4. Top/Bottom Corrections Selected by ICCn Bits

NOTE

If an ICC*n* bit in the PWM_ICCTRL register changes during a PWM period, the new value does not take effect until the next PWM period so ICC*n* bits take effect at the end of each PWM cycle regardless of the state of the load okay (LDOK) bit.

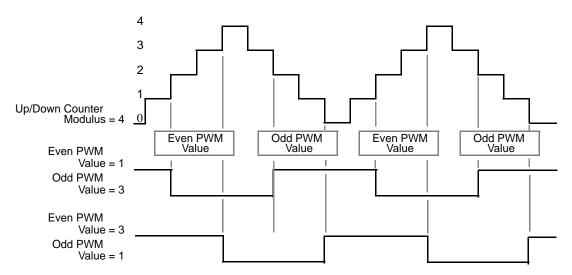


Figure 7-17. Asymmetric Waveform - Phase Shift PWM Output

7.2.6 Variable Edge Placement PWM Output

In complementary mode with edge-aligned mode, the timing of both edges of the PWM output can be controlled using the PECn bits in the PWM_ICCTRL register and the CINVn bits in the PWM_SCTRL register. The edge aligned pulse created by the even value register and the associated CINV bit is XORed with the pulse created by the odd value register and its associated CINV. The results of the XOR are fed into the complement and dead-time logic. In contrast to asymetric PWM output mode, the PWM phase shift can pass the PWM cycle boundary, as shown in Figure 7-18.

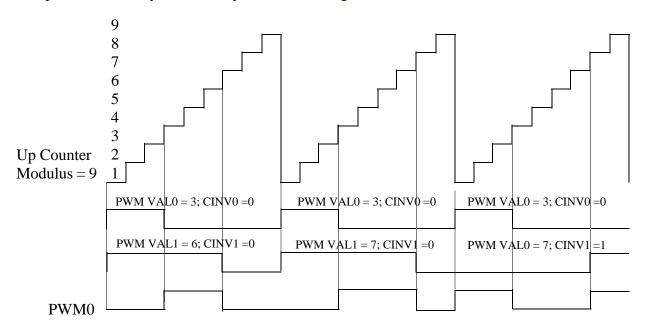


Figure 7-18. Variable Edge Placement Waveform - Phase Shift PWM Output

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7.2.7 PWM Output Polarity

Positive polarity means when the PWM is active its output is high. Conversely, *negative* polarity means when the PWM is active its output is low.

Output polarity of the PWMs is determined by two options:

- TOPNEGnn controls the polarity of PWM0, PWM2 and PWM4 outputs, which typically drive the top transistors of the pair. When TOPNEGnn is set these outputs are active-low.
- BOTNEG*nn* controls the polarity of PWM1, PWM3 and PWM5 outputs, which typically drive the bottom transistors of the pair. When BOTNEG*nn* is set these outputs are active-low.

Both TOPNEGnn and BOTNEGnn bits are in the configure (PWM_CNFG) register. Please see Figure 7-19.

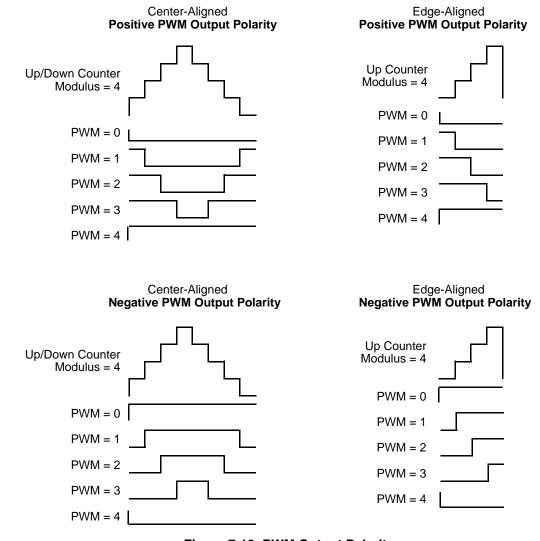


Figure 7-19. PWM Output Polarity

7.2.8 Software Output Control

Setting output control enable (OUTCTRL*n*) bit, the PWM outputs are driven by software rather than by the PWM generator.

In an independent mode, with OUTCTRL*n*=1, the output bit OUT*n*, controls the PWM*n* channel. Setting and clearing the OUT*n* bit activates and deactivates the corresponding PWM channel.

The OUTCTRLn and OUTn bits are in the PWM output control (PWM_OUT) register.

During software output control, TOPNEGnn and BOTNEGnn still control output polarity.

In complementary channel operation, odd and even OUTCTRL*n* must be identical and switched concurrently for proper operation. The even-numbered OUT*n* bits replace the PWM generator outputs. The deadtime generators inserts deadtime whenever an even OUT*n* bit toggles. Deadtime is not inserted when the odd OUT*n* bit toggles. The even OUT*n* bit controls complementary channel pairs when the odd OUT*n* bit is set. However, the even OUT*n* bit still controls complementary channel pairs with odd PWM*n* deactivated if the odd OUT*n* bit is cleared. In other words, setting the odd OUT*n* bit makes its corresponding PWM*n* the complement of its even pair, while clearing the odd OUT*n* bit deactivates the odd PWM*n*. Please refer to Figure 7-20.

Setting the OUTCTL*n* bits do not disable the PWM generators. They continue to run, but no longer control the output pins. When the OUTCTL*n* bits are cleared, the outputs of the PWM generator takes control of PWM outputs at the beginning of the next PWM cycle. Please refer to Figure 7-20.

Software can drive the PWM outputs, even when the PWM Enable (PWMEN) bit is set to zero.

NOTE

Avoid an unexpected deadtime insertion by clearing the OUTn bits before setting and after clearing the OUTCTLn bits.

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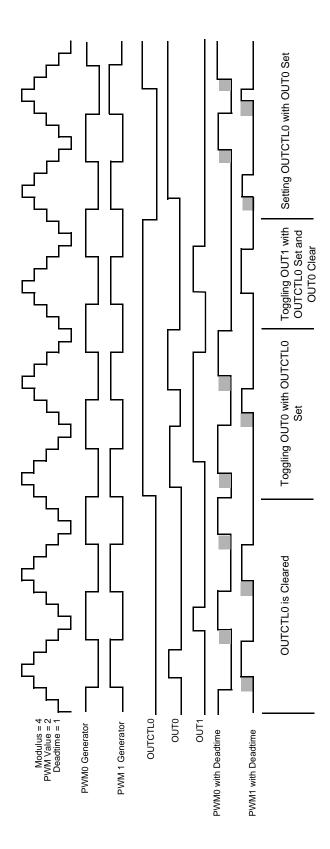


Figure 7-20. Software Output Control in Complementary Mode

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7.2.9 Generator Loading

7.2.9.1 Load Enable

The load okay (LDOK) bit enables loading the PWM generator with:

- A prescaler divisor from the PRSC1 and PRSC0 bits in the control (PWM_CTRL) register
- A PWM period from the PWM counter modulus (PWM_CMOD) registers
- A PWM pulse width from the all PWM value (PWM_VAL*n*) registers

LDOK prevents reloading of these PWM parameters simultaneously. Setting LDOK allows the prescale bits, PWM_CMOD and PWM_VAL*n* registers to be loaded into a set of buffers. The loaded buffers are used by the PWM generator at the beginning of the next PWM reload cycle. Set LDOK by reading it, and then writing a 1 to it. After loading, LDOK is automatically cleared.

7.2.9.2 Load Frequency

The LDFQ3, LDFQ1, and LDFQ0 bits in the PWM_CTRL register select an integral loading frequency of one to 16-PWM reload opportunities. The LDFQ bits take effect at every PWM reload opportunity, regardless of the state of the LDOK bit. The HALF bit in the PWM_CTRL register controls half-cycle reloads for center-aligned PWMs. If the HALF bit is set, a reload opportunity occurs at both beginning of the PWM cycle and at the PWM half cycle. If the HALF bit is not set, a reload opportunity occurs only at the beginning of the cycle. Reload opportunities can only occur at the beginning of a PWM cycle in edge-aligned mode.

NOTE

Loading a new modulus on a half cycle will force the counter to the new modulus value *minus one* count on the next PWM clock cycle. Half cycle reloads are only changes reload rate in center-aligned mode. Enabling or disabling half cycle reloads in edge-aligned mode will have no effect on the reload rate.

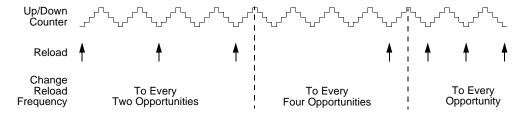


Figure 7-21. Full Cycle Reload Frequency Change

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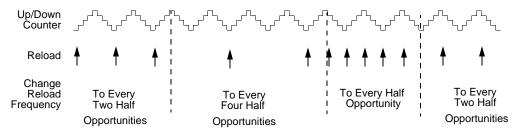


Figure 7-22. Half Cycle Reload Frequency Change

7.2.9.3 Reload Flag

At every reload opportunity the PWM reload flag (PWMF) bit in the PWM_CTRL register is set regardless of the state of the LDOK bit. If the PWM reload interrupt enable (PWMRIE) bit is set, the PWMF flag generates a core interrupt request allowing software to calculate new PWM parameters in real time. When PWMRIE is not set, reloads still occur at the selected reload rate without generating interrupt requests. Clear the PWMF bit by reading it then write a 0 to it.

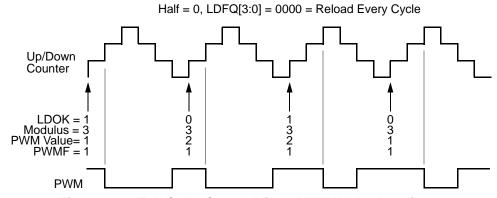


Figure 7-23. Full-Cycle Center-Aligned PWM Value Loading

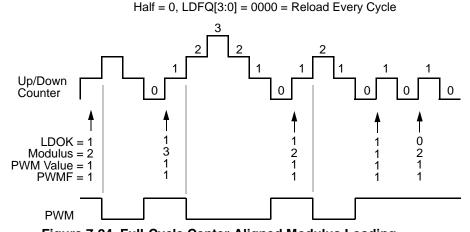


Figure 7-24. Full-Cycle Center-Aligned Modulus Loading

PWM

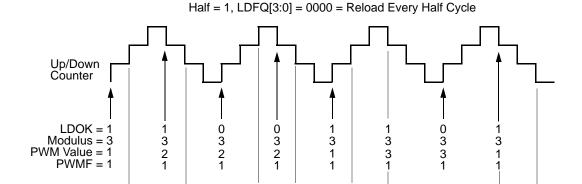


Figure 7-25. Half-Cycle Center-Aligned PWM Value Loading

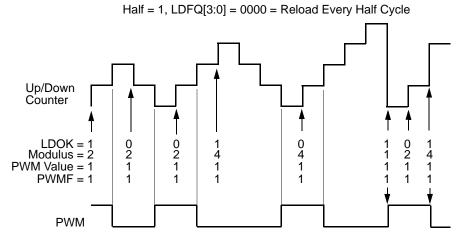


Figure 7-26. Half-Cycle Center-Aligned Modulus Loading

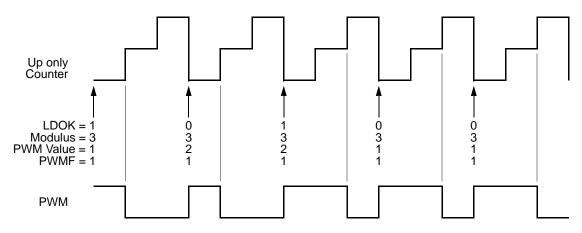


Figure 7-27. Edge-Aligned PWM Value Loading

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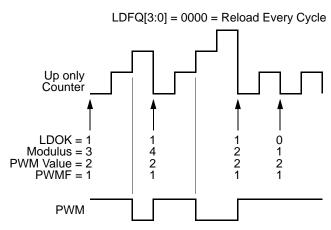


Figure 7-28. Edge-Aligned Modulus Loading

7.2.9.4 Synchronization Output

The PWM uses reload events to output a synchronization pulse, which can be used as an input to the timer module. A high-true pulse occurs for each PWM cycle start of the PWM, regardless of the state of the LDOK bit and load frequency.

7.2.9.5 Initialization

Initialize all registers and set the load okay (LDOK) bit before setting the ENABLE (PWMEN) bit. With LDOK set, setting the PWMEN bit is first set, a reload will immediately occur, thereby setting the PWMF bit. The PWMF bit generates an interrupt request if the PWMRIE bit is set. In complementary channel operation, the combination of IPOL*n* bits and ICC*n* bits determine the even or odd numbered PWM valueregisters control the outputs for the first PWM cycle.

NOTE

Even if LDOK is not set, setting PWMEN also sets the PWMF bit. To prevent a core interrupt request, clear the PWMRIE bit before setting PWMEN bit.

Setting PWMEN bit for the first time after reset without first setting LDOK loads a prescaler divisor of one, a PWM value of \$0000, and an unknown modulus. If the LDOK bit is not set after the PWMEN bit is cleared, then set (without a RESET) the value last loaded will be used in the PWM generated. If the deadtime register is changed after PWMEN or OUTCTLn bits are set, an improper deadtime insertion will occur.

Initializing the deadtime register after setting PWMEN or OUTCTL*n* can cause an improper deadtime insertion. However, the deadtime can never be shorter than the specified value.

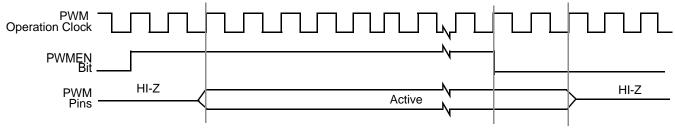


Figure 7-29. PWMEN and PWM Pins in Independent Operation (OUTCTL0-5 = 0)

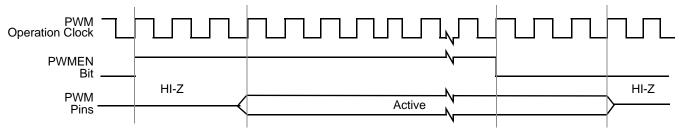


Figure 7-30. PWMEN and PWM Pins in Complement Operation (OUTCTL0, 2, 4 = 0)

When the PWMEN bit is cleared:

- The PWMn pins will be in their inactive status unless OUTCTLn=1
- The PWM counter is cleared and does not count
- The PWM generator forces its outputs to zero
- The PWMF and pending interrupt requests are not cleared
- All fault circuitry remains active
- Software output control remains active if OUTCTLn=1
- Deadtime insertion continues during software output control

7.2.10 Fault Protection

Fault protection can disable any combination of PWM pins. Faults are generated by either a 1 or 0, determined by the fault polarity control bits in the fault control (PWM_FCTRL) register on any of the FAULT pins. Each FAULT pin can be mapped arbitrarily to any of the PWM pins. When fault protection hardware disables PWM pins, the PWM generator continues to run, only the output pins are deactivated. The fault decoder disables PWM pins selected by the fault logic and the disable mapping register. Please see Figure 7-31. Each bank of four bits in the disable mapping registers (PWM_DMAPn) controls the mapping for a single PWM pin. Please refer to Table 7-5. The fault protection is enabled even when the PWM is not enabled; therefore, if a fault is latched in, it must be cleared prior to enabling the PWM to prevent an unexpected interrupt. Please see Section 7.4.5, "PWM Fault Status Acknowledge Register (PWM_FLTACK)."

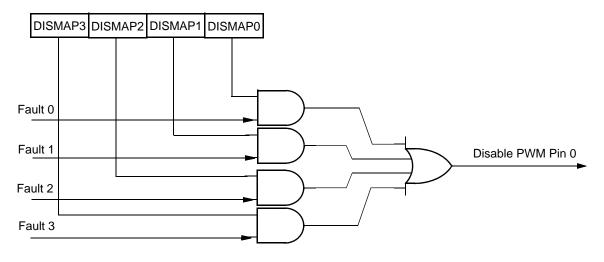


Figure 7-31. Fault Decoder for PWM 0

Table 7-5. Fault Mapping

PWM Pin	Controlling Register Bits
PWM0	DISMAP3—DISMAP0
PWM1	DISMAP7—DISMAP4
PWM2	DISMAP11-DISMAP8
PWM3	DISMAP15—DISMAP12
PWM4	DISMAP19—DISMAP16
PWM5	DISMAP23—DISMAP20

NOTE

For parts with less than four fault pins, the same controls apply. The unavailable DISMAP field bits should be set to zero. For example, if fault 3 is not available as an input, set DISMAP3=0.

7.2.10.1 **Fault Pin Filter**

Each fault pin has a filter to test for fault conditions. A fault input transition to a high state is not declared until the input is sampled high on two consecutive PWM operation clocks. Only then FFLAGn and FPINn are set. The FPINn bit will remain set until the fault input is detected low on two consecutive PWM operation clocks. Clear FFLAGn by writing a 1 to the corresponding fault acknowledge (FTACKn) bit. If the FIEn, FAULTn pin interrupt enable bit is set, the FFLAGn flag generates an interrupt request. The interrupt request latch remains set until one of the following actions occur:

- Software clears the FFLAGn flag by writing a 1 to the FTACKn bit
- Software clears the FIEn bit by writing a 0 to it
- A reset occurs

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7.2.10.2 Automatic Fault Clearing

In automatic mode, when FMODE*n* is set, disabled PWM pins are enabled when the FAULT*n* pin returns to 0 and a new PWM half cycle begins. Please refer to Figure 7-32. Clearing the FFLAG*n* flag does not affect disabled PWM pins when FMODE*n* is set.

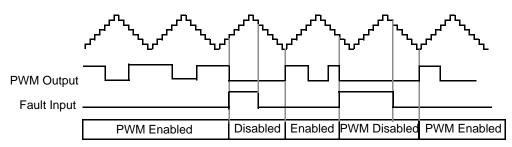


Figure 7-32. Automatic Fault Clearing

7.2.10.3 Manual Fault Clearing

In manual mode, the fault pins are grouped in pairs, each pair sharing common functionality. A fault condition on Fault pins 0 and 2 can be cleared by software clearing the corresponding FFLAG bit, allowing the PWM(s) to enable at the next PWM half cycle regardless of the logic level at the fault pin. The PWM outputs will remain enabled even if the logic level of the fault pin is still high. The fault pin must go low and then back high to register a new fault and disable the PWM outputs. Figure 7-33. A fault condition on fault pins 1 and 3 can be cleared only by software clearing corresponding FFLAGn bit, allowing the PWM(s) to enable if a logic low at the fault pin is detected at the start of the next PWM half cycle boundary. Please see Figure 7-34.

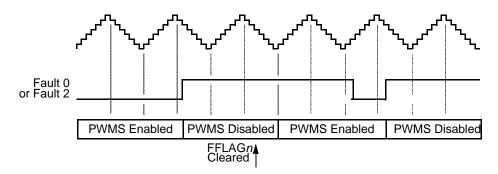


Figure 7-33. Manual Fault Clearing (Example 1)

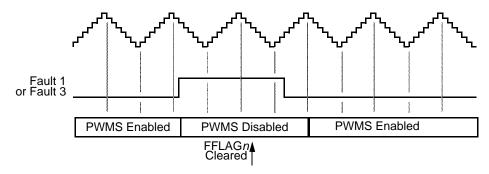


Figure 7-34. Manual Fault Clearing (Example 2)

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NOTE

PWM half-cycle boundaries occur at both the PWM cycle start and when the counter equals the modulus, so in edge-aligned operation full cycles and half cycles are equal.

NOTE

Fault protection also applies during software output control when the OUTCTL*n* bits are set. Fault clearing still occurs at half PWM cycle boundaries while the PWM generator is engaged where PWMEN=1. However, the OUT*n* bits can also control the PWM pins while the PWM generator is off where PWMEN=0. Thus, fault clearing occurs at PWM operation clock cycles while the PWM generator is off and at the start of PWM cycles when the generator is engaged.

7.2.11 External Synchronization of PWM Counting (EXT_SYNC)

When not being used as a fault input, the FAULT2 pin may be used for external synchronization. If SYNC_OUT_EN is set, then a positive pulse is put out on FAULT2 at the start of every cycle. This pulse can be used to synchronize other PWMs.

If SYNC_OUT_EN is clear and SYNC_WINDOW has a value other than 0, then input syncronization is enabled. FAULT2 is the external sync input and must not be used as a fault input. The PWM_DMAPn register should be cleared so that FAULT2 does not disable any of the PWM outputs. Filtering of the external sync input is controlled with the PWM_FFILT2 register and polarity is controlled by FPOL2. Upon recognizing an incoming pulse, the PWM counter is reset to 0 if the current counter value is within the window defined by SYNC_WINDOW.

7.3 Signal Descriptions

The pulse width modulator has external pins named PWM0–PWM5 and FAULT0–FAULT3.

7.3.1 PWM0-PWM5 Pins

PWM0–PWM5 are the output pins of the six PWM channels.

7.3.2 FAULT0-FAULT3 Pins

FAULT0–FAULT3 are input pins for disabling selected PWM outputs.

The FAULT2 pin can also be used as the external sync (EXT_SYNC) input when not used as a fault input. This sync input is used to reset the counter to 0 if it occurs during the period defined by the SYNC_WINDOW field. FAULT2 can also be used as the external sync output. This signal is the PWM reload sync pulse slightly stretched so that it won't be filtered by the I/O of the chip. External synchronization only works at cycle boundaries so half cycle reloads do not show up on the external sync signal.

7.3.3 Inter-module Connection Signals

There are three inputs which allow for external control of the complementary PWM pairs. The muxing to determine the driving signal is controlled by bits in the SIM_IPSn registers as well as the PWM_SCTRL register.

TMR outputs can be connected to these inputs to allow different frequencies for each PWM pair. The resulting ADC register outputs can be used to control PWM turn-on and turn-off timing and allow hysteresis control based on the values in the ADC high limit and low limit registers. These pins can also be driven by external GPIO inputs or internal comparator outputs.

7.4 Memory Map and Registers

7.4.1 Module Memory Map

Table 7-6. PWM Registers

Address	Reg Name	Description
PWM_BASE + 0x19	PWM_FFILT3	Fault3 filter register
PWM_BASE + 0x18	PWM_FFILT2	Fault2 filter register
PWM_BASE + 0x17	PWM_FFILT1	Fault1 filter register
PWM_BASE + 0x16	PWM_FFILT0	Fault0 filter register
PWM_BASE + 0x15	PWM_SYNC	PWM synchronization window register
PWM_BASE + 0x14	PWM_SCTRL	PWM source control register
PWM_BASE + 0x13	PWM_ICCTRL	PWM internal correction control register
PWM_BASE + 0x12	PWM_PORT	PWM port register
PWM_BASE + 0x11	PWM_CCTRL	PWM channel control register
PWM_BASE + 0x10	PWM_CNFG	PWM config register
PWM_BASE + 0x0F	PWM_DMAP2	PWM disable mapping register two
PWM_BASE + 0x0E	PWM_DMAP1	PWM disable mapping register one
PWM_BASE + 0x0D	PWM_DTIM1	PWM deadtime register 1
PWM_BASE + 0x0C	PWM_DTIM0	PWM deadtime register 0
PWM_BASE + 0x0B	PWM_VAL5	PWM value register 5
PWM_BASE + 0x0A	PWM_VAL4	PWM value register 4
PWM_BASE + 0x09	PWM_VAL3	PWM value register 3
PWM_BASE + 0x08	PWM_VAL2	PWM value register 2
PWM_BASE + 0x07	PWM_VAL1	PWM value register 1
PWM_BASE + 0x06	PWM_VAL0	PWM value register 0
PWM_BASE + 0x05	PWM_CMOD	PWM counter modulo register

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Table 7-6. PWM Registers (continued)

Address	Reg Name	Description
PWM_BASE + 0x04	PWM_CNTR	PWM counter register
PWM_BASE + 0x03	PWM_OUT	PWM output control register
PWM_BASE + 0x02	PWM_FLTACK	PWM fault status acknowledge
PWM_BASE + 0x01	PWM_FCTRL	PWM fault control register
PWM_BASE + 0x00	PWM_CTRL	PWM control register

7.4.2 Register Descriptions

The address of a register is the sum of a base address and an address offset. The base address is defined at the device level and the address offset is defined at the module level.

7.4.3 PWM Control Register (PWM_CTRL)

Address: PWM_BASE+0x0

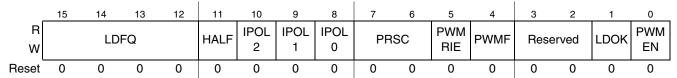


Figure 7-35. PWM Control Register (PWM_CTRL)

Table 7-7. PWM Control Register (PWM_CTRL) Descriptions

Field	Description			
15–12 LDFQ	Load Frequency Bits. These buffered read/write bits select the PWM load frequency according to the table below. Reset clears the LDFQ bits, selecting loading every PWM opportunity. A PWM opportunity is determined by the half bit. Note: The LDFQn bits take effect when the current load cycle is complete, regardless of the state of the load okay bit, LDOK. Reading the LDFQn bits reads the buffered values and not necessarily the values currently in effect.			
	LDFQ[3:0]	PWM reload frequency	LDFQ[3:0]	PWM reload frequency
	0000	Every PWM opportunity	1000	Every 9 PWM opportunities
	0001	Every 2 PWM opportunities	1001	Every 10 PWM opportunities
	0010	Every 3 PWM opportunities	1010	Every 11 PWM opportunities
	0011	Every 4 PWM opportunities	1011	Every 12 PWM opportunities
	0100	Every 5 PWM opportunities	1100	Every 13 PWM opportunities
	0101	Every 6 PWM opportunities	1101	Every 14 PWM opportunities
	0110	Every 7 PWM opportunities	1110	Every 15 PWM opportunities
	0111	Every 8 PWM opportunities	1111	Every 16 PWM opportunities
11 HALF	Half Cycle Reload. This read/write bit enables half-cycle reloads in center-aligned PWM mode. This bit has no effect on edge-aligned PWMs. 0 = Half-cycle reloads disabled 1 = Half-cycle reloads enabled			
10 IPOL2	Current Polarity Bit 2. This buffered read/write bit selects the PWM value register for the PWM4 and PWM5 pins in top/bottom software correction. Reset clears IPOL2. 0 = PWM value register PWM_VAL4 in next PWM cycle 1 = PWM value register PWM_VAL5 in next PWM cycle Note: The IPOLn bits take effect at the beginning of the next load cycle, regardless of the state of the load okay bit, LDOK. Select top/bottom software correction by writing 00 or 01 to the current select bits, ISENS[1:0], in the PWM control register. Reading the IPOLn bits reads the buffered values and not necessarily the values currently in effect.			
9 IPOL1	Current Polarity 1. This buffered read/write bit selects the PWM value register for the PWM2 and PWM3 pins in top/bottom software correction. Reset clears IPOL1. 0 = PWM value register PWM_VAL2 in next PWM cycle 1 = PWM value register PWM_VAL3 in next PWM cycle			
8 IPOL0	Current Polarity 0. This buffered read/write bit selects the PWM value register for the PWM0 and PWM1 pins in top/bottom software correction. Reset clears IPOL0. 0 = PWM value register PWM_VAL0 in next PWM cycle 1 = PWM value register PWM_VAL1 in next PWM cycle			

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Table 7-7. PWM Control Register (PWM_CTRL) Descriptions (continued)

Field	Description			
7, 6 PRSC	Prescaler. These buffered read/write bits select the PWM clock frequency illustrated in the table below.			ne table below.
11100		PRSC[1:0]	PWM clock frequency	
		00	f _{IPBus}	
		01	f _{IPBus} /2	
		10	f _{IPBus} /4	
		11	f _{IPBus} /8	
			alues and not necessarily the values next PWM cycle and only when the I	
5 PWMRIE	PWM Reload Interrupt Enable. This read/write bit enables the PWMF flag to generate interrupt requests. Reset clears PWMRIE. 0 = PWMF interrupt requests disabled 1 = PWMF interrupt requests enabled			
4 PWMF	PWM Reload Flag. his read/write flag is set at the beginning of every reload cycle regardless of the state of the LDOK bit. Clear PWMF by reading PWM control register with PWMF set and then writing a zero to the PWMF bit. If another reload occurs before the clearing sequence is complete, writing zero to PWMF has no effect. Reset clears PWMF. 0 = No new reload cycle since last PWMF clearing 1 = New reload cycle since last PWMF clearing Note: Clearing PWMF clears pending PWMF interrupt requests.			
3, 2	Reserved.			
1 LDOK	Load Okay. This read/write bit loads the prescaler bits of PWM_CTRL and the entire PMMCM and VAL registers into a set of buffers. The buffered prescaler divisor, PWM counter modulus value, and PWM pulse width take effect at the next PWM reload. Set LDOK by writing a one to it. LDOK is automatically cleared after the new values are loaded, or can be manually cleared before a reload by writing a zero to it. Reset clears LDOK. 0 = Do not load new modulus, prescaler, and PWM values 1 = Load prescaler, modulus, and PWM values Note: For proper initialization of the LDOK and PWMEN bits, see Section 7.2.9.5, "Initialization."			
0 PWMEN	PWM Enable. This read/write bit enables the PWM generator and the PWM pins. When PWMEN equals zero, the PWM pins are in their inactive states unless OUTCTLn equals one. A reset clears PWMEN. 0 = PWM generator and PWM pins disabled unless OUTCTL = 1 1 = PWM generator and PWM pins enabled For proper initialization of the LDOK and PWMEN bits, see Section 7.2.9.5, "Initialization."			

7.4.4 PWM Fault Control Register (PWM_FCTRL)

Address: PWM_BASE+0x1

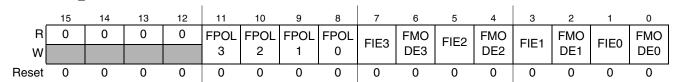


Figure 7-36. PWM Fault Control Register (PWM_FCTRL)

Table 7-8. PWM Fault Control Register (PWM_FCTRL) Descriptions

Field	Description
15–12	Reserved.
11–8 FPOLn	FAULTn Polarity Control. These read/write bits control the polarity of the FAULTn pin inputs. A reset clears FPOLn. FPOL2 is also used to control the polarity of the external sync input and output. 0 = A 1 on FAULTn indicates a fault condition 1 = A 0 on FAULTn indicates a fault condition
	FAULTn Pin Interrupt Enable. This read/write bit enables interrupt requests generated by the filtered FAULTn pin. A reset clears FIEn. 0 = FAULTn interrupt requests disabled 1 = FAULTn interrupt requests enabled Note: The fault protection circuit is independent of the FIEn bits and is always active. If a fault is detected, the PWM pins are disabled according to the PWM disable mapping register.
FMODE	FAULTn Pin Clearing Mode. This read/write bit selects automatic or manual clearing of FAULTn pin faults. A reset clears FMODEn. 0 = Manual fault clearing of FAULTn pin faults 1 = Automatic fault clearing of FAULTn pin faults

7.4.5 PWM Fault Status Acknowledge Register (PWM_FLTACK)

Address: PWM_BASE+0x2

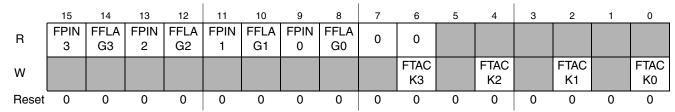


Figure 7-37. PWM Fault Status Acknowledge Register (PWM_FLTACK)

Table 7-9. PWM Fault Status Acknowledge Register (PWM_FLTACK) Descriptions

Field	Description
15, 13, 11, 9 FPINn	FAULTn Pin. This read-only bit reflects the current state of the filtered FAULTn pin. A reset has no effect on FPINn. 0 = 0 on the FAULTn pin 1 = 1 on the FAULTn pin
14, 12, 10, 8 FFLAGn	FAULTn Pin. This read-only flag is set within two CPU cycles after a rising edge on the filtered FAULTn pin. Clear FFLAGn by writing a one to the FTACKn bit in this register (PWM_FLTACK). A reset clears FFLAGn. 0 = No fault on the FAULTn pin 1 = Fault on the FAULTn pin
7	Reserved.
6, 4, 2, 0 FTACKn	FAULTn Pin Acknowledge. Writing a one to FTACKn clears FFLAGn. Writing a zero has no effect. Reset clears FTACKn. The fault protection is enabled even when the PWM is not enabled; therefore, a fault is latched in, requiring it to be cleared in order to prevent an interrupt when the PWM is enabled.
1, 3, 5	Reserved.

7.4.6 PWM Output Control Register (PWM_OUT)

Address: PWM_BASE+0x3

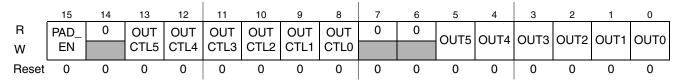


Figure 7-38. PWM Output Control Register (PWM_OUT)

Table 7-10. PWM Output Control Register (PWM_OUT) Descriptions

Field	Description				
15 PAD_EN	Output Pad Enable. The PWMn output pads can be enabled or disabled by setting the PAD_EN bit. The power-up default has the pads disabled. This bit does not affect the functionality of the PWM, so the PWM module can be energized with the output pads disabled. This enable is to power-up with a safe default value for the PWM drivers. 0 = Output pads disabled 1 = Output pads enabled				
14	Reserved.				
13–8 OUTCTL 5–0	Output Control Enables. These read/write bits enable software control of their corresponding PWM pin. When OUTCTLn is set, the OUTn bit activates and deactivates the PWMn output or the SRCn bits of the PWM source control register is used to select an alternate control of the PWM outputs. A reset clears the OUTCTL bits. 0 = Software control disabled (normal PWM operation) 1 = Software control enabled				
7, 6	Reserved.				
5–0 OUT5–0	When the co	orresponding	OUTCTL bit is set, these read/write bits	s control the PWM pins, illustrated in the	able below.
		OUT <i>n</i> bit	Complementary Channel Operation	Independent Channel Operation	
		OUT0	0—PWM0 is inactive 1—PWM0 is active	0—PWM0 is inactive 1—PWM0 is active	
		OUT1	0—PWM1 is inactive 1—PWM1 is complement of PWM 0	0—PWM1 is inactive 1—PWM1 is active	
		OUT2	0—PWM2 is inactive 1—PWM2 is active	0—PWM2 is inactive 1—PWM2 is active	
		OUT3	0—PWM3 is inactive 1—PWM3 is complement of PWM 2	0—PWM3 is inactive 1—PWM3 is active	
		OUT4	0—PWM4 is inactive 1—PWM4 is active	0—PWM4 is inactive 1—PWM4 is active	
		OUT5	0—PWM5 is inactive 1—PWM5 is complement of PWM 4	0—PWM5 is inactive 1—PWM5 is active	
	Note: OUT1, OUT3, and OUT5 must be set during complementary operation even if the SRCn fields of the reg indicate an alternate control signal is being used in place of software control.			the PSRC	

7.4.6.1 PWM Counter Register (PWM_CNTR)

This read-only register displays the state of the 15-bit PWM counter. Reserved bit 15, cannot be modified. It is read as zero.

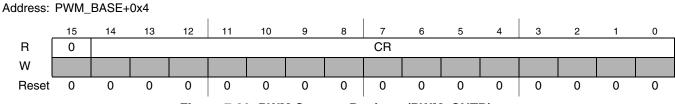


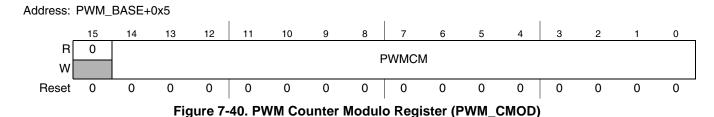
Figure 7-39. PWM Counter Register (PWM CNTR)

7.4.7 PWM Counter Modulo Register (PWM_CMOD)

The 15-bit unsigned value written to this buffered, read/write register defines the PWM period in PWM clock periods. Reserved bit 15 cannot be modified. It is read as zero.

NOTE

The PWM counter modulo register is buffered. The value written does not take effect until the LDOK bit is set and the next PWM load cycle begins. Reading PWM_CMOD reads the value in a buffer. It is not necessarily the value the PWM generator is currently using.



7.4.8 PWM Value Registers (PWM_VAL0-5)

The 16-bit signed value in these buffered, read/write registers defines the PWM pulse width in PWM clock periods for each PWM output channel.

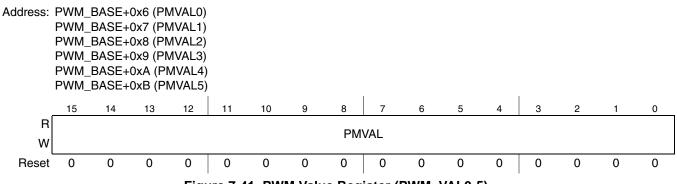


Figure 7-41. PWM Value Register (PWM_VAL0-5)

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NOTE

The PWM value registers are buffered. The value written does not take effect until the LDOK bit is set and the next PWM load cycle begins. Reading VALn reads the value in a buffer and not necessarily the value the PWM generator is currently using.

A PWM value less than or equal to zero deactivates the PWM output for the entire PWM period. A PWM value greater than, or equal to the modulus, activates the PWM output for the entire PWM period. Please see Table 7-2.

NOTE

The terms activate and deactivate refer to the high and low logic states of the PWM outputs.

7.4.9 PWM Deadtime Registers (PWM_DTIM0, PWM_DTIM1)

Deadtime operation is only applicable to complementary channel operation. The 12-bit values written to these write-protected registers are in terms of PWM clock cycles. Reset sets the PWM deadtime registers to a default value of 0x0FFF, selecting a deadtime of 4096-PWM clock cycles minus one PWM clock cycle. These registers are write protected after the WP bit in the PWM configuration register is set. Please refer to Section 7.4.11, "PWM Configure Register (PWM_CNFG)." Reserved bits 15–12 cannot be modified. They are read as zero.

NOTE

Deadtime is affected by changes to the prescaler value. The deadtime duration is determined as follows: $DT = P \times PWMDT - 1$, where DT is deadtime, P is the prescaler value, PWMDT is the programmed value of dead time. For example: if the prescaler is programmed for a divide-by-two and PWMDT is set to five, then P = 2 and the deadtime value is equal to $DT = 2 \times 5 - 1 = 9$ PWM clock cycles. A special case exists when the P = 1, DT = PWMDT



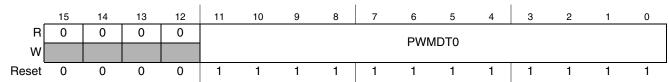


Figure 7-42. PWM Deadtime Register 0 (PWM_DTIM0)

Address: PWM_BASE+0xD



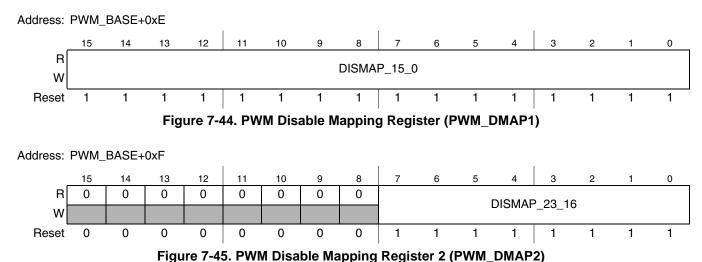
Figure 7-43. PWM Deadtime Register 1 (PWM_DTIM1)

The PWMDT0 field is used to control the deadtime during 0 to 1 transitions of the even PWM output (assuming normal polarity). The PWMDT1 field is used to control the deadtime during 0 to 1 transitions of the odd PWM output.

PWM_DTIM1 is not present on the 80X and 83XX families. In these cases, PWM_DTIM0 controls deadtime for all transitions.

7.4.10 PWM Disable Mapping Registers (PWM DMAP1-2)

These write-protectable registers determine which PWM pins are affected by the fault protection inputs, illustrated in Table 7-5 in Section 7.2.10, "Fault Protection." Reset sets all of the bits used in the PWM disable mapping registers. These registers are write protected after the WP bit in the PWM configure register is set. Reserved bits 15-8 in the PWM_DMAP2 register cannot be modified. The bits are read as zero.



7.4.11 PWM Configure Register (PWM CNFG)

This write-protectable register contains the configuration bits determining PWM modes of operation detailed below. This register cannot be modified after the WP bit is set.

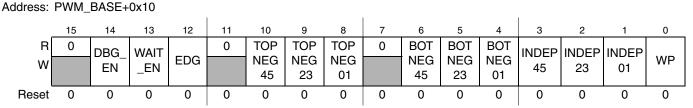


Figure 7-46. PWM Configure Register (PWM_CNFG)

Table 7-11. PWM Configure Register (PWM_CNFG) Descriptions

Field	Description
15	Reserved.
14 DBG_EN	Debug Enable. When set to one, the PWM continues to run while the chip is in EOnCE debug mode. If the device enters EOnCE mode and this bit is zero, then the PWM outputs are switched to their inactive state until EOnCE mode is exited. At that point the PWM pins resume operation as programmed in the PWM registers. For certain types of motors (such as 3-phase AC), it is imperative that this bit be left in its default state (in which the
	PWM is disabled in EOnCE mode). Failure to do so could result in damaging the motor. For other types of motors (example: DC motors), this bit might safely be set to one, enabling the PWM in debug mode. The key point is PWM parameter updates do not occur in debug mode. Any motors requiring such updates should be disabled during EOnCE mode. If in doubt, leave this bit cleared to zero.
13 WAIT_EN	Wait Enable. When set to one, the PWM continues to run while the chip is in wait mode. In this mode, the peripheral clock continues to run but the DSC clock does not. If the device enters wait mode and this bit is zero, then the PWM outputs are switched to their inactive state until wait mode is exited. At that point the PWM pins resume operation as programmed in the PWM registers.
	For certain types of motors (such as 3-phase AC), it is imperative that this bit be left in its default state (in which the PWM is disabled in wait mode). Failure to do so could result in damaging the motor. For other types of motors (example: DC motors), this bit might safely be set to one, enabling the PWM in wait mode. The key point is PWM parameter updates do not occur in this mode. Any motors requiring such updates should be disabled during wait mode. If in doubt, leave this bit set to zero.
12 EDG	Edge-Aligned or Center-Aligned PWMs. This write-protectable bit determines whether all PWM channels use edge-aligned or center-aligned waveforms. 0 = Center-aligned PWMs 1 = Edge-aligned PWMs
11	Reserved.
10–8 TOPNEG	Top-side PWM Polarity Bit. This write-protectable bit determines the polarity for the top-side PWMs. 0 = Positive top-side polarity 1 = Negative top-side polarity Note: Each pair of PWM channels can be configured: channel zero to one, channel two to three, and channel four to five.
7	Reserved.
6–4 BOTNEG	Bottom-side PWM Polarity Bit. This write-protectable bit determines the polarity for the bottom-side PWMs. 0 = Positive bottom-side polarity 1 = Negative bottom-side polarity Note: Each pair of PWM channels can be configured: channel zero to one, channel two to three, and channel four to five.

0

Reset

0

Table 7-11. PWM Configure Register (PWM_CNFG) Descriptions (continued)

Field	Description
3–1 INDEP	Independent or Complimentary Pair Operation. This write-protectable bit determines if the motor control PWM channels are independent PWMs or complementary PWM pairs. 0 = Complementary PWM pair 1 = Independent PWMs Note: Each pair of PWM channels can be configured: channel zero to one, channel two to three, and channel four to five.
0 WP	Write Protect. This write-protectable bit enables write protection to be used for all write-protectable registers. While clear, WP allows write-protectable registers to be written. When set, WP prevents any further writes to write-protectable registers. After it is set, WP can be cleared only by a reset. Write-protectable registers include PWM_SCTRL, PWM_DMAP1-PWM_DMAP2, PWM_DTIM0 and PWM_DTIM1, PWM_CNFG, PWM_SYNC, PWM_FFILTn, and the ENHA bit in the PWM_CCTRL register. The VLMODE[1:0], SWP0, SWP1, and SWP2 bits in the PWM_CCTRL register are protected when the ENHA bit is set to zero in the PWM_CCTRL register. ENHA is in turn protected by setting WP in the PWM_CNFG register. 0 = Write-protectable registers may written to 1 = Write-protectable registers are read only Note: The write to the PWM_CNFG register that sets the WP bit is the last write accepted to that register until the part is reset.

7.4.12 PWM Channel Control Register (PWM_CCTRL)

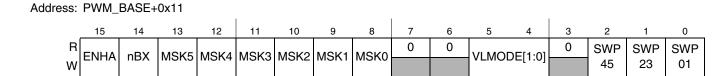


Figure 7-47. PWM Channel Control Register (PWM_CCTRL)

0

0

0

0

This write-protectable register contains the configuration bits that determine PWM modes of operation as detailed below. The ENHA bit cannot be modified after the WP bit in the PWM_CNFG register is set. ENHA in turn provides protection for the nBX, VLMODE[1:0], SWP45, SWP23 and SWP01 bits. The Mask bits are not write protectable.

Table 7-12. PWM Channel Control Register (PWM_CCTRL) Descriptions

Field	Description
15 ENHA	Enable Hardware Acceleration. This bit enables writing to the nBX, VLMODE[1:0], SWP45, SWP23, and SWP01 bits. The bit is write protected by the PWM_CNFG register WP bit. 0 = Disable writing to nBX, VLMODE[1:0], SWP45, SWP23, and SWP01 bits 1 = Enable writing to nBX, VLMODE[1:0], SWP45, SWP23, and SWP01 bits
14 nBX	MC56F80X Compatibility. This bit is used to enable/disable improved SWAP and MASK operations. In one case, SWAP/MASK operates identical to the DSP56F80X version of this module. In the other case, these functions have been moved to an improved location in the PWM data flow. If the later is chosen, the MC56F80X compatible features are not supported. See Figure 7-1 for details. 0 = SWAP and MASK provide DSP56F80X compatible operation 1 = SWAPn and MASKn provide new functionality as shown in Figure 7-1 This bit is write protected when ENHA is zero. Note: This bit must be set to 0 in order to use SWAP in INDEPENDENT mode.

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Table 7-12. PWM Channel Control Register (PWM_CCTRL) Descriptions (continued)

Field	Description
13–8 MSK[5:0]	Mask. These six bits determine the mask for each of the PWM logical channels. 0 = Unmasked 1 = Masked, channel set to a value of zero percent duty cycle The SWAP and MASK functions have two different modes of operation controlled by the nBX bit in the PWM_CCTRL register. Figure 7-48 is somewhat of a simplification. See Figure 7-1 and Section 7.3, "Signal Descriptions," for details.
7, 6	Reserved.
5, 4 VLMODE	Value Register Load Mode. These two bits determine the way the value registers are being loaded. 00 = Each value register is accessed independently 01 = Writing to value register zero also writes to value registers one to five 10 = Writing to value register zero also writes to value registers one to three 11 = Reserved These bits are write protected when ENHA is zero.
3	Reserved.
2 Swap45	The SWAP and MASK functions have two different modes of operation controlled by the nBX bit in the PWM_CCTRL register. Figure 7-48 is somewhat of a simplification. See Figure 7-1 and Section 7.3, "Signal Descriptions," for details. 0 = No swap 1 = Channel four and channel five are swapped This bit is write protected when ENHA is zero.
1 Swap23	The SWAP and MASK functions have two different modes of operation controlled by the nBX bit in the PWM_CCTRL register. Figure 7-48 is somewhat of a simplification. See Figure 7-1 and Section 7.3, "Signal Descriptions," for details. 0 = No swap 1 = Channel two and channel three are swapped This bit is write protected when ENHA is zero.
0 Swap01	The SWAP and MASK functions have two different modes of operation controlled by the nBX bit in the PWM_CCTRL register. Figure 7-48 is somewhat of a simplification. See Figure 7-1 and Section 7.3, "Signal Descriptions," for details. 0 = No swap 1 = Channel zero and one are swapped This bit is write protected when ENHA is zero.

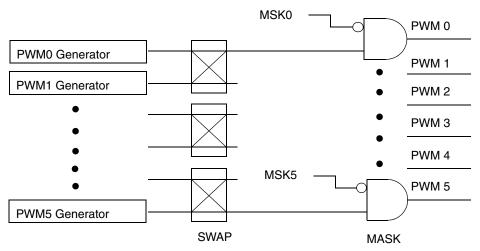


Figure 7-48. Channel Swapping

7.4.13 PWM Port Register (PWM_PORT)

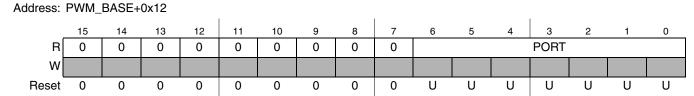


Figure 7-49. PWM Port Register (PWM_PORT)

This register contains values of the three current status inputs, bits six, five, and four, as well as the four fault inputs, bits three, two, one, and zero. This is a read-only register, therefore, any writes to the register do not affect it. This register may be read while the PWM is active. Reserved bits 15–7 cannot be modified. They are read as zero.

7.4.14 PWM Internal Correction Control Register (PWM_ICCTRL)

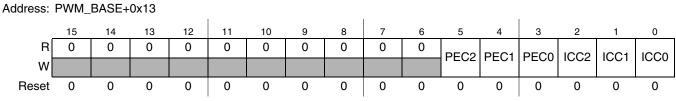


Figure 7-50. PWM Internal Correction Control Register (PWM_ICCTRL)

This register is used to control PWM pulse generation for various applications, such as a power-supply phase-shifting application.

ICCn bits apply only in center-aligned operation during complementary mode. These control bits determine whether values set in the IPOL*n* bits control which VAL*n* register is used, or whether PWM count direction controls which PWM value register is used.

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The PECn bits only apply in edge-aligned operation during complementary mode. Setting the PECn bits overrides the ICCn settings. These control bits allow the PWM pulses generated by both the odd and even VAL regs to be XORed together prior to the complementary logic and deadtime insertion.

NOTE

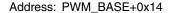
The PECn bits are buffered. The value written does not take effect until the LDOK bit is set and the next PWM load cycle begins. Reading PECn reads the value in a buffer and not necessarily the value the PWM generator is currently using.

Figure 7-51. PWM Internal Correction Control Register (PWM_ICCTRL) Descriptions

Field	Description
15–6	Reserved.
5 PEC2	Pulse Edge Control. This bit controls PWM4/PWM5 pair. 0 = Normal operation. 1 = Allow one of PWM_VAL4 and PWM_VAL5 to activate the PWM pulse and the other to deactivate the pulse.
4 PEC1	Pulse Edge Control. This bit controls PWM2/PWM3 pair. 0 = Normal operation. 1 = Allow one of PWM_VAL2 and PWM_VAL3 to activate the PWM pulse and the other to deactivate the pulse.
3 PEC0	Pulse Edge Control. This bit controls PWM0/PWM1 pair. 0 = Normal operation. 1 = Allow one of PWM_VAL0 and PWM_VAL1 to activate the PWM pulse and the other to deactivate the pulse.
2 ICC2	Internal Current Control. This bit controls PWM4/PWM5 pair. 0 = IPOL2 setting determines whether to use the PWM_VAL4 or PWM_VAL5 register. 1 = Use PWM_VAL4 register when the PWM counter is counting up. Use PWM_VAL5 register when counting down.
1 ICC1	Internal Current Control, This bit controls PWM2/PWM3 pair. 0 = IPOL1 setting determines whether to use the PWM_VAL2 or PWM_VAL3 register. 1 = Use PWM_VAL2 register when the PWM counter is counting up. Use PWM_VAL3 register when counting down.
0 ICC0	Internal Current Control. This bit controls PWM0/PWM1 pair. 0 = IPOL0 setting determines whether to use the PWM_VAL0 or PWM_VAL1 register. 1 = Use PWM_VAL0 register when the PWM counter is counting up. Use PWM_VAL1 register when counting down.

7.4.15 PWM Source Control Register (PWM_SCTRL)

This register contains the control bits that are used to determine the signals to be used as the source signals for the complementary PWM outputs. This register is affected by the WP bit in the PWM_CNFG register. It can only be written when that bit is clear.



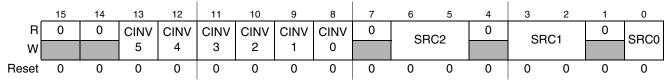


Figure 7-52. PWM Source Control Register (PWM SCTRL)

Table 7-13. PWM Source Control Register (PWM_SCTRL) Descriptions

Field	Description
15, 14	Reserved.
13 CINV5	PWM Compare Invert 5. This bit controls the polarity of PWM compare output 5. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 5 is high when PWM_CNTR is less than PWM_VAL5 1 = PWM output 5 is high when PWM_CNTR is greater than PWM_VAL5
12 CINV4	PWM Compare Invert 4. This bit controls the polarity of PWM compare output 4. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 4 is high when PWM_CNTR is less than PWM_VAL4 1 = PWM output 4 is high when PWM_CNTR is greater than PWM_VAL4
11 CINV3	PWM Compare Invert 3. This bit controls the polarity of PWM compare output 3. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 3 is high when PWM_CNTR is less than PWM_VAL3 1 = PWM output 3 is high when PWM_CNTR is greater than PWM_VAL3
10 CINV2	PWM Compare Invert 2. This bit controls the polarity of PWM compare output 2. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 2 is high when PWM_CNTR is less than PWM_VAL2 1 = PWM output 2 is high when PWM_CNTR is greater than PWM_VAL2
9 CINV1	PWM Compare Invert 1. This bit controls the polarity of PWM compare output 1. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 1 is high when PWM_CNTR is less than PWM_VAL1 1 = PWM output 1 is high when PWM_CNTR is greater than PWM_VAL1
8 CINV0	PWM Compare Invert 0. This bit controls the polarity of PWM compare output 0. Please see the output operations in Figure 7-2 and Figure 7-3. 0 = PWM output 0 is high when PWM_CNTR is less than PWM_VAL0 1 = PWM output 0 is high when PWM_CNTR is greater than PWM_VAL0
7	Reserved.
6, 5 SRC2	PWM 2 Source. This field controls the PWM5/PWM4 pair. Make sure OUTCTL4 and OUTCTL5 (bits 12 and 13 of the PWM Output Control register) are set when using these bits 00 = Use PWM generator as PWM source (operation is consistent with 80x and 83xx devices). 01 = Use PSRC2 input as PWM source. The specific signal driving this input is based on muxing controlled by the SIM IPS register. This information can be found in the device data sheet. 1x = Use the value selected in SRC0 as the PWM source.
4	Reserved.
3, 2 SRC1	PWM 1 Source. This field controls the PWM2/PWM3 pair. Make sure OUTCTL2 and OUTCTL3 (bits 10 and 11 of the PWM Output Control register) are set when using these bits 00 = Use PWM generator as PWM source (operation is consistent with 80x and 83xx devices). 01 = Use PSRC1 input as PWM source. The specific signal driving this input is based on muxing controlled by the SIM IPS register. This information can be found in the device data sheet. 1x = Use the value selected in SRC0 as the PWM source.
1	Reserved.
0 SRC0	PWM 0 Source. This bit controls the PWM0/PWM1 pair. Make sure OUTCTL0 and OUTCTL1 (bits 8 and 9 of the PWM Output Control register) are set when using these bits. 0 = Use PWM generator as PWM source (operation is consistent with 80x and 83xx devices). 1 = Use PSRC0 input as PWM source. The specific signal driving this input is based on muxing controlled by the SIM IPS register. This information can be found in the device data sheet.

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7.4.16 PWM Synchronization Window Register (PWM_SYNC)

This register is used to define the window of time during which the external sync can reset the PWM counter. This register is affected by the WP bit in the PWM_CNFG register. It can only be written when that bit is clear.

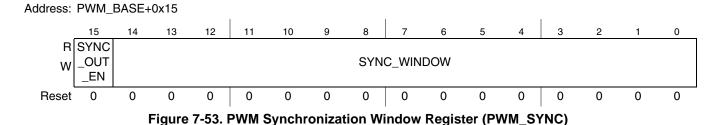


Table 7-14. PWM Synchronization Window Register (PWM SYNC) Descriptions

Field	Description
15 SYNC_ OUT_EN	Synchronization Output Enable — Bit 15 This bit controls the enable for the sync output. Do not set this bit when the FAULT2 pin is to be used as a fault input. 0 = Synchronization output pulse disabled. 1 = Synchronization output pulse enabled on FAULT2 pin (EXT_SYNC).
14–0 SYNC_ WINDOW	Synchronization Window — Bits 14-0 This field defines the window off opportunity for the external sync signal to reset the PWM counter. For center aligned operation (EDG=0) if the value of the PWM counter is less than the value of SYNC_WINDOW, then external synchronization is enabled. This means that for a SYNC_WINDOW value of 0 that external synchronization can never take place (ie, it is disabled). For a SYNC_WINDOW value of 0x7FFF, the external sync can occur at any time (ie, always enabled). For edge aligned operation (EDG=1) if the value of the PWM counter is less that the value of the SYNC_WINDOW or if the difference between the value of the PWM counter and the PWM counter modulo value is less than the value of SYNC_WINDOW, then external synchronization is enabled. SYNC_WINDOW should be set to 0 when SYNC_OUT_EN is set to 1. This enables the sync output on the FAULT2 pin (EXT_SYNC) and disable the sync input on that same pin.

7.4.17 Fault Filter Registers (PWM_FFILT0, PWM_FFILT1, PWM_FFILT2, PWM_FFILT3)

These registers are used to program the characteristics of the filters for the fault inputs. These registers are affected by the WP bit in the PWM_CNFG register. They can only be written when that bit is clear.

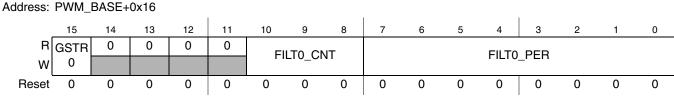


Figure 7-54. Fault0 Filter Register (PWM_FFILT0)

Address: PWM_BASE+0x17

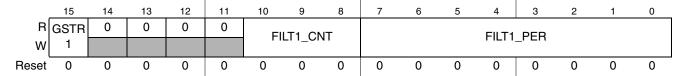


Figure 7-55. Fault1 Filter Register (PWM_FFILT1)

Address: PWM_BASE+0x18

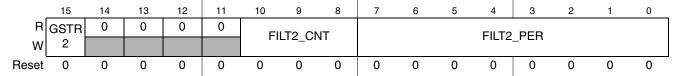


Figure 7-56. Fault2 Filter Register (PWM_FFILT2)

Address: PWM_BASE+0x19

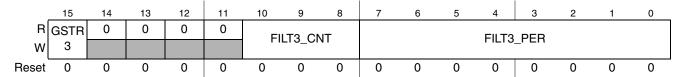


Figure 7-57. Fault3 Filter Register (PWM_FFILT3)

Table 7-15. Fault3 Filter Register (PWM_FFILT3) Descriptions

Field	Description
15 GSTRn	Fault Glitch Stretch Enable. This bit is used to enabled the fault input glitch stretching logic. This logic ensures that narrow fault glitches are stretched to be at least 2 PWM clock cycles wide. In some cases a narrow fault input can cause problems do to the short PWM output shutdown/re-activation time. The stretching logic insures that a glitch on the fault input when the fault filter is disabled is registered in the fault flags. 0 = Fault input glitch stretching is disabled. 1 = Active input fault signal edge is stretched to at least 2 PWM clocks.
10–8 FILTn_C NT	Input Filter Sample Count. These bits represent the number of consecutive samples that must agree prior to the input filter accepting an input transition. A value of 0x0 represents 3 samples. A value of 0x7 represents 10 samples. The value of FILT_CNT affects the input latency as described in Section 7.4.17.1, "Input Filter Considerations."
7–0 FILTn_P ER	Input Filter Sample Period . These bits represent the sampling period (in PWM clock cycles) of the fault input signals. Each input is sampled multiple times at the rate specified by FILT_PER. If FILT_PER is 0x00 (default), then the input filter is bypassed. The value of FILT_PER affects the input latency as described in Section 7.4.17.1, "Input Filter Considerations."

7.4.17.1 Input Filter Considerations

The FILT_PER value should be set such that the sampling period is larger the period of the expected noise. This way a noise spike corrupts only one sample. The FILT_CNT value should be chosen to reduce the probability of noisy samples causing an incorrect transition to be recognized while keeping latency to a minimum. The probability of an incorrect transistion is defined as the probability of an incorrect sample raised to the FILT_CNT + 3 power.

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The values of FILT_PER and FILT_CNT must also be traded off against the desire for minimal latency in recognizing input transitions. Turning on the input filter (setting FILT_PER to a non-zero value) introduces a latency of: (((FILT_CNT + 3) x FILT_PER + 2) PWM clock periods. Even when the filter is enabled, there is a combinational path to disable the PWM outputs. This is to ensure rapid response to fault conditions and also to ensure fault response if the PWM module loses its clock. The latency induced by the filter is seen in the time to set the FFLAG and FPIN bits of the PWM_FLTACK register.

7.5 Resets

All PWM registers are reset to their default values upon any system reset.

7.6 Clocks

The PWM operation clock runs at either system clock or 3× system clock, which is selected in the SIM module.

7.7 Interrupts

PWM sources can generate CPU interrupt requests:

- Reload flag (PWMF)—PWMF is set at the beginning of every reload cycle. The reload interrupt enable bit, PWMRIE, enables PWMF to generate CPU interrupt requests. PWMF and PWMRIE are in PWM control register (PWM_CTRL)
- Fault flags (FFLAG0–FFLAG3)—The FFLAGn bit is set when a logic one occurs on the FAULTn pin. The fault pin interrupt enable bits, FIE0–FIE3, enable the FFLAGn flags to generate CPU interrupt requests. FFLAG0–FFLAG3 are in the fault status register. FIE0–FIE3 are in the fault control register

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Chapter 8 General-Purpose Input/Output (GPIO)

8.1 Overview

The general-purpose input/output (GPIO) module allows direct read or write access to pin values, or the ability to assign a pin to be used as an external interrupt. GPIO pins are multiplexed with other peripherals on the package. The device data sheet specifies the assigned GPIO ports and the multiplexed pin package.

A GPIO pin may be configured in three ways:

- As GPIO input with, or without, pullup
- As GPIO output with push-pull mode
- As a peripheral pin when multiplexed with another module

GPIOs are placed on the chip in groups of one to sixteen bits, called ports and designated as A, B, C, etc. Please refer to the data sheet for the specific definition of each of the GPIO ports on the chip.

8.1.1 Features

The GPIO module design includes these features:

- Individual control for each pin to be in either peripheral mode or GPIO mode
- Individual direction control for each pin in GPIO mode
- Individual pullup enable control for each pin in either normal or GPIO mode
- Individual output drive strength control (high-power mode or low-power mode) for each pin
- Individual output edge slew-rate control for each pin to reduce switch noise
- Individual input filter control for each pin
- Ability to monitor pin logic values even when GPIO mode is not enabled, by using the GPIO_n_RAWDATA register

8.1.2 Modes of Operation

The GPIO module design contains two major modes of operation:

• Peripheral Mode — The pin is controlled by the peripheral module, but if the pin is not configured as analog input then output drive strength, edge slew rate control, input filter, and pullup enable are still controlled by GPIO registers.

General-Purpose Input/Output (GPIO)

• GPIO Mode — In this mode the GPIO module controls the pins. Any data output and input can be written to or read from GPIO data registers. GPIO pins can generate the edge interrupt.

8.1.3 Block Diagram

Figure 8-1 illustrates the logic associated with just one of the bits in each GPIO register. Each GPIO pin can be configured as:

- An input, with or without pullup functions
- A low-pass input filter
- An edge interrupt
- An output

A low-pass input filter pullup or input edge interrupt would be controlled by the respective register.

The GPIO's pullup is configured by writing the Pullup Enable (GPIO_n_PUR) Register. When the pin is configured as a peripheral function, the pullups are controlled by the GPIO_n_PUR register and the direction is specified by the peripheral used. If the I/O is set to be an output, the pullup is disabled.

A pin may have several peripheral functions, one of which may be an analog function. To access its analog function, the pin must be in peripheral mode with an analog input enabled. Selecting between an analog peripheral or a digital peripheral is controlled by the GPIO Peripheral Select Register (GPSn) in the SIM module. When the GPIO is in peripheral mode and its analog peripheral function is selected, the digital output buffer and pullup are disabled. The digital input buffer is also disconnected from the pin so that the digital input is not responding to analog voltages on the pad.

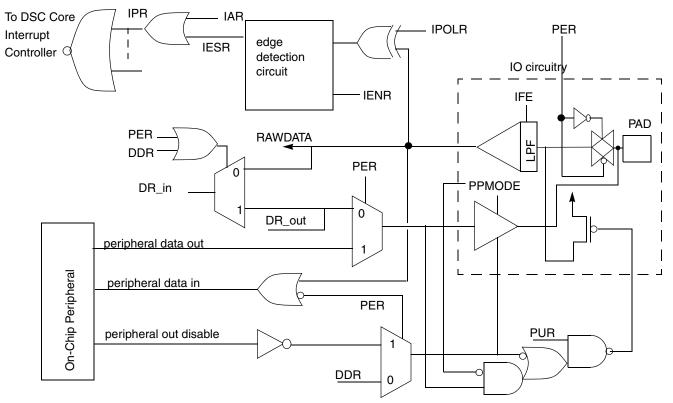


Figure 8-1. Bit View of the GPIO Logic with Mux of Analog Input

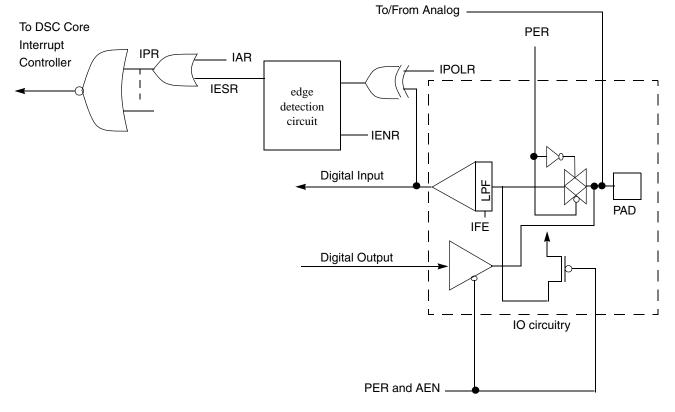


Figure 8-2. GPIO Multiplexed With Analog

8.2 **GPIO Interrupts**

The GPIO supports the hardware interrupt from the input pin. To enable a GPIO interrupt, the corresponding bit in the Interrupt Enable Register (GPIO_n_IENR) must be set to one. The Interrupt Polarity Register (GPIO_n_IPOLR) controls the edge polarity of the input that is able to generate an interrupt. When an edge detection circuit detects an edge input, the corresponding bit in the Interrupt Edge Sensitive Register (GPIO_n_IESR) is set to one. The interrupt request is recorded in a corresponding bit in the Interrupt Pending Register (GPIO_n_IPR) if a corresponding GPIO interrupt is enabled. The GPIO_n_IPR register can be cleared by writing ones into the GPIO_n_IESR register bits.

The interrupt signals in each port are OR'ed together to present only a single interrupt per port to the interrupt controller. The interrupt service routine must then check the contents of the interrupt pending register to determine which pin(s) caused the interrupt.

IPOLR	Interrupt Asserted	Remark
0	High	If the IENR is set to one, as the input goes to high an interrupt is recorded by the GPIO_n_IPR register.
1	Low	If the IENR is set to one, as the input goes to low an interrupt is recorded by the GPIO_n_IPR register.

Table 8-1. GPIO Interrupt Assert Functionality

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8.3 Clocks and Resets

The GPIO module runs at standard system bus speeds and assumes reset states as defined in the device data sheet. Reset occurs whenever any source of system reset occurs (POR, external reset, COP reset, etc.).

8.4 Memory Map and Registers

8.4.1 Module Memory Map

Each GPIO module has up to ten registers.

Register names, addresses and descriptions are shown in Table 8-2. The peripheral and register naming convention is that the occurrences of "_n_" in the register names below are replaced with "_A_", "_B_", "_C_", ... in the peripheral memory map.

Address	Reg Name	Description
GPIO_n_BASE + 0x0000	GPIO_n_PUR	Pullup Enable Register
GPIO_n_BASE + 0x0001	GPIO_n_DR	Data Register
GPIO_n_BASE + 0x0002	GPIO_n_DDR	Data Direction Register
GPIO_n_BASE + 0x0003	GPIO_n_PER	Peripheral Enable Register ¹
GPIO_n_BASE + 0x0004	Reserved	_
GPIO_n_BASE + 0x0005	GPIO_n_IENR	Interrupt Enable Register
GPIO_n_BASE + 0x0006	GPIO_n_IPOLR	Interrupt Polarity Register
GPIO_n_BASE + 0x0007	GPIO_n_IPR	Interrupt Pending Register
GPIO_n_BASE + 0x0008	GPIO_n_IESR	Interrupt Edge Sensitive Register
GPIO_n_BASE + 0x0009	Reserved	_
GPIO_n_BASE + 0x000A	GPIO_n_RAWDATA	Provides an unclocked version of the data values currently present on each GPIO pin - even when not in GPIO mode.
GPIO_n_BASE + 0x000B	GPIO_n_DRIVE	Drive Strength Control Register
GPIO_n_BASE + 0x000C	GPIO_n_IFE	Input Filter Control Register
GPIO_n_BASE + 0x000D	GPIO_n_SLEW	Slew Rate Control Register

Table 8-2. Module Memory Map

8.4.2 Register Descriptions

Each GPIO register contains up to 16 bits, each of which performs an identical function for one of the GPIO pins controlled by that GPIO port. The only difference that arises is with regard to initial operating conditions at reset, as some GPIO modes are on by default, and some are not. Some pullup resistors may be enabled, others not. Please see the data sheet for the reset state of each register.

¹ Reset values of the peripheral enable register vary from port to port. Please see the data sheet for specific values.

NOTE

The reset value of these registers may be different depending on the reset function of specific pins. Please see the data sheet.

8.4.2.1 GPIO_Pullup Enable Register (GPIO_n_PUR)

The PUR register is for internal pullup enabling and disabling. If the pin is configured as an output, the PUR is not used. This register is read and write. Unimplemented bits read as 0. Please see the data sheet for details.

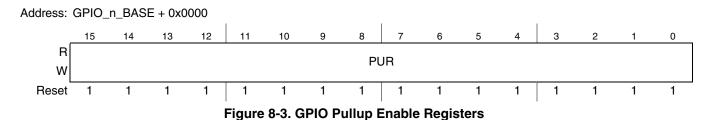
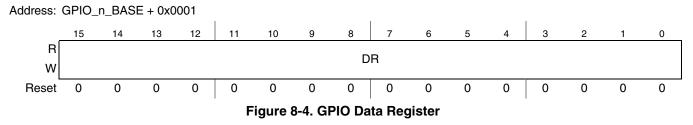


Table 8-3. GPIO_Pullup Enable Register (GPIO_n_PUR) Descriptions

Field	Description
15–0 PUR	0 Pullup is disabled 1 Pullup is enabled

8.4.2.2 Data Register (GPIO_n_DR)

The DR register is for holding data that comes either from the pin or the IP bus. In other words, the DR register is the data interface between the pin and the IP bus.

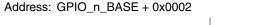


Data written to this register appears on the pins if the pins are configured as GPIO output. Data read from this register is the same as the read state on the pins if those pins are configured as GPIO input.

8.4.2.3 Data Direction Register (GPIO_n_DDR)

This read/write register configures the state of the pin as either input or output when the PER bit is set to zero. When DDR is set to zero, the pin is an input. When DDR is set to one, the pin is an output.

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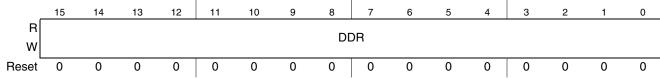


Figure 8-5. GPIO Data Direction Register

Table 8-4. Data Direction Register (GPIO_n_DDR) Description

Field	Description
15–0 DDR	0 Pin is an input 1 Pin is an output

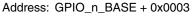
8.4.2.4 Peripheral Enable Register (GPIO_n_PER)

This read/write register determines the configuration of the GPIO pins.

When the PER value is one, the GPIO module is configured for peripheral mode. In this mode, a peripheral controls the GPIO pin where the data transfer direction depends on the function of the peripheral.

When the PER value is zero, the pin is configured for GPIO mode. In this mode, the GPIO module controls the output enable to the pin and the supplying of any data to be output. Also in GPIO mode, any input data can be read from a GPIO memory mapped register.

If write protection (via the SIM PROT register) is implemented on an individual chip, then this register value cannot be changed after the write protect signal has been asserted.



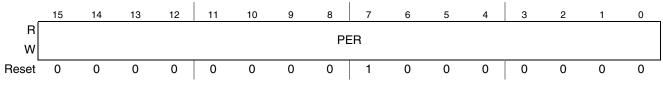


Figure 8-6. GPIO Peripheral Enable Registers

Table 8-5. Peripheral Enable Register (GPIO n PER) Description

Field	Description
15–0 PER	O Pin is for GPIO (GPIO mode) Pin is for peripheral (Peripheral mode)

8.4.2.5 Interrupt Enable Register (GPIO_n_IENR)

This read/write register enables or disables the edge detection for any incoming interrupt from the pin. This register is set to one for interrupt detection. The interrupts are recorded in GPIO_n_IPR.

General-Purpose Input/Output (GPIO)

Address: GPIO_n_BASE + 0x0005

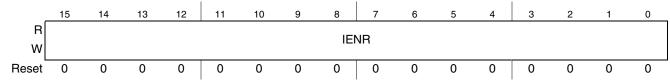


Figure 8-7. GPIO Interrupt Enable Register

Table 8-6. Interrupt Enable Register (GPIO_n_IENR) Description

Field	Description
15–0 IENR	0 Interrupt is disabled 1 Interrupt is enabled

8.4.2.6 Interrupt Polarity Register (GPIO_n_IPOLR)

This read/write register is used for polarity detection caused by any external interrupts. The interrupt at the pin is active low when this register is set to one (falling edge causes the interrupt). The interrupt seen at the pin is active high when this register is set to zero (rising edge causes the interrupt). This is true only when the IENR is set at one. There is no effect on the interrupt if the IENR is set to zero.



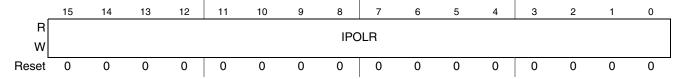


Figure 8-8. GPIO Interrupt Polarity Register

Table 8-7. Interrupt Polarity Register (GPIO_n_IPOLR) Description

Field	Description
15–0 IPOLR	0 Interrupt occurred on rising edge1 Interrupt occurred on falling edge

8.4.2.7 Interrupt Pending Register (GPIO_n_IPR)

This read-only register is used to record any incoming interrupts. The user can read this register to determine which pin has caused the interrupt. This register can be cleared by writing ones into the IESR (Interrupt Edge Sensitive Register) register.

Address: GPIO_n_BASE + 0x0007

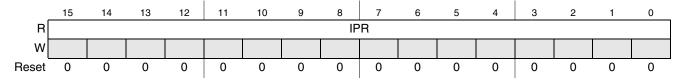


Figure 8-9. GPIO Interrupt Pending Register

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Table 8-8. Interrupt Pending Register (GPIO_n_IPR) Description

Field	Description
15–0	0 No Interrupt
IPR	1 Interrupt occurred

8.4.2.8 Interrupt Edge Sensitive Register (GPIO_n_IESR)

When an edge is detected by the edge detector circuit, and the IENR is set to one, the IESR records the interrupt. This read/write register clears the corresponding IPR bit field by writing one to the appropriate IESR bit. Writing zero to an IESR bit is ignored.

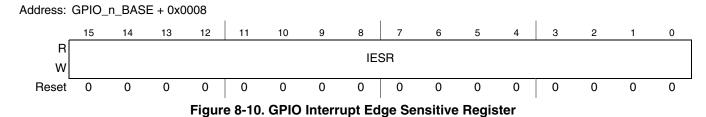


Table 8-9. Interrupt Edge Sensitive Register (GPIO_n_IESR) Description

Field	Description
	No edge detected if read; no effect if writing An edge detected if read; clear corresponding IPR bit if writing

8.4.2.9 Raw Data Register (GPIO_n_RAWDATA)

This read-only register allows the CPU direct access to the logic values on each GPIO pin, even when pins are not in the GPIO mode. The value at reset is unknown. Values are not clocked and are subject to change at any time. Read several times to ensure a stable value.

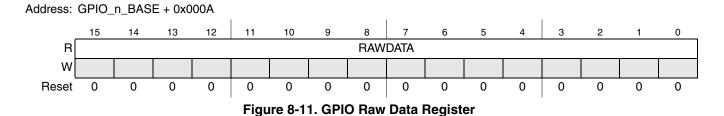


Table 8-10. Raw Data Register (GPIO_n_RAWDATA) Description

Field	Description
15–0 RAWDATA	0 0 present on GPIO pin 1 1 present on GPIO pin

8.4.2.10 Drive Strength Control Register (GPIO_n_DRIVE)

This register can be used to explicitly set the drive strength of each output driver. If write protection (via the SIM PROT register) is implemented, then this register value cannot be changed after the write protect signal has been asserted.

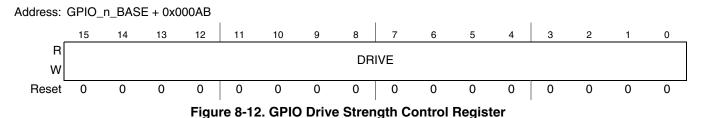


Table 8-11. GPIO Drive Strength Control Register Descriptions

Field	Description
DRIVE	0 = Low drive strength 1 = High drive strength Consult the device data sheet to see how this parameter affects output timing.

8.4.2.11 Input Filter Control Register (GPIO_n_IFE)

This register can be used to enable/disable the low pass filter associated with each GPIO pin. If write protection (via the SIM PROT register) is implemented, then this register value cannot be changed after the write protect signal has been asserted.



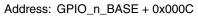
Table 8-12. GPIO Input Filter Control Register Descriptions

Fie	eld	Description
		0 = Input filter disabled 1 = Input filter enabled

8.4.2.12 Slew Rate Control Register (GPIO_n_SLEW)

This register can be used to enable/disable slew rate control for each output driver. This allows the user to trade off fast output edges versus improved EMC performance for a given application. If write protection (via the SIM PROT register) is implemented, then this register value cannot be changed after the write protect signal has been asserted.

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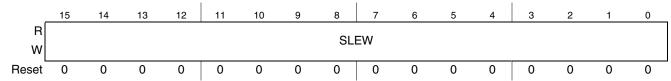


Figure 8-14. GPIO Slew Rate Control Register

Table 8-13. GPIO Slew Rate Control Register Descriptions

Field	Description
SLEW	0 = Output edges are slew rate controlled. 1 = Fast Output Edges (slew rate control is disabled) Consult the device data sheet to see how this parameter affects output timing.

General-Purpose Input/Output (GPIO)

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Chapter 9 Inter-Integrated Circuit (I²C)

9.1 Introduction

The inter-integrated circuit (IIC) provides a method of communication between a number of devices. The interface is designed to operate up to 100 kb/s with maximum bus loading and timing. The device is capable of operating at higher baud rates, up to a maximum of 480 kb/s, with reduced bus loading. The maximum communication length and the number of devices that can be connected are limited by a maximum bus capacitance of 400 pF. Compliant with System Management Bus Specification (SMBus), version2.

9.1.1 Features

The IIC includes these distinctive features:

- Compatible with IIC bus standard
- Multi-master operation
- Software programmable for one of 64 different serial clock frequencies
- Software selectable acknowledge bit
- Interrupt driven byte-by-byte data transfer
- Arbitration lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- START and STOP signal generation/detection
- Repeated START signal generation/detection
- Acknowledge bit generation/detection
- Bus busy detection
- General call recognition
- 10-bit address extension
- Support System Management Bus Specification (SMBus), version2

9.1.2 Modes of Operation

A brief description of the IIC in the various DSC core modes is given here.

- Run mode. This is the basic mode of operation. To conserve power in this mode, disable the module.
- Wait mode. The module continues to operate while the DSC core is in wait mode and can provide a wake-up interrupt.

• Stop mode. The IIC is inactive in LPstop mode for reduced power consumption. The STOP instruction does not affect IIC register states. Partial power down (PPD) resets the register contents.

9.1.3 Block Diagram

Figure 9-1 is a block diagram of the IIC.

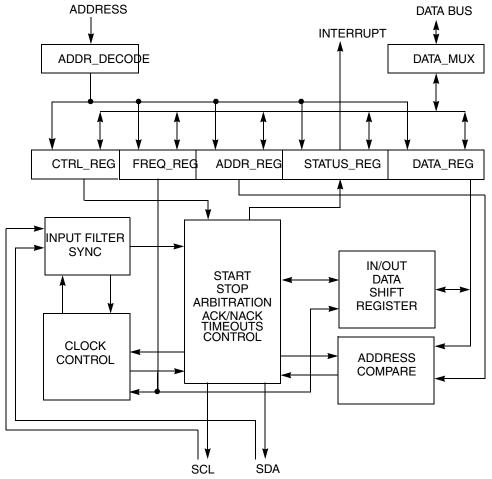


Figure 9-1. IIC Functional Block Diagram

9.2 External Signal Description

This section describes each user-accessible pin signal.

9.2.1 SCL — Serial Clock Line

The bidirectional SCL is the serial clock line of the IIC system.

9.2.2 SDA — Serial Data Line

The bidirectional SDA is the serial data line of the IIC system.

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9.3 Register Definition

9.3.1 Module Memory Map

The IIC has ten 8-bit registers that are zero-extended with bits 15 to 8 into 16-bit registers. The base address of the module is in the data sheet. The IIC register map is fixed and begins at the module's base address. Table 9-1 summarizes the IIC module's address space. The following section describes the bit-level arrangement and functionality of each register. Addresses are 16-bit word addresses, as each register is 16 bits including the zero extension bits, bits 15 to 8.

Address Use Access IIC Address Register 1 (I2C_ADDR) Read/write Base + 0x0000 IIC Frequency Divider Register (I2C_FREQDIV) Read/write Base + 0x0001 Base + IIC Control Register 1 (I2C_CR1) Read/write 0x0002 IIC Status Register (I2C_SR) Read Base + 0x0003 IIC Data IO Register (I2C_DATA) Read/write Base + 0x0004 Base + IIC Control Register 2 (I2C_CR2) Read/write 0x0005 Base + SMBUS IIC Control and Status Register Read/write 0x0006 (I2C_SMB_CSR) Base + IIC Address Register 2 (I2C_ADDR) Read/write 0x0007 IIC SCL Low Time Out Register High (I2C_SLT1) Base + Read/write 8000x0 Base + IIC SCL Low Time Out Register Low (I2C_SLT2) Read/write 0x0009

Table 9-1. Module Memory Map

This section consists of the IIC register descriptions in address order.

Refer to the direct-page register summary in the Memory chapter of this data sheet for the absolute address assignments for all IIC registers. This section refers to registers and control bits only by their names. A Freescale-provided equate or header file is used to translate these names into the appropriate absolute addresses.

9.3.2 IIC Address Register 1 (IICA1)

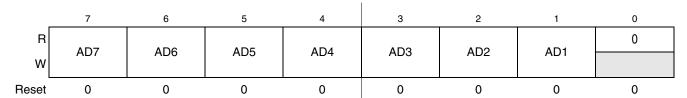


Figure 9-2. IIC Address Register 1 (IICA1)

Table 9-2. IICA1 Field Descriptions

Field	Description
	Slave Address 1. The AD field contains the slave address to be used by the IIC module. This field is used on the 7-bit address scheme and the lower seven bits of the 10-bit address scheme.
0	Reserved.

9.3.3 IIC Frequency Divider Register (IICF)

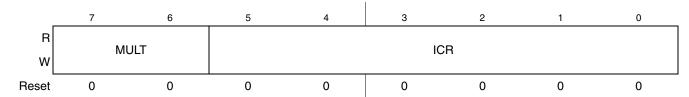


Figure 9-3. IIC Frequency Divider Register (IICF)

Table 9-3. IICF Field Descriptions

Field	Description
7, 6 MULT	IIC Multiplier Factor. The MULT bits define the multiplier factor mul. This factor is used along with the SCL divider to generate the IIC baud rate. The multiplier factor mul as defined by the MULT bits is provided below. 00 mul = 01 01 mul = 02 10 mul = 04 11 Reserved
5–0 ICR	IIC Clock Rate. The ICR bits are used to prescale the bus clock for bit rate selection. These bits and the MULT bits are used to determine the IIC baud rate, the SDA hold time, the SCL Start hold time and the SCL Stop hold time. Table 9-5 provides the SCL divider and hold values for corresponding values of the ICR.

The SCL divider multiplied by multiplier factor mul is used to generate IIC baud rate.

IIC baud rate = bus speed (Hz)/(mul * SCL divider)

Eqn. 9-1

SDA hold time is the delay from the falling edge of SCL (IIC clock) to the changing of SDA (IIC data).

SDA hold time = bus period (s) * mul * SDA hold value

Eqn. 9-2

SCL Start hold time is the delay from the falling edge of SDA (IIC data) while SCL is high (Start condition) to the falling edge of SCL (IIC clock).

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SCL Start hold time = bus period (s) * mul * SCL Start hold value

Eqn. 9-3

SCL stop hold time is the delay from the rising edge of SCL (IIC clock) to the rising edge of SDA SDA (IIC data) while SCL is high (stop condition).

SCL Stop hold time = bus period (s) * mul * SCL Stop hold value

Eqn. 9-4

For example if the bus speed is 8 MHz, the table below shows the possible hold time values with different ICR and MULT selections to achieve an IIC baud rate of 100 kb/s.

Table 9-4. I2C_FREQDIV Field Hold Times

MULT	ICR	Hold times (μs)		
WIOLI	ICh	SDA	SCL Start	SCL Stop
0x2	0x00	3.500	3.000	5.500
0x1	0x07	2.500	4.000	5.250
0x1	0x0B	2.250	4.000	5.250
0x0	0x14	2.125	4.250	5.125
0x0	0x18	1.125	4.750	5.125

Table 9-5. IIC Divider and Hold Values

ICR (hex)	SCL Divider	SDA Hold Value	SCL Hold (Start) Value	SDA Hold (Stop) Value
00	20	7	6	11
01	22	7	7	12
02	24	8	8	13
03	26	8	9	14
04	28	9	10	15
05	30	9	11	16
06	34	10	13	18
07	40	10	16	21
08	28	7	10	15
09	32	7	12	17
0A	36	9	14	19
0B	40	9	16	21
0C	44	11	18	23
0D	48	11	20	25
0E	56	13	24	29

ICR (hex)	SCL Divider	SDA Hold Value	SCL Hold (Start) Value	SCL Hold (Stop) Value
20	160	17	78	81
21	192	17	94	97
22	224	33	110	113
23	256	33	126	129
24	288	49	142	145
25	320	49	158	161
26	384	65	190	193
27	480	65	238	241
28	320	33	158	161
29	384	33	190	193
2A	448	65	222	225
2B	512	65	254	257
2C	576	97	286	289
2D	640	97	318	321
2E	768	129	382	385

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Table 9-5. IIC Divider and Hold Values (continued)

ICR (hex)	SCL Divider	SDA Hold Value	SCL Hold (Start) Value	SDA Hold (Stop) Value
0F	68	13	30	35
10	48	9	18	25
11	56	9	22	29
12	64	13	26	33
13	72	13	30	37
14	80	17	34	41
15	88	17	38	45
16	104	21	46	53
17	128	21	58	65
18	80	9	38	41
19	96	9	46	49
1A	112	17	54	57
1B	128	17	62	65
1C	144	25	70	73
1D	160	25	78	81
1E	192	33	94	97
1F	240	33	118	121

ICR (hex)	SCL Divider	SDA Hold Value	SCL Hold (Start) Value	SCL Hold (Stop) Value
2F	960	129	478	481
30	640	65	318	321
31	768	65	382	385
32	896	129	446	449
33	1024	129	510	513
34	1152	193	574	577
35	1280	193	638	641
36	1536	257	766	769
37	1920	257	958	961
38	1280	129	638	641
39	1536	129	766	769
3A	1792	257	894	897
3B	2048	257	1022	1025
3C	2304	385	1150	1153
3D	2560	385	1278	1281
3E	3072	513	1534	1537
3F	3840	513	1918	1921

9.3.4 IIC Control Register (IICC1)

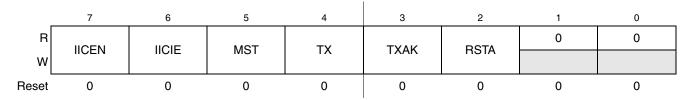


Figure 9-4. IIC Control Register (IICC1)

Table 9-6. IICC1 Field Descriptions

Field	Description
	IIC Enable. The IICEN bit determines whether the IIC module is enabled. 0 IIC is not enabled. 1 IIC is enabled.
	IIC Interrupt Enable. The IICIE bit determines whether an IIC interrupt is requested. 0 IIC interrupt request not enabled. 1 IIC interrupt request enabled.

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Table 9-6. IICC1 Field Descriptions (continued)

Field	Description
5 MST	Master Mode Select. When the MST bit is changed from a 0 to a 1, a START signal is generated on the bus and master mode is selected. When this bit changes from a 1 to a 0 a STOP signal is generated and the mode of operation changes from master to slave. O Slave mode. Master mode.
4 TX	Transmit Mode Select. The TX bit selects the direction of master and slave transfers. In master mode this bit should be set according to the type of transfer required. Therefore, for address cycles, this bit is always high. When addressed as a slave this bit should be set by software according to the SRW bit in the status register. O Receive. Transmit.
3 TXAK	Transmit Acknowledge Enable. This bit specifies the value driven onto the SDA during data acknowledge cycles for both master and slave receivers. There are two conditions that affect NAK/ACK generation. If FACK (fast NACK/ACK) is cleared, O An acknowledge signal is sent out to the bus on the following receiving data byte. No acknowledge signal response is sent to the bus on the following receiving data byte. If FASK bit is set. no ACK or NACK is sent out after receiving one data byte until this TXAK bit is written An acknowledge signal is sent out to the bus on the current receiving data byte No acknowledge signal response is sent to the bus on the current receiving data byte Note: SCL is held to low until TXAK is written.
2 RSTA	Repeat START. Writing a 1 to this bit generates a repeated START condition provided it is the current master. Attempting a repeat at the wrong time results in loss of arbitration. No repeat start detected in bus operation. Repeat start generated. Write Only read always 0.
1, 0	Reserved.

9.3.5 IIC Status Register (IICS)

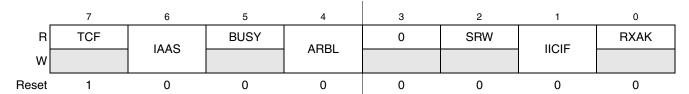


Figure 9-5. IIC Status Register (IICS)

Table 9-7. IICS Field Descriptions

Field	Description
7 TCF	Transfer Complete Flag. This bit is set on the completion of a byte and acknowledge bit transfer. Note that this bit is only valid during or immediately following a transfer to the IIC module or from the IIC module. The TCF bit is cleared by reading the IICD register in receive mode or writing to the IICD in transmit mode. O Transfer in progress. 1 Transfer complete.
6 IAAS	Addressed as a Slave. The IAAS bit is set when one of the following conditions is met • When the calling address matches the programmed slave address, • If the GCAEN bit is set and a general call is received. • If SIICAEN bit is set, when the calling address matches the 2nd programmed slave address • If ALERTEN bit is set and SMBus alert response address is received • This bit is set before ACK bit. The DSC core needs to check the SRW bit and set TX/RX bit accordingly. Writing the IICC1 register with any value clears this bit. 0 Not addressed. 1 Addressed as a slave.
5 BUSY	Bus Busy. The BUSY bit indicates the status of the bus regardless of slave or master mode. The BUSY bit is set when a START signal is detected and cleared when a STOP signal is detected. 0 Bus is idle. 1 Bus is busy.
4 ARBL	Arbitration Lost. This bit is set by hardware when the arbitration procedure is lost. The ARBL bit must be cleared by software, by writing a 1 to it. O Standard bus operation. Loss of arbitration.
3	Reserved
2 SRW	Slave Read/Write. When addressed as a slave the SRW bit indicates the value of the R/W command bit of the calling address sent to the master. O Slave receive, master writing to slave. 1 Slave transmit, master reading from slave.
1 IICIF	 IIC Interrupt Flag. The IICIF bit is set when an interrupt is pending. This bit must be cleared by software, by writing a 1 to it in the interrupt routine. One of the following events can set the IICIF bit: One byte transfer including ACK/NACK bit completes if FACK = 0 One byte transfer including ACK/NACK bit completes if FACK = 1 and this byte is an address byte One byte transfer excluding ACK/NCAK bit completes if FACK = 1 and this byte is a data byte. an ACK or NACK is sent out on the bus by writing 0 or 1 to TXAK after this bit is set. Match of slave addresses to calling address (primary slave address, general call address, alert response address, and second slave address) Arbitration lost Timeouts in SMBus mode except high timeout No interrupt pending. Interrupt pending.
0 RXAK	Receive Acknowledge. When the RXAK bit is low, it indicates an acknowledge signal has been received after the completion of one byte of data transmission on the bus. If the RXAK bit is high it means that no acknowledge signal is detected. O Acknowledge received. No acknowledge received.

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9.3.6 IIC Data I/O Register (IICD)

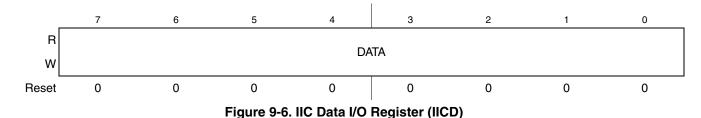


Table 9-8. IICD Field Descriptions

Field	Description
	Data. In master transmit mode, when data is written to the IICD, a data transfer is initiated. The most significant bit is sent first. In master receive mode, reading this register initiates receiving of the next byte of data.

NOTE

When transitioning out of master receive mode, the IIC mode should be switched before reading the IICD register to prevent an inadvertent initiation of a master receive data transfer.

In slave mode, the same functions are available after an address match has occurred.

Note that the TX bit in IICC must correctly reflect the desired direction of transfer in master and slave modes for the transmission to begin. For instance, if the IIC is configured for master transmit but a master receive is desired, then reading the IICD does not initiate the receive.

Reading the IICD returns the last byte received while the IIC is configured in either master receive or slave receive modes. The IICD does not reflect every byte that is transmitted on the IIC bus, nor can software verify that a byte has been written to the IICD correctly by reading it back.

In master transmit mode, the first byte of data written to IICD following assertion of MST (Start bit) or assertion of RSTA bit (repeated Start) is used for the address transfer and should comprise of the calling address (in bit 7 to bit 1) concatenated with the required R/\overline{W} bit (in position bit 0).

9.3.7 IIC Control Register 2 (IICC2)

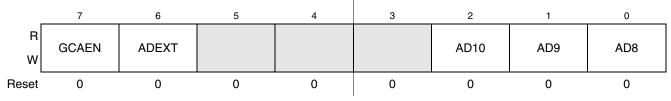


Figure 9-7. IIC Control Register (IICC2)

Table 9-9. IICC2 Field Descriptions

Field	Description						
7 GCAEN	General Call Address Enable. The GCAEN bit enables or disables general call address. O General call address is disabled General call address is enabled.						
6 ADEXT	Address Extension. The ADEXT bit controls the number of bits used for the slave address. 7-bit address scheme 1 10-bit address scheme						
5–3	Reserved.						
2–0 AD	Slave Address. The AD field contains the upper three bits of the slave address in the 10-bit address scheme. This field is valid only when the ADEXT bit is set.						

9.3.8 IIC SMBus Control and Status Register (IICSMB)

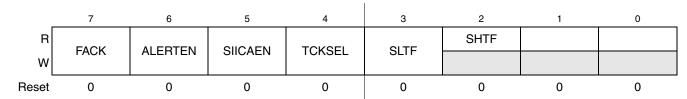


Figure 9-8. IIC SMBus Control and Status Register (IICSMB)

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Table 9-10.	IICSMB Field	Descriptions

Field	Description
7 FACK	Fast NACK/ACK Enable. For SMBus packet error checking, DSC core should be able to issue an ACK or NACK according to the result of receiving data byte. O ACK or NACK is sent out on the following receiving data byte. Writing an 0 to TXAK after receiving data byte generates an ACK; Writing an 1 to TXAK after receiving data byte generates a NACK
6 ALERTEN reserved	SMBus Alert Response Address Enable. The ALERTEN bit enables or disable SMBus alert response address. O SMBus alert response address matching is disabled. SMBus alert response address matching is enabled.
5 SIICAEN	Second IIC Address Enable. The SIICAEN bit enables or disable SMBus device default address. 0 IIC Address Register 2 matching is disabled. 1 IIC Address Register 2 matching is enabled.
4 TCKSEL	Time Out Counter Clock Select. This bit selects the clock sources of Time Out Counter 1 Time Out Counter counts at bus/64 frequency 2 Time Out Counter counts at the bus frequency
3 SLTF	SCL Low Timeout Flag. This read-only bit is set to 1 when IICSLT loaded non zero value (LoValue) and a SCL Low Time Out occurs. This bit is cleared by software, by writing a 1 to it No LOW TIME OUT occurs. A LOW TIME OUT occurs. Note: LOW TIME OUT function is disabled when IIC SCL LOW TIMER OUT register is set to zero
2 SHTF	SCL High Timeout Flag. This read-only bit is set to 1 when SCL and SDA are held high more than clock * LoValue/512, which indicates the bus free. This bit is cleared automatically. 0 No HIGH TIMEOUT occurs. 1 An HIGH TIMEOUT occurs.
1, 0	Reserved.

NOTE

A master can assume that the bus is free if it detects that the clock and data signals have been high for greater than t_{HIGH_MAX}, however, the SHTF rises in bus transmission process but bus idle state.

When TCKSEL=1 there is no meaning to monitor SHTF because the bus speed is too high to match the protocol of SMBus.

9.3.9 IIC Address Register 2 (I2C_ADDR)

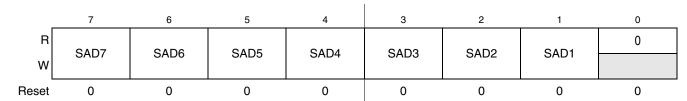


Figure 9-9. IIC Address Register 2 (I2C_ADDR)

Table 9-11. IIC Address Register 2 (I2C_ADDR) Descriptions

Field	Description
7–1 SAD[7:1]	SMBUs Address. The AD field contains the slave address to be used by the SMBus. This field is used on the device default address or other related address
0	Reserved.

IIC SCL Low Time Out Register High (I2C_SLT1) 9.3.10

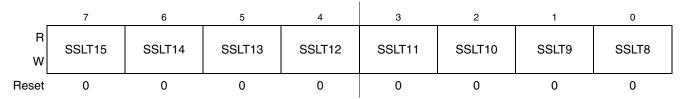


Figure 9-10. IIC SCL Low Time Out Register High (I2C_SLT1)

Table 9-12. IIC SCL Low Time Out Register High (I2C_SLT1) Descriptions

Field	Description
	The value in this register is the most significant byte of SCL low time out value that determines the time-out period of SCL low.

9.3.11 **IIC SCL Low Time Out register Low (I2C_SLT2)**

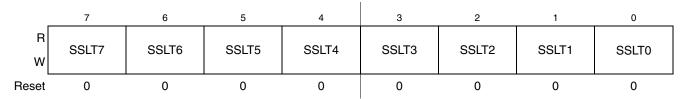


Figure 9-11. IIC SCL Low Time Out register Low (I2C_SLT2)

Table 9-13. IIC SCL Low Time Out register Low (I2C_SLT2) Descriptions

Field	Description
	The value in this register is the least significant byte of SCL low time out value that determines the time-out period of SCL low.

9.4 **Functional Description**

This section provides a complete functional description of the IIC module.

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9.4.1 IIC Protocol

The IIC bus system uses a serial data line (SDA) and a serial clock line (SCL) for data transfer. All devices connected to it must have open drain or open collector outputs. A logic AND function is exercised on both lines with external pull-up resistors. The value of these resistors is system dependent.

Normally, a standard communication is composed of four parts:

- START signal
- Slave address transmission
- Data transfer
- · STOP signal

The STOP signal should not be confused with the DSC core STOP instruction. The IIC bus system communication is described briefly in the following sections and illustrated in Figure 9-12.

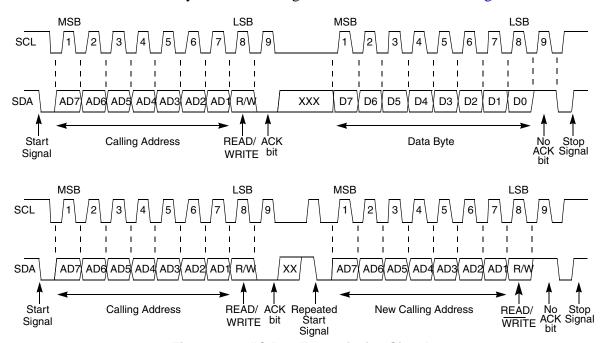


Figure 9-12. IIC Bus Transmission Signals

9.4.1.1 START Signal

When the bus is free; i.e., no master device is engaging the bus (both SCL and SDA lines are at logical high), a master may initiate communication by sending a START signal. As shown in Figure 9-12, a START signal is defined as a high-to-low transition of SDA while SCL is high. This signal denotes the beginning of a new data transfer (each data transfer may contain several bytes of data) and brings all slaves out of their idle states.

9.4.1.2 Slave Address Transmission

The first byte of data transferred immediately after the START signal is the slave address transmitted by the master. This is a seven-bit calling address followed by a R/\overline{W} bit. The R/\overline{W} bit tells the slave the desired direction of data transfer.

- 1 = Read transfer, the slave transmits data to the master.
- 0 =Write transfer, the master transmits data to the slave.

Only the slave with a calling address that matches the one transmitted by the master responds by sending back an acknowledge bit. This is done by pulling the SDA low at the 9th clock (see Figure 9-12).

No two slaves in the system may have the same address. If the IIC module is the master, it must not transmit an address that is equal to its own slave address. The IIC cannot be master and slave at the same time. However, if arbitration is lost during an address cycle, the IIC reverts to slave mode and operate correctly even if it is being addressed by another master.

9.4.1.3 Data Transfer

Before successful slave addressing is achieved, the data transfer can proceed byte-by-byte in a direction specified by the R/\overline{W} bit sent by the calling master.

All transfers that come after an address cycle are referred to as data transfers, even if they carry sub-address information for the slave device

Each data byte is 8 bits long. Data may be changed only while SCL is low and must be held stable while SCL is high as shown in Figure 9-12. There is one clock pulse on SCL for each data bit, the MSB being transferred first. Each data byte is followed by a 9th (acknowledge) bit, which is signalled from the receiving device. An acknowledge is signalled by pulling the SDA low at the ninth clock. In summary, one complete data transfer needs nine clock pulses.

If the slave receiver does not acknowledge the master in the 9th bit time, the SDA line must be left high by the slave. The master interprets the failed acknowledge as an unsuccessful data transfer.

If the master receiver does not acknowledge the slave transmitter after a data byte transmission, the slave interprets this as an end of data transfer and releases the SDA line.

In either case, the data transfer is aborted and the master does one of two things:

- Relinquishes the bus by generating a STOP signal.
- Commences a new calling by generating a repeated START signal.

9.4.1.4 STOP Signal

The master can terminate the communication by generating a STOP signal to free the bus. However, the master may generate a START signal followed by a calling command without generating a STOP signal first. This is called repeated START. A STOP signal is defined as a low-to-high transition of SDA while SCL at logical 1 (see Figure 9-12).

The master can generate a STOP even if the slave has generated an acknowledge at which point the slave must release the bus.

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9.4.1.5 Repeated START Signal

As shown in Figure 9-12, a repeated START signal is a START signal generated without first generating a STOP signal to terminate the communication. This is used by the master to communicate with another slave or with the same slave in different mode (transmit/receive mode) without releasing the bus.

9.4.1.6 Arbitration Procedure

The IIC bus is a true multi-master bus that allows more than one master to be connected on it. If two or more masters try to control the bus at the same time, a clock synchronization procedure determines the bus clock, for which the low period is equal to the longest clock low period and the high is equal to the shortest one among the masters. The relative priority of the contending masters is determined by a data arbitration procedure, a bus master loses arbitration if it transmits 1 while another master transmits 0. The losing masters immediately switch over to slave receive mode and stop driving SDA output. In this case, the transition from master to slave mode does not generate a STOP condition. Meanwhile, a status bit is set by hardware to indicate loss of arbitration.

9.4.1.7 Clock Synchronization

Because wire-AND logic is performed on the SCL line, a high-to-low transition on the SCL line affects all the devices connected on the bus. The devices start counting their low period and after a device's clock has gone low, it holds the SCL line low until the clock high state is reached. However, the change of low to high in this device clock may not change the state of the SCL line if another device clock is still within its low period. Therefore, synchronized clock SCL is held low by the device with the longest low period. Devices with shorter low periods enter a high wait state during this time (see Figure 9-13). When all devices concerned have counted off their low period, the synchronized clock SCL line is released and pulled high. There is then no difference between the device clocks and the state of the SCL line and all the devices start counting their high periods. The first device to complete its high period pulls the SCL line low again.

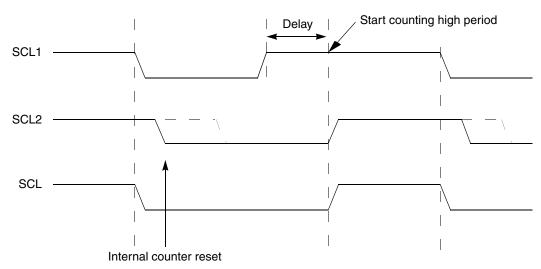


Figure 9-13. IIC Clock Synchronization

9.4.1.8 Handshaking

The clock synchronization mechanism can be used as a handshake in data transfer. Slave devices may hold the SCL low after completion of one byte transfer (9 bits). In such case, it halts the bus clock and forces the master clock into wait states until the slave releases the SCL line.

9.4.1.9 Clock Stretching

The clock synchronization mechanism can be used by slaves to slow down the bit rate of a transfer. After the master has driven SCL low the slave can drive SCL low for the required period and then release it. If the slave SCL low period is greater than the master SCL low period then the resulting SCL bus signal low period is stretched.

9.4.2 10-bit Address

For 10-bit addressing, 0x11110 is used for the first 5 bits of the first address byte. Various combinations of read/write formats are possible within a transfer that includes 10-bit addressing.

9.4.2.1 Master-Transmitter Addresses a Slave-Receiver

The transfer direction is not changed (see Table 9-14). When a 10-bit address follows a START condition, each slave compares the first seven bits of the first byte of the slave address (11110XX) with its own address and tests whether the eighth bit (R/\overline{W}) direction bit) is 0. It is possible that more than one device finds a match and generate an acknowledge (A1). Each slave that finds a match compares the eight bits of the second byte of the slave address with its own address, but only one slave finds a match and generate an acknowledge (A2). The matching slave remains addressed by the master until it receives a STOP condition (P) or a repeated START condition (Sr) followed by a different slave address.



Figure 9-14. Master-Transmitter Addresses Slave-Receiver with a 10-bit Address

After the master-transmitter has sent the first byte of the 10-bit address, the slave-receiver sees an IIC interrupt. User software must ensure that for this interrupt, the contents of I2C_DATA are ignored and not treated as valid data.

9.4.2.2 Master-Receiver Addresses a Slave-Transmitter

The transfer direction is changed after the second R/\overline{W} bit (see Table 9-15). Up to and including acknowledge bit A2, the procedure is the same as that described for a master-transmitter addressing a slave-receiver. After the repeated START condition (Sr), a matching slave remembers that it was addressed before. This slave then checks whether the first seven bits of the first byte of the slave address following Sr are the same as they were after the START condition (S), and tests whether the eighth (R/\overline{W}) bit is 1. If there is a match, the slave considers that it has been addressed as a transmitter and generates acknowledge

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A3. The slave-transmitter remains addressed until it receives a STOP condition (P) or a repeated START condition (Sr) followed by a different slave address.

After a repeated START condition (Sr), all other slave devices also compare the first seven bits of the first byte of the slave address with their own addresses and test the eighth (R/\overline{W}) bit. However, none of them are addressed because $R/\overline{W} = 1$ (for 10-bit devices), or the 11110XX slave address (for 7-bit devices) does not match.

s	Slave Address first 7 bits	R/W	A1	Slave Address second byte	A2	Sr	Slave Address first 7 bits	R/W	А3	Data	А	 Data	A	Р
	11110 + AD10 + AD9	0		AD[8:1]			11110 + AD10 + AD9	1						

Figure 9-15. Master-Receiver Addresses a Slave-Transmitter with a 10-bit Address

After the master-receiver has sent the first byte of the 10-bit address, the slave-transmitter sees an IIC interrupt. User software must ensure that for this interrupt, the contents of I2C_DATA are ignored and not treated as valid data.

9.4.3 Address Matching

All received addresses can be requested in 7-bit or 10-bit address format. IIC address register 1, which contains the IIC primary slave address, always participates in the address matching process. If the GCAEN bit is set, general call participates in the address matching process. If the ALERTEN bit is set, alert response participates in the address matching process. If SIICAEN bit is set, the IIC address register 2 participates in the address matching process.

When the IIC responds to one of the above mentioned addresses, it acts as a slave-receiver and the IAAS bit is set after the address cycle. Software must read the I2C_DATA register after the first byte transfer to determine with which the address matches.

9.4.4 System Management Bus Specification

SMBus provides a control bus for system and power management related tasks. A system may use SMBus to pass messages to and from devices instead of tripping individual control lines. Removing the individual control lines reduces pin count. Accepting messages ensures future expandability. With the system management bus, a device can provide manufacturer information, tell the system what its model/part number is, save its state for a suspend event, report different types of errors, accept control parameters, and return its status.

9.4.4.1 Timeouts

The TTIMEOUT,MIN parameter allows a master or slave to conclude that a defective device is holding the clock low indefinitely or a master is intentionally trying to drive devices off the bus. It is highly recommended that a slave device release the bus (stop driving the bus and let SCL and SDA float high) when it detects any single clock held low longer than TTIMEOUT,MIN. Devices that have detected this

condition should reset their communication and be able to receive a new START condition in no later than TTIMEOUT.MAX.

SMBus defines a clock low time-out, TTIMEOUT of 35 ms and specifies TLOW: SEXT as the cumulative clock low extend time for a slave device and specifies TLOW: MEXT as the cumulative clock low extend time for a master device.

SCL Low Timeout

If the SCL line is held low by a slave device on the bus, no further communication is possible. Furthermore, the master cannot force the SCL line high to correct the error condition. To solve this problem, the SMBus protocol specifies that devices participating in a transfer must detect any clock cycle held low longer than a timeout value condition. Devices that have detected the timeout condition must reset the communication. When active master, if the IIC detects that SMBCLK low has exceeded the value of $t_{\text{Timeout_min}}$ it must generate a stop condition within or after the current data byte in the transfer process. When slave, upon detection of the $t_{\text{Timeout_min}}$ condition, the IIC resets its communication and be able to receive a new START condition.

SCL High (SMBus Free) Timeout

The IIC assumes that the bus is idle when it has determined that the SMBCLK and SMBDAT signals have been high for at least t_{High_max}. HIGH timeout can occur in two ways: 1) HIGH timeout detected after a STOP condition appears on the bus; 2) HIGH timeout detected after a START condition, but before a STOP condition appears on the bus. Any master detecting either scenario can assume the bus is free then SHTF rises. HIGH timeout occurred in scenario 2 if it ever detects that both the following is true: BUSY bit is high and SHTF is high.

CSMBCLK TIMEOUT MEXT

Figure 1-10: Timeout measurement intervals illustrates the definition of the timeout intervals, t_{Low_SEXT} and t_{Low_MEXT} . When master mode, the I^2C must not cumulatively extend its clock cycles for a period greater than t_{Low_MEXT} within a byte, where each byte is defined as START-to-ACK, ACK-to-ACK, or ACK-to-STOP. When CSMBCLK TIMEOUT MEXT occurs, SMBus MEXT rises and also trigger the SLTF.

CSMBCLK TIMEOUT SEXT

A master is allowed to abort the transaction in progress to any slave that violates the t_{Low_SEXT} or $t_{Timeout_min}$ specifications. This can be accomplished by the master issuing a STOP condition at the conclusion of the byte transfer in progress. When slave, the I^2C must not cumulatively extend its clock cycles for a period greater than t_{Low_SEXT} during any message from the initial START to the STOP. When CSMBCLK TIMEOUT SEXT occurs SEXT rises and also trigger SLTF.

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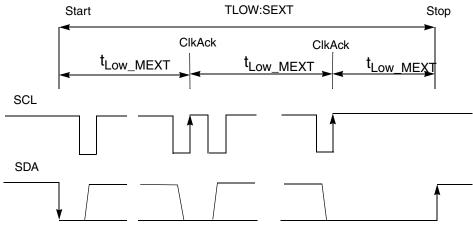


Figure 9-16. Timeout Measurement Intervals

NOTE

CSMBCLK TIMEOUT SEXT and MEXT are optional functions that are implemented in a second step.

9.4.4.2 FAST ACK and NACK

To improve reliability and communication robustness, implementation of packet error checking (PEC) by SMBus devices is optional for SMBus devices but required for devices participating in and only during the address resolution protocol (ARP) process. The PEC is a CRC-8 error checking byte, calculated on all the message bytes. The PEC is appended to the message by the device that supplied the last data byte. If the PEC is present but not correct, a NACK is issued by receiver. Otherwise an ACK is issued. To calculate the CRC-8 by software, this module can hold SCL line to low after receiving eighth SCL (bit 8) if this byte is a data byte. So software can determine whether an ACK or NACK should be sent out to the bus by setting or clearing TXAK bit if FASK (fast ACK/NACK enable bit) is enabled.

SMBus requires devices to acknowledge their own address always, as a mechanism to detect a removable devices presence on the bus (battery, docking station, etc.) Besides indicating a slave device busy condition, SMBus is using the NACK mechanism also indicates the reception of an invalid command or data. Because such a condition may occur on the last byte of the transfer, it is required that SMBus devices have the ability to generate the not acknowledge after the transfer of each byte and before the completion of the transaction. This is important because SMBus does not provide any other resend signaling. This difference in the use of the NACK signaling has implications on the specific implementation of the SMBus port, especially in devices that handle critical system data such as the SMBus host and the SBS components.

NOTE

In the last byte of master receive slave transmit mode, the master should send NACK to bus so FACK should be switched off before the last byte transmit.

9.5 Resets

The IIC is disabled after reset. The IIC cannot cause a DSC core reset.

9.6 Interrupts

The IIC generates a single interrupt.

An interrupt from the IIC is generated when any of the events in Table 9-14 occur, provided the IICIE bit is set. The interrupt is driven by bit IICIF (of the IIC status register) and masked with bit IICIE (of the IIC control register). The IICIF bit must be cleared by software by writing a 1 to it in the interrupt routine. The user can determine the interrupt type by reading the status register. For SMBus timeouts interrupt, the interrupt is driven by SLTF and masked with bit IICIE. The SLTF bit must be cleared by software by writing a 1 to it in the interrupt routine. The user can determine the interrupt type by reading the status register.

NOTE

In master receive mode the FACK should be set zero before the last byte transfer.

Interrupt Source	Status	Flag	Local Enable
Complete 1-byte transfer	TCF	IICIF	IICIE
Match of received calling address	IAAS	IICIF	IICIE
Arbitration Lost	ARBL	IICIF	IICIE
SMBus Timeout Interrupt Flag	SLTF	IICIF	IICIE

Table 9-14. Interrupt Summary

9.6.1 Byte Transfer Interrupt

The TCF (transfer complete flag) bit is set at the falling edge of the ninth clock to indicate the completion of byte transfer.

9.6.2 Address Detect Interrupt

When the calling address matches the programmed slave address (IIC address register) or when the GCAEN bit is set and a general call is received, the IAAS bit in the status register is set. The DSC core is interrupted, provided the IICIE is set. The DSC core must check the SRW bit and set its Tx mode accordingly.

9.6.3 Arbitration Lost Interrupt

The IIC is a true multi-master bus that allows more than one master to be connected on it. If two or more masters try to control the bus at the same time, the relative priority of the contending masters is determined by a data arbitration procedure. The IIC module asserts this interrupt when it loses the data arbitration process and the ARBL bit in the status register is set.

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Arbitration is lost in the following circumstances:

- SDA sampled as a low when the master drives a high during an address or data transmit cycle.
- SDA sampled as a low when the master drives a high during the acknowledge bit of a data receive cycle.
- A START cycle is attempted when the bus is busy.
- A repeated START cycle is requested in slave mode.
- A STOP condition is detected when the master did not request it.

This bit must be cleared by software by writing a 1 to it.

9.6.4 Timeouts Interrupt in SMbus

When IICIE is set, the IIC asserts a timeout interrupt output SLTF upon detection of any of the mentioned timeout conditions, with one exception. The HIGH TIMEOUT mechanism shall not be used to influence the timeout interrupt output, because the HIGH TIMEOUT indicates an idle condition on the bus. SLTF rises when it matches the HIGH TIMEOUT and fall automatically to just indicate the bus status.

9.7 Initialization/Application Information

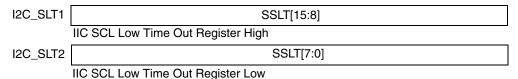


Figure 9-17. High and Low Registers

9.7.1 Module Initialization (Slave)

- Write: I2C_CR2
 - To enable or disable general call
 - To select 10-bit or 7-bit addressing mode
- Write: I2C_ADDR
 - To set the slave address
- Write: I2C_CR1
 - To enable IIC and interrupts
- Initialize RAM variables (IICEN = 1 and IICIE = 1) for transmit data
- Initialize RAM variables used to achieve the routine

9.7.2 Module Initialization (Master)

- Write: I2C_FREQDIV
 - To set the IIC baud rate (example provided in this chapter)
- Write: I2C_CR1

- To enable IIC and interrupts
- Initialize RAM variables (IICEN = 1 and IICIE = 1) for transmit data
- Initialize RAM variables used to achieve the routine
- Write: I2C_CR1
 - To enable TX
- Write: I2C CR1
 - To enable MST (master mode)
- Write: I2C_DATA
 - With the address of the target slave. The LSB of this byte determines whether the communication is master receive or transmit.

9.7.3 Module Use

The routine can handle both master and slave IIC operations. For slave operation, an incoming IIC message that contains the proper address begins IIC communication. For master operation, communication must be initiated by writing to the I2C DATA register.

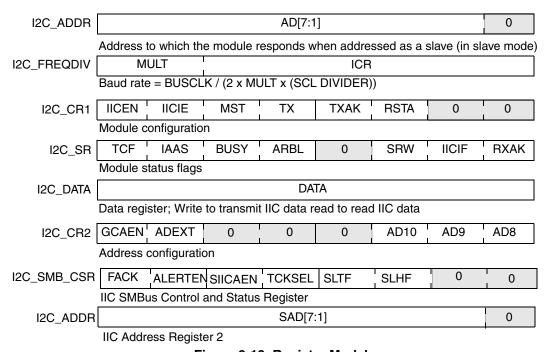
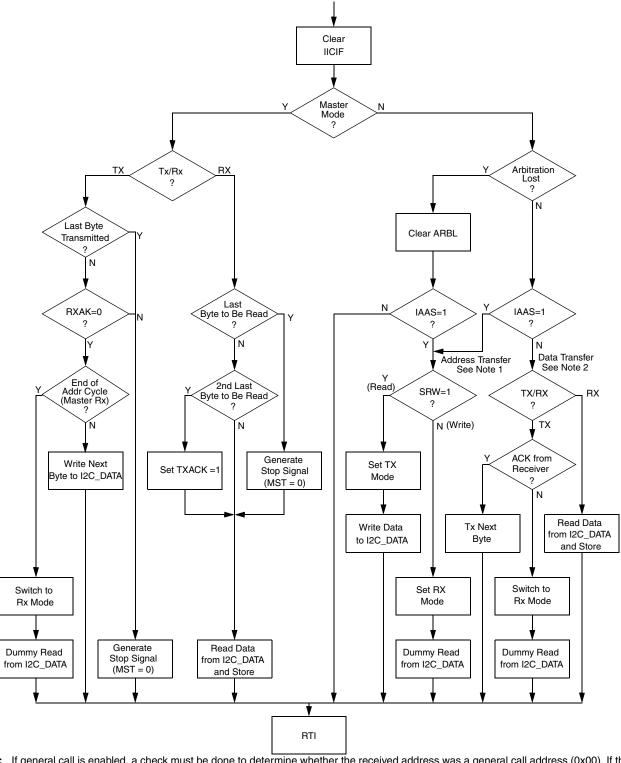


Figure 9-18. Register Model

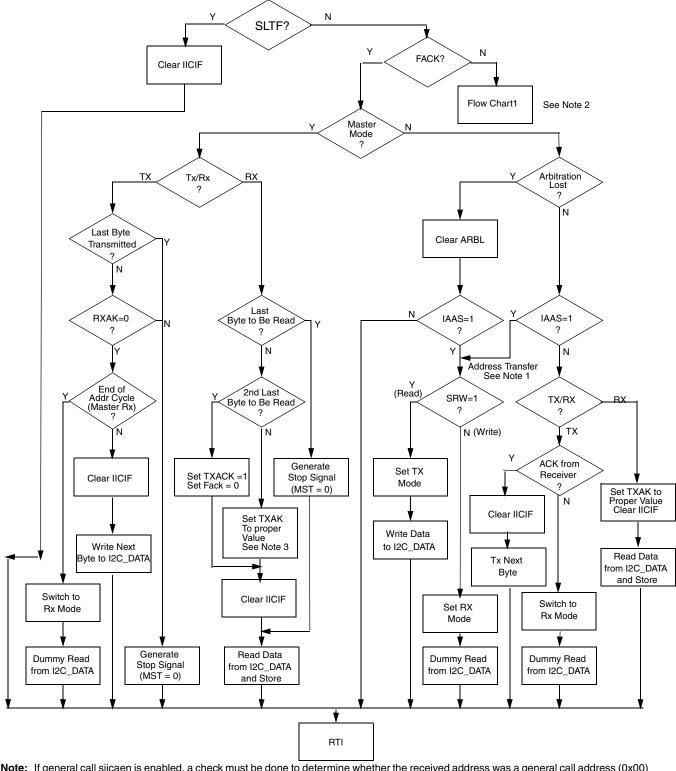
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Note: If general call is enabled, a check must be done to determine whether the received address was a general call address (0x00). If the received address was a general call address, then the general call must be handled by user software.

Note: When 10-bit addressing is used to address a slave, the slave sees an interrupt following the first byte of the extended address. User software must ensure that for this interrupt, the contents of I2C_DATA are ignored and not treated as a valid data transfer.

Figure 9-19. Typical IIC Interrupt Routine



Note: If general call siicaen is enabled, a check must be done to determine whether the received address was a general call address (0x00) or SMbus device default address. If the received address was one of them, then it must be handled by user software.

Note: Flow chart1 means figure 1-12 Typical IIC Interrupt Routine.

Note: Delay about 1-2bit scl cycle waiting data register updated then clear IICIF.

Figure 9-20. Typical IIC SMBus Interrupt Routine

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Chapter 10 Serial Communications Interface (SCI)

10.1 Overview

The SCI allows asynchronous serial communications with peripheral devices.

10.2 Features

- Full-duplex or single-wire operation
- Standard mark/space non-return-to-zero (NRZ) format
- 13-bit integer and 3-bit fractional baud rate selection
- Programmable 8-bit or 9-bit data format
- Separately enabled transmitter and receiver
- Separate receiver and transmitter DSC core interrupt requests
- Programmable polarity for transmitter and receiver
- Two receiver wakeup methods: idle line or address mark
- Interrupt-driven operation with seven flags:
 - Transmitter empty
 - Transmitter idle
 - Receiver full
 - Receiver overrun
 - Noise error
 - Framing error
 - Parity error
- Receiver framing error detection
- Hardware parity checking
- 1/16 bit-time noise detection

10.3 Block Diagram

The block diagram is located in Figure 10-1.

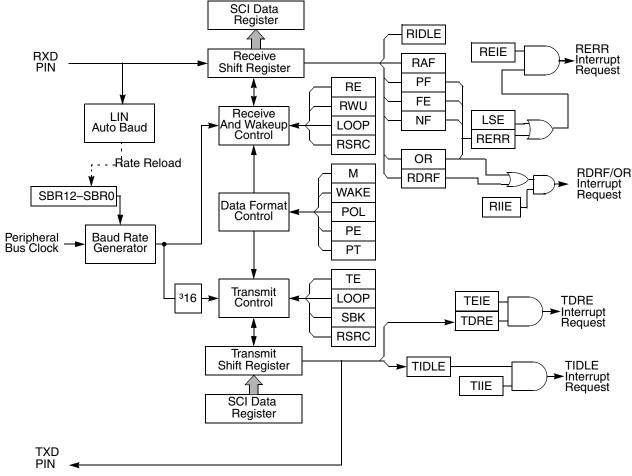


Figure 10-1. SCI Block Diagram

10.4 Signal Descriptions

10.4.1 Overview

Table 10-1. Signal Properties

Name	I/O Type	/O Type Function		
TXD	Output	Output Transmit Data Pin		
RXD	Input	Receive Data Pin	_	

10.4.2 External Pin Descriptions

10.4.2.1 TXD - Transmit Data

The transmit data pin (TXD) is the SCI transmitter pin.

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10.4.2.2 RXD – Receiver Data

The receiver data pin (RXD) is the SCI receiver pin.

10.5 Memory Map and Registers

10.5.1 Overview

There are five user-accessible registers on the SCI:

- SCI baud rate register (SCI RATE)
- SCI control register (SCI_CTRL1)
- SCI control register2 (SCI_CTRL2)
- SCI status register (SCI_STAT)
- SCI data register (SCI_DATA)

10.5.2 Module Memory Map

Table 10-2 shows the five user-accessible registers on the SCI.

Table 10-2. Module Memory Map

Address	Reg Name	Access
BASE + 0x0000	SCI Baud Rate Register (SCI_RATE)	Read/Write
BASE + 0x0001	SCI Control Register (SCI_CTRL1)	Read/Write
BASE + 0x0002	SCI Control Register 2 (SCI_CTRL2)	Read/Write
BASE + 0x0003	SCI Status Register (SCI_STAT)	Read Only
BASE + 0x0004	SCI Data Register (SCI_DATA)	Read/Write

10.5.3 Register Descriptions

10.5.3.1 SCI Baud Rate Register

Read: anytime Write: anytime

Address: Base + 0x0

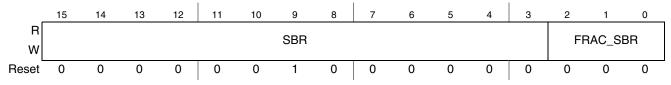


Figure 10-2. SCI Baud Rate Register (SCI_RATE)

Serial Communications Interface (SCI)

Table 10-3. SCI Baud Rate Register (SCI_RATE) Descriptions

Field	Description
15–3 SBR	SCI Baud Rate, a value from 1 to 8191.
2-0 FRAC_ SBR	Fractional SCI Baud Rate, a value from 0/8ths to 7/8ths. These two fields combine to form the divider to determine the baud rate of the SCI. SCI_RATE[SBR] represents the integer portion of the baud rate divider and SCI_RATE[FRAC_SBR] represents the fractional portion. Therefore, the range of the divider is from 1.000 to 8191.875. The formula for calculating baud rate is:
	SCI baud rate = $\frac{\text{peripheral bus clock}}{16 \times (\text{SBR+(FRAC_SBR/8)})}$
	Note: The baud rate generator is disabled until SCI_CTRL1[TE] or SCI_CTRL1[RE] is set for the first time after reset. The baud rate generator is disabled when SCI_RATE[SBR] and SCI_RATE[FRAC_SBR] = 0.
	Note: If SCI_CTRL2[LINMODE] is set, the value of this register is automatically adjusted to match the data rate of the LIN master device. Reading this register yields the auto-baud value set.

10.5.3.2 SCI Control Register

Read: anytime

Write: anytime

Address: Base + 0x1

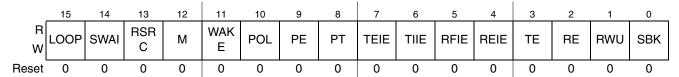


Figure 10-3. SCI Control Register (SCI_CTRL1)

Table 10-4. SCI Control Register (SCI_CTRL1) Descriptions

Field	Description				
15 LOOP	Loop Select. This bit enables loop operation ("Loop Operation"). In loop operation the RXD pin is disconnected from the SCI, and the transmitter output goes into the receiver input. Both the transmitter and the receiver must be enabled to use the internal loop function as opposed to single-wire operation ("Single-Wire Operation") that requires only or or the other to be enabled. 1 Loop operation enabled 0 Normal operation enabled The receiver input is determined by SCI_CTRL1[RSRC]. The transmitter output is controlled by SCI_CTRL1[TE]. If SCI_CTRL1[TE] is set and SCI_CTRL1[LOOP] = 1, the transmitter output appears on the TXD pin. If SCI_CTRL1[TE] is clear and SCI_CTRL1[LOOP] = 1, the TXD pin is high-impedance.				
		LOOP	RSRC	Function	
		0	Х	Normal operation	
		1	0	Loop mode with internal TXD fed back to RXD	
		1	1	Single-wire mode with TXD output fed back to RXD	
14 SWAI	Stop in Wait Mode. This bit disables the SCI in wait mode. 1 SCI disabled in wait mode 0 SCI enabled in wait mode				
13 RSRC	Receiver Source. When SCI_CTRL1[LOOP] = 1, SCI_CTRL1[RSRC] determines the internal feedback path for the receiver, as indicated in Table 10-1. 1 Receiver input connected to TXD pin 0 Receiver input connected internally to transmitter output				
12 M	Data Format Mode. This bit determines whether data characters are eight or nine bits long. 1 One start bit, nine data bits, one stop bit 0 One start bit, eight data bits, one stop bit				
11 WAKE	Wakeup Condition. This bit determines which condition wakes the SCI: a one (address mark) in the most significant bit position of a received data character or an idle condition on the RXD pin. 1 Address mark wakeup 0 Idle line wakeup				
10 POL	Polarity. This bit determines whether to invert the data as it goes from the transmitter to the TXD pin and from the RXD pin to the receiver. All bits (start, data, and stop) are inverted as they leave the transmit shift register and before they enter the receive shift register. 1 Invert transmit and receive data bits (inverted mode) 0 Don't invert transmit and receive data bits (normal mode) Note: It is recommended that SCI_CTRL1[POL] be toggled only when SCI_CTRL1[TE]=0 and SCI_CTRL1[RE]=0.				
9 PE	Parity Enable. This bit enables the parity function. When enabled, the parity function replaces the most significant bit of the data character with a parity bit. 1 Parity function enabled 0 Parity function disabled				
8 PT	Parity Type. This bit determines whether the SCI generates and checks for even parity or odd parity of the data bits. With even parity, an even number of ones clears the parity bit and an odd number of ones sets the parity bit. With odd parity, an odd number of ones clears the parity bit and an even number of ones sets the parity bit. 1 Odd parity 0 Even parity				

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Serial Communications Interface (SCI)

Table 10-4. SCI Control Register (SCI_CTRL1) Descriptions (continued)

Field	Description
7 TEIE	Transmitter Empty Interrupt Enable. This bit enables the transmit data register empty flag, SCI_STAT[TDRE], to generate interrupt requests. 1 SCI_STAT[TDRE] interrupt requests enabled 0 SCI_STAT[TDRE] interrupt requests disabled
6 TIIE	Transmitter Idle Interrupt Enable. This bit enables the transmitter idle flag, SCI_STAT[TIDLE], to generate interrupt requests. 1 SCI_STAT[TIDLE] interrupt requests enabled 0 SCI_STAT[TIDLE] interrupt requests disabled
5 RFIE	Receiver Full Interrupt Enable. This bit enables the receive data register full flag, SCI_STAT[RDRF], or the overrun flag, SCI_STAT[OR], to generate interrupt requests. 1 SCI_STAT[RDRF] and SCI_STAT[OR] interrupt requests enabled 0 SCI_STAT[RDRF] and SCI_STAT[OR] interrupt requests disabled
4 REIE	Receive Error Interrupt Enable. This bit enables the receive error flags (SCI_STAT[NF], SCI_STAT[PF], SCI_STAT[FE], and SCI_STAT[OR]) to generate interrupt requests. 1 Error interrupt requests enabled 0 Error interrupt requests disabled
3 TE	Transmitter Enable. This bit enables the SCI transmitter and configures the TXD pin as the SCI transmitter output. SCI_CTRL1[TE] can be used to queue an idle preamble. 1 Transmitter enabled 0 Transmitter disabled
2 RE	Receiver Enable. This bit enables the SCI receiver. 1 Receiver enabled 0 Receiver disabled
1 RWU	Receiver Wakeup. This bit enables the wakeup function and inhibits further receiver interrupt requests. See "Receiver Wakeup" for a description of receiver wakeup operation. Normally, hardware wakes the receiver by automatically clearing SCI_CTRL1[RWU]. 1 Standby state 0 Normal operation
0 SBK	Send Break. Toggling this bit sends one break character (10 or 11 zeroes). As long as this bit is set, the transmitter sends zeroes. 1 Transmit break characters 0 No break characters

10.5.3.3 SCI Control Register 2

Read: anytime Write: anytime

Address: BASE + 0x2

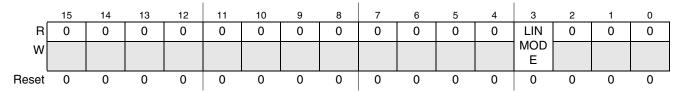


Figure 10-4. SCI Control Register 2 (SCI_CTRL2)

Table 10-5. SCI Control Register 2 (SCI_CTRL2) Descriptions

Field	Description
15–4	Reserved
3 LIN MODE	 Enable LIN Slave Mode. This bit should be used only in Local Interconnect Network (LIN) applications. 1 Enable LIN slave functionality. This includes a search for the break character followed by sync character (0x55) from the master LIN device. When the break is detected (11 consecutive samples of zero) the subsequent sync character is used to measure the baud rate of the transmitting master and the SCI_RATE register is automatically reloaded with the value needed to "match" that baud rate. 0 The LIN auto baud feature is disabled and the SCI_RATE register maintains whatever value the processor writes to it. Note: During initialization the SCI_RATE register should be loaded to a value that is within 15% of the actual master data rate; otherwise 0x00 data may be misinterpreted as a break. Note: If the first character following a break is not the LIN sync character (0x55) the SCI_RATE register is not
0–2	adjusted and SCI_STAT[LSE] is set. Reserved.

10.5.3.4 SCI Status Register

Read: anytime

Write: this register is not writable

Address: BASE + 0x3

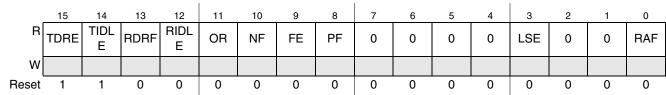


Figure 10-5. COP_VLP Status Register (SCI_STAT)

Table 10-6. COP_VLP Status Register (SCI_STAT) Descriptions

Field	Description
15 TDRE	Transmit Data Register Empty Flag. This bit is set when the Transmit Shift register receives a character from the Data register.
	Clear TDRE by reading the SCI_STAT register, then write to the SCI_DATA register.
14 TIDLE	Transmitter Idle Flag. This bit is set when the TDRE flag is set and no data, preamble, or break character is being transmitted. When TIDLE is set, the TXD pin becomes idle (1). Clear TIDLE by reading the SCI_STAT register, then write to the SCI_DATA register. 0 Transmission in progress 1 No transmission in progress
13 RDRF	Receive Data Register Full Flag. This bit is set when the data in the Receive Shift register transfers to the Data register. Clear RDRF by reading the SCI_STAT register, then read the SCI_DATA register. 0 Data not available in the SCI_DATA register 1 Received data available in the SCI_DATA register
12 RIDLE	Receiver Idle Line Flag. This bit is set when ten consecutive 1s (if M = 0) or eleven consecutive 1s (if M = 1) appear on the receiver input. After the RIDLE flag is cleared by the receiver detecting a 0, a valid frame must again set the RDRF flag before an idle condition can set the RIDLE flag. 0 Receiver input is either active now or has never become active since the RIDLE flag was last cleared by reset 1 Receiver input has become idle (after receiving a valid frame) Note: When the Receiver Wake-Up (RWU) bit is set, an idle line condition does not set the RIDLE flag.
11 OR	Overrun Flag. This bit is set when software fails to read the SCI_DATA register before the Receive Shift register receives the next frame. The data in the Shift register is lost, but the data already in the SCI_DATA register is not affected. Clear OR by reading the SCI_STAT register, then write the SCI_STAT register with any value. 0 No overrun 1 Overrun
10 NF	Noise Flag. This bit is set when the SCI detects noise on the receiver input. The NF bit is set during the same cycle as the RDRF flag, but it is not set in the case of an overrun. Clear NF by reading the SCI_STAT register, then write the SCI_STAT register with any value. 0 No noise 1 Noise
9 FE	Framing Error Flag. This bit is set when a 0 is accepted as the STOP bit. The FE bit is set during the same cycle as the RDRF flag but it is not set in the case of an overrun. FE inhibits further data reception until it is cleared. Clear FE by reading the SCI_STAT register, then write the SCI_STAT register with any value. 0 No framing error 1 Framing error
8 PF	Parity Error Flag. This bit is set when the Parity Enable (PE) bit is set and the parity of the received data does not match its parity bit. Clear PF by reading the SCI_STAT register, then write the SCI_STAT register with any value. 0 No parity error 1 Parity error
7–4	Reserved.
3 LSE	LIN Sync Error. This bit is active only when LIN MODE is set. When LSE is set, an RERR interrupt will occur if REIE is set. LSE is set when a LIN sync search detects a non-sync character (anything other than 0x55). Having this bit set indicates either a protocol error was detected from the Master LIN device or there is a gross mismatch in data rates. This bit is cleared by reading the SCI_STAT register with LSE set and then writing the SCI_STAT register with any value. 0 No error occurred since the SCI LIN MODE was enabled or the bit was last cleared. 1 A sync error prevented loading of the SBR with a revised value after the break was detected.

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Table 10-6. COP_VLP Status Register (SCI_STAT) Descriptions

Field	Description
2, 1	Reserved
0 RAF	Receiver Active Flag. This bit is set when the receiver detects a 0 during the RT1 time period of the START bit search. RAF is cleared when the receiver detects false START bits (usually from noise or baud rate mismatch) or when the receiver detects a preamble. 0 No reception in progress 1 Reception in progress

10.5.3.5 SCI Data Register

Read: anytime; reading accesses SCI receive data register

Write: anytime; writing accesses SCI transmit data register





Figure 10-6. SCI Data Register (SCI_DATA)

Table 10-7. SCI Data Register (SCI_DATA) Descriptions

Field	Description
15–9	Reserved
8–0 RECEIVE/ TRANSMIT DATA	Writing to these bits loads the transmit data. Reading these bits accesses the receive data. Note: When configured for 8-bit data, bits 7 to 0 contain the data received.

10.6 Functional Description

10.6.1 General

Figure 10-7 shows the structure of the SCI module. The SCI allows full duplex, asynchronous, NRZ serial communication between the DSP and remote devices, including other DSPs. The SCI transmitter and receiver operate independently, although they use the same baud rate generator. The DSC core monitors the status of the SCI, writes the data to be transmitted, and processes received data.

When initializing the SCI, be sure to set the proper peripheral enable bits in the GPIO as well as any pullup enables.

10.6.1.1 Data Frame Format

The SCI uses the standard NRZ mark/space data frame format illustrated in Figure 10-7.

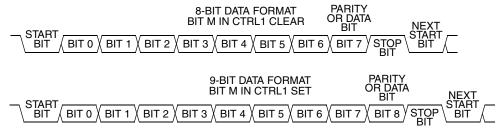


Figure 10-7. SCI Data Frame Formats

Each data character is contained in a frame that includes a start bit, eight or nine data bits, and a stop bit. Clearing SCI_CTRL1[M] configures the SCI for 8-bit data characters. A frame with eight data bits has a total of 10 bits, with formats as shown in Table 10-8.

Data Bits Start Bit Address Bit Parity Bit Stop Bit 1 8 0 0 1 1 7 0 1 1 11 7 0 1

Table 10-8. Example 8-Bit Data Frame Formats

Setting SCI_CTRL1[M] configures the SCI for 9-bit data characters. A frame with nine data bits has a total of 11 bits with formats as shown in Table 10-9.

Start Bit	Data Bits	Address Bit	Parity Bit	Stop Bit
1	9	0	0	1
1	8	0	0	2
1	8	0	1	1
1	8	1 ¹	0	1

Table 10-9. Example 9-Bit Data Frame Formats

10.6.1.2 **Baud Rate Generation**

A 13-bit modulus counter in the baud rate generator derives the baud rate for both the receiver and the transmitter. The value written to the SCI_RATE[SBR] and SCI_RATE[FRAC_SBR] bits determines the peripheral bus clock divisor. The baud rate clock is synchronized with the IP bus clock and drives the receiver. The baud rate clock divided by 16 drives the transmitter. The receiver has an acquisition rate of 16 samples per bit time.

Baud rate generation is subject to two sources of error:

Integer division of the peripheral bus clock may not give the exact target frequency.

The address bit identifies the frame as an address character. See "Receiver Wakeup."

The address bit identifies the frame as an address character. See "Receiver Wakeup."

• Synchronization with the bus clock can cause phase shift.

Table 10-10 lists some examples of achieving target baud rates with a peripheral bus clock frequency of 60 MHz.

Table 10-10. Example Baud Rates (Peripheral Bus Clock = 60 MHz)

SBR Bits	Receiver Clock (Hz)	Transmitter Clock (Hz)	Target Baud Rate	Error (%)
32.5	1,846,154	115,385	115,200	0.16
65.125	921,305	57,582	57,600	-0.03
97.625	614,597	38,412	38,400	0.03
195.25	307,298	19,206	19,200	0.03
390.625	153,600	9,600	9600	0.00
781.25	76,800	4,800	4800	0.00
1562.5	38,400	2,400	2400	0.00
3125	19,200	1,200.0	1200	0.00
6250	9,600	600.0	600	0.00

Table 10-11 lists some examples of achieving target baud rates with a peripheral bus clock frequency of 32 MHz.

Table 10-11. Example Baud Rates (Peripheral Bus Clock = 32 MHz)

SBR Bits	Receiver Clock (Hz)	Transmitter Clock (Hz)	Target Baud Rate	Error (%)
17.375	1,841,727	115,108	115,200	-0.08
34.75	920,863	57,554	57,600	-0.08
52.125	613,909	38,369	38,400	-0.08
104.125	307,323	19,208	19,200	0.04
208.375	153,569	9,598	9,600	-0.02
416.625	76,808	4,800	4,800	0.01
833.375	38,398	2,400	2,400	-0.01
1666.625	19,200	1,200	1,200	0.00
3333.375	9,600	600	600	0.00

NOTE

Maximum baud rate is peripheral bus clock rate divided by 16. System overhead may preclude processing the data at this speed.

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10.6.1.3 Transmitter

Figure 10-8 shows the block diagram of the transmitter functions. Detailed discussion of the transmitter functions is in the following sections.

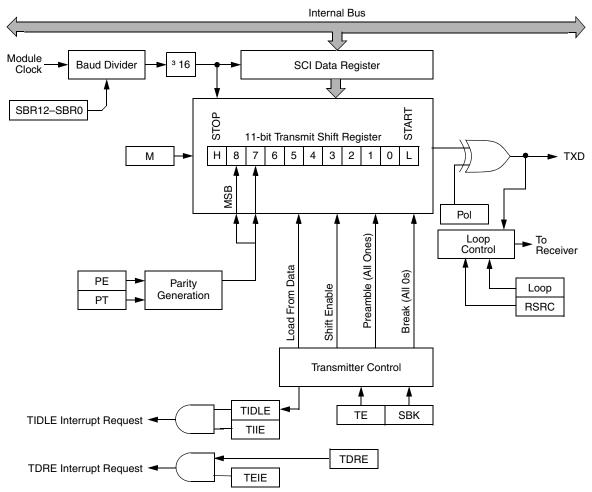


Figure 10-8. SCI Transmitter Block Diagram

Character Length

The SCI transmitter can accommodate either 8-bit or 9-bit data characters. The state of SCI_CTRL1[M] determines the length of data characters.

Character Transmission

During a SCI transmission, the transmit shift register shifts a frame out to the TXD pin. The SCI data register (SCI_DATA) is the write-only buffer between the internal data bus and the transmit shift register.

To initiate an SCI transmission:

- 1. Enable the transmitter by writing a one to the transmitter enable bit (SCI_CTRL1[TE]).
- 2. Clear the transmit data register empty flag, SCI_STAT[TDRE], by first reading the SCI status register (SCI_STAT) and then writing to the SCI data register (SCI_DATA).
- 3. Repeat step 2 for each subsequent transmission.

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Writing SCI_CTRL1[TE] bit from 0 to a 1 automatically loads the transmit shift register with a preamble of 10 ones (if SCI_CTRL1[M] = 0) or 11 ones (if SCI_CTRL1[M] = 1). After the preamble shifts out, control logic automatically transfers the data from the SCI data register into the transmit shift register. A logic zero start bit automatically goes into the least significant bit position of the transmit shift register. A logic one stop bit goes into the most significant bit (MSB) position of the frame.

Hardware supports odd or even parity. When parity is enabled, the MSB of the data character is replaced by the parity bit.

The transmit data register empty flag, SCI_STAT[TDRE], becomes set when the SCI data register transfers a character to the transmit shift register. SCI_STAT[TDRE] indicates that the SCI data register can accept new data from the internal data bus. If the transmitter empty interrupt enable bit, SCI_CTRL1[TEIE], is also set, SCI_STAT[TDRE] generates a transmitter interrupt request.

When the transmit shift register is not transmitting a frame and SCI_CTRL1[TE]=1, the TXD pin goes to the idle condition, logic one. If at any time software clears SCI_CTRL1[TE], the transmitter relinquishes control of the port I/O pin upon completion of the current transmission, causing the TXD pin to go to a high z state.

If software clears SCI_CTRL1[TE] while a transmission is in progress (SCI_STAT[TIDLE] = 0), the frame in the transmit shift register continues to shift out. Then transmission stops even if there is data pending in the SCI data register. To avoid accidentally cutting off the last frame in a message, always wait for SCI_STAT[TDRE] to go high after the last frame before clearing SCI_CTRL1[TE].

To separate messages with preambles with minimum idle line time, use this sequence between messages:

- 1. Write the last character of the first message to SCI_DATA.
- 2. Wait for SCI_STAT[TDRE] to go high while SCI_CTRL2[TFWM] = 00, indicating the transfer of the last frame to the transmit shift register.
- 3. Queue a preamble by clearing and then setting SCI_CTRL1[TE].
- 4. Write the first character of the second message to SCI_DATA.

Break Characters

Writing a logic one to the send break bit, SCI_CTRL1[SBK], loads the transmit shift register with a break character. A break character contains all logic zeroes and has no start, stop, or parity bit. Break character length depends on SCI_CTRL1[M]. As long as SCI_CTRL1[SBK] is at logic one, transmitter logic continuously loads break characters into the transmit shift register. After software clears SCI_CTRL1[SBK], the shift register finishes transmitting the last break character and then transmits at least one logic one. The automatic logic one at the end of the last break character guarantees the recognition of the start bit of the next frame.

The SCI recognizes a break character when a start bit is followed by eight or nine logic zero data bits and a logic zero where the stop bit should be. Receiving a break character has these effects on SCI registers:

- Sets the framing error flag, SCI_STAT[FE]
- Sets the receive data register full flag, SCI_STAT[RDRF], if SCI_CTRL2[RFWM] = 00
- Clears the SCI data register (SCI_DATA)

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 May set the overrun flag, SCI_STAT[OR], noise flag, SCI_STAT[NF], parity error flag, SCI_STAT[PF], or the receiver active flag, SCI_STAT[RAF]. See Section 10.5.3.4, "SCI Status Register."

Preambles

A preamble contains all logic ones and has no start, stop, or parity bit. Preamble length depends on SCI_CTRL1[M]. The preamble is a synchronizing mechanism that begins the first transmission initiated after writing SCI_CTRL1[TE] from 0 to 1.

If SCI_CTRL1[TE] is cleared during a transmission, the TXD pin becomes idle after completion of the transmission in progress. Clearing and then setting SCI_CTRL1[TE] during a transmission queues a preamble to be sent after the frame currently being transmitted.

NOTE

Toggle SCI_CTRL1[TE] for a queued preamble when SCI_STAT[TDRE] becomes set and immediately before writing the next character to the SCI_DATA register.

When queueing a preamble, return SCI_CTRL1[TE] to logic one before the stop bit of the current frame shifts out to the TXD pin. Setting SCI_CTRL1[TE] after the stop bit appears on TXD causes data previously written to the SCI data register to be lost.

10.6.1.4 Receiver

Figure 10-9 shows the block diagram of the SCI receiver. Detailed discussion of the receiver function is in the paragraphs that follow.

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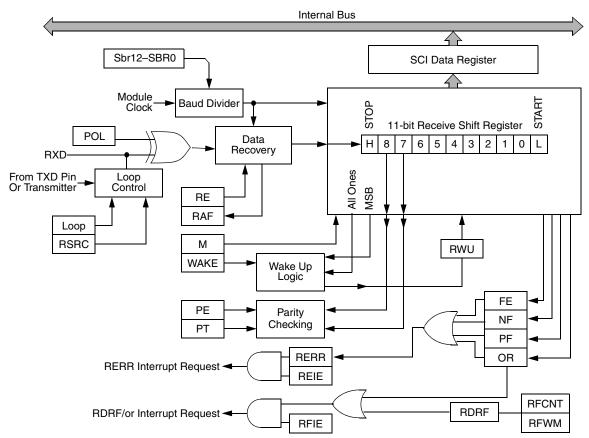


Figure 10-9. SCI Receiver Block Diagram

Character Length

The SCI receiver can accommodate either 8-bit or 9-bit data characters. The state of SCI_CTRL1[M] determines the length of data characters.

Character Reception

During an SCI reception, the receive shift register shifts a frame in from the RXD pin. The SCI data register/FIFO is the read-only buffer between the internal data bus and the receive shift register.

After a complete frame shifts into the receive shift register, the data portion of the frame along with the SCI_STAT[FE], SCI_STAT[NF], SCI_STAT[PF], and SCI_STAT[LSE] status flags transfer to the SCI data register. The receive data register full flag, SCI_STAT[RDRF], becomes set when the RX FIFO word count is above the watermark, indicating that a received character can be read. When the FIFO is enabled, there can be received data words to be read even if SCI_STAT[RDRF] is not set. If the receive interrupt enable bit, SCI_CTRL1[RFIE], is also set, SCI_STAT[RDRF] generates a Receiver Full interrupt request.

The SCI_STAT[FE], SCI_STAT[NF], SCI_STAT[PF], and SCI_STAT[LSE] flags are associated with the current character to be read from the receive data register/FIFO.

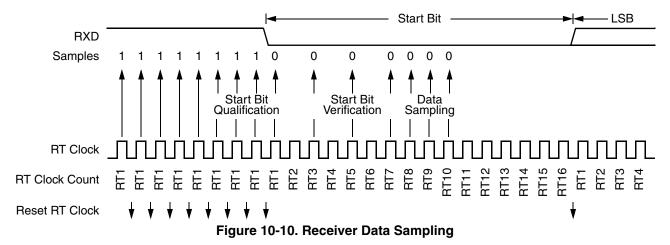
Data Sampling

The receiver samples the RXD pin at the RT clock rate. The RT clock is an internal signal with a frequency 16 times the baud rate. To adjust for baud rate mismatch, the RT clock (Figure 10-10) is resynchronized:

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- After every start bit
- After the receiver detects a data bit change from logic one to logic zero (after the majority of data bit samples at RT8, RT9, and RT10 returns a valid logic one, and the majority of the next RT8, RT9, and RT10 samples returns a valid logic zero)

To locate the start bit, data recovery logic does an asynchronous search for a logic zero preceded by three logic ones. When the falling edge of a possible start bit occurs, the RT clock begins to count to 16.



To verify the start bit and to detect noise, data recovery logic takes samples at RT3, RT5, and RT7. Table 10-12 summarizes the results of the start bit verification samples.

RT3, RT5, and Start Bit Verification Noise Flag **RT7 Samples** 000 Yes 0 1 001 Yes 010 Yes 1 011 No 0 100 Yes 1 101 0 No 110 No 0 111 0 No

Table 10-12. Start Bit Verification

If start bit verification is not successful, the RT clock is reset and a new search for a start bit begins.

To determine the value of a data bit and to detect noise, recovery logic takes samples at RT8, RT9, and RT10. Table 10-13 summarizes the results of the data bit samples.

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Table 10-13. Data Bit Recovery

RT8, RT9, and RT10 Samples	Data Bit Determination	Noise Flag
000	0	0
001	0	1
010	0	1
011	1	1
100	0	1
101	1	1
110	1	1
111	1	0

NOTE

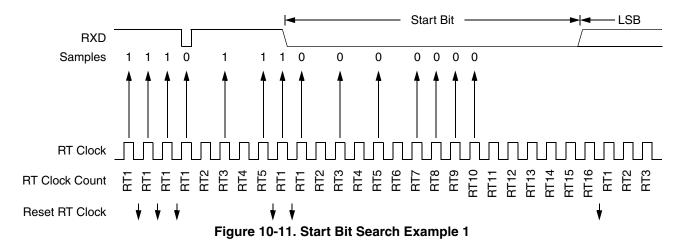
The RT8, RT9, and RT10 samples do not affect start bit verification. If any or all of the RT8, RT9, and RT10 start bit samples are logic ones following a successful start bit verification, the noise flag (SCI_STAT[NF]) is set and the receiver assumes that the bit is a start bit (logic zero).

To verify a stop bit and to detect noise, recovery logic takes samples at RT8, RT9, and RT10. Table 10-14 summarizes the results of the stop bit samples.

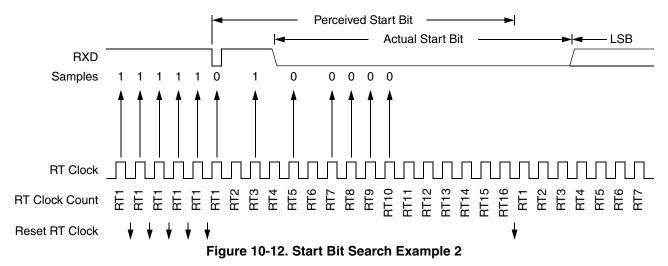
Table 10-14. Stop Bit Recovery

RT8, RT9, and RT10 Samples	Framing Error Flag	Noise Flag
000	1	0
001	1	1
010	1	1
011	0	1
100	1	1
101	0	1
110	0	1
111	0	0

In Figure 10-11 the verification samples RT3 and RT5 determine that the first low detected was noise and not the beginning of a start bit. The RT clock is reset and the start bit search begins again. The noise flag is not set because the noise occurred before the start bit was found.



In Figure 10-12 noise is perceived as the beginning of a start bit because the verification sample at RT3 is high. The RT3 sample sets the noise flag. Although the perceived bit time is misaligned, the data samples RT8, RT9, and RT10 are within the bit time and data recovery is successful.



In Figure 10-13 a large burst of noise is perceived as the beginning of a start bit, although the test sample at RT5 is high. The RT5 sample sets the noise flag. Although this is a worst-case misalignment of perceived bit time, the data samples RT8, RT9, and RT10 are within the bit time, and data recovery is successful.

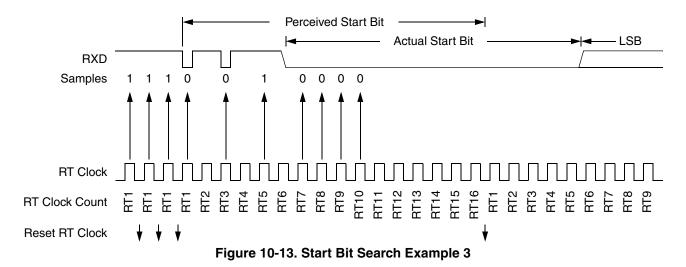


Figure 10-14 shows the effect of noise early in the start bit time. Although this noise does not affect proper synchronization with the start bit time, it does set the noise flag.

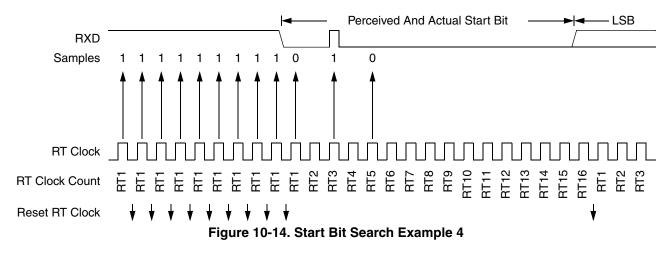
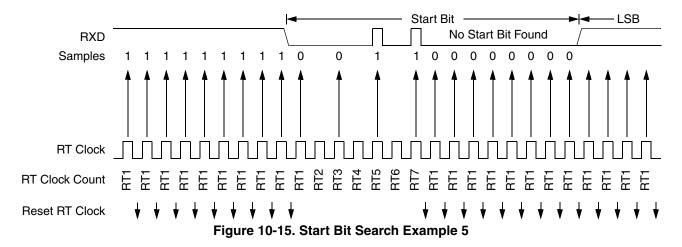
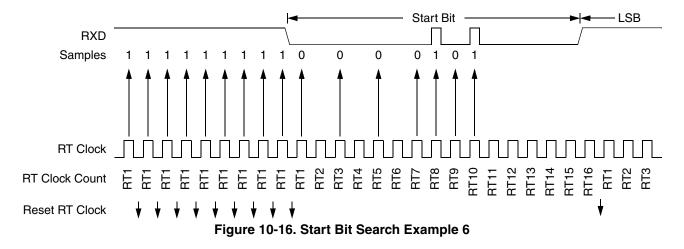


Figure 10-15 shows a burst of noise near the beginning of the start bit that resets the RT clock. The sample after the reset is low but is not preceded by three high samples that would qualify as a falling edge. Depending on the timing of the start bit search and on the data, the frame may be missed entirely or it may set the framing error flag.



In Figure 10-16 a noise burst makes the majority of data samples RT8, RT9, and RT10 high. This sets the noise flag but does not reset the RT clock. In start bits only, the RT8, RT9, and RT10 data samples are ignored.



Framing Errors

If the data recovery logic does not detect a logic one where the stop bit should be in an incoming frame, it sets the framing error flag, SCI_STAT[FE]. A break character also sets SCI_STAT[FE] because a break character has no stop bit. SCI_STAT[FE] is set at the same time that SCI_STAT[RDRF] is set.

Baud Rate Tolerance

A transmitting device may be operating at a baud rate below or above the receiver baud rate. Accumulated bit time misalignment can cause one of the three stop bit data samples to fall outside the actual stop bit. Then a noise error occurs. If more than one of the samples is outside the stop bit, a framing error occurs. In most applications, the baud rate tolerance is much more than the degree of misalignment that is likely to occur.

As the receiver samples an incoming frame, it resynchronizes the RT clock on any valid falling edge within the frame. Resynchronization within frames corrects misalignments between transmitter bit times and receiver bit times.

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Slow Data Tolerance

Figure 10-17 shows how much a slow received frame can be misaligned without causing a noise error or a framing error. The slow stop bit begins at RT8 instead of RT1 but arrives in time for the stop bit data samples at RT8, RT9, and RT10.

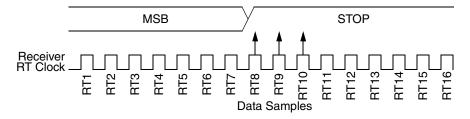


Figure 10-17. Slow Data

For an 8-bit data character, data sampling of the stop bit takes the receiver

9 bit
$$\times$$
 16 RT cycles + 10 RT cycles = 154 RT cycles.

Eqn. 10-1

With the misaligned character shown in Figure 10-17, the receiver counts 154 RT cycles at the point when the count of the transmitting device is 9 bit times \times 16 RT cycles + 3 RT cycles = 147 RT cycles.

The maximum percent difference between the receiver count and the transmitter count of a slow 8-bit data character with no errors is:

$$\frac{154 - 147}{154} \times 100 = 4.54\%$$
 Eqn. 10-2

For a 9-bit data character, data sampling of the stop bit takes the receiver

10 bit
$$\times$$
 16 RT cycles + 10 RT cycles = 170 RT cycles.

Eqn. 10-3

With the misaligned character shown in Figure 10-17, the receiver counts 170 RT cycles at the point when the count of the transmitting device is

10 bit
$$\times$$
 16 RT cycles + 3 RT cycles = 163 RT cycles.

Egn. 10-4

The maximum percent difference between the receiver count and the transmitter count of a slow 9-bit character with no errors is:

$$\frac{170-163}{170} \times 100 = 4.12\%$$
 Eqn. 10-5

Fast Data Tolerance

Figure 10-18 shows how much a fast received frame can be misaligned without causing a noise error or a framing error. The fast stop bit ends at RT10 instead of RT16 but is still sampled at RT8, RT9, and RT10.

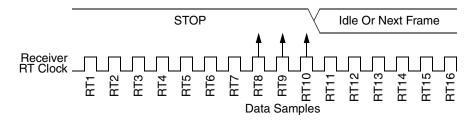


Figure 10-18. Fast Data

For an 8-bit data character, data sampling of the stop bit takes the receiver

9 bit
$$\times$$
 16 RT cycles + 10 RT cycles = 154 RT cycles.

Egn. 10-6

With the misaligned character shown in Figure 10-18, the receiver counts 154 RT cycles at the point when the count of the transmitting device is

10 bit
$$\times$$
 16 RT cycles = 160 RT cycles.

Eqn. 10-7

The maximum percent difference between the receiver count and the transmitter count of a fast 8-bit character with no errors is:

$$\frac{154-160}{154} \times 100 = 3.90\%$$
 Eqn. 10-8

For a 9-bit data character, data sampling of the stop bit takes the receiver

10 bit
$$\times$$
 16 RT cycles + 10 RT cycles = 170 RT cycles.

Egn. 10-9

With the misaligned character shown in Figure 10-18, the receiver counts 170 RT cycles at the point when the count of the transmitting device is

11 bit
$$\times$$
 16 RT cycles = 176 RT cycles.

Eqn. 10-10

The maximum percent difference between the receiver count and the transmitter count of a fast 9-bit character with no errors is:

$$\frac{170-176}{170} \times 100 = 3.53\%$$
 Eqn. 10-11

Receiver Wakeup

So that the SCI can ignore transmissions intended only for other receivers in multiple-receiver systems, the receiver can be put into a standby state. Setting the receiver wakeup bit, SCI_CTRL1[RWU], puts the receiver into a standby state during which receiver interrupts are disabled.

The transmitting device can address messages to selected receivers by including addressing information in the initial frame or frames of each message.

SCI_CTRL1[WAKE] determines how the SCI is brought out of the standby state to process an incoming message. SCI_CTRL1[WAKE] enables either idle line wakeup or address mark wakeup:

• Idle input line wakeup (SCI_CTRL1[WAKE = 0) — In this wakeup method, an idle condition on the RXD pin clears SCI_CTRL1[RWU] and wakes up the SCI. The initial frame or frames of every

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message contain addressing information. All receivers evaluate the addressing information, and receivers for which the message is addressed process the frames that follow. Any receiver for which a message is not addressed can set its SCI_CTRL1[RWU] bit and return to the standby state. SCI_CTRL1[RWU] remains set and the receiver remains on standby until another preamble appears on the RXD pin.

Idle line wakeup requires that messages be separated by at least one preamble and that no message contain preambles.

The preamble that wakes a receiver does not set the receiver idle bit, SCI_STAT[RIDLE], or the receive data register full flag, SCI_STAT[RDRF].

• Address mark wakeup (SCI_CTRL1[WAKE] = 1) — In this wakeup method, a logic one in the most significant bit (MSB) position of a frame clears SCI_CTRL1[RWU] and wakes up the SCI. The logic one in the MSB position marks a frame as an address frame that contains addressing information. All receivers evaluate the addressing information, and the receivers for which the message is addressed process the frames that follow. Any receiver for which a message is not addressed can set its RWU bit and return to the standby state. SCI_CTRL1[RWU] remains set and the receiver remains on standby until another address frame appears on the RXD pin.

The logic one MSB of an address frame clears the receiver's SCI_CTRL1[RWU] bit before the stop bit is received and sets SCI_STAT[RDRF].

Address mark wakeup allows messages to contain preambles but requires that the MSB be reserved for use in address frames.

NOTE

With SCI_CTRL1[WAKE] clear, setting SCI_CTRL1[RWU] after the RXD pin has been idle can cause the receiver to wake immediately.

Single-Wire Operation

Normally, the SCI uses two pins for transmitting and receiving. In single-wire operation, the RXD pin is disconnected from the SCI and is available as a general-purpose I/O pin. The SCI uses the TXD pin for both receiving and transmitting.

Setting SCI_CTRL1[TE] configures TXD as the output for transmitted data. Clearing SCI_CTRL1[TE] configures TXD as the input for received data.

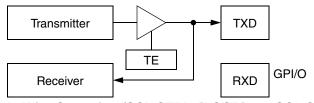


Figure 10-19. Single-Wire Operation (SCI_CTRL1[LOOP] = 1, SCI_CTRL1[RSRC] = 1)

Enable single-wire operation by setting SCI_CTRL1[LOOP] and the receiver source bit, SCI_CTRL1[RSRC]. Setting SCI_CTRL1[LOOP] disables the path from the RXD pin to the receiver. Setting SCI_CTRL1[RSRC] connects the receiver input to the output of the TXD pin driver.

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Loop Operation

In loop operation the transmitter output goes to the receiver input. The RXD pin is disconnected from the SCI and is available as a general-purpose I/O pin.

Setting SCI_CTRL1[TE] connects the transmitter output to the TXD pin. Clearing SCI_CTRL1[TE] disconnects the transmitter output from the TXD pin.

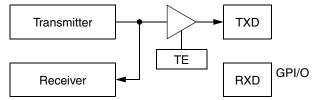


Figure 10-20. Loop Operation (SCI CTRL1[LOOP] = 1, SCI CTRL1[RSRC] = 0)

Enable loop operation by setting SCI_CTRL1[LOOP] and clearing SCI_CTRL1[RSRC]. Setting SCI_CTRL1[LOOP] disables the path from the RXD pin to the receiver. Clearing SCI_CTRL1[RSRC] connects the transmitter output to the receiver input. Both the transmitter and receiver must be enabled (SCI_CTRL1[TE] = 1 and SCI_CTRL1[RE] = 1).

10.6.1.5 LIN Slave Operation

LIN slave operation occurs when SCI_CTRL2[LIN MODE] is set. The receiver searches for a break character (a start bit, 8 bits of data all 0, and a 0 in the stop bit location). After a break character is detected (11 consecutive samples of logic zero), the next field to be received is the sync field. The sync field is a word with 0x55 data that produces an alternating 0 and 1 pattern. The receiver detects the falling edge at the beginning of the start bit and starts counting system clocks until the falling edge at the beginning of data bit 7 is detected, at which point it stops counting. This count is divided by 8 (for the 8-bit periods that have passed) and further divided by 16 to provide new SCI_RATE[SBR] and SCI_RATE[FRAC_SBR] values. If the data value of the sync field is 0x55, then these new SCI_RATE[SBR] and SCI_RATE[FRAC_SBR] values are placed in the baud rate register. Then the slave is considered synced to the master and further data words are received properly. If the data value of the sync field isn't 0x55, then the LIN sync error (SCI_STAT[LSE]) bit is set and subsequent received data bytes should be ignored.

In order for the break character to successfully detected, the initial band rate for this slave device must be within 15% of the nominal band rate for the LIN master device.

10.6.1.6 Low-Power Options

Run Mode

Clearing the transmitter enable or receiver enable bits (SCI_CTRL1[TE] or SCI_CTRL1[RE]) reduces power consumption in run mode. SCI registers are still accessible when SCI_CTRL1[TE] or SCI_CTRL1[RE] is cleared, but clocks to the core of the SCI are disabled.

Wait Mode

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SCI operation in wait mode depends on the state of SCI_CTRL1[SWAI].

• If SCI_CTRL1[SWAI] is clear, the SCI operates normally when the DSC core is in wait mode.

Model dood Reference Maridal, Nev. 0

• If SCI_CTRL1[SWAI] is set, SCI clock generation ceases and the SCI module enters a power-conservation state when the DSC core is in wait mode. In this condition, SCI registers are not accessible. Setting SCI_CTRL1[SWAI] does not affect the state of the receiver enable bit, SCI_CTRL1[RE], or the transmitter enable bit, SCI_CTRL1[TE].

If SCI_CTRL1[SWAI] is set, any transmission or reception in progress stops at wait mode entry. The transmission or reception resumes when either an internal or external interrupt brings the DSC out of wait mode. Exiting wait mode via reset will abort any transmission or reception in progress and will reset the SCI.

Stop Mode

The SCI is inactive in stop mode for reduced power consumption. The STOP instruction does not affect SCI register states. SCI operation resumes after an external interrupt brings the DSC core out of stop mode. Exiting stop mode via reset will abort any transmission or reception in progress and will reset the SCI.

10.7 Resets

Any system reset completely resets the SCI.

10.8 Clocks

All timing is derived from the IP bus clock, which is the main clock for this module. Section 10.6.1.2, "Baud Rate Generation" for a description of how the data rate is determined.

10.9 Interrupts

10.9.1 General

Table 10-15. Interrupt Summary

Interrupt	Source	Description
TDRE	Transmitter	Transmit Data Register Empty Interrupt
TIDLE	Transmitter	Transmit Idle Interrupt
RERR	Receiver	Receive Error (FE, NF, PF, or OR) Interrupt
RDRF/OR	Receiver	Receive Data Register Full / Overrun interrupt

10.9.2 Description of Interrupt Operation

10.9.2.1 Interrupt Sources

Table 10-16. SCI Interrupt Sources

Interrupt Source	Flag	Local Enable	Description
Transmitter	SCI_STAT[TDRE]	SCI_CTRL1[TEIE]	Transmit Data Register Empty Interrupt
Transmitter	SCI_STAT[TIDLE]	SCI_CTRL1[TIIE]	Transmit Idle Interrupt
Receiver	SCI_STAT[RDRF]	SCI_CTRL1[RFIE]	Receive Data Register Full / Overrun interrupt
	SCI_STAT[OR]		
Receiver	SCI_STAT[FE]	SCI_CTRL1[REIE]	Receive Error (FE, NF, PF, or OR) Interrupt
	SCI_STAT[PE]		
	SCI_STAT[NF]		
	SCI_STAT[OR]		

Transmitter Empty Interrupt

This interrupt is enabled by setting SCI_CTRL1[TEIE]. When this interrupt is enabled, an interrupt is generated when data is transferred from the SCI data register to the transmit shift register. The interrupt service routine should read SCI_STAT and verify that SCI_STAT[TDRE] is set, and then write the next data to be transmitted to SCI_DATA, which clears SCI_STAT[TDRE].

Transmitter Idle Interrupt

This interrupt is enabled by setting SCI_CTRL1[TIIE]. This interrupt indicates that SCI_STAT[TDRE] is set and the transmitter is no longer sending data, preamble, or break characters. The interrupt service routine should read SCI_STAT and verify SCI_STAT[TIDLE] is set, and then initiate a preamble, break, or write a data character to SCI_DATA. Any of these actions clear SCI_STAT[TIDLE] because the transmitter is then busy.

Receiver Full Interrupt

This interrupt is enabled by setting SCI_CTRL1[RFIE]. This interrupt indicates that receive data is available in SCI_DATA. The interrupt service routine should read SCI_STAT and verify that SCI_STAT[RDRF] is set, and then read the data from SCI_STAT, which clears SCI_STAT[RDRF].

Receive Error Interrupt

This interrupt is enabled by setting SCI_CTRL1[REIE]. This interrupt indicates that any of the listed errors was detected by the receiver:

- Noise flag (SCI_STAT[NF]) set
- Parity Error flag (SCI_STAT[PF]) set
- Framing Error flag (SCI_STAT[FE]) set
- OverRun flag (SCI_STAT[OR]) set

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The interrupt service routine should read SCI_STAT to determine which of the error flags was set. The error flag is cleared by writing (anything) to SCI_STAT. Then the appropriate action should be taken by the software to handle the error condition.

Recover from Wait Mode

Any enabled SCI interrupt request can bring the DSC core out of wait mode.

Serial Communications Interface (SCI)

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Chapter 11 Serial Peripheral Interface (SPI)

11.1 Introduction

11.1.1 Overview

This document describes the serial peripheral interface module. The SPI module allows full-duplex, synchronous, serial communication between the DSC and peripheral devices, including other DSCs and MCUs. Software can poll the SPI status flags or SPI operation can be interrupt-driven. The block contains four 16-bit memory-mapped registers for control parameters, status, and data transfer.

Features of the SPI module include the following:

- Full-duplex operation
- Master and slave modes
- Double-buffered operation with separate transmit and receive registers
- Programmable length transactions (2 to 16 bits)
- Programmable transmit and receive shift order (MSB or LSB first)
- 12 master mode frequencies (maximum = bus frequency ÷ 2)
- Maximum slave mode frequency = bus frequency ÷ 4
- Serial clock with programmable polarity and phase
- Two separately enabled interrupts:
 - SPRF (SPI receiver full)
 - SPTE (SPI transmitter empty)
- Mode fault error flag with DSC interrupt capability
- Overflow error flag with DSC interrupt capability
- Wired OR mode functionality enabling connection to multiple SPIs

Maximum SPI data rates are limited by I/O pad performance as specified in the data sheet.

11.1.2 Block Diagram

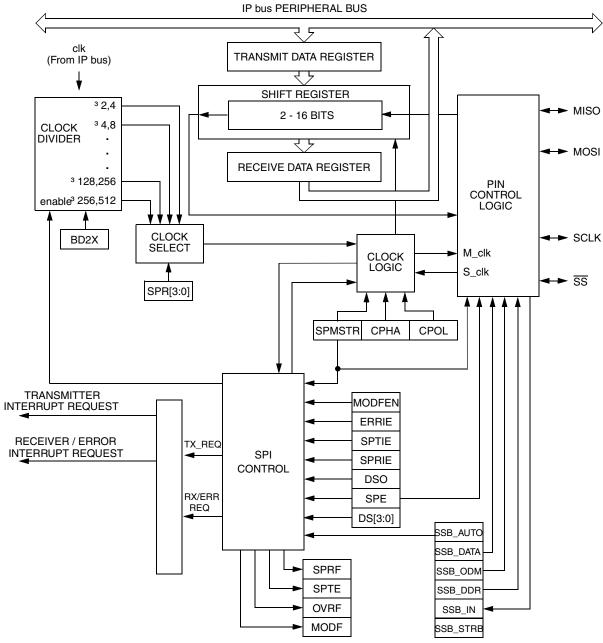


Figure 11-1. SPI Block Diagram

11.2 Signal Descriptions

11.2.1 External I/O Signals

The following are external I/O signals at the chip interface.

Table 11-1. External I/O

Signal Name	Signal Name Description	
MOSI	Master-out Slave-in Pad Pin	Bidirectional
MISO	Master-in Slave-out Pad Pin	Bidirectional
SCLK	Slave Clock Pad Pin	Bidirectional
SS	Slave Select Pad Pin (Active Low)	Bidirectional

11.2.2 MISO (Master In/Slave Out)

MISO is one of the two SPI module pins that transmits serial data. In full duplex operation, the MISO pin of the master SPI module is connected to the MISO pin of the slave SPI module. The master SPI simultaneously receives data on its MISO pin and transmits data from its MOSI pin.

Slave output data on the MISO pin is enabled only when the SPI is configured as a slave. The SPI is configured as a slave when its SPMSTR bit (see Section 11.3.2.1, "SPI Status and Control Register (SPI_SCTRL)") is logic zero and its \overline{SS} pin is at logic zero. To support a multiple-slave system, a logic one on the \overline{SS} pin puts the MISO pin in a high-impedance state.

11.2.2.1 MOSI (Master Out/Slave In)

MOSI is one of the two SPI module pins that transmits serial data. In full-duplex operation, the MOSI pin of the master SPI module is connected to the MOSI pin of the slave SPI module. The master SPI simultaneously transmits data from its MOSI pin and receives data on its MISO pin.

11.2.2.2 SCLK (Serial Clock)

The serial clock synchronizes data transactions between master and slave devices. In a master DSC, the SCLK pin is the clock output. In a slave DSC, the SCLK pin is the clock input. In full duplex operation, the master and slave DSC exchange data in the same number of clock cycles as the number of bits of transmitted data.

11.2.2.3 SS (Slave Select)

The SS pin has various functions depending on the current state of the SPI. For an SPI configured as a slave, the \overline{SS} is used to select a slave. For CPHA = 0, the \overline{SS} is used to define the start of a transaction. Because it is used to indicate the start of a transaction, the \overline{SS} must be toggled high and low between each full length set of data transmitted for the CPHA = 0 format. However, it can remain low between transactions for the CPHA = 1 format. See Figure 11-9.

When an SPI is configured as a slave, the \overline{SS} pin is always configured as an input. The MODFEN bit can prevent the state of the \overline{SS} from creating a MODF error.

NOTE

A logic one voltage on the \overline{SS} pin of a slave SPI puts the MISO pin in a high-impedance state. The slave SPI ignores all incoming SCLK clocks, even if it was already in the middle of a transaction. A mode fault occurs if the \overline{SS} pin changes state during a transaction.

When an SPI is configured as a master, the \overline{SS} input can be used in conjunction with the MODF flag to prevent multiple masters from driving MOSI and SCLK. For the state of the \overline{SS} pin to set the MODF flag, the MODFEN bit in the SCLK register must be set.

SPE **SPMSTR MODFEN** State of SS Logic **SPI Configuration** χ^1 SS ignored by SPI 0 Χ Not Enabled Input-only to SPI 1 0 Х Slave SS input ignored by SPI, SS output 1 0 Master without MODF may be activated under software or hardware control to select slave devices. Input-only to SPI Master with MODF

Table 11-2. SPI IO Configuration

11.3 Memory Map and Registers

11.3.1 Module Memory Map

Four registers control and monitor SPI operation. These registers should be accessed only with word accesses. Accesses other than word lengths result in undefined results. The SPI bit in the SIM module's SIM_PCE register must be 1 before the SPI registers can be changed.

Address	Name	Description
SPI_BASE + 0x0	SPI_SCTRL	SPI Status and Control Register
SPI_BASE + 0x1	SPI_DSCTRL	SPI Data Size and Control Register
SPI_BASE + 0x2	SPI_DRCV	SPI Data Receive Register
SPI_BASE + 0x3	SPI_DXMIT	SPI Data Transmit Register
SPI_BASE + 0x4	_	Reserved for FIFO compatibility
SPI_BASE + 0x5	_	Reserved for FIFO compatibility

Table 11-3. SPI Module Address Map

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 $^{^{1}}$ X = don't care

11.3.2 Register Descriptions

11.3.2.1 SPI Status and Control Register (SPI_SCTRL)

The SPI_SCTRL does the following:

- Selects master SPI baud rate
- Determines data shift order
- Enables SPI module interrupt requests
- Configures SPI module as master or slave
- Selects serial clock polarity and phase

NOTE

Using BFCLR or BFSET instructions on the SPI_SCTRL register can cause unintended side effects on the status bits.



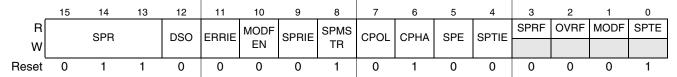


Figure 11-2. SPI Status and Control Register (SPI_SCTRL)

Table 11-4. SPI Status and Control Register (SPI_SCTRL) Descriptions

Field	Description					
15–13 SPR	SPI Baud Rate Select. In master mode, these read/write bits select one of eight baud rates as shown in the table below. SPR2, SPR1 and SPR0 have no effect in slave mode. Reset sets SPR[2:0] to b011. Use the following formula to calculate the SPI baud rate: $Baud rate = \frac{clk}{RD}$					
			BD			
			e: lk = peripheral bus clock D = baud rate divisor			
			Baud Rate [Divisor (BD)		
	SPR[2:0]	BD2X=0, SPR3=0	BD2X=1, SPR3=0	BD2X=0, SPR3=1	BD2X=1, SPR3=1	
	000	2	4	512	1024	
	001	4	8	1024	2048	
	010	8	16	2048	4096	
	011	16	32	4096	4096	
	100	32	64	4096	4096	
	101	64	128	4096	4096	
	110	128	256	4096	4096	
	111	256	512	4096	4096	
	Note: The maximum data transmission rate for the SPI is typically limited by the bandwidth of the I/O drivers on the chip. Typical limits are shown in the table below. These apply to both master and slave mode, and the BD field needs to be set to keep the module within these ranges. See Section 11.4.3, "Transmission Data." Below is a table that lists the transmission baud rate limitations due to I/O as a function of technology.					
			Normal	'	Wired-OR	
	TSMC 0.2	25	40 MHz		10 MHz	
	TSMC 0.18		40 MHz		10 MHz	
12 DSO	Data Shift Order. This reamaster and slave SPI moset, when reading the fround the MSB is at the corbits. 1 LSB transmitted first (0 MSB transmitt	dules need to trans m the SPI_DRCV r rect bit position. If th _SB -> MSB)	mit and receive the sam egister or writing to the S	e length packets. Re SPI_DXMIT the LSB	gardless of how this bit is always at bit location	
11 ERRIE	Error Interrupt Enable. This read/write bit enables the MODF (if MODFEN is also set) and OVRF bits to generate					

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Table 11-4. SPI Status and Control Register (SPI_SCTRL) Descriptions (continued)

Field	Description
10 MODFE	Mode Fault Enable. This read/write bit, when set to 1, allows the MODF flag to be set. If the MODF flag is set, clearing the MODFEN does not clear the MODF flag.
N	0 The level of the SS pin does not affect the operation of an enabled SPI configured as a master.
	1 If configured as a master, a transaction in progress stops if SS goes low.
	For an enabled SPI configured as a slave, having MODFEN low only prevents the MODF flag from being set. It does not affect any other part of SPI operation.
9 SPRIE	SPI Receiver Interrupt Enable. This read/write bit enables interrupt requests generated by the SPRF bit or the receive FIFO watermark register. 1 SPRF interrupt requests enabled 0 SPRF interrupt requests disabled
8 SPMST R	SPI Master. This read/write bit selects master mode operation or slave mode operation. 1 Master mode 0 Slave mode
7 CPOL	Clock Polarity. This read/write bit determines the logic state of the SCLK pin between transactions. To transmit data between SPI modules, the SPI modules must have identical CPOL values. 1 Falling edge of SCLK starts transaction 0 Rising edge of SCLK starts transaction
6 CPHA	Clock Phase. This read/write bit controls the timing relationship between the serial clock and SPI data. See Figure 11-8 and Figure 11-10. To transmit data between SPI modules, the SPI modules must have identical CPHA values. When CPHA = 0, the SS pin of the slave SPI module must be set to logic one between data words, as shown in Figure 11-9. DO NOT use CPHA = 0 while in DMA mode.
5 SPE	SPI Enable. This read/write bit enables the SPI module. Clearing SPE causes a partial reset of the SPI. When changing the SPE bit, you must change only the SPE bit. Use a separate write statement to change any other bits. In master mode the SPE bit can be cleared by a mode fault condition. 1 SPI module enabled 0 SPI module disabled
4 SPTIE	SPI Transmit Interrupt Enable. This read/write bit enables interrupt requests generated by the SPTE bit or the transmit FIFO watermark register. 1 SPTE interrupt requests enabled 0 SPTE interrupt requests disabled
3 SPRF	SPI Receiver Full. This clearable, read-only flag is set each time data is transferred from the shift register to the receive data register and there is no space available in the Rx queue to receive new data (Rx FIFO is full). SPRF generates an interrupt request if the SPRIE bit in the SPI control register is set. This bit automatically clears after reading the SPI_DRCV register. 1 Receive data register or FIFO is full 0 Receive data register or FIFO is not full (if using the FIFO, then read the RFCNT register to determine the number of valid words available)
2 OVRF	Overflow. This clearable, read-only flag is set if software does not read the data in the receive data register before the next full data enters the shift register. In an overflow condition, the data already in the receive data register is unaffected, and the data shifted in last is lost. Clear the OVRF bit by reading the SPI status and control register with OVRF set, and then reading the receive data register. 1 Overflow 0 No overflow

Serial Peripheral Interface (SPI)

Table 11-4. SPI Status and Control Register (SPI_SCTRL) Descriptions (continued)

Field	Description
1 MODF	Mode Fault. This clearable, read-only flag is set in a slave SPI if the SS pin goes high during a transaction with the MODFEN bit set. In a master SPI, the MODF flag is set if the SS pin goes low at any time with the MODFEN bit set. Clear the MODF bit by writing a one to the MODF bit when it is set. 1 SS pin at inappropriate logic level 0 SS pin at appropriate logic level
0 SPTE	SPI Transmitter Empty. This clearable, read-only flag is set each time the transmit data register transfers data into the shift register and there is no more new data available in the Tx queue (Tx FIFO is empty). SPTE generates an interrupt request if the SPTIE bit in the SPI control register is set. SPTE is cleared by writing to the SPI_DXMIT register. 1 Transmit data register or FIFO is empty. 0 Transmit data register or FIFO is not empty. If using the FIFO, then read the TFCNT register to determine how many words can be written safely. Note: Do not write to the SPI data register unless the SPTE bit is high. Otherwise, data may be lost.

11.3.2.2 SPI Data Size and Control Register (SPI_DSCTRL)

This read/write register determines the data length for each transaction. The master and slave must transfer the same size data on each transaction. A new value takes effect only at the time the SPI is enabled (SPE bit in SPI_SCTRL register set from a zero to a one). To have a new value take effect, first disable the SPI, then re-enable it with the new value in the register.

To use the \overline{SS} control functions in master mode, the appropriate bit must be set in GPIO_n_PER register to enable peripheral control of the \overline{SS} pin.

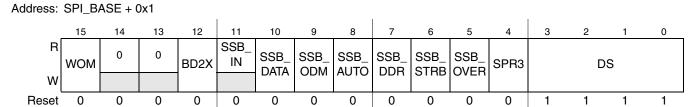


Figure 11-3. SPI Data Size and Control Register

Table 11-5. Abbreviation Field Descriptions

Field	Description		
15 WOM	Wired-OR Mode. The wired-OR mode (WOM) control bit is used to select the nature of the SPI pins. 1 The SPI pins are configured as open-drain drivers with the pullups disabled. 0 The SPI pins are configured as push-pull drivers.		
14, 13	Reserved.		
12 BD2X	Baud Divisor Times 2. When set the baud rate divisor is multiplied by 2. (See the description of the SPR field in Table 11-4.)		
11 SSB_IN	SS Input. This read only bit shows the current state of the SS pin in all modes.		

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Table 11-5. Abbreviation Field Descriptions (continued)

Field	Description
10 SSB_DAT A	SS Data. This read/write bit is the value to drive on the SS pin. This bit is disabled when SSB_AUTO = 1 or SSB_STRB = 1. 1 SS pin is driven high if SSB_DDR = 1 0 SS pin is driven low if SSB_DDR = 1
9 SSB_OD M	SS Open Drain Mode. This read/write bit enables open drain mode on the SS pin in master mode. 1 SS is configured as an open drain pin (only drives low output level). This mode is useful for multiple master systems. 0 SS is configured for high and low drive. This mode is generally used in single master systems.
8 SSB_AUT O	SS Automatic Mode. This read/write bit enables hardware control of the SS pin in master mode. (The legacy design requires software to control the SS output pin.) The initial falling edge of SS is generated and SS is held low until the Tx buffer or FIFO is empty. This bit may be used alone or in combination with the SS_STRB to generate the required SS signal. SS output signal is hardware-generated to create the initial falling edge and final rising edge. The idle state of the SS is high. SS output signal is software-generated by directly manipulating the various bits in this register or the GPIO registers (compatible with legacy SPI software).
7 SSB_DD R	SS Data Direction Register. This read/write bit controls input/output mode on the SS pin in master mode.1SS is configured as an output pin. Use this setting in master mode with MODFEN = 0.0SS is a configured as an input pin. Use this setting in slave mode or in master mode with MODFEN = 1.
6 SSB_ST RB	SS Strobe Mode. This read/write bit enables hardware pulse of the SS pin in master mode between words. This bit may be used alone or in combination with the SS_AUTO to generate the required SS signal. Pulses are generated between words irrespective of the setting of CPHA. 1 SS output signal is pulsed high between words. This adds 1.5 baud clocks to the total word period. The idle state of the SS is low unless SSB_AUTO is high — in that case the idle state is high. 0 No SS pulse between words.
5 SSB_OV ER	SS Override Register. This read/write bit overrides the internal SS signal input from the I/O pad and replaces it with a level equal to the setting of the SPMSTR bit. This allows the SPI to function in slave mode, CPHA = 1, without committing a GPIO pin to be tied low. This bit should not be used in multi-slave systems or when CPHA = 0. In master mode a mode fault error cannot be generated, so this bit should not be used in a multi-master system. 1 SS internal module input is selected to be equal to SPMSTR 0 SS internal module input is selected to be connected to a GPIO pin

Serial Peripheral Interface (SPI)

Table 11-5. Abbreviation Field Descriptions (continued)

Field	Description SPI Baud Rate Select. See the description of the SPR field in Table 11-4.			
4 SPR3				
3–0 DS3–DS0	Transaction data size.			
		DS3-DS0	Size of Transaction	
		0000	Not Allowed	
		0001	2 bits	
		0010	3 bits	
		0011	4 bits	
		0100	5 bits	
		0101	6 bits	
		0110	7 bits	
		0111	8 bits	
		1000	9 bits	
		1001	10 bits	
		1010	11 bits	
		1011	12 bits	
		1100	13 bits	
		1101	14 bits	
		1110	15 bits	
		1111	16 bits	

11.3.2.3 SPI Data Receive Register (SPI_DRCV)

The SPI data receive register consists of a read-only data register. Reading data from the register shows the last data received after a complete transaction. The SPRF bit is set when new data is transferred to this register.

Address: SPI_BASE + 0x2

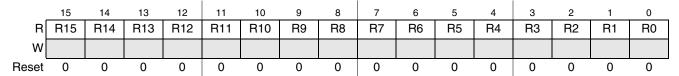


Figure 11-4. SPI Data Receive Register

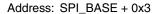
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Table 11-6. SPI Data Receive Register Descriptions

Field	Description
15–0 R	Receive Data

11.3.2.4 SPI Data Transmit Register (SPI_DXMIT)

The SPI data transmit register consists of a write-only data register. Writing data to this register writes the data to the transmit data buffer. When the SPTE bit is set, new data should be written to this register. If new data is not written while in master mode, a new transaction does not begin until this register is written. When selected in slave mode, the old data is retransmitted. When not selected and in slave mode, transmit data remains unchanged. All data should be written with the LSB at bit 0. This register can only be written when the SPI is enabled, in other words when SPE = 1.



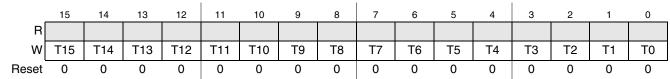


Figure 11-5. SPI Data Transmit Register

Table 11-7. SPI Data Transmit Register Descriptions

Field	Description
15–0 T	Transmit Data

11.4 Functional Description

11.4.1 Operating Modes

11.4.1.1 Master Mode

The SPI operates in master mode when the SPI master bit, SPMSTR, is set.

NOTE

Configure the SPI module as master or slave before enabling the SPI. Enable the master SPI before enabling the slave SPI. Disable the slave SPI before disabling the master SPI.

Only a master SPI module can initiate transactions. With the SPI enabled, software begins the transaction from the master SPI module by writing to the transmit data register. If the shift register is empty, the data immediately transfers to the shift register, setting the SPI transmitter empty bit, SPTE. The data begins shifting out on the MOSI pin under the control of the SPI serial clock, SCLK.

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The SPR2, SPR1, and SPR0 bits in the SPI_SCTRL register control the baud rate generator and determine the speed of the shift register. Through the SCLK pin, the baud rate generator of the master also controls the shift register of the slave peripheral.

As the data shifts out on the MOSI pin of the master, external data shifts in from the slave on the master's MISO pin. The transaction ends when the receiver full bit, SPRF, becomes set. At the same time that SPRF becomes set, the data from the slave transfers to the data receive register, SPI_DRCV. In normal operation, SPRF signals the end of a transaction. Software clears SPRF by reading the SPI_DRCV. Writing to the SPI data transmit register, SPI_DXMIT, clears the SPTE bit.

Figure 11-6 is an example configuration for a full-duplex master-slave configuration. Having the \overline{SS} bit of the master DSC held high is only necessary if MODFEN = 1. Tying the slave DSC \overline{SS} bit to ground should only be done if CPHA = 1.

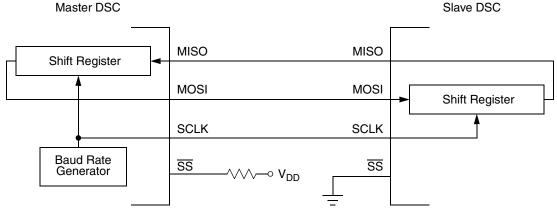


Figure 11-6. Full-Duplex Master-Slave Connections

11.4.1.2 Slave Mode

The SPI operates in slave mode when the SPMSTR bit is clear. In slave mode the SCLK pin is the input for the serial clock from the master DSC. Before a data transaction occurs, the \overline{SS} pin of the slave SPI must be at logic zero. \overline{SS} must remain low until the transaction is complete or a mode fault error occurs.

NOTE

The SPI must be enabled (SPE = 1) for slave transactions to be received.

Data in the transmitter shift register is unaffected by SCLK transitions in the event that the SPI is operating as a slave but is deselected ($\overline{SS} = 1$).

In a slave SPI module, data enters the shift register under the control of the serial clock, SCLK, from the master SPI module. After a full data word enters the shift register of a slave SPI, it transfers to the receive data register, SPI_DRCV, and the SPRF bit is set. To prevent an overflow condition, slave software then must read the receive data register before another full data word enters the shift register.

The maximum frequency of the SCLK for an SPI configured as a slave is less than 1/2 the bus clock frequency. The frequency of the SCLK for an SPI configured as a slave does not have to correspond to any SPI baud rate as defined by the SPR bits. The SPR bits control only the speed of the SCLK generated by an SPI configured as a master.

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When the master SPI starts a transaction, the data in the slave shift register begins shifting out on the MISO pin. The slave can load its shift register with new data for the next transaction by writing to its transmit data register. The slave must write to its transmit data register at least one bus cycle before the master starts the next transaction. Otherwise the data that was last transmitted is reloaded into the slave shift register and shifts out on the MISO pin again. Data written to the slave shift register during a transaction remains in a buffer until the end of the transaction.

When the clock phase bit (CPHA) is set, the first edge of SCLK starts a transaction. When CPHA is clear, the falling edge of \overline{SS} starts a transaction.

NOTE

SCLK must be in the proper idle state before the slave is enabled to preserve the proper SCLK, MISO, and MOSI timing relationships.

11.4.1.3 Wired-OR Mode

Wired-OR functionality is provided to permit the connection of multiple SPIs. Figure 11-7 illustrates the sharing of a single master device between multiple slave SPIs. When the WOM bit is set, the outputs switch from conventional complementary CMOS output to open drain outputs. This lets the internal pullup resistor bring the line high, and whichever SPI drives the line pulls it low as needed.

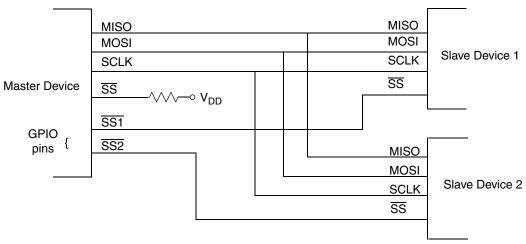


Figure 11-7. Master With Two Slaves

11.4.2 Transaction Formats

During an SPI transaction, data is simultaneously transmitted (shifted out serially) and received (shifted in serially). A serial clock synchronizes shifting and sampling on the two serial data lines. A slave select line allows selection of an individual slave SPI device; slave devices that are not selected do not interfere with SPI bus activities. On a master SPI device, the slave select line can optionally be used to indicate multiple-master bus contention.

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Serial Peripheral Interface (SPI)

11.4.2.1 Data Transaction Length

The SPI can support data lengths of two to sixteen bits. This can be configured in the data size register, SPI_DSCTRL. When the data length is less than sixteen bits, the receive data register pads the upper bits with zeros.

NOTE

Data can be lost if the data length is not the same for both master and slave devices.

11.4.2.2 Data Shift Ordering

The SPI can be configured to transmit or receive the MSB of the desired data first or last. This is controlled by the data shift order, DSO, bit in the SPI_SCTRL. Regardless of which bit is transmitted or received first, the data shall always be written to the data transmit register, SPI_DXMIT, and read from the receive data register, SPI_DRCV, with the LSB in bit 0 and the MSB in correct position depending on the data transaction size.

11.4.2.3 Clock Phase and Polarity Controls

Software can select any of four combinations of serial clock (SCLK) phase and polarity using two bits in the SPI control register (SPI_SCTRL). The clock polarity is specified by the CPOL control bit, which selects an active high or low clock and has no significant effect on the transaction format.

The clock phase (CPHA) control bit selects one of two fundamentally different transaction formats. The clock phase and polarity should be identical for the master SPI device and the communicating slave device. In some cases, the phase and polarity are changed between transactions to allow a master device to communicate with peripheral slaves having different requirements.

NOTE

Before writing to the CPOL bit or the CPHA bit, disable the SPI by clearing the SPI enable bit (SPE).

11.4.2.4 Transaction Format When CPHA = 0

Figure 11-8 shows an SPI transaction in which CPHA is logic zero. The figure should not be used as a replacement for data sheet parametric information. Two waveforms are shown for SCLK: one for CPOL = 0 and another for CPOL = 1. The diagram may be interpreted as a master or slave timing diagram since the serial clock (SCLK), master in/slave out (MISO), and master out/slave in (MOSI) pins are directly connected between the master and the slave. The MISO signal is the output from the slave, and the MOSI signal is the output from the master. When CPHA = 0, the first SCLK edge is the MSB capture strobe. Therefore the slave must begin driving its data before the first SCLK edge, and a falling edge on the \overline{SS} pin is used to start the slave data transaction. The slave's \overline{SS} pin must be toggled back to high and then low again between each data word transmitted, as shown in Figure 11-9.

When CPHA = 0 for a slave, the falling edge of \overline{SS} indicates the beginning of the transaction. This causes the SPI to leave its idle state and begin driving the MISO pin with the first bit of its data. After the transaction begins, no new data is allowed into the shift register from the transmit data register. Therefore,

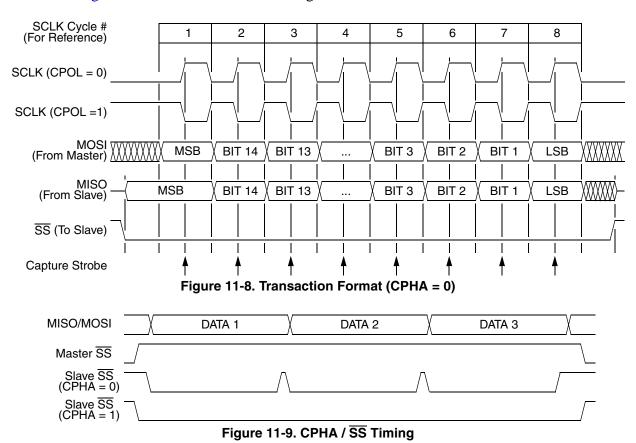
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the SPI data register of the slave must be loaded with transmit data before the falling edge of \overline{SS} . Any data written after the falling edge is stored in the transmit data register and transferred to the shift register after the current transaction. Also for correct operation of the slave, SPE must be active before the negative edge of \overline{SS} to correctly send/receive the first word. The \overline{SS} line is the slave select input to the slave. The slave SPI drives its MISO output only when its slave select input (\overline{SS}) is at logic zero, so that only the selected slave drives to the master.

When CPHA = 0 for a master, normal operation would begin by the master initializing the \overline{SS} pin of the slave high. A transfer would then begin by the master setting the \overline{SS} pin of the slave low and then writing the SPI_DXMIT register. After completion of a data transfer, the \overline{SS} pin would be put back into the high state by the master device. While MODFEN = 1, the \overline{SS} pin of the master must be high or a mode fault error occurs. If MODFEN = 0, the state of the \overline{SS} pin is ignored.

NOTE

Figure 11-8 assumes 16-bit data lengths and the MSB shifted out first.



11.4.2.5 Transaction Format When CPHA = 1

Figure 11-10 shows an SPI transaction in which CPHA is logic one. The figure should not be used as a replacement for data sheet parametric information. Two waveforms are shown for SCLK: one for CPOL = 0 and another for CPOL = 1. The diagram may be interpreted as a master or slave timing diagram since the serial clock (SCLK), master in/slave out (MISO), and master out/slave in (MOSI) pins are

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Serial Peripheral Interface (SPI)

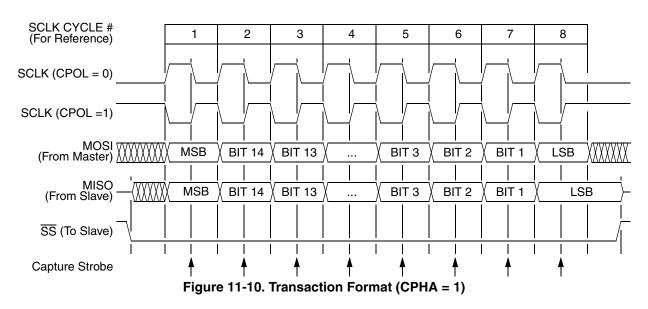
directly connected between the master and the slave. The MISO signal is the output from the slave, and the MOSI signal is the output from the master.

When CPHA = 1 for a slave, the first edge of the SCLK indicates the beginning of the transaction. This causes the SPI to leave its idle state and begin driving the MISO pin with the first bit of its data. After the transaction begins, no new data is allowed into the shift register from the transmit data register. Therefore, the SPI data register of the slave must be loaded with transmit data before the first edge of SCLK. Any data written after the first edge is stored in the transmit data register and transferred to the shift register after the current transaction. The \overline{SS} line is the slave select input to the slave. The slave SPI drives its MISO output only when its slave select input (\overline{SS}) is at logic zero, so that only the selected slave drives to the master.

When CPHA = 1 for a master, the MOSI pin begins being driven with new data on the first SCLK edge. If MODFEN = 0 the \overline{SS} pin of the master is ignored. Otherwise the \overline{SS} pin of the master must be high or a mode fault error occurs. The \overline{SS} pin can remain low between transactions. This format may be preferable in systems having only one master and only one slave driving the MISO data line.

NOTE

The following figure assumes 16-bit data lengths and the MSB shifted out first.



11.4.2.6 Transaction Initiation Latency

When the SPI is configured as a master (SPMSTR = 1), writing to the SPI_DXMIT starts a transaction. CPHA has no effect on the delay to the start of the transaction, but it does affect the initial state of the SCLK signal. When CPHA = 0, the SCLK signal remains inactive for the first half of the first SCLK cycle. When CPHA = 1, the first SCLK cycle begins with an edge on the SCLK line from its inactive to its active level. The SPI clock rate (selected by SPR2, SPR1, and SPR0) affects the delay from the write to SPI_DXMIT and the start of the SPI transaction. The internal baud clock in the master is a derivative of the internal DSC clock. To conserve power, it is enabled only after the SPMSTR bit is set and there is a new word written to the SPI_DXMIT. If the SPI_DXMIT has no new word when the current transaction

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completes, the internal baud clock is stopped. The initiation delay is a single SPI bit time as shown in Figure 11-11. That is, the delay is four DSC bus cycles for DIV4, eight DSC bus cycles for DIV8, sixteen DSC bus cycles for DIV16, thirty-two DSC bus cycles for DIV32, etc.

NOTE

Figure 11-11 assumes 16-bit data lengths and the MSB shifted out first.

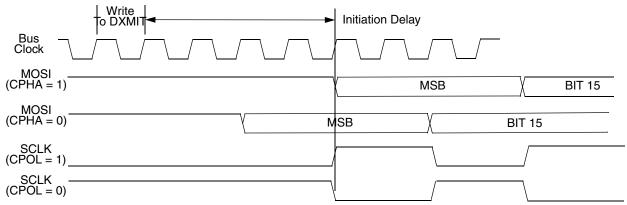
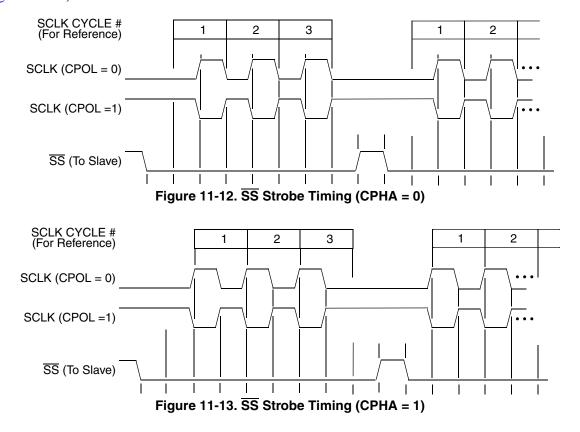


Figure 11-11. Transaction Start Delay (Master)

11.4.2.7 SS Hardware Generated Timing in Master Mode

If the SSB_STRB bit is set in master mode, the SPI generates a word strobe pulse on \overline{SS} for a slave device (see Figure 11-12).

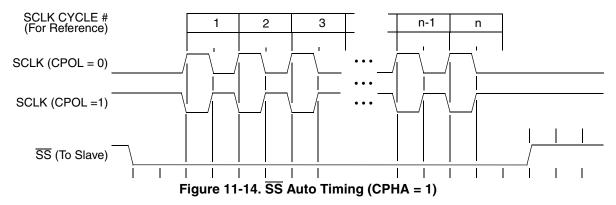


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If the SSB_AUTO bit is set in master mode, the SPI generates the initial falling edge and the final rising edge of \overline{SS} for a slave device. The \overline{SS} output has a falling edge one bit time before the first edge of SCLK (see Figure 11-14).



11.4.3 Transmission Data

The double-buffered data transmit register allows data to be queued and transmitted. For an SPI configured as a master, the queued data is transmitted immediately after the previous transaction has completed. The SPI transmitter empty flag (SPTE) indicates when the transmit data buffer is ready to accept new data. Write to the data transmit register only when the SPTE bit is high. Figure 11-15 shows the timing associated with doing back-to-back transactions with the SPI (SCLK has CPHA = 1; CPOL = 0).

NOTE

The following figure assumes 16-bit data lengths and the MSB shifted out first.

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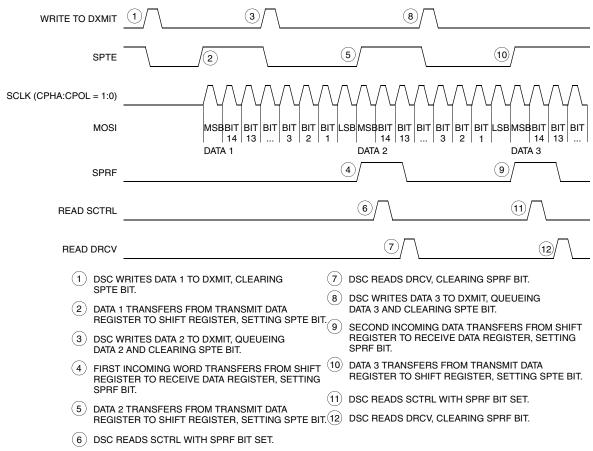


Figure 11-15. SPRF / SPTE DSC Interrupt Timing

The transmit data buffer allows back-to-back transactions without the slave precisely timing its writes between transactions, as occurs in a system with a single data buffer. Also, in slave mode, if no new data is written to SPI_DXMIT, the last value contained in SPI_DXMIT is retransmitted if the external master starts a new transaction.

For an idle master that has no data loaded into its transmit buffer and no word currently being transmitted, the SPTE is set again no more than two bus cycles after SPI_DXMIT is written. This allows the user to queue up at most a 32-bit value to send. For an SPI operating in slave mode, the load of the shift register is controlled by the external master, and back-to-back writes to the transmit data register are not possible. The SPTE bit indicates when the next write can occur.

11.4.4 Error Conditions

The following flags signal SPI error conditions:

- Overflow (OVRF) Failing to read the SPI_DRCV register before the next data word completes
 entering the shift register sets the OVRF bit. The new data word does not transfer to the receive
 data register, and the unread data word can still be read. OVRF is in the SPI status and control
 register.
- Mode fault error (MODF) The MODF bit indicates that the voltage on the slave select pin (\overline{SS}) is inconsistent with the mode of the SPI. MODF is in the SPI status and control register.

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11.4.4.1 Overflow Error

The overflow flag (OVRF) becomes set if the receive data register still has unread data from a previous transaction when the capture strobe of bit 1 of the next transaction occurs. The bit 1 capture strobe occurs in the middle of SCLK when the data length equals transaction data length – 1. If an overflow occurs, all data received after the overflow and before the OVRF bit is cleared does not transfer to the receive data register and does not set the SPI receiver full bit (SPRF). The unread data that is transferred to the receive data register before the overflow occurred can still be read. Therefore, an overflow error always indicates the loss of data. Clear the overflow flag by reading the SPI status and control register and then reading the SPI data register.

OVRF generates a receiver/error DSC interrupt request if the error interrupt enable bit (ERRIE) is also set. It is not possible to enable MODF or OVRF individually to generate a receiver/error DSC interrupt request. However, leaving MODFEN low prevents MODF from being set.

If the DSC SPRF interrupt is enabled and the OVRF interrupt is not, watch for an overflow condition. Figure 11-16 shows how it is possible to miss an overflow. The first part of the figure shows how it is possible to read the SPI_SCTRL and SPI_DRCV to clear the SPRF without problems. However, as illustrated by the second transaction example, the OVRF bit can be set in between the time that SPI_SCTRL and SPI_DRCV are read.

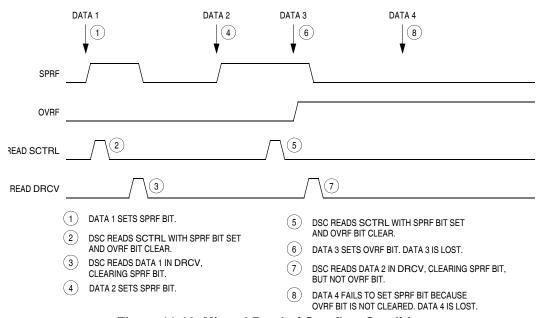


Figure 11-16. Missed Read of Overflow Condition

In this case, an overflow can easily be missed. Since no more SPRF interrupts can be generated until this OVRF is serviced, it is not obvious that data is being lost as more transactions are completed. To prevent this, either enable the OVRF interrupt or do another read of the SPI_SCTRL following the read of the SPI_DRCV. This ensures that the OVRF was not set before the SPRF was cleared and that future transactions can set the SPRF bit. Figure 11-17 illustrates this process. Generally, to avoid this second SPI_SCTRL read, enable the OVRF to the DSC by setting the ERRIE bit.

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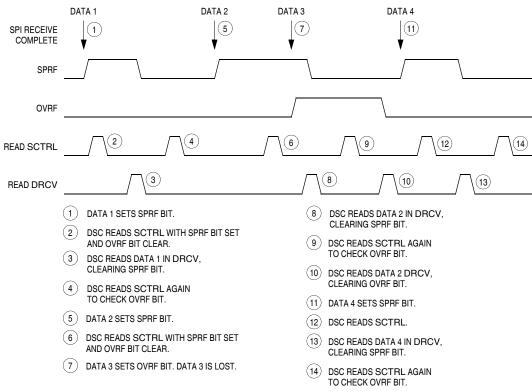


Figure 11-17. Clearing SPRF When OVRF Interrupt Is Not Enabled

11.4.4.2 Mode Fault Error

Setting the SPMSTR bit selects master mode and configures the SCLK and MOSI pins as outputs and the MISO pin as an input. Clearing SPMSTR selects slave mode and configures the SCLK and MOSI pins as inputs and the MISO pin as an output. The mode fault bit, MODF, becomes set any time the state of the slave select pin, \overline{SS} , is inconsistent with the mode selected by SPMSTR. To prevent SPI pin contention and damage to the DSC, a mode fault error occurs if:

- The SS pin of a slave SPI goes high during a transaction.
- The \overline{SS} pin of a master SPI goes low at any time.

For the MODF flag to be set, the mode fault error enable bit (MODFEN) must be set. Clearing the MODFEN bit does not clear the MODF flag but does prevent MODF from being set again after MODF is cleared.

MODF generates a receiver/error DSC interrupt request if the error interrupt enable bit (ERRIE) is also set. It is not possible to enable MODF or OVRF individually to generate a receiver/error DSC interrupt request. However, leaving MODFEN low prevents MODF from being set.

Master Mode Fault

In a master SPI with the mode fault enable bit (MODFEN) set, the mode fault flag (MODF) is set if \overline{SS} goes to logic zero. A mode fault in a master SPI causes the following events to occur:

• If ERRIE = 1, the SPI generates an SPI receiver/error DSC interrupt request.

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- The SPE bit is cleared (SPI disabled).
- The SPTE bit is set.
- The SPI state counter is cleared.

NOTE

Setting the MODF flag does not clear the SPMSTR bit. The SPMSTR bit has no function when SPE = 0. Reading SPMSTR when MODF = 1 shows the difference between a MODF occurring when the SPI is a master and when it is a slave.

When CPHA = 0, a MODF occurs if a slave is selected (\overline{SS} is at logic zero) and later unselected (\overline{SS} is at logic one) after the first bit of data has been received (SCLK is toggled at least once). This happens because \overline{SS} at logic zero indicates the start of the transaction (MISO driven out with the value of MSB) for CPHA = 0. When CPHA = 1, a slave can be selected and then later unselected with no transaction occurring. Therefore, MODF does not occur since a transaction was never begun.

In a master SPI, the MODF flag is not cleared until the \overline{SS} pin is at a logic one or the SPI is configured as a slave.

Slave Mode Fault

When configured as a slave (SPMSTR = 0), the MODF flag is set if the \overline{SS} goes high during a transaction. When CPHA = 0, a transaction begins when \overline{SS} goes low and ends after the incoming SCLK goes back to its idle level following the shift of the last data bit. When CPHA = 1, the transaction begins when the SCLK leaves its idle level and \overline{SS} is already low. The transaction continues until the SCLK returns to its idle level following the shift of the last data bit.

In a slave SPI (SPMSTR = 0), the MODF bit generates an SPI receiver/error DSC interrupt request if the ERRIE bit is set. The MODF bit does not clear the SPE bit or reset the SPI in any way. Software can abort the SPI transaction by clearing the SPE bit of the slave.

NOTE

A logic one voltage on the \overline{SS} pin of a slave SPI puts the MISO pin in a high impedance state. Also, the slave SPI ignores all incoming SCLK clocks, even if it was already in the middle of a transaction. A mode fault occurs if the \overline{SS} pin changes state during a transaction.

In a slave SPI, if the MODF flag is not cleared by writing a one to the MODF bit, the condition causing the mode fault still exists. In this case, the interrupt caused by the MODF flag can be cleared by disabling the ERRIE or MODFEN bits (if set) or by disabling the SPI. Disabling the SPI using the SPE bit causes a partial reset of the SPI and may cause the loss of a message currently being received or transmitted.

To clear the MODF flag, write a one to the MODF bit in the SPI_SCTRL register. The clearing mechanism must occur with no MODF condition existing or else the flag is not cleared.

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11.4.5 Resetting the SPI

Any system reset completely resets the SPI. Partial resets occur whenever the SPI enable bit (SPE) is low. Whenever SPE is low, the following occurs:

- 1. The SPTE flag is set.
- 2. Any slave mode transaction currently in progress is aborted.
- 3. Any master mode transaction currently in progress is continued to completion.
- 4. The SPI state counter is cleared, making it ready for a new complete transaction.
- 5. All the SPI port logic is disabled.

Items 4 and 5 occur after 2 when in slave mode, or after 3 when in master mode.

The following items are reset only by a system reset:

- The SPI_DXMIT and SPI_DRCV registers
- All control bits in the SPI_SCTRL register (MODFEN, ERRIE, SPR2, SPR1, and SPR0)
- The status flags SPRF, OVRF, and MODF

By not resetting the control bits when SPE is low, the user can clear SPE between transactions without having to set all control bits again when SPE is set back high for the next transaction.

By not resetting the SPRF, OVRF, and MODF flags, the user can still service these interrupts after the SPI has been disabled. The user can disable the SPI by writing 0 to the SPE bit. The SPI is also disabled by a mode fault occurring in an SPI that was configured as a master.

11.5 Interrupts

Four SPI status flags can be enabled to generate DSC interrupt requests.

Table 11-8. SPI Interrupts

Flag	Interrupt Enabled By	Description
SPTE (Transmitter Empty)	SPI Enable SPI Transmitter Interrupt Enable (SPTIE = 1, SPE = 1)	The SPI transmitter interrupt enable bit (SPTIE) enables the SPI transmitter empty (SPTE) flag or TFWM to generate transmitter interrupt requests, provided that the SPI is enabled (SPE = 1). The SPTE bit becomes set every time data transfers from the transmit data register (SPI_DXMIT) to the shift register and there is no more new data available in the Tx queue. The clearing mechanism for the SPTE flag is a write to the SPI_DXMIT.
SPRF (Receiver Full)	SPI Receiver Interrupt Enable (SPRIE = 1)	The SPI receiver interrupt enable bit (SPRIE) enables the SPI receiver full (SPRF) bit or RFWM to generate receiver interrupt requests. The SPRF is set every time data transfers from the shift register to the receive data register (SPI_DRCV) and there is no more room available in the RX queue to receive new data. The clearing mechanism for the SPRF flag is to read the SPI_DRCV.

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Table 11-8. SPI Interrupts (continued)

Flag	Interrupt Enabled By	Description
OVRF (Overflow)	SPI Receiver/Error Interrupt Enable (ERRIE = 1)	The error interrupt enable bit (ERRIE) enables both the MODF and OVRF bits to generate a receiver/error interrupt request.
MODF (Mode Fault)	SPI Receiver/Error Interrupt Enable MODF Enable (ERRIE = 1, MODFEN = 1)	The mode fault enable bit (MODEFEN) enables the mode fault (MODF) bit to generate the receiver/error interrupt request regardless of the state of the SPE bit. The mode fault enable bit (MODFEN) can prevent the MODF flag from being set, so that only the OVRF bit is enabled by the ERRIE bit to generate receiver/error DSC interrupt requests

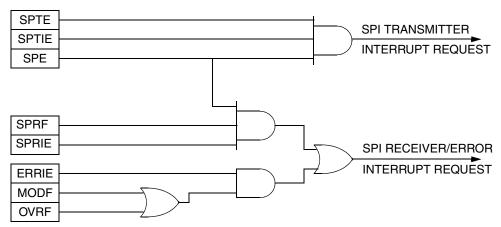


Figure 11-18. SPI Interrupt Request Generation

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Chapter 12 Interrupt Controller (WINTC)

12.1 Introduction

12.1.1 Overview

The interrupt controller (WINTC) module arbitrates the various interrupt requests (IRQs). The WINTC notifies the 56800E core when an interrupt of sufficient priority exists and tells the core where (at what address in p-memory space) to service the interrupt.

12.1.2 Features

The WINTC module design includes these distinctive features:

- All interrupt priority levels are initialized upon reset:
 - Level 3

Unmaskable level 3 interrupts include — illegal instruction, hardware stack overflow, misaligned data access, SWI3 instruction

Maskable level 3 interrupts include — EOnCE step counter, EOnCE breakpoint unit, EOnCE trace buffer

- Level 2 SWI2, USER4, USER5, USER6
- Level 1 SWI1, USER1, USER2, USER3
- Level 0 Low voltage detects, ADCs, PWM, timers, SPI, SCI, GPIO, I2C, RTC, EOnCE transmit register empty, EOnCE receive register full
- Level LP SWILP
- Up to three level 0 interrupts may be re-assigned as level 1 interrupts (USER1, USER2, USER3).
- Up to three level 0 interrupts may be re-assigned as level 2 interrupts (USER4, USER5, USER6). One of these can act as a fast interrupt. 1
- Performs edge detection on 56800E-generated interrupts.
- Clears 56800E interrupts upon receiving the hardware interrupt acknowledge from the core (software is not responsible for clearing 56800E-generated interrupts).
- Notification to SIM module to restart clocks out of wait and stop modes.
- Drives initial address on the address bus after reset.

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^{1.} Freescale recommends that customers refrain from assigning both normal interrupts and the fast interrupt to level 2 using this mechanism. If software requires a fast interrupt, assign the fast interrupt to priority level 2 and set the others to level 1. This gives the fast interrupt priority over the normal interrupts.

Interrupt Controller (WINTC)

- Interrupt enable/disable controls
 - The following interrupt sources are always enabled: illegal instruction, hardware stack overflow, misaligned data access, SWI3 instruction
 - EOnCE interrupts can be enabled/disabled via the INTC_ICSR register
 - All peripheral interrupts are enabled/disabled via the control registers for each peripheral

12.1.3 Modes of Operation

12.1.3.1 Functional Mode

The WINTC is in this mode by default.

12.1.3.2 Wait and Stop Mode Operation

From the WINTC perspective, wait and LPwait are identical. Similarly, stop and LPstop are identical. The interrupt asserted output of the WINTC is routed to the power management controller, which is responsible for bringing the part out of low power mode if an interrupt is received while the LPWUI control bit is set.

During wait, LPwait, stop, and LPstop modes, the system clocks and the core are turned off. The WINTC signals a pending IRQ to the system integration module (SIM) to restart the clocks and service the IRQ. An IRQ can wake the core only if the IRQ is enabled prior to entering the wait or stop mode.

12.1.4 Block Diagram

Figure 12-1 is the block diagram of the WINTC module. Talking points for the functional description (Section 12.2, Functional Description) are labeled with circled numbers for easy identification.

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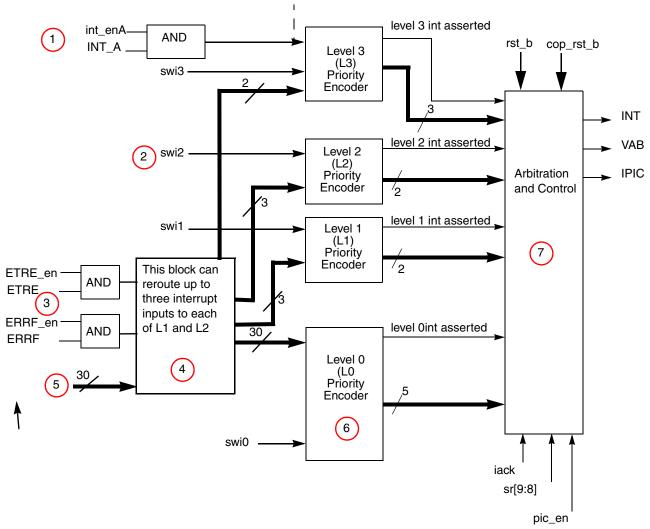


Figure 12-1. Interrupt Controller Block Diagram

12.2 Functional Description

12.2.1 Discussion of the Interrupt Controller Block Diagram

The 56800E DSC core is designed to handle interrupt levels LP, 0, 1, 2, and 3. One function of this module is to allocate each on-chip interrupt source to one of these levels. The numbered sections that follow correspond to the labels shown in Figure 12-1.

- 1. Level three interrupts are used for 56800E generated interrupts:
 - Always enabled are:
 - Illegal_op
 - Stack_overflow
 - Misaligned
 - Swi3

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Interrupt Controller (WINTC)

- Those that can be enabled/disabled are:
 - Eonce_step_counter
 - Eonce_breakpoint_unit_0
 - Eonce_trace_buffer

Enable controls for EOnCE interrupts are located in INTC_ICSR, and are described in Section 12.3.3.1, Control & Status Register (INTC_ICSR).

- 2. Software interrupts are generated within the 56800E core and are always enabled.
- 3. Abbreviations used here are:
 - ETRE = EOnCE transmit register empty
 - ERRF = EOnCE receiver register full

The enable bits for these interrupt sources are in the INTC_ICSR register.

- 4. This block redirects up to three interrupts to each of the priority level 1 and 2 decode blocks. These are selected from any of those interrupts preassigned to level zero, or to the EOnCE transmit register empty or receiver register full interrupts (which are initially assigned to level 3).
- 5. These interrupt sources are pre-assigned to level zero, but can be reassigned as discussed above.
 - LVD
 - OCCS
 - ADCs: adca, adcb
 - PWM
 - Comparators: cmp0, cmp1, cmp2
 - QP Timers: tmr0, tmr1
 - HFM
 - SPI: receiver, transmitter
 - SCI: receiver, transmitter
 - I2C
 - GPIO: gpioa, gpiob, gpioc, gpiod, gpioe, gpiof
 - RTC
- 6. The level priority encoders are responsible for arbitrating between multiply asserted interrupts and presenting the highest priority to the general arbiter. If multiple interrupts within a level are asserted, the interrupt with the lowest vector number in the vector table is asserted. Outputs of the block are a single bit signal indicating that an interrupt of that level is pending, plus a multibit signal that identifies which of the possible interrupts is being given priority at that level.
- 7. The arbitration and control block is responsible for arbitrating between the various levels of interrupts, as well as other control functions performed by the WINTC.

12.2.2 Overview

The interrupt controller is a slave on the IP bus. It contains registers that allow any peripheral interrupt to be mapped to any of interrupt levels 0, 1, and 2. Next, all of the interrupt requests of a given level are

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priority encoded to determine the lowest numerical value of the active interrupt requests for that level. Within a given priority level, the interrupt associated with the lowest vector number is the highest priority.

12.2.3 Normal Interrupt Handling

After the WINTC has determined that an interrupt is to be serviced and which interrupt has the highest priority, an interrupt vector address is generated. Normal interrupt handling concatenates the INTC_VBA and the vector number to determine the vector address. In this way an offset into the vector table is generated for each interrupt.

12.2.4 Interrupt Nesting

Interrupt exceptions may be nested to allow an IRQ of higher priority than the current exception to be serviced. The following tables define the nesting requirements for each priority level.

SR[9]	SR[8] Exceptions Permitted		Exceptions Masked
0	0	Priorities 0, 1, 2, 3	None
0	1	Priorities 1, 2, 3	Priority 0
1	0	Priorities 2,3	Priorities 0, 1
1	1	Priority 3	Priorities 0, 1, 2

Table 12-1. Interrupt Mask Bit Definition

Table 12-2. Interrupt Priority Encoding

IPIC_LEVEL[1:0]	Current Interrupt Priority Level	Required Nested Exception Priority
00	No interrupt or SWILP	Priorities 0, 1, 2, 3
01	Priority 0	Priorities 1, 2, 3
10	Priority 1	Priorities 2, 3
11	Priorities 2 or 3	Priority 3

12.2.5 Fast Interrupt Handling

Fast interrupts are described in section 9.3.2.2 of the *DSP56800E Reference Manual* (DSP56800ERM). The interrupt controller recognizes fast interrupts before the 56800E core does.

A fast interrupt is defined (to the WINTC) by:

- Assigning an interrupt source to USER6
- Locating the associated interrupt service routine at the USER6 vector, and ensuring that the first instruction in the ISR routine is not a JSR or BSR.

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Interrupt Controller (WINTC)

12.3 Memory Map and Registers

This module arbitrates, telling the processor when to react to an interrupt, and to which vector in the interrupt vector table program control should be transferred. Control registers for the WINTC are located in the IP bus space.

12.3.1 Interrupt Vector Table

Table 12-3 provides the reset and interrupt priority structure for this device, including on-chip peripherals.

All level 3 interrupts are serviced before level 2, which are serviced before level 1, and so on. For a selected priority level, the lowest vector number has the highest priority. All interrupt priorities are pre-assigned as shown in the table. Up to three level 0 interrupts can be re-assigned as level 1 interrupts: USER1, USER2, and USER3. When an interrupt is re-assigned, its original vector becomes inactive, and the ISR address must be placed in USER1/2/3 instead.

In a similar fashion, up to three level 0 interrupts can be re-assigned as level 2 interrupts: USER4, USER5, and USER6. If activated, USER6 can act as a fast interrupt. A fast interrupt is actually a level 2 interrupt in which the first instruction fetched from the vector table is not a JSR or BSR instruction. By placing the ISR routine for the assigned device directly at USER6, and configuring the ISR as a fast interrupt, the hardware automatically treats the interrupt as fast.

The location of the vector table is determined by the INTC_VBA. See Section 12.3.3.2, Vector Base Address Register (INTC_VBA), for the reset value of the INTC_VBA.

In some configurations, the reset address and COP reset address correspond to vector 0 and 1 of the interrupt vector table. In these instances, the first two locations in the vector table must contain branch or jmp instructions. All other entries must contain jsr instructions.

Vector **USER Priority** Vector Module Base Source **Enable Description Encoding** No. Level **Address** SIM N/A P:0x00 Reserved for Reset overlay² COP N/A P:0x02 Reserved for COP Reset overlay Core 2 N/A 3 P:0x04 56800E Unmaskable Illegal Instruction non-recoverable N/A 3 3 P:0x06 Unmaskable **HW Stack Overflow** Core

Table 12-3. Interrupt Vector Table Contents¹

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Table 12-3. Interrupt Vector Table Contents¹ (continued)

Module	Vector No.	USER Encoding	Priority Level	Vector Base Address	Source	Enable	Description
Core	4	N/A	3	P:0x08	56800E	Unmaskable	Misaligned Long Word Access
Core	5	N/A	3	P:0x0A	automatically cleared by core after the interrupt	INTC_ICSR [STPCNT]	EOnCE Step Counter
Core	6	N/A	3	P:0x0C	has been accepted	INTC_ICSR[BK PT]	EOnCE Breakpoint Unit
Core	7	N/A	3	P:0x0E		INTC_ICSR[TR BUF]	EOnCE Trace Buffer
Core	8	0x08	3	P:0x10		INTC_ICSR[ET RE]	EOnCE Transmit Register Empty
Core	9	0x09	3	P:0x12		INTC_ICSR[ER RF]	EOnCE Receive Register Full
PMC	10	0x0A	0	P:0x14	PMC_SCR [OORF]	PMC_SCR [OORIE]	Out of Regulation
					PMC_SCR [LVDF]	PMC_SCR [LVDIE]	Low Voltage Detect
occs	11	0x0B	0	P:0x16	OCCS_STAT [LOLI1]	OCCS_CTRL [PLLIE1]	PLL / OCCS Loss of Lock1
					OCCS_STAT [LOLI0]	OCCS_CTRL [PLLIE0]	PLL / OCCS Loss of Lock0
					OCCS_STAT [LOCI]	OCCS_CTRL [LOCIE]	PLL / OCCS Loss of Reference Clock
ADCA	12	0x0C	0	P:0x18	ADCSC1A [COCO]	ADCSC1A [AIEN]	ADCA Conversion Complete
ADCB	13	0x0D	0	P:0x1A	ADCSC1B [COCO]	ADCSC1B [AIEN]	ADCB Conversion Complete
PWM	14	0x0E	0	P:0x1C	PWM_CTRL [PWMF]	PWM_CTRL [PWMRIE]	Reload PWM
					PWM_FLTAK [FFLAG[3:0]]	PWM_FCTRL [FIE[3:0]]	PWM Fault[3:0]
CMP0	15	0x0F	0	P:0x1E	CMP0_SR [CFR]	CMP0_CR1 [IER]	Comparator 0 Comparator Flag Rising
					CMP0_SR [CFF]	CMP0_CR1 [IEF]	Comparator 0 Comparator Flag Falling
CMP1	16	0x10	0	P:0x20	CMP1_SR [CFR]	CMP1_CR1 [IER]	Comparator 1 Comparator Flag Rising
					CMP1_SR [CFF]	CMP1_CR1 [IEF]	Comparator 1 Comparator Flag Falling

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Table 12-3. Interrupt Vector Table Contents¹ (continued)

Module	Vector No.	USER Encoding	Priority Level	Vector Base Address	Source	Enable	Description
CMP2	17	0x11	0	P:0x22	CMP2_SR [CFR]	CMP2_CR1 [IER]	Comparator 2 Comparator Flag Rising
					CMP2_SR [CFF]	CMP2_CR1 [IEF]	Comparator 2 Comparator Flag Falling
HFM	18	0x12	0	P:0x24	FM_USTAT [ACCERR]	FM_CNFG [AEIE]	HFM Access Error Interrupt
					FM_USTAT [CCIF]	FM_CNFG [CCIE]	HFM Command Complete
					FM_USTAT [CBEIF]	FM_CNFG [CBEIE]	HFM Command, Data, and Address Buffers Empty
SPI	19	0x13	0	P:0x26	SPI_SCTRL [SPRF]	SPI_SCTRL [SPRIE]	SPI Receiver Full Interrupt
					SPI_SCTRL [OVRF]	SPI_SCTRL [ERRIE]	SPI Receiver Overflow Interrupt
					SPI_SCTRL [MODF]		SPI Receiver Mode Fault Interrupt
	20	0x14	0	P:0x28	SPI_SCTRL [SPTE]	SPI_SCTRL [SPTIE]	SPI Transmitter Empty
SCI	21	0x15	0	P:0x2A	SCI_STAT [TDRE]	SCI_CTRL1 [TEIE]	SCI Transmitter Empty
					SCI_STAT [TIDLE]	SCI_CTRL1 [TIIE]	SCI Transmitter Idle
	22	0x16	0	P:0x2C	SCI_STAT [FE]	SCI_CTRL1	SCI Receiver Error (Framing error)
					SCI_STAT [PE]	[REIE]	SCI Receiver Error (Parity error)
					SCI_STAT [NF]		SCI Receiver Error (Noise Flag)
					SCI_STAT [OR]		SCI Receiver Error (Overrun Flag)
					SCI_STAT [LSE]		SCI Receiver Error (LIN Sync Error)
					[RDRF] [OR]	SCI_CTRL1 [RFIE]	SCI Receiver Full/Overrun

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Table 12-3. Interrupt Vector Table Contents¹ (continued)

Module	Vector No.	USER Encoding	Priority Level	Vector Base Address	Source	Enable	Description
I2C	23	0x17	0	P:0x2E	I2C_SR [TCF,IICIF]	I2C_CR1 [IICIE]	I2C Complete 1-byte Transfer
					I2C_SR [IIAS,IICIF]		I2C Match of Received Calling Addr
					I2C_SR [ARBL, IICIF]		I2C Arbitration Lost
					I2C_SR2[STIF]	I2C_CR2 [SMBEN] & I2C_CR1 [IICIE]	I2C SMBus Timeout
PIT	24	0x18	0	P:0x30	PIT_CTRL [PRF]	PIT_CTRL [PRIE]	Programmable Interval Timer
Timer 0	25	0x19	0	P:0x32	TMR0_SCTRL [TCF]	TMR0_SCTRL [TCFIE]	Timer Channel 0 Compare
					TMR0_SCTRL [TOF]	TMR0_SCTRL [TOFIE]	Timer Channel 0 Overflow
					TMR0_SCTRL [IEF]	TMR0_SCTRL [IEFIE]	Timer Channel 0 Input Edge
					TMR0_CSCTRL [TCF1]	TMR0_CSCTR L [TCF1EN]	Timer Channel 0 Compare 1
					TMR0_CSCTRL [TCF2]	TMR0_CSCTR L [TCF2EN]	Timer Channel 0 Compare 2
Timer 1	26	0x1A	0	P:0x34	TMR1_SCTRL [TCF]	TMR1_SCTRL [TCFIE]	Timer Channel 1 Compare
					TMR1_SCTRL [TOF]	TMR1_SCTRL [TOFIE]	Timer Channel 1 Overflow
					TMR1_SCTRL [IEF]	TMR1_SCTRL [IEFIE]	Timer Channel 1 Input Edge
					TMR1_CSCTRL [TCF1]	TMR1_CSCTR L [TCF1EN]	Timer Channel 1 Compare 1
					TMR1_CSCTRL [TCF2]	TMR1_CSCTR L [TCF2EN]	Timer Channel 1 Compare 2
GPIO A	27	0x1B	0	P:0x36	GPIO_A_IESR	GPIO_A_IENR	GPIO A
GPIO B	28	0x1C	0	P:0x38	GPIO_B_IESR	GPIO_B_IENR	GPIO B
GPIO C	29	0x1D	0	P:0x3A	GPIO_C_IESR	GPIO_C_IENR	GPIO C
GPIO D	30	0x1E	0	P:0x3C	GPIO_D_IESR	GPIO_D_IENR	GPIO D
GPIO E	31	0x1F	0	P:0x3E	GPIO_E_IESR	GPIO_E_IENR	GPIO E
GPIO F	32	0x20	0	P:0x40	GPIO_F_IESR	GPIO_F_IENR	GPIO F
RTC	33	0x21	0	P:0x42	RTCSC[RTIF]	RTCSC[RTIE]	Real Time Counter

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Interrupt Controller (WINTC)

Table 12-3. Interrupt Vector Table Contents¹ (continued)

Module	Vector No.	USER Encoding	Priority Level	Vector Base Address	Source	Enable	Description
RESERV ED	34-39	0x22 to 0x27	0	P:0x44 to P:0x4E	RESERVED	RESERVED	RESERVED
Core	40	N/A	0	P:0x50	Software	56800E CCPL	SW interrupt 0
Core	41	N/A	1	P:0x52	Interrupt		SW interrupt 1
Core	42	N/A	2	P:0x54			SW interrupt 2
Core	43	N/A	3	P:0x56		Unmaskable	SW interrupt 3
SWILP	44	N/A	-1	P:0x58		56800E CCPL	SW interrupt Low Priority
USER1	45	N/A	1	P:0x5A	Programmable	USER1 ³	User programmable L1 Interrupt
USER2	46	N/A	1	P:0x5C		USER2 ³	User programmable L1 Interrupt
USER3	47	N/A	1	P:0x5E		USER3 ³	User programmable L1 Interrupt
USER4	48	N/A	2	P:0x60		USER4 ³	User programmable L2 Interrupt
USER5	49	N/A	2	P:0x62		USER5 ³	User programmable L2 Interrupt
USER6	50	N/A	2	P:0x64		USER6 ³	User programmable L2 Interrupt MAY BE FAST INTERRUPT

Two words are allocated for each entry in the vector table. This does not allow the full address range to be referenced from the vector table; providing only 19 bits of address.

12.3.2 Module Memory Map

In the table above, the user encoding is simply the hex value of the unmapped vector number.

All WINTC registers are memory mapped on the IP bus. See the Memory Map chapter of this document for the base address of this module.

Table 12-4. Module Memory Map

Address	Reg Name	Description
Base + 0	INTC_ICSR	Interrupt Control and Status Register
Base + 1	INTC_VBA	Vector Base Address Register
Base + 2	INTC_IAR0	Interrupt Assignment Register 0
Base + 3	INTC_IAR1	Interrupt Assignment Register 1
Base + 4	INTC_IAR2	Interrupt Assignment Register 2

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² If the INTC_VBA is set to 0x0000 (for MC56F8006) or 0x0800 (for MC56F8002) the first two locations of the vector table overlay the chip reset addresses since the reset address would match the base of this vector table.

This interrupt is not enabled unless the corresponding USERN field is programmed. In which case, the controls for the programmed function take precedence.

12.3.3 Register Descriptions

12.3.3.1 Control & Status Register (INTC_ICSR)

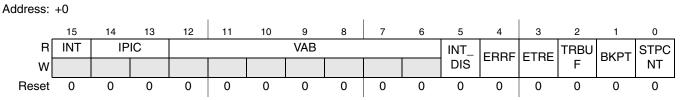


Figure 12-2. Control and Status Register (INTC_ICSR)

Figure 12-3. Control and Status Register (INTC_ICSR) Descriptions

Ciald			December				
Field	Description						
15 INT	Interrupt. This bit reflects the state of the interrupt to the core. 1 = An interrupt is being sent to the core 0 = No interrupt is being sent to the core						
14 IPIC	the priority level needed	l for a ne	s reflect the new interrupt priority level bits being sent to the c w IRQ to interrupt the current interrupt being sent to the Co to a new interrupt service routine.				
		Value	Meaning				
		00	Required nested exception priority levels are 0, 1, 2, or 3.				
		01	Required nested exception priority levels are 1, 2, or 3.				
		10	Required nested exception priority levels are 2 or3.				
		11	Required nested exception priority level is 3.				
12–6 VAB			bits [7:1] of the vector address bus used at the time the las SC core jumps to a new interrupt service routine.	t IRQ was taken. This			
5 INT_DIS	Interrupt disable. This b 1 = All interrupts disable 0 = Normal operation. (ed.	the user to disable all interrupts that can be disabled.				
4 ERRF	EOnCE Receive Regist	er Full In	terrupt Enable				
3 ETRE	EOnCE Transmit Regist	er Empt	y Interrupt Enable				
2 TRBUF	EOnCE Trace Buffer Interrupt Enable						
1 BKPT	EOnCE Breakpoint Unit 0 Interrupt Enable						
0 STPCNT	EOnCE Step Counter Invalues are: 1 = Interrupt(s) Enabled 0 = Interrupt(s) Disabled	· 	Enable. These fields are used to enable/disable interrupts for	certain IRQs. Possible			

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12.3.3.2 Vector Base Address Register (INTC_VBA)

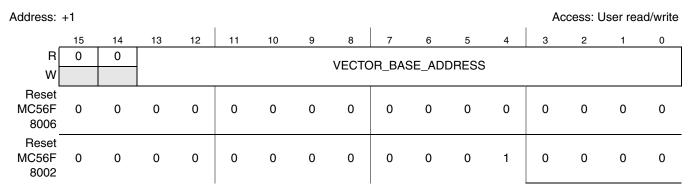


Figure 12-4. Vector Base Address Register (INTC_VBA)

Table 12-5. Abbreviation Field Descriptions

Field	Description
15, 14	Reserved.
	Interrupt Vector Base Address. The value in this register is used as the upper 14 bits of the interrupt vector VAB[20:0]. The lower seven bits are determined based on the highest priority interrupt and are then appended onto INTC_VBA before presenting the full VAB to the core. Table 12-6 shows two different reset values for INTC_VBA, depending on part number.

Table 12-6. INTC_VBA Reset Values and Associated Parametrics by Part Number

Part Number	Program Flash Size	Boot Address	Reset value of INTC_VBA
MC56F8006	16 KB	0x00 0000	0x0000
MC56F8002	12 KB	0x00 0800	0x0010

12.3.3.3 Interrupt Assignment Registers (INTC_IAR0, INTC_IAR1, INTC_IAR2)

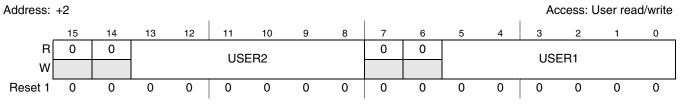


Figure 12-5. Interrupt Assignment Register 0 (INTC_IAR0)

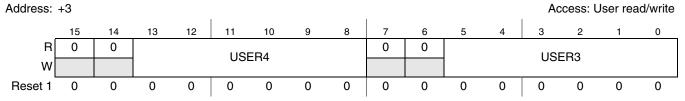


Figure 12-6. Interrupt Assignment Register 1 (INTC_IAR1)

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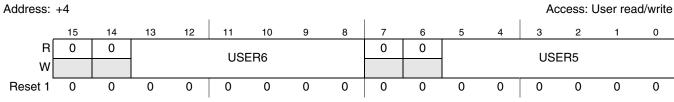


Figure 12-7. Interrupt Assignment Register 2 (INTC_IAR2)

These three registers are used to define the interrupt sources to be used for the USER1–3 (level 1) and USER4–6 (level 2) interrupts. Note that USER6 can be used to implement a level 2 fast interrupt. Possible values for USER1 through USER6 fields are:

0x00 = NOT ASSIGNED

0x0A through 0x27 (inclusive) = USER encoding value (from the third column of Table 12-3) for the interrupt source to be remapped to the USER-assigned interrupt in question. The user encoding is simply the hex value of the unmapped vector number for a given interrupt source.

all other values = RESERVED.

12.4 Resets

This module consumes the core asynchronous reset. It also receives a control signal from the SIM that indicates whether the reset was the result of a COP timeout. WINTC registers are reset to their default values on any reset event. The WINTC directs the processor to vector 0 or vector 1 depending upon whether the reset resulted from a COP. See Section 12.3.3.2, "Vector Base Address Register (INTC_VBA)," for more information about reset sources.

The WINTC provides the core with a reset vector address on the VAB pins whenever RST_B is asserted from the SIM. The reset vector is presented until the first rising clock edge after RST_B is released.

After reset all of the WINTC registers are in their default states. This means that all interrupts are disabled except the core IRQs with fixed priorities (illegal instruction, SW interrupt 3, HW stack overflow, misaligned long word access, SW interrupt 2, SW interrupt 1, SW interrupt 0, and SW interrupt LP), which are enabled at their fixed priority levels.

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Chapter 13 On-Chip Clock Synthesis (OCCS)

13.1 Introduction

13.1.1 Overview

This module provides the 2X system clock frequency to the system integration module (SIM), which uses it to generate the various chip clocks.

The on-chip clock synthesis module allows product design using an internal relaxation oscillator to run the device at user selectable frequencies up to 32 MHz bus clock.

13.1.2 Features

The on-chip clock synthesis (OCCS) module interfaces to the oscillator and PLL. This device has more options for clock generation than do the other members of the MC56F8000 family. OCCS clock sources include:

- On-Chip Relaxation Oscillator (ROSC). This module nominally generates an 8 MHz clock signal. It is also capable of operating at 400 kHz when the device is in low power mode.
- VLP Crystal Oscillator (COSC). This very low power module is designed for use with a 32 kHz crystal (low range mode), or a crystal or resonator in the 1 to 16 MHz range (high range mode). When used with the on-chip PLL of this device, the maximum crystal/resonator frequency is 10 MHz.
- Off chip external clock source

Additional OCCS module features are as follows:

- Ability to power down internal relaxation oscillator
- Ability to put the internal relaxation oscillator into a 400 kHz standby mode
- Ability to power down external oscillator
- 8-bit postscaler operates on either the PLL output or, in the case where the PLL is not in use, one of the oscillators or the external clock source
- Ability to power down the internal PLL
- Provides 2X master clock frequency and 3X high-speed peripheral clock signals.¹
- Can be driven from an external clock source
- Support for partial power down mode. Control signals to the relaxation oscillator and crystal oscillator are latched / kept safe during partial power down mode of the DSC.

^{1.} The PLL must be used for generation of high-speed peripheral clocks.

On-Chip Clock Synthesis (OCCS)

The clock generation module provides the programming interface for the PLL and internal relaxation oscillator and crystal oscillator.

Key features of the very-low-power crystal oscillator module are:

- Supports 32 kHz crystals (low range mode)
- Supports 1–16 MHz crystals and resonators (high range mode)
- Automatic gain control (AGC) to optimize power consumption in both frequency ranges using low-power mode
- High gain option in both frequency ranges
- Voltage and frequency filtering to guarantee clock frequency and stability

13.2 Modes of Operation

An internal relaxation oscillator, crystal oscillator, or external frequency source can be used to provide a reference clock (sys_clk_x2) to the SIM.

The 2X system clock source output from the OCCS can be described by one of the following equations:

2X system frequency = oscillator frequency / (postscaler)

2X system frequency = (oscillator frequency X 8) / (postscaler)

where:

```
postscaler = 1, 2, 4, 8, 16, 32, 64, 128, or 256 = PLL output divider
```

The SIM is responsible for further dividing these frequencies by two, which lends a 50% duty cycle in the system clock output.

The on-chip clock synthesis module of this device has the following registers:

- PLL control register (OCCS_CTRL)
- Divide-by register (OCCS_DIVBY)
- OCCS status register (OCCS_STAT)
- Oscillator control register (OCCS_OCTRL)
- External clock check reference register (OCCS_CLKCHKR)
- External clock check target register (OCCS_CLKCHKT)
- Protection register (OCCS PROT)

For more information on these registers, refer to Section 13.6, "Register Descriptions."

13.2.1 Internal Clock Source

The internal relaxation oscillator is optimized for accuracy and programmability while providing several different power saving configurations to accommodate different operating conditions. The internal oscillator has very little variability with temperature and voltage, but it does vary as much as $\pm 20\%$ as a function of wafer fabrication process. It also is very fast in reaching a stable frequency (well under 1 μ s).

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Under typical conditions, the circuit provides an 8 MHz clock at the center of its tuning range. The tuning range is controlled by 10 bits. To optimize power, the architecture supports a standby state and a power-down state. During the reset sequence, the internal relaxation oscillator is enabled by default. Application code can then switch to the external source or crystal oscillator and power down the internal relaxation oscillator if desired.

13.2.2 Crystal (or Ceramic Resonator) Oscillator

The internal crystal oscillator circuit is designed to interface with a parallel-resonant crystal resonator in the frequency range, specified for the external crystal, of either 32 kHz or 1–16 MHz. A ceramic resonator can be substituted for the 1–16 MHz range. When used to supply a source to the internal PLL, the crystal/resonator must be in the 4 MHz to 8 MHz range. Oscillator circuits are shown in Figure 13-1, Figure 13-2, and Figure 13-3. Follow the crystal supplier's recommendations when selecting a crystal, because crystal parameters determine the component values required to provide maximum stability and reliable start-up. The load capacitance values used in the oscillator circuit design should include all stray layout capacitances. The crystal and associated components should be mounted as near as possible to the EXTAL and XTAL pins to minimize output distortion and minimize startup stabilization time.

When using low-frequency, low-power mode, the only external component is the crystal itself. In the other oscillator modes, load capacitors (C_x, C_y) and feedback resistor (R_F) are required. In addition, a series resistor (R_S) may be used in high-gain modes.

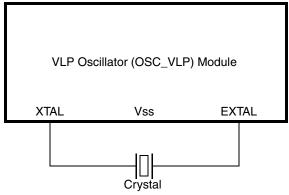


Figure 13-1. Crystal Connections — Low-Frequency, Low-Power Mode

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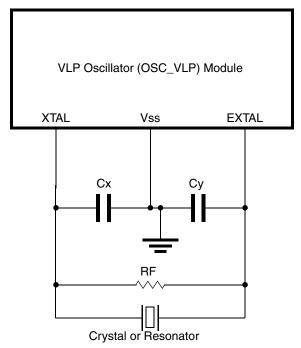


Figure 13-2. Crystal/Resonator Connections — High-Frequency, Low-Power Mode

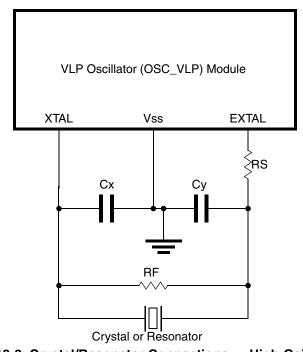


Figure 13-3. Crystal/Resonator Connections — High-Gain Modes

13.2.3 External Clock Source — Crystal Oscillator Option

Figure 13-4 illustrates how to connect an external clock circuit with an external oscillator module source using XTAL as the input. Such a module could have a lower voltage than the IO voltage used on the GPIO pins.

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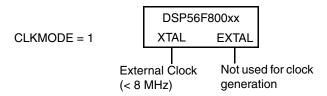


Figure 13-4. Connecting an External Clock Signal Using XTAL

13.2.4 External Clock Source — GPIO

The recommended method of connecting an external clock is given in Figure 13-5. In this case the clock would have a voltage magnitude of V_{DD} , as would be typical of a GPIO signal. See the data sheet for which GPIO can support this function.



Figure 13-5. Connecting an External Clock Signal Using GPIO

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13.3 Block Diagram

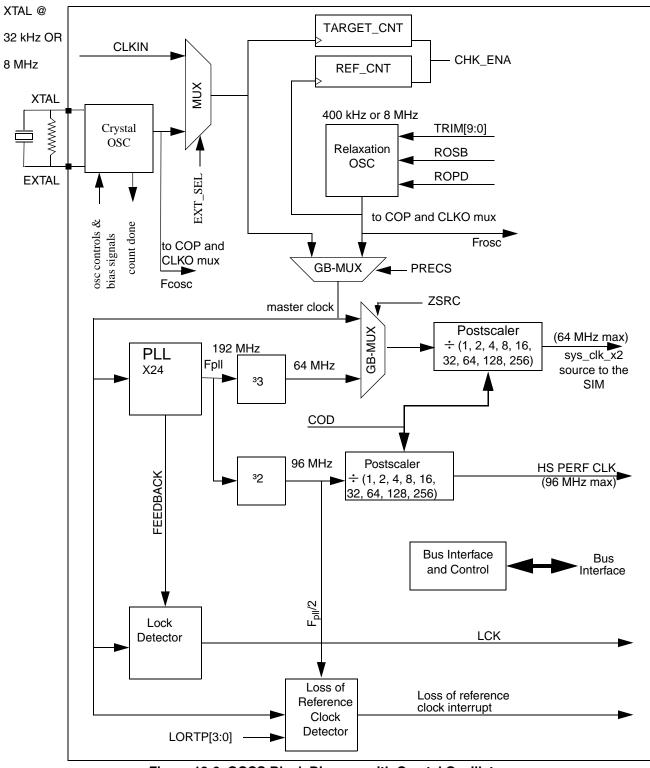


Figure 13-6. OCCS Block Diagram with Crystal Oscillator

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Figure 13-6 shows the block diagram of the clock generation module. This block differs from that found on the MC56F802x/3x series of devices in the following ways:

- The postscaler divisor now can be as large as 256
- The postscaler can now also be used to divide down an external clock or one of the oscillator outputs for use as sys_clk_x2.
- The crystal oscillator now has the option to run with a 32 kHz watch crystal.

13.4 Pin Descriptions

13.4.1 External Reference

The relaxation oscillator is always included on chip and the reset mode is to use this as the clock source for the chip. The customer then has the option of switching to an external clock reference if desired.

13.4.2 Oscillator Inputs (XTAL, EXTAL)

The oscillator inputs can be used to connect an external crystal, ceramic resonator, or to directly drive the chip with an external clock source, thus bypassing the internal crystal oscillator circuit. Design considerations for the external clock mode of operation are discussed in Section 13.2, "Modes of Operation."

13.4.3 CLKO

This family of DSCs has a CLKO pin that can be programmed to bring out any of a number of internal clock signals to this device pin. CLKO functionality is selected in the system integration module as (SIM). It is mentioned here because a number of OCCS clocks are made available for use on that pin.

CAUTION

There is no defined phase or registered clock domain relationship between the signals present on CLKO and their internal counterparts. CLKO is useful for observing internal frequencies, but cannot be used to sequence data onto or off of the chip.

13.5 Memory Map and Registers

13.5.1 Module Memory Map

The address of a peripheral module register is the sum of its base address and its address offset. The base address is defined at the SOC system level and the address offset is defined at the SOC peripheral module level.

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Address	Reg Name	Description
OCCS_BASE + 0x0000	OCCS_CTRL	PLL control register
OCCS_BASE + 0x0001	OCCS_DIVBY	Divide-by register
OCCS_BASE + 0x0002	OCCS_STAT	OCCS status register
OCCS_BASE + 0x0003	Reserved	Reserved or blank
OCCS_BASE + 0x0004	OCCS_OCTRL	Oscillator control register
OCCS_BASE + 0x0005	OCCS_CLKCHKR	External clock check reference register
OCCS_BASE + 0x0006	OCCS_CLKCHKT	External clock check target register
OCCS_BASE + 0x0007	OCCS_PROT	Protection register

13.6 Register Descriptions

13.6.1 PLL Control Register (OCCS_CTRL)

Address: OCCS_BASE + 0x0000 = Access: User read/write 0XF120

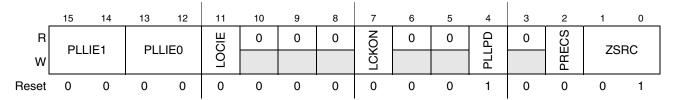


Figure 13-7. PLL Control Register (OCCS_CTRL)

Table 13-2. PLL Control Register (OCCS_CTRL) Descriptions

Field	Description
PLLIE1 [15:14]	PLL Interrupt Enable 1. An optional interrupt can be generated when the PLL lock status bit (LCK1) in the OCCS status register (OCCS_STAT) changes: 11 Enable interrupt on any edge change of LCK1 10 Enable interrupt on falling edge of LCK1 01 Enable interrupt on any rising edge of LCK1 00 Disable interrupt
PLLIE0 [13:12]	PLL Interrupt Enable 0. An optional interrupt can be generated if the PLL lock status bit (LCK0) in the OCCS status register (OCCS_STAT) changes: 11 = Enable interrupt on any edge change of LCK0 10 = Enable interrupt on falling edge of LCK0 01 = Enable interrupt on any rising edge of LCK0 00 = Disable interrupt

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Table 13-2. PLL Control Register (OCCS_CTRL) Descriptions

Field	Description
LOCIE [11]	Loss of Reference Clock Interrupt Enable. The loss of reference clock circuit monitors the output of the on-chip oscillator circuit. In the event of loss of reference clock, an optional interrupt can be generated. An optional interrupt can be generated if the oscillator circuit output clock is lost. Interrupt disabled Interrupt enabled
Reserved [10:8]	These reserved bits are read/write as zero, ensuring future compatibility.
LCKON [7]	Lock Detector On. 0 Lock detector disabled 1 Lock detector enabled
Reserved [6:5]	These reserved bits cannot be modified and are read/write as zero, ensuring future compatibility.
PLLPD [4]	PLL Power Down. The PLL can be turned off by setting the PLLPD bit. There is a four IPbus clock delay from changing the bit to signaling the PLL. When the PLL is powered down, the gear shifting logic automatically switches to ZSRC[1:0] = 01b to prevent loss of reference clock to the core. 0 PLL enabled 1 PLL powered down
Reserved [3]	This is a reserved bit and cannot be modified. It is read as zero.
PRECS [2]	Prescaler Clock Select. This bit is used to select between (the external clock source or oscillator) and the internal relaxation oscillator. O Relaxation oscillator selected (reset value). External reference selected. Note: This bit should not be set unless the external reference is enabled in the GPIO/SIM/KTR.
ZSRC [1:0]	CLOCK Source. The CLOCK source determines the sys_clk_x2 source to the SIM module, which generates divided down versions of this signal for use by memories and IP bus. ZSRC is automatically set to 01b during STOP_MODE, or if PLLPD is set to prevent loss of reference clock to the core. For this device, ZSRC may have the following values (see ZSRCS[1:0] — CLOCK source status - bits 1–0). 00 Reserved 01 master clock 10 PLL output 11 Reserved

13.6.2 PLL Divide-By Register (OCCS_DIVBY)

Address: OCCS_BASE + 0x001 Access: User read/write R LORTP COD Reset

Figure 13-8. PLL Divide-By Register (OCCS_DIVBY)

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Table 13-3. PLL Divide-By Register (OCCS_DIVBY) Descriptions

Field	Description				
LORTP [15:12]	Loss of Reference Clock Trip Point. These bits control the amount of time required for the loss of reference clock interrupt to be generated. this failure detection time is ([LORTP + 1] × 10) × (reference clock period)/(PLL Multiplier/2). The PLL Multiplier is fixed at 24.				
COD [11:8]	Clock Output Divide or Postscaler. The PLL output clock can be divided down by a 4-bit postscaler. The input of the postscaler is a selectable clock source for the DSP core as determined by the ZSRC[1:0] in the OCCS_CTRL register. The output of the postscaler is guaranteed to be glitch free, even when COD has been changed. This device supports dynamic power management via on the fly changes to the COD field.				
		COD[3:0]	Clock Output Divider		
		0000	Divide by 1		
		0001	Divide by 2		
		0010	Divide by 4		
		0011	Divide by 8		
		0100	Divide by 16		
		0101	Divide by 32		
		0110	Divide by 64		
		0111	Divide by 128		
		1xxx	Divide by 256		
	Note: This field has been expanded by one bit from that found on prior devices. Encoding is slightly different.				
Reserved [7:0]	These are reserved bits and cannot be modified. They are read as zero.				

13.6.3 OCCS Status Register (OCCS_STAT)

A PLL interrupt is generated if any of the LOLI or LOCI bits are set and the respective interrupt enable is set in the OCCS_CTRL register.

Address: OCCS_BASE + 0x0002 Access: User read/write

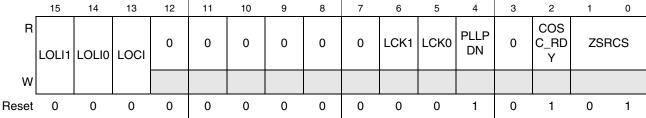


Figure 13-9. OCCS Status Register (OCCS_STAT)

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Table 13-4. OCCS Status Register (OCCS_STAT) Descriptions

Field	Description
LOLI1 [15]	LOLI1 shows the status of the lock detector state from LCK1 circuit. This bit is cleared by writing a one to LOLI1. 1 = PLL not locked 0 = PLL locked This bit is not set (by the hardware) if the corresponding OCCS_CTRL PLLIE1 bit is cleared (set to zero).
LOLI0 [14]	LOLI0 shows the status of the lock detector state from LCK0 circuit. This bit is cleared by writing a one to LOLI0. 1 = PLL not locked 0 = PLL locked This bit is not set (by the hardware) if the corresponding OCCS_CTRL PLLIE0 bit is cleared (set to zero).
LOCI [13]	Loss of Reference Clock Interrupt. LOCI shows the status of the reference clock detection circuit. This bit is cleared by writing a one to LOCI. 1 = Lost of oscillator clock detected 0 = Oscillator clock normal
Reserved [12:7]	These reserved bits cannot be modified. They are read as zero.
LCK1 [6]	Loss of Lock 1. 1 = PLL is locked (fine) 0 = PLL is unlocked
LCK0 [5]	Loss of Lock 0. 1 = PLL is locked (coarse) 0 = PLL is unlocked
PLLPDN [4]	PLL Power Down. PLL power down status is delayed by four IPbus clocks from the PLLPD bit in the OCCS_CTRL register. 1= PLL powered down 0 = PLL not powered down
Reserved [3]	These reserved bits cannot be modified. They are read as zero.
COSC_RDY [2]	Oscillator Ready. Indicates that the crystal oscillator has completed its power up sequence and is stable. 1 = The crystal oscillator is powered, enabled and ready for use 0 = The crystal oscillator is not ready for use Note: See CNT_DONE_4096 signal in the OSC_VLP_BUG
ZSRCS [1:0]	CLOCK Source Status. ZSRCS indicates the current sys_clk_x2 clock source. Because the synchronizing circuit switches the system clock source, ZSRCS takes more than one IPBUS clock to indicate the new selection. 00 = Synchronizing in progress 01 = master clock 10 = Postscaler output 11 = Synchronizing in progress

13.6.4 Oscillator Control Register (OCCS_OSCTL)

This register controls aspects of both the internal relaxation oscillator and the crystal/resonator oscillator, as shown in Figure 13-10.

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Address: OCCS_BASE + 0x0004

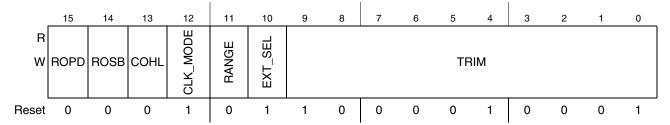


Figure 13-10. Oscillator Control (OCCS_OCTRL) with Crystal Oscillator

Table 13-5. Oscillator Control (OCCS_OCTRL) with Crystal Oscillator Descriptions

Field	Description
ROPD [15]	Relaxation Oscillator Power Down. This bit is used to power down the relaxation oscillator. The user may power down the relaxation oscillator if the external reference is being used. To prevent loss of clock to the core or the PLL, this bit should be asserted only if the clock source has been changed to the external source by setting the PRECS bit in OCCS_CTRL. 1 = Relaxation oscillator powered down 0 = Relaxation oscillator enabled
ROSB [14]	Relaxation Oscillator Standby. This bit is used to control the power usage and gross frequency of the relaxation oscillator. It is reset to the more accurate but higher power state. 1 = Normal mode. The relaxation oscillator output frequency is 8 MHz. 0 = Standby mode. The relaxation oscillator output frequency is reduced to 400 kHz (±50%). The PLL should be disabled in this mode and master clock should be selected as the output clock.
COHL [13]	Crystal Oscillator High/Low Power Level. This bit is used to control the power usage of the crystal oscillator. It is reset to the high power state, which allows either a crystal or resonator to be used. 1 = Low power mode. This is the desired mode when a crystal is used. 0 = High power mode. This mode is required when a resonator is used.
CLK_MODE [12]	Crystal Oscillator Clock Mode. This bit is used to control the crystal/resonator clock selection. When direct clock mode is selected, this bit also turns off the crystal oscillator for power savings. 1 = Direct clock mode. Setting this bit shuts down the crystal oscillator and allows an external clock source on the XTAL pin of the device to drive the clock input to the chip directly. 0 = Crystal oscillator enabled. Note: If the crystal oscillator is turned off and then turned on again, the clock should not be switched back to the oscillator until after the crystal has had time to stabilize. See the crystal data sheet to determine this time duration.
RANGE [11]	This bit is used to select to the frequency range of the crystal oscillator 0 = A 32 kHz crystal must be attached to the oscillator pins 1 = A crystal in the range of 1 MHz to 16 MHz must be attached to the oscillator pins. PRECS should be 0 before changing the value of RANGE to avoid glitches on the system clock.
EXT_SEL [10]	This bit is used to select to source of the external clock input. 0 = Use XTAL as the external clock input 1 = Use CLKIN as the external clock input PRECS should be 0 before changing the value of EXT_SEL to avoid glitches on the system clock.
TRIM [9:0]	Internal Relaxation Oscillator TRIM. These bits change the size of the internal capacitor used by the internal relaxation oscillator. By testing the frequency of the internal clock and changing this trim accordingly, the accuracy of the internal clock can be improved by 40%. Incrementing these bits by one increases the clock period by 0.078% of the unadjusted value. Decrementing this register by one decreases the clock period by 0.078%. Reset sets these bits to 0x200.

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13.6.5 External Clock Check (OCCS_CLKCHKR and OCCS_CLKCHKT)

These registers are used in applications to verify the activity of an external clock source or crystal/resonator oscillato,r before it is selected as the active system clock source, as shown in Figure 13-11 and Figure 13-12. PRECS must be 0 to use this function.

Address: OCCS_BASE + 0x0005

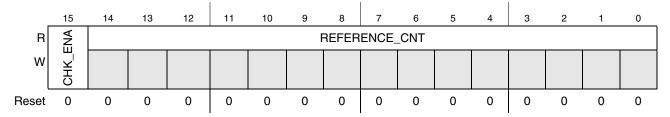


Figure 13-11. External Clock Check Reference (OCCS_CLKCHKR)

Table 13-6. External Clock Check Reference (OCCS_CLKCHKR) Descriptions

Field	Description
CHK_ENA [15]	Check Enable. This bit is used to start and stop the clock checking function. Allow enough time after the CLK_ENA is cleared to allow for two ROSC clock periods before attempting to start another verification cycle. 1 = Writing a one clears the REF_CNT and TARGET_CNT registers and starts the clock checking function. The CLK_ENA bit remains high while the operation is in progress. 0 = Writing a low while the clock checking operation is in progress stops the check in its current state. Reading a low after a check has been started indicates that the check operation is complete and the final values are valid in the REF_CNT and TARGET_CNT registers.
REF_COU NT [14:0]	Reference Count. Number of ROSC clock cycles that have been counted. This count is initialized to zero on the positive transition of CHK_ENA. The test is terminated when: RANGE = 0: When REF_COUNT = 0x7FFF RANGE = 1: When REF_COUNT = 0x0080 Note: This counter value is not synchronized to the bus clock and any value read while CHK_ENA is high should not be considered accurate.

Address: OCCS_BASE + 0x0006

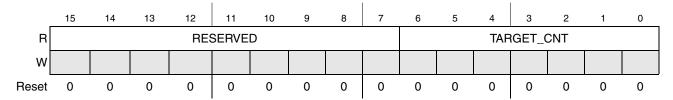


Figure 13-12. External Clock Check Target (OCCS_CLKCHKT)

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Table 13-7. External Clock Check Target (OCCS_CLKCHKT) Descriptions

Field	Description
RESERVED [15:7]	Reserved.
	OCCS_CLKCHKT Target Count. Number of external clock cycles that have been counted. Note: This counter value is not synchronized to the bus clock and any value read while CHK_ENA is high should not be considered accurate.

13.6.6 Protection Register (OCCS_PROT)

This register provides features for runaway code protection of safety-critical register fields. By choosing an appropriate subset of protection registers the end user can define the trade-off between power management and protection of the OCCS operating configuration.

Flexibility is provided so that write protection control values may themselves be optionally locked (write protected). To this end, protection controls in this register have two bit values. The right bit determines the setting of the control, and the left bit determines whether the value is locked. When a protection control is set to a locked value, it can be altered only by a chip reset that restores its default non-locked value. While a protection control remains set to non-locked values, it can be rewritten to any new value.

Address: OCCS_BASE + 0x0007

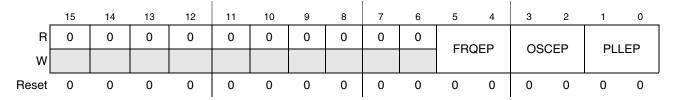


Figure 13-13. Protection Register (OCCS_PROT)

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Table 13-8. Protection Register (OCCS_PROT) Descriptions

Field	Description
RESERVED [15:6]	Reserved.
FRQEP [5:4]	Frequency Enable Protection. Enables write protection of the COD and ZSRC fields. 00 - Write protection off (default) 01 - Write protection on 10 - Write protection off and locked until chip reset 11 - Write protection on and locked until chip reset
OSCEP [3:2]	Oscillator Enable Protection. Enables write protection of the OCCS_OCTRL register and its PRECS field. 00 - Write protection off (default) 01 - Write protection on 10 - Write protection off and locked until chip reset 11 - Write protection on and locked until chip reset
PLLEP [1:0]	PLL Enable Protection. Enables write protection of the PLLPDN, LOCIE, and LORTP fields. By write protecting these registers (PLLPD=0, LOCIE=1) the loss of reference detector can not be disabled. 00 - Write protection off (default) 01 - Write protection on 10 - Write protection off and locked until chip reset 11 - Write protection on and locked until chip reset

13.7 Functional Description

A block diagram of the OCCS module is shown in Figure 13-6.

Possible clock source choices are:

- Internal relaxation oscillator
- External ceramic resonator
- External crystal
- External clock source on either XTAL or a GPIO port (GPIOB6 for this device)

Each of these clock sources can be selected to drive the remainder of the clock generation circuitry. This circuitry allows direct use of the clock, or the clock can be used as an input to the PLL that generates a higher frequency clock for use within the chip.

The clock multiplexer (ZSRC MUX) selects the direct clock on power up. A different clock source can be selected by writing to the PLL control register (OCCS_CTRL). After a new clock source is selected, the new clock is activated within four clock periods of the new clock after the clock selection request is re-clocked by the current IPbus clock.

The postscaler output is guaranteed by design to be glitch-free when changing the divide ratio.

Transitions to/from direct to postscaler frequencies are guaranteed to be glitch-free by design on the sys_clk_x2 clock. Before switching to the PLL, the PLL must be locked. The OCCS status register (OCCS_STAT) shows the status of the DSP core clock source. Because the synchronizing circuit changes modes to avoid any glitches, the OCCS_STAT ZCLOCK source (ZSRC) shows overlapping modes as an intermediate step. After PLL lock is detected the DSP core clock can be switched to the PLL by writing to the ZSRC bits in the OCCS_CTRL register.

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Special consideration must be given to the HS_PERF_CLK (3X peripheral clock). High speed peripheral clocking is available only when the phase locked loop is used as the clock source for the system. 3X clock modes should be disabled in the SIM peripheral clock rate register (SIM_PCR) until after the ZSRCS[1:0] status bits (see Section 13.6.3, "OCCS Status Register (OCCS_STAT)) signal that the switch to the PLL is complete. The 3X mode should be disabled before switching back to master clock. 3X mode is not available when using master clock. Failure to abide by the restrictions above can result in glitches on the HS_PERF_CLK during switchover to the phase locked loop output. This may adversely affect device operation.

Frequencies going out of the OCCS are controlled by the postscaler, and/or the divide-by ratio within the PLL. For proper operation of the PLL, the user must keep the VCO, within the PLL, in its operational range of 120–240 MHz, the output of the VCO is depicted as F_{pll} in Figure 13-6. The input frequency multiplied by the divide-by ratio is the frequency at which the VCO is running.

The PLL lock time is 10 ms or less when coming from a powered down state to a power up state. It is recommended when powering down, or powering up, the PLL be deselected as the clocking source. Only after lock is achieved should the PLL be used as a valid clocking source.

Table 13-9 shows the possible clock sources and configurations.

Table 13-9. Clock Choices Without Crystal Oscillator

Clock Source	Clock Selected	Configuration Steps	
Relaxation Oscillator	Direct	Default. Change TRIM as needed to obtain the desired clock rate	
Relaxation Oscillator	Postscaler	 Change TRIM as needed to obtain the desired clock rate Change COD, if desired Enable the PLL (PLLPD=0) Wait for PLL lock (LCK1=1 and LCK0=1) Change ZSRC to select the postscaler clock (ZSRC=10). 	
External Clock Source	Direct	 The clock source (CLKIN) should be enabled in the GPIO and SIM as necessary. Select CLKIN as the source clock (PRECS=1, EXT_SEL=1). Wait 6 NOPs for the synchronizing circuit to change clocks. The relaxation oscillator can be powered down (ROPD=1) to conserve power. 	
External Clock Source	Postscaler	 The clock source (CLKIN) should be enabled in the GPIO and SIM as necessary. Select CLKIN as the source clock (PRECS=1, EXT_SEL=1). Wait 6 NOPs for the synchronizing circuit to change clocks. The relaxation oscillator can be powered down (ROPD=1) to conserve power Change COD, if desired Enable the PLL (PLLPD=0) Wait for PLL lock (LCK1=1 and LCK0=1) Change ZSRC to select the postscaler clock (ZSRC=10). 	

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Table 13-10. Clock Choices with Crystal Oscillator

Clock Source	Clock Selected	Configuration Steps	
Relaxation Oscillator	Direct	Default.	T
			The crystal oscillator should be powered down (CLK_MODE=1) to conserve power. Default state
		2.	Change TRIM as needed to obtain the desired clock rate
Relaxation Oscillator	Postscaler		The crystal oscillator should be powered down (CLK_MODE=1) to conserve power.
		2.	Change TRIM as needed to obtain the desired clock rate
		3.	Change COD, if desired
		4.	Enable the PLL (PLLPD=0)
		5.	Wait for PLL lock (LCK1=1 and LCK0=1)
		6.	Change ZSRC to select the postscaler clock (ZSRC=10).
Ceramic Resonator	Direct	1.	The crystal oscillator should be powered up (CLK_MODE=0).
		2.	Select high frequency RANGE (RANGE=0).
		3.	Wait for the oscillator to stabilize (up to 10 ms)
			The clock source should be changed to the crystal oscillator (EXT_SEL=0, PRECS=1, in that order)
		5.	Wait 6 NOPs for the synchronizing circuit to change clocks.
			The relaxation oscillator can be powered down (ROPD=1) to conserve
			power
Ceramic Resonator	Postscaler		The crystal oscillator should be powered up (CLK_MODE=0).
			Select high frequency RANGE (RANGE=0).
		Wait for the crystal oscillator to stabilize (up to 10ms)	
		The clock source should be changed to the crystal oscillator (EXT_SEL=0, PRECS=1, in that order)	
		5.	Wait 6 NOPs for the synchronizing circuit to change clocks.
		6. The relaxation oscillator can be powered down (ROPD=1) to conserve power	
		7. Change COD, if desired	
		8.	Enable the PLL (PLLPD=0)
		9.	Wait for PLL lock (LCK1=1 and LCK0=1)
		10.	Change ZSRC to select the postscaler clock (ZSRC=10).
Crystal	Direct	1.	The crystal oscillator should be powered up (CLK_MODE=0).
		2.	Change the oscillator to low power mode (COHL=1)
		3.	Wait for the crystal oscillator to stabilize (up to 10ms)
			The clock source should be changed to the crystal oscillator (EXT_SEL=0, PRECS=1, in that order)
		5.	Wait 6 NOPs for the synchronizing circuit to change clocks.
			The relaxation oscillator can be powered down (ROPD=1) to conserve power

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Table 13-10. Clock Choices with Crystal Oscillator (continued)

Clock Source	Clock Selected	Configuration Steps	
Crystal	Postscaler	 The crystal oscillator should be powered up (CLK_MODE=0). Change the oscillator to low power mode (COHL=1) Wait for the crystal oscillator to stabilize (up to 10 ms) The clock source should be changed to the crystal oscillator (EXT_SEL=0, PRECS=1, in that order) Wait 6 NOPs for the synchronizing circuit to change clocks. The relaxation oscillator can be powered down (ROPD=1) to conserve power Change COD, if desired Enable the PLL (PLLPD=0) Wait for PLL lock (LCK1=1 and LCK0=1) Change ZSRC to select the postscaler clock (ZSRC=10). 	
External Clock Source	Direct	 The clock source (CLKIN) should be enabled in the GPIO and SIM as necessary. Set the CLK_MODE bit in OCCS_OCTRL register to 1. Select CLKIN as the source clock (PRECS=1). The clock source should be changed to the crystal oscillator (EXT_SEL=1, PRECS=1, in that order). Wait 6 NOPs for the synchronizing circuit to change clocks. The relaxation oscillator can be powered down (ROPD=1) to conserve power. Change PLLCID, if desired. At this point the EXTAL pin can be used as a GPIO by deasserting the appropriate PE bit in the GPIO_X_PER. 	
External Clock Source	Postscaler	 The clock source (CLKIN) should be enabled in the GPIO and SIM as necessary. Set the CLK_MODE bit in OCCS_OCTRL register to 1. Select CLKIN as the source clock (PRECS=1). The clock source should be changed to the crystal oscillator (EXT_SEL=1, PRECS=1, in that order) Wait 6 NOPs for the synchronizing circuit to change clocks. The relaxation oscillator can be powered down (ROPD=1) to conserve power Change COD, if desired Enable the PLL (PLLPD=0) Wait for PLL lock (LCK1=1 and LCK0=1) Change ZSRC to select the postscaler clock (ZSRC=10). At this point the EXTAL pin can be used as a GPIO by deasserting the appropriate PE bit in the GPIO_X_PER. 	

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13.8 Relaxation Oscillator

13.8.1 Trimming Frequency on the Internal Relaxation Oscillator

The internal relaxation oscillator frequency varies as much as $\pm 20\%$ due to process, temperature, and voltage dependencies. The voltage and temperature dependencies have been designed to be a maximum of approximately 2% error. The process dependencies account for the rest.

For an individual part, the process dependencies are constant. An individual part can operate at approximately 2% variance from its unadjusted operating point over the entire spec range of the application. If the unadjusted operating point can be changed, the entire variance can be limited to 2%.

The method of changing the unadjusted operating point is by changing the trim factor (TRIM) in the OCCS_OCTRL. The default value for TRIM is 0x200. The clock period of the relaxation oscillator clock can be changed enough to cancel the process variability mentioned before. The factory determines the best setting for this TRIM value and makes that value available to the application program to change the default of 0x200 to this factory value during the startup code.

13.9 External Reference

If higher clock precision is required the chip can be operated from an external clock source.

13.10 Crystal Oscillator

The crystal oscillator is designed to operate with either an external crystal or an external ceramic oscillator. If a crystal above 8 MHz is used, the COHL bit must be set to 0. If an 8 MHz or lower crystal/resonator is used on the board the power level of this oscillator can be lowered to reduce power consumption (see the COHL bit in the OCCS_OCTRL register).

13.10.1 Switching Clock Sources

To robustly switch between the internal relaxation oscillator clock, external oscillator clock and CLKIN, the changeover switch assumes the clocks are completely asynchronous, so a synchronizing circuit is provided to make the transition. When the select input (PRECS) is changed, the switch continues to operate off the original clock for between 1 and 2 cycles as the select input is transitioned through one side of the synchronizer. Next, the output is held low for between 1 and 2 cycles of the new clock as the select input transitions through the other side. Then the output starts switching at the new clock's frequency. This transition guarantees by design that no glitches are seen on the output even though the select input may change asynchronously to the clocks. The unpredictably of the transition period is a necessary result of the asynchronicity. The switch automatically selects the internal relaxation oscillator clock during reset.

Switching from the internal relaxation oscillator clock to the crystal oscillator clock source or vice-versa requires both clock sources to be enabled and stable. A simple flow follows:

- If switching to the crystal oscillator, make sure that it has been enabled by way of GPIO and is powered up (CLK_MODE=0). Check the value of the COSC_RDY bit.
- If switching to the relaxation oscillator, make sure that it is powered up (ROPD is clear).

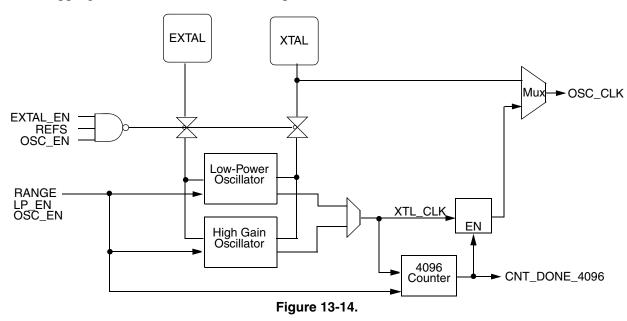
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- Wait for a few cycles for the clock to become active.
- Switch clocks.
- Execute 4 NOP instructions.
- Disable the previous clock source (that is, power down the relaxation oscillator if crystal is selected).

The key point to remember in this flow is that the clock source should not be switched unless the desired clock is on and stable.

When a new DSC core clock is selected, the clock generation module synchronizes the request and selects the new clock. The OCCS status register (OCCS_STAT) shows the status of the DSC core clock source. Because the synchronizing circuit changes modes as to avoid any glitches, the ZSRCS bits in OCCS_STAT show overlapping modes as an intermediate step.



13.11 Phase Locked Loop

13.11.1 PLL Recommended Range of Operation

The voltage controlled oscillator (VCO) within the PLL has a characterized operating range extending from 120 MHz to 240 MHz. Chip level limitations may restrict using the PLL at its maximum operating frequency, refer to the chip level specification for specific guidance. The output of the PLL, F_{pll} , is fed to the input of the postscaler.

13.11.2 PLL Lock Time Specification

In many applications, the lock time of the PLL is the most critical PLL design parameter. Proper design and use of the PLL ensures the highest stability and lowest lock time.

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13.11.2.1 Lock Time Definition

Typical control systems refer to the lock time as the reaction time, within specified tolerances, of the system to a step input. In a PLL, the step input occurs when the PLL is turned on or when it suffers a noise hit. The tolerance is usually specified as a percent of the step input or when the output settles to the desired value plus or minus a percent of the frequency change. Therefore, the reaction time is constant in this definition, regardless of the size of the step input.

When the PLL is coming from a powered down state, PLL_PDN high, to a powered up condition, PLL_PDN low, the maximum lock time, with a divide by count of 16 or less, is 10 ms. Other systems refer to lock time as the time the system takes to reduce the error between the actual output and the desired output to within specified tolerances. Therefore, the lock time varies according to the original error in the output. Minor errors may be shorter or longer in many cases.

13.11.2.2 Parametric Influences on Reaction Time

Lock time is designed to be as short as possible while still providing the highest possible stability. The reaction time is not constant, however. Many factors directly and indirectly affect the lock time.

The most critical parameter affecting the reaction time of the PLL is the reference frequency, master clock, illustrated in Figure 13-6. This frequency is the input to the phase detector and controls how often the PLL makes corrections. For stability, it is desirable for the corrections to be small and frequent. Therefore, a higher reference frequency provides optimal performance; 8 MHz is preferred.

13.12 PLL Frequency Lock Detector Block

This digital block monitors the VCO output clock and sets the LCK[1:0] bits in the OCCS status register (OCCS_STAT) based on its frequency accuracy. The lock detector is enabled with the LCKON bit of the PLL control register (OCCS_CTRL), as well as the PLL_PDN bit of OCCS_CTRL. After it is enabled, the detector starts two counters whose outputs are periodically compared. The input clocks to these counters are the VCO output clock divided by 24, called feedback, and the PLL input clock, shown as master clock in Figure 13-6. The period of the pulses being compared cover one whole period of each clock. This is due to the feedback clock not guaranteeing a 50 percentage duty cycle. The design of this block was accomplished with the assumption the feedback clock transitions high on the rising edge of master clock.

Feedback and master clock clocks are compared after 16, 32, and 64 cycles. If, after 32 cycles, the clocks match, the LCK0 bit is set to one. If, after 64 cycles of master clock, there is the same number of master clock clocks as feedback clocks, the LCK1 bit is also set. An LCK bit will stay set until:

- Clocks fail to match
- On reset caused by LCKON, PLL_PDN
- Chip_level reset

When the circuit sets the LCK1, the two counters are reset and start the count again. The lock detector is designed so if LCK1 is reset to zero because clocks did not match, LCK0 can stay high. This provides the processor information about the accuracy of the two clocks with respect to each other.

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13.13 Loss of Reference Clock Detector

The loss of reference clock detector is designed to generate an interrupt when the reference clock to the PLL is interrupted. An LOR interrupt should occur after (LORTP + 1) \times 10 \times 2 \times (PLL output clock period) reference clocks. Figure 13-15 illustrates the general operation of the LOR detector, which relies on the fact that the phase locked loop can continue running for a time after its reference clock has been disturbed. This provides time for detection of the problem and an orderly system shutdown.

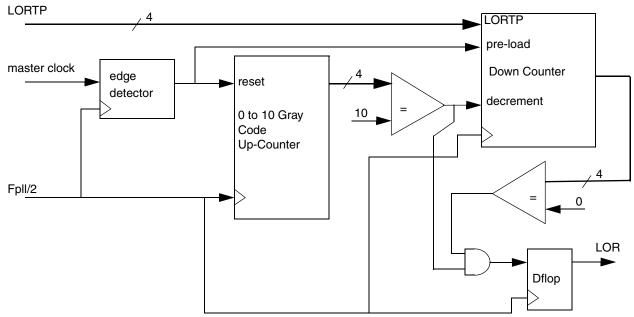


Figure 13-15. Simplified Block Diagram of the Loss Of Reference Clock Detector

13.14 Clocks

Table 13-11 summarizes the various clock signals pertaining to the OCCS module. All clocks are ultimately derived from the oscillator output.

Clock	Source	Characteristics	
IP Bus Clock	IP Bus Bridge	Derived from sys_clk and has the same frequency Used for all peripheral register reads & writes	
sys_clk_x2	This module	Primary source for all on-chip clocks excluding the oscillator clock used by the ADC module. This signal is divided by two in the SIM to generate the master system frequency.	
Feedback	PLL	Feedback pin of the PLL	
f _{rosc}	Relaxation oscillator	Nominally this is 8 MHz. 400 kHz in standby.	
f _{cosc}	Crystal oscillator	Nominally this is 32 kHz or 8 MHz.	
f _{pll}	This module	Output of the PLL	

Table 13-11. Clock Summary

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13.15 Interrupts

The interrupts listed in Table 13-12 are OR'ed into a single processor core interrupt, the OCCS interrupt, which uses vector 11 (base 10).

Table 13-12. Interrupt Summary

Interrupt	Source	Description	Reference
LOLI1	OCCS_STAT	Lock 1 Interrupt	Section 13.6.1
LOLI0	OCCS_STAT	Lock 2 Interrupt	Section 13.6.1
LOCI	OCCS_STAT	Loss of Reference Clock Interrupt	Section 13.6.1

If the LOCI interrupt is enabled and the PLL is enabled then the LOCI is permitted to wake the system from some stop modes.

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Chapter 14 System Integration Module (SIM)

14.1 Introduction

This specification describes the operation and functionality of the system integration module for this device.

14.1.1 Overview

The SIM is a system catchall for the glue logic that ties together the system-on-chip. It controls distribution of resets and clocks and provides a number of control features.

The system integration module is responsible for the following functions:

- Reset sequencing
- Clock generation and distribution
- Implementation of stop and wait low power modes
- System status registers
- Registers for software access to the JTAG ID of the chip
- Short addressing controls
- Test registers
- External and internal peripheral signal muxing control

These are discussed in more detail in the sections that follow.

14.1.2 References

Due to its nature as glue logic, the SIM interacts with a variety of other on-chip resources. The following references may be helpful when reading this chapter.

- Chapter 16, "Computer Operating Properly (COP)"
- Chapter 15, "Power Management Controller (PMC)"

14.1.3 Features

The SIM has the following features:

- System bus clocks with pipeline holdoff support
 - Data RAM clock with holdoff control
 - Program flash clocks

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System Integration Module (SIM)

- IP bus interface clock with holdoff control
- HFM IP bus interface clock and PCLK
- DSC core system clock
- General-purpose system clock (both standard and inverted versions)
- System clocks for non-pipelined interfaces
 - PCLK clock for DSC core
 - NCLK clock for DSC core
 - A continuously running system clock
 - A continuously running system clock with enable for HFM
- Peripheral clocks including high speed option for TMR, PWM, and SCI
- ITCK clock to the DSC core interface
- Power Saving Clock gating for peripherals.
- Three power modes (run, wait, stop) to control power use
 - Stop mode shuts down DSC core, system clock, and peripheral clock.
 - Wait mode shuts down DSC core and unnecessary system clock operation.
 - Run mode supports full part operation.
 - The three modes above may be combined with the low power mode of the power management controller to generate LPstop, LPwait, and LPrun modes.
- Controls with write protection to enable/disable the DSC core WAIT and STOP instructions. Partial power-down mode cannot be entered if the STOP instruction is disabled.
- Controls to permit selected peripherals to run in stop mode to generate stop recovery interrupts.
- Controls for programmable peripheral and GPIO connections.
- Manages internal reset deassertion sequence.
- Software initiated reset.
- A holdoff output to abort peripheral bus transactions when the system bus pipeline is held off.
- Short addressing base location control.
- Peripheral protection control to provide runaway code protection for safety critical applications.
- Features to support testing of the SIM and the IC.
 - Internal derived clocks and clock outputs disabled or controlled by scan clock input for scan mode
 - Internal derived resets and reset outputs asserted or controlled by reset pad input for scan mode
 - Power-on reset input can be disabled and replaced with reset pin input for test
 - Clock to DSC core can be disabled (stalled) for test
 - Regulator standby control disabled for scan mode
- Registers containing the JTAG ID of the chip

14.1.4 Modes of Operation

Because the SIM is responsible for distributing clocks and resets across the chip, it must understand the various chip operating modes and take appropriate action. These include:

14.1.4.1 Reset Mode

There are actually three submodes:

- Clock Reset Mode The core, all peripherals, and the CLKGEN module are all in reset. clkgen_rst_b, perip_rst_b, and core_rst_b are active.
- System Reset Mode Core and all peripherals are reset. perip_rst_b and core_rst_b are active.
- Core-Only Reset Mode Core in reset, peripherals are active (perip_rst_b inactive, core_rst_b active).

The latter mode is required to provide the on-chip flash interface units to load data from flash into HFM registers.

Note that the interrupt controller must present the boot address one cycle before the reset is de-asserted.

14.1.5 Run Mode

This is the primary mode of operation for this device. In this mode, the DSC core controls chip operation.

LPrun is identical to run from the DSC core and SIM perspective.

14.1.6 Debug Mode

DSC core is in debug mode (controlled via JTAG/EOnCE). All peripherals with the exception of the COP and PWM's continue to run. COP is disabled and PWM outputs are optionally switched off (see the PWM spec for details) to disable any motor from being driven.

14.1.7 Wait Mode

In wait mode, the core clk and memory clocks are disabled. The COP can optionally be stopped. Similarly, the PWM outputs can optionally be switched off to disable any motor from being driven. All other peripherals continue to run.

LPwait is identical to wait from the DSC core and SIM perspective.

14.1.8 Stop Mode

DSC core, memory and most peripheral clocks are shut down. The COP can optionally be stopped. The PLL must be explicitly shut down prior to entering stop mode if desired. Selected peripherals can optionally continue to run in stop mode for the purpose of generating interrupts to wake the part from stop mode.

LPstop is identical to stop from the DSC core and SIM perspective.

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14.2 Memory Map and Registers

14.2.1 Module Memory Map

A write to an address without an associated register is an NOP. A read from an address without an associated register returns unknown data.

Table 14-1. Module Memory Map

Address	Reg Name	Description
SIM_BASE + 0x0000	SIM_CTRL	SIM Control Register
SIM_BASE + 0x0001	SIM_RSTAT	SIM Reset Status Register
SIM_BASE + 0x0002	SIM_MSHID	SIM Most Significant Half JTAG ID
SIM_BASE + 0x0003	SIM_LSHID	SIM Least Significant Half JTAG ID
SIM_BASE + 0x0004	Reserved	_
SIM_BASE + 0x0005	SIM_CLKOUT	SIM Clock Output Select Register
SIM_BASE + 0x0006	SIM_PCR	SIM Peripheral Clock Rate Register
SIM_BASE + 0x0007	SIM_PCE	SIM Peripheral Clock Enable Register
SIM_BASE + 0x0008	SIM_SDR	SIM Stop Disable Register
SIM_BASE + 0x0009	SIM_ISAL	SIM I/O Short Address Location Register
SIM_BASE + 0x000A	SIM_PROT	SIM Protection Register
SIM_BASE + 0x000B	SIM_GPSA	SIM GPIO Peripheral Select Register for GPIOA
SIM_BASE + 0x000C	SIM_GPSB0	SIM GPIO Peripheral Select Register 0 for GPIOB
SIM_BASE + 0x000D	SIM_GPSB1	SIM GPIO Peripheral Select Register 1 for GPIOB
SIM_BASE + 0x000E	SIM_GPSC	SIM GPIO Peripheral Select Register for GPIOC
SIM_BASE + 0x000F	SIM_GPSD	SIM GPIO Peripheral Select Register for GPIOD
SIM_BASE + 0x0010	SIM_IPS0	SIM Internal Peripheral Select Register 0
SIM_BASE + 0x0011	SIM_IPS1	SIM Internal Peripheral Select Register 1

14.2.2 Register Descriptions

14.2.2.1 Control Register (SIM_CTRL)

Address: SIM_BASE + 0x0000

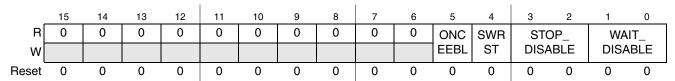


Figure 14-1. Control Register (SIM_CTRL)

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Figure 14-2. Control Register (SIM_CTRL) Descriptions

Field	Description
15–6	Reserved
5 ONCEE BL	OnCE Enable 0 = OnCE clock to DSC core enabled when core is enabled 1 = OnCE clock to DSC core is always enabled
4 SWRST	Software Reset — Writing a 1 to this field causes the part to reset.
3, 2 STOP_ DISABL E	·
1, 0 WAIT_ DISABL E	Wait Disable 00 Wait mode is entered when the DSC core executes a WAIT instruction 01 The WAIT instruction does not cause entry into wait mode 10 Wait mode is entered when the DSC core executes a WAIT instruction and the WAIT_disable field is write-protected until the next reset 11 The WAIT instruction does not cause entry into wait mode and the WAIT_disable field is write-protected until the next reset

14.2.2.2 Reset Status Register (SIM_RSTAT)

This register is updated upon any system reset and indicates the cause of the most recent reset. It also controls whether the COP reset vector or regular reset vector in the vector table is used. This register is asynchronously reset during power-on reset (see Chapter 15, "Power Management Controller (PMC)) and subsequently is synchronously updated based on the level of the external reset, software reset, or COP reset inputs. It is one-hot encoded, and only one source is ever indicated. In the event that multiple reset sources assert simultaneously, the highest precedence source is indicated. The precedence from highest to lowest is (POR/PPD/LVDR)¹, EXTR, COP_LOR, COP_CPU, and SWR. POR is always set during a power-on reset; however, POR is cleared and EXTR is set if the external reset pin is asserted or remains asserted after the power-on reset has deasserted.

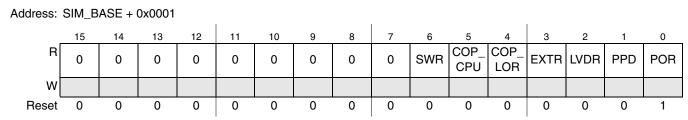


Figure 14-3. Reset Status Register (SIM_RSTAT)

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^{1.} Only one of PPD, POR, or LVDR is asserted. Any of the three take precedence in the one-hot encoding of RTSTAT.

Table 14-2. Reset Status Register (SIM_RSTAT)Descriptions

Field	Description
15–7	Reserved.
6 SWR	Software Reset. When set, this bit indicates that the previous system reset occurred as a result of a software reset (wrote 1 to SW Rst bit in the SIM_CTRL register). It is not set if a COP, external, or POR reset also occurred.
5 COP_ CPU	COP DSC Core Time-out Reset. When set, this bit indicates that the previous system reset was caused by the computer operating properly (COP) module signalling a DSC core time-out reset. It is not set if an external reset, POR reset, or COP loss of reference reset also occurred. If COP_CPU is set as code starts executing then the COP reset vector in the vector table is used. Otherwise the normal reset vector is used.
4 COP_ LOR	COP Loss of Reference Reset. When set, this bit indicates that the previous system reset was caused by the computer operating properly (COP) module signalling a loss of reference clock reset. It is not set if an external or POR reset also occurred. If COP_LOR is set as code starts executing then the COP reset vector in the vector table is used. Otherwise the normal reset vector is used.
3 EXTR	External Reset. When set, this bit indicates that the previous system reset was caused by an external reset. It is set only if the external reset pin was asserted or remained asserted after the power-on reset de-asserted.
2 LVDR	Low Voltage Detect Reset. This bit is set when the PMC forces a reset upon detecting a low-voltage event.
1 PPD	Partial Power Down. This bit is set as a result of the reset that occurs during recovery from partial power down. It is a snapshot of PMC_SCR[PPDF] upon exit from reset.
0 POR	Power on Reset. This bit is set during a power on reset.

14.2.2.3 Most Significant Half of JTAG ID (SIM_MSHID)

This read-only register returns the most significant half of the JTAG ID for the chip. This register reads 0x1F2.

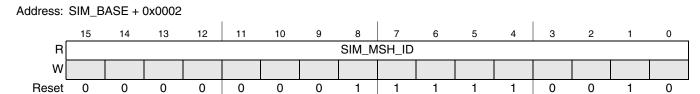


Figure 14-4. Most Significant Half of JTAG_ID (SIM_MSHID)

14.2.2.4 Least Significant Half of JTAG ID (SIM_LSHID)

This read-only register returns the least significant half of the JTAG ID for the chip. This register reads 0x601D.

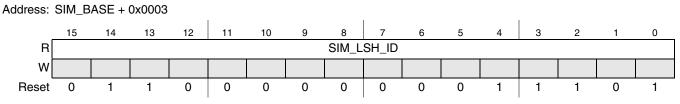


Figure 14-5. Least Significant Half of JTAG_ID (SIM_LSHID)

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14.2.2.5 Clock Output Select Register (SIM_CLKOUT)

The clock output select register can be used to multiplex out selected clocks generated inside the clock generation, SIM, and ADC modules onto the CLKO_0 and CLKO_1 clock output signals. Glitches may be produced when the clock is enabled or switched. The delay from the clock source to the output is unspecified. The observability of the CLKO_0 and CLKO_1 clock output signals is subject to the frequency limitations of the associated I/O cell.

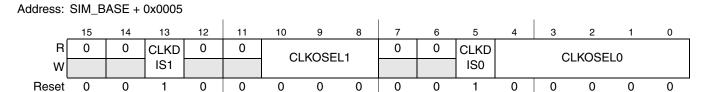


Figure 14-6. Clock Output Select Register (SIM_CLKOUT)

Table 14-3. Clock Output Select Register (SIM_CLKOUT) Descriptions

Field	Description														
15, 14	Reserved														
13 CLKDIS 1	Disable 0 CLKO_n output is enabled and outputs the signal indicated by CLKOSELn 1 SIM_CLKOUT is 0														
12, 11	Reserved														
10–8 CLKOSE L1	CLKO_1 Select. Selects clock to be muxed out on the CLKO_1 pin as defined in the following table. Internal delay to CLKO_1 output is unspecified. Signal at the output pad is undefined when CLKO_1 signal frequency exceeds rated frequency of IO circuitry. CLKO_1 may glitch when CLKDIS1 and CLKOSEL1 settings are changed. Note: CLKDIS1 and CLKOSEL1 define what CLKO_1 is. Propagation of CLKO_1 to external pad requires proper setting of related GPSn and GPIO_X_PER fields.														
		CLKOSEL1 USER/TEST FUNCTION NOTES													
		x0 USER Continuous System Clock System frequency, continuous after POR													
		x1 USER Peripheral Clock Peripheral frequency, continuous when not in reset													
		x2	USER	High-Speed Peripheral Clock	3x system frequency, continuous only while PLL selected										
		х3	x3 USER Master Clock Master clock source before PLL (ROSC, OSC or external clock) continuous												
		x4	USER	1kHz Low Power Oscillator											
		х5	USER	Crystal Oscillator Output	_										
		х6	USER	Relaxation Oscillator Output	_										
		x7	TEST	Reserved	_										

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Table 14-3. Clock Output Select Register (SIM_CLKOUT) Descriptions (continued)

Field	Description
7, 6	Reserved
5 CLKDIS 0	Disable. 0 CLKO_n output is enabled and outputs the signal indicated by CLKOSELn 1 = SIM_CLKOUT is 0
4–0 CLKOSE L0	CLKO_0 Select. Selects clock to be muxed out on the CLKO_0 pin as defined in the following table. Internal delay to CLKO_0 output is unspecified. Signal at the output pad is undefined when CLKO_0 signal frequency exceeds rated frequency of IO circuitry. CLKDISO and CLKOSELO define what CLKO_0 is. Propagation of CLKO_0 to external pad requires proper setting of related GPSn and GPIO_X_PER fields.
	Table 14-4, SIM_CLKOUT Selection Using CLKOSEL0

CLKOSEL0	USER/TEST	FUNCTION	NOTES
x00	USER	Continuous System Clock	System frequency, continuous after POR
x01	USER	Peripheral Clock	Peripheral frequency, continuous when not in reset
x02	USER	High-speed Peripheral Clock	3x system frequency, continuous only while PLL selected
x03	USER	Master Clock	Master clock source before PLL (ROSC, OSC or external clock) continuous
x04	USER	1 kHz Low Power Oscillator	_
x05	USER	Crystal Oscillator Output	_
x06	USER	Relaxation Oscillator Output	_
x07-0x1F	TEST	Reserved	_

14.2.2.6 Peripheral Clock Rate Register (SIM_PCR)

All peripherals by default are clocked at the system clock rate, which is a maximum of 32 MHz. Selected peripherals clocks have the option to be clocked at three times this normal rate, which is a maximum of 96 MHz. This register is used to enable high-speed clocking for those peripherals that support it.

High-speed peripheral clocking is dependent on the 3x master clock output of the PLL. When the PLL is not selected in OCCS, its 3x master clock output is held low. All SIM_PCR bits should therefore be set to zero during any period in which the PLL is not on and selected in OCCS.

Peripherals should not be left in an enabled or operating mode while reconfiguring their clocks using the controls in SIM or OCCS. SIM_PCR bits should therefore be changed only while the respective peripheral is disabled. Refer to the peripheral user guide for further details.

MC56F8006 Reference Manual, Rev. 0 14-8 Freescale Semiconductor When a peripheral is operated in high-speed mode, the I/O rate to the peripheral remains limited to the system clock rate because that is the rate that the DSC core processor operates. For peripherals with a single clock input, that clock is operated at the high-speed rate and a high-speed I/O gasket is used to coordinate I/O with the processor. For peripherals with separate I/O and "run" clocks, the I/O clock is operated at the normal peripheral clock rate and only the "run" clock is operated at the 3x high-speed rate.

Address: SIM_BASE + 0x0006

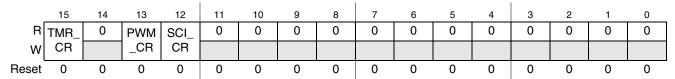


Figure 14-7. Peripheral Clock Rate Register (SIM_PCR)

Table 14-5. Peripheral Clock Rate Register (SIM_PCR) Descriptions

Field	Description
15 TMR_ CR	General Purpose Timer Clock Rate. This bit selects the clock speed for the General Purpose Timer module. 0 Timer clock rate equals core clock rate, maximum 32 MHz (default) 1 Timer clock rate equals 3X core clock rate Note: TMR_CR must be set to 0 if the PLL is not on and selected in OCCS. The timer should be disabled prior to altering TMR_CR. See peripheral user guide for details.
14	Reserved
13 PWM_ CR	PWM Clock Rate. This bit selects the clock speed for the PWM module. 0 PWM peripheral bus clock rate equals core clock rate, maximum 32 MHz (default) 1 PWM peripheral bus clock rate equals 3X core clock rate Note: PWM_CR must be set to 0 if the PLL is not on and selected in OCCS. The PWM should be disabled prior to altering PWM_CR. See peripheral user guide for details.
12 SCI_CR	SCI Clock Rate. This bit selects the clock speed for the SCI module. 0 SCI clock rate equals core clock rate, maximum 32 MHz (default) 1 SCI clock rate equals 3X core clock rate Note: SCI_CR must be set to 0 if the PLL is not on and selected in OCCS. The SCI should be disabled prior to altering SCI_CR. See peripheral user guide for details.
11–0	Reserved.

14.2.2.7 Peripheral Clock Enable Register (SIM_PCE)

The peripheral clock enable register is used to enable or disable clocking of individual peripherals as a power savings feature. Significant power savings is achieved by enabling only the clocks of peripherals that are in use. When a peripheral's clock is disabled, no functionality is available to that peripheral, including I/O.

Peripherals should not be left in an enabled or operating mode while their clocks are disabled or while reconfiguring their clocks using the controls in SIM or OCCS. SIM_PCE bits should therefore be changed only while the respective peripheral is disabled. Refer to the peripheral user guide for further details.

Setting the SIM_PCE bit does not guarantee the peripheral's clock is running. Enabled peripheral clocks become disabled in stop mode unless the peripheral's STOP disable control in the SDn registers is set to 1.

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Address: SIM_BASE + 0x0007

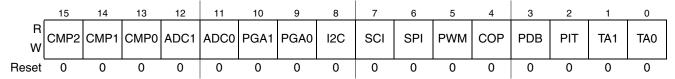


Figure 14-8. Peripheral Clock Enable Register 0 (SIM_PCE)

Table 14-6. Abbreviation Field Descriptions

Field	Description
15 CMP2	CMP2 IP bus Clock Enable
14 CMP1	CMP1 IP bus Clock Enable
13 CMP0	CMP0 IP bus Clock Enable
12 ADC1	ADC1 IP bus Clock Enable
11 ADC0	ADC0 IP bus Clock Enable
10 PGA1	PGA1 IP bus Clock Enable
9 PGA0	PGA0 IP bus Clock Enable
8 I2C	I2C IP bus Clock Enable
7 SCI	SCI IP bus Clock Enable
6 SPI	SPI IP bus Clock Enable
5 PWM	PWM IP bus Clock Enable
4 COP	COP Timer IP bus Clock Enable
3 PDB	Programmable Delay Block IP bus Clock Enable
2 PIT	Programmable Interval Timer IP bus Clock Enable
1 TA1	Quad Timer A Channel 1 IP bus Clock Enable
0 TA0	Quad Timer A Channel 0 IP bus Clock Enable. Each bit enables peripheral clocking to the indicated peripheral. 0 The corresponding peripheral is not clocked 1 The corresponding peripheral is clocked

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14.2.2.8 Stop Disable Register (SIM_SDR)

By default, peripheral clocks are disabled during stop mode in order to maximize power savings. The stop disable controls in SD act to override the individual peripheral clocks so that they continue to operate in stop mode. Because asserting an interrupt causes the system to return to run mode, this feature is provided so that selected peripherals can be left operating in stop mode for the purpose of generating a wakeup interrupt.

For power-conscious applications it is recommended that only a minimum set of peripherals be configured to remain operational during stop mode.

Peripherals should be put in a non-operating (disabled) configuration prior to entering stop mode unless their corresponding stop disable control is set to 1. Refer to the peripheral user guide for further details. IP bus reads and writes cannot be made to a module that has its clock disabled.

The SD register controls have lower precedence than the SIM_PCE (peripheral clock enable) register controls. If the peripheral's SIM_PCE control is set to 0, the peripheral clock is disabled in all modes including stop mode.

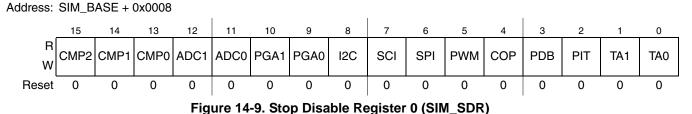


Table 14-7. Stop Disable Register 0 (SIM SDR) Descriptions

Field Description

15 CMP2	CMP2 IP bus Stop Disable
14 CMP1	CMP1 IP bus Stop Disable
13 CMP0	CMP0 IP bus Stop Disable
12 ADC1	ADC1 IP bus Stop Disable
11 ADC0	ADC0 IP bus Stop Disable
10 PGA1	PGA1 IP bus Stop Disable
9 PGA0	PGA0 IP bus Stop Disable
8 I2C	I2C IP bus Stop Disable
7 SCI	SCI IP bus Stop Disable

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Table 14-7. Stop Disable Register 0 (SIM_SDR) Descriptions (continued)

Field	Description
6 SPI	SPI IP bus Stop Disable
5 PWM	PWM IP bus Stop Disable
4 COP	COP Timer IP bus Stop Disable
3 PDB	Programmable Delay Block IP bus Stop Disable
2 PIT	Programmable Interval Timer IP bus Stop Disable
1 TA1	Quad Timer A Channel 1 IP bus Stop Disable
0 TA0	Quad Timer A Channel 0 IP bus Stop Disable. Each bit enables peripheral clocking to the indicated peripheral. 0 The corresponding peripheral is not clocked. 1 The corresponding peripheral is clocked during stop.

14.2.2.9 I/O Short Address Location Register (SIM_ISAL)

The I/O short address location registers are used to specify the memory referenced via the I/O short address mode. The I/O short address mode allows the instruction to specify the lower six bits of address and the upper address bits are not directly controllable. This register allows limited control of the full address, as shown in Figure 14-10.

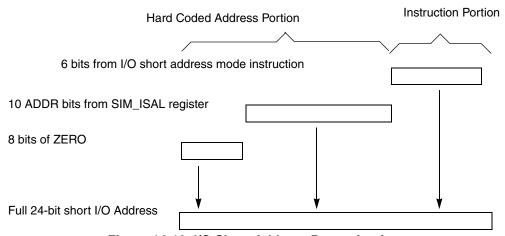


Figure 14-10. I/O Short Address Determination

With this register set, an interrupt driver can set the SIM_ISAL register to point to its peripheral registers and then use the I/O short addressing mode to reference them. The ISR should restore this register to its previous contents prior to returning from interrupt.

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NOTE

The default value of this register points to the beginning of the on-chip peripheral region at 0xF000.

The pipeline delay between setting this register set and using short I/O addressing with the new value is 5 cycles.

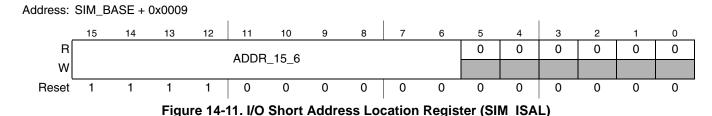


Table 14-8. I/O Short Address Location Register (SIM_ISAL)Descriptions

Field	Description																					
15–6 ADDR_	The I/O short address is calculated as shown below. For instance, to point to 0xF400 (the HFM on this device), write 0xF400 to SIM_ISAL.																					
15_6	Below is a calculati	ion	of th	ne ba	ase	addı	ress	for	shoı	rt I/O	ado	dress	ing.									
	-	23	22	21	20	19	18	17	16	15	14	13	12 1	11 -	10	9 8	7 6	5	4 3	2	1 0	
		0	0	0	0	0	0	0	0			AD	DR[15:6	6]			0	0 0	0	0 0	
5–0	Reserved																					

14.2.2.10 Protection Register (SIM PROT)

This register provides write protection of selected control fields for safety critical applications. The primary purpose is to prevent unsafe conditions due to the unintentional modification of these fields in the time between the onset of a code runaway and a reset by the COP watchdog. GPIO and internal peripheral select protection (GIPSP) write-protect the registers in the SIM and GPIO modules that control inter-peripheral signal muxing and I/O cell configuration. Peripheral clock enable protection (PCEP) write-protects the SIM registers that contain peripheral-specific clock controls. Some peripherals provide additional safety features. Refer to peripheral specifications for details.

GIPSP protects the contents of the SIM registers that control muxing of peripheral signals onto GPIO (GPSn) and the SIM registers that select between optional peripheral inputs (IPSn). GIPSP also write-protects some registers in the GPIO module. These include the GPIO_X_PER registers that select between peripheral or GPIO ownership of the I/O cell, the GPIO_X_PPMODE registers that control the I/O cell's push/pull mode, and GPIO_X_DRIVE registers that control the I/O cell's drive strength.

PCEP write-protects the SIM peripheral clock enable registers (PCEn), the SIM peripheral stop disable registers (SDn), and the SIM peripheral clock rate registers (SIM_PCR).

Flexibility is provided so that write-protection control values may themselves be optionally locked (write-protected). To this end, protection controls in this register have two bit values. The right bit determines the setting of the control, and the left bit determines whether the value is locked. While a

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protection control remains unlocked, protection can be disabled and re-enabled at will. After a protection control is locked, its value can be altered only by a chip reset that restores its default non-locked value.

Address: SIM_BASE + 0x000A

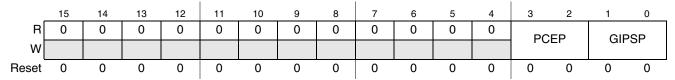


Figure 14-12. Protection Register (SIM_PROT)

Table 14-9. Protection Register (SIM_PROT) Descriptions

Field	Description
15–4	Reserved
3, 2 PCEP	Peripheral Clock Enable Protection. Enables write protection of all fields in the PCEn, SDn, and SIM_PCR registers. 00 — Write protection off (default) 01 — Write protection on 10 — Write protection off and locked until chip reset 11 — Write protection on and locked until chip reset
1, 0 GIPSP	GPIO and Internal Peripheral Select Protection. Enables write protection of GPSn and IPSn registers. Also write-protects all GPIO_X_PER, GPIO_X_PPMODE, GPIO_X_DRIVE, GPIO_X_SLEW and GPIO_X_IFE registers. 00 — Write protection off (default) 01 — Write protection on 10 — Write protection off and locked until chip reset 11 — Write protection on and locked until chip reset

14.2.2.11 GPIO Peripheral Select Registers (GPSn)

Most I/Os have an associated GPIO that, when enabled, can control and observe the I/O pad. In addition to the GPIO function, many I/Os can be configured to control one of several peripheral functions. To select between peripheral or GPIO control of the I/O, one must program the GPIO_X_PER register within the GPIO module. When the GPIO_X_PER bit for the I/O is 0, the GPIO has control of the I/O. When the GPIO_X_PER bit of the GPIO is 1, the fields in the GPSn registers select which peripheral function has control of the I/O. The output path to an I/O pad for the case where an I/O has two peripheral functions is illustrated in Figure 14-13. Similar muxing is required on peripheral function inputs to receive input from the properly selected I/O.

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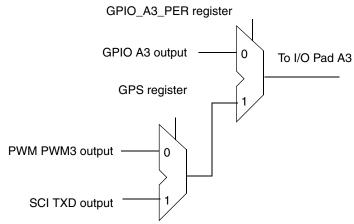


Figure 14-13. Overall Control of I/O Pads Using GPS Control

In some cases, the user must choose between several I/Os, each of which has the option to be programmed to control a specific peripheral function. If the user wishes to use that function, it is required that one and only one of these I/Os be configured to control that peripheral function. If more than one I/O is configured to control the peripheral function, the peripheral output signal fans out to each I/O but the peripheral input signal is the logical OR or AND of all the I/O signals. The user may, of course, opt not to use a function. If no I/O is configured to control a peripheral function, then the peripheral output signal is inaccessible and the peripheral input signal is tied to an application-appropriate constant value.

The registers that follow are organized by GPIO bank. A field is provided to select the peripheral function of each I/O in that GPIO bank that has more than one alternative peripheral function. Inputs specific to one peripheral function do not have a select list in the GPIO. Complete lists of GPIO-to-peripheral and peripheral-to-peripheral connections are provided in the module details section of the chip specification.

GPSn settings should not be altered while an affected peripheral is in an enabled (operational) configuration.

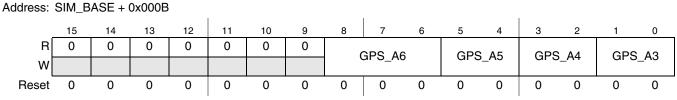


Figure 14-14. GPIO Peripheral Select Register for GPIOA (SIM_GPSA)

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Table 14-10. GPIO Peripheral Select Register for GPIOA (SIM_GPSA) Descriptions

Field	Description						
15–9	Reserved						
8–6 GPS_A6	Configure G	PIO A6.					
GFS_A6		Field Value	Function	Peripheral	Direction		
		000	FAULT0	PWM	Input		
		001	ANA1 & ANB1	ADC A, ADC B	Analog Input		
		010	SCL	I ² C	Input / Output		
		011	TXD	SCI	Input / Output		
		100	CLKO_1	SIM	Output		
		101, 110, 111		Reserved			
5–4	Configure G	PIO A5.					
GPS_A5		Field Value	Function	Peripheral	Direction		
		00	PWM5	PWM	Output		
		01	FAULT2	PWM	Input / Output		
		10	TIN3	General Purpose Timer	Input		
		11		RESERVED			
3, 2	Configure GPIO A4						
		Field Value	Function	Peripheral	Direction		
		00	PWM4	PWM	Output		
		01	SDA	I ² C	Input / Output		
		10	FAULT1	PWM	Input		
		11	TIN2	General Purpose Timer	Input		
1, 0	Configure G	PIO A3. This field se	elects the alternate fun	ction for GPIO A3.			
GPS_A3		Field Value	Function	Peripheral	Direction		
		00	PWM3	PWM	Output		
		01	TXD	SCI	Input / Output		
		10	EXTAL	Crystal Oscillator	Analog Output		
		11		RESERVED	<u> </u>		

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Address: SIM_BASE + 0x000C

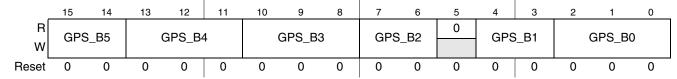


Figure 14-15. GPIO Peripheral Select Register 0 for GPIOB (SIM_GPSB0)

Table 14-11. GPIO Peripheral Select Register 0 for GPIOB (SIM_GPSB0) Descriptions

Field	Description						
15, 14	Configure GPIO B5.						
GPS_B5		Field Value	Function	Peripheral	Direction		
		00	T1	General Purpose Timers	Input / Output		
		01	FAULT3	PWM	Input		
		10	SCLK	SPI	Input / Output		
		11	Reserved				
13–11	Configure G	PIO B4.					
GPS_B4		Field Value	Function	Peripheral	Direction		
		000	T0	General Purpose Timers	Input / Output		
		001	CLKO_0	SIM	Output		
		010	MISO	SPI	Input / Output		
		011	SDA	I ² C	Input / Output		
		100	RXD	SCI	Input		
		101	ANA0 & ANB0	ADC A & ADC B	Analog Input		
		110, 111	Reserved				
10–8	Configure G	PIO B3.					
GPS_B3		Field Value	Function	Peripheral	Direction		
		000	MOSI	SPI	Input / Output		
		001	TIN3	General Purpose Timers	Input		
		010	ANA3 & ANB3	ADC A & ADC B	Analog Input		
		011	PWM5	PWM	Output		
		100	CMP1_OUT	Comparator 1	Output		
		101, 110, 111		RESERVED			

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Table 14-11. GPIO Peripheral Select Register 0 for GPIOB (SIM_GPSB0) Descriptions (continued)

Field			Desc	ription			
7, 6 GPS_B2	Configure GPIO B2						
ai 0_b2		Field Value	Function	Peripheral	Direction		
		00	MISO	SPI	Input / Output		
		01	TIN2	General Purpose Timers	Input		
		10	ANA2 & ANB2	ADC A & ADC b	Analog Input		
		11	CMP0_OUT	Comparator 0	Output		
5	Reserved.						
4, 3	Configure GPIO B1						
GPS_B1		Field Value	Function	Peripheral	Direction		
		00	SSB	SPI	Input / Output		
		01	SDA	I ² C	Input / Output		
		10	ANA12 / CMP2_P3	ADC A / Comparator 2	Analog Input		
		11		Reserved			
2–0 GPS_B0	Configure G	PIO B0					
5 5 <u>_</u> =5		Field Value	Function	Peripheral	Direction		
		000	SCLK	SPI	Input		
		001	SCL	l ² C	Input / Output		
		010	ANB13	ADC B	Analog Input		
		011	PWM3	PWM	Output		
		100	T1	General Purpose Timers	Input / Output		
		101, 110, 111		Reserved			

Address: SIM_BASE + 0x000D

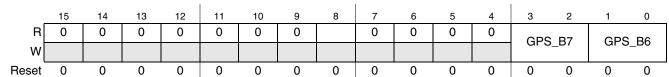


Figure 14-16. GPIO Peripheral Select Register 1 for GPIOB (SIM_GPSB1)

Table 14-12. GPIO Peripheral Select Register 1 for GPIOB (SIM_GPSB1) Descriptions

Field			Desc	ription	
15–4	Reserved				
3, 2 GPS_B7	Configure G	iPIO B7.			
ar o_br		Field Value	Function	Peripheral	Direction
		00	TXD	SCI	Input / Output
		01	SCL	l ² C	Input / Output
		10	CMP2_M3 / ANA11	Comparator 2 / ADC A	Analog Input
		11		RESERVED	
0, 1 GPS_B6	Configure G	PIO B6.			
GI 3_B0		Field Value	Function	Peripheral	Direction
		00	RXD	SCI	Input
		01	SDA	I ² C	Input / Output
		10	CMP0_P2 / ANA13	Comparator 0 / ADC A	Analog Input
		11	CLKIN	_	Input

Address: SIM_BASE + 0x000E

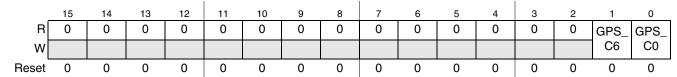


Figure 14-17. GPIO Peripheral Select Register for GPIOC (SIM_GPSC)

Table 14-13. GPIO Peripheral Select Register for GPIOC (SIM_GPSC) Descriptions

Field	Description
15–2	Reserved

Table 14-13. GPIO Peripheral Select Register for GPIOC (SIM_GPSC) Descriptions (continued)

Field	Description							
1 GPS_C6	Configure GPIO C6.							
di 0_00		Field Value	Function	Peripheral	Direction			
		0	ANB4 / CMP1_P1	ADC B / Comparator 1	Analog Input			
		1	PWM2	PWM	Output			
0 GPS_C0	Configure G	iPIO C0.						
GI 0_00		Field Value	Function	Peripheral	Direction			
		0	ANA5 / CMP1_M1	ADC A / Comparator 1	Analog Input			
		1	FAULT0	PWM	Input			

Address: SIM_BASE + 0x000F

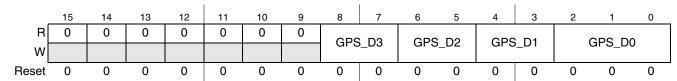


Figure 14-18. GPIO Peripheral Select Register for GPIOD (SIM_GPSD)

Table 14-14. GPIO Peripheral Select Register for GPIOD (SIM_GPSD) Descriptions

Field	Description							
15–9	Reserved							
8, 7 GPS_D3	Configure GPIO D3.							
o o		Field Value	Function	Peripheral	Direction			
		00	TMS	JTAG	Input			
		01	ANB11	ADC B	Analog Input			
		10	T1	General Purpose Timers	Input / Output			
		11	CMP1_OUT	Comparator 1	Output			

Table 14-14. GPIO Peripheral Select Register for GPIOD (SIM_GPSD) Descriptions (continued)

Field	Description								
6, 5 GPS_D2	Configure GPIO D2.								
GI 0_52	Field Value		Function	Peripheral	Direction				
		00	TCK	JTAG	Input				
		01	ANA4/CMP1_P2	ADC A / Comparator 2	Analog Input				
		10	CMP1_OUT	Comparator 2	Output				
		11		RESERVED					
	In some pac	ckages, D2 is not us	sable as TCK.						
4, 3 GPS_D1	Configure GPIO D1.								
GI 3_D1		Field Value	Function	Peripheral	Direction				
		00	TDO	JTAG	Output				
		01	ANB10	ADC B	Analog Input				
		10	T0	General Purpose Timers	Input / Output				
		11	CMP2_OUT	Comparator 2	Output				
2-0	Configure G	iPIO D0.							
GPS_D0		Field Value	Function	Peripheral	Direction				
		000	TDI	JTAG	Input				
		001	ANB12	ADC B	Analog Input				
		010	SSB	SPI	Input / Output				
		011	TIN2	General Purpose Timers	Input				
		100	CMP0_OUT	Comparator 0	Output				
		101, 110, 111		RESERVED					

14.2.2.12 Internal Peripheral Select Registers (IPSn)

The internal integration of peripherals provides situations where an input to a peripheral can be fed from one of several sources. These registers are organized by peripheral type and provide a selection list for every peripheral input that has more than one alternative source to indicate which source is selected.

In cases where one of the alternative sources is GPIO, the setting in these registers must be made consistently with the settings in the GPSn and GPIO_X_PER registers. Specifically, whenever an IPSn field is configured to select GPIO as the source, then GPSn register settings must configure one (and only one) GPIO to feed this peripheral input function. Also, the GPIO_X_PER bit for that GPIO must be set to 1 to enable peripheral control (and disable GPIO control) of the I/O.

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Peripheral inputs that only come from one source do not have a select list in this register because the connection is implicit. Likewise, when a GPIO connects to a single peripheral function, then the connection is again implicit and GPSn does not include a selection field for that GPIO. Complete tables of GPIO-to-peripheral and peripheral-to-peripheral connections, including any such implicit connections, are provided in the module details section of this specification.

If a peripheral input function is configured in IPSn to be fed from GPIO (or implicitly comes from GPIO) but no GPIO is configured using GPSn to feed this peripheral input (or implicitly feeds it), then an appropriate constant signal is applied to the input.

IPSn settings should not be altered while an affected peripheral is in an enabled (operational) configuration. See the peripheral user guide for further details.

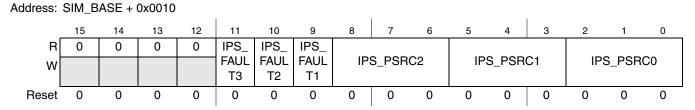


Figure 14-19. Internal Peripheral Select Register 0 (SIM_IPS0)

Table 14-15. Internal Peripheral Select Register 0 (SIM_IPS0) Descriptions

Field	Description								
15–12	Reserved								
11 IPS_	Select the alternate in	nput source to feed	PWM FAULT3 input.						
FAULT3		Field Value	Function	Peripheral					
		0	Package Pin	GPIO B5					
		1	CMP2_OUT	Comparator 2					
10 IPS_									
FAULT2		Field Value	Function	Peripheral					
		0	Package Pin	GPIO A5					
		1	CMP1_OUT	Comparator 1					
9 IPS_	Select the alternate in	nput source to feed	PWM FAULT1 input.						
FAULT1		Field Value	Function	Peripheral					
		0	Package Pin	GPIO A4					
		1	CMP0_OUT	Comparator 0					
				•					

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Table 14-15. Internal Peripheral Select Register 0 (SIM_IPS0) Descriptions (continued)

Field		Description					
8–6 IPS_	Select alternate input source to feed the PWM PSRC[2] input.						
PSRC2		Field Value	Function	Peripheral			
		000	CMP0_OUT	Comparator 0			
		001	CMP1_OUT	Comparator 1			
		010	CMP2_OUT	Comparator 2			
		011	T0	General Purpose Timer Channel 0			
		100	T1	General Purpose Timer Channel 0			
		101, 110, 111		Reserved			
5–3 IPS_	Select alternate	input source to feed	d the PWM PSRC[1] inp	put.			
PSRC1		Field Value	Function	Peripheral			
		000	CMP0_OUT	Comparator 0			
		001	CMP1_OUT	Comparator 1			
		010	CMP2_OUT	Comparator 2			
		011	T0	General Purpose Timer Channel 0			
		100	T1	General Purpose Timer Channel 0			
		101, 110, 111		Reserved			
2-0 IPS_	Select alternate	input source to feed	d the PWM PSRC[0] inp	out.			
PSRC0		Field Value	Function	Peripheral			
		000	CMP0_OUT	Comparator 0			
		001	CMP1_OUT	Comparator 1			
		010	CMP2_OUT	Comparator 2			
		011	T0	General Purpose Timer Channel 0			
		100	T1	General Purpose Timer Channel 0			
		101, 110, 111		Reserved			

Address: SIM_BASE + 0x0011

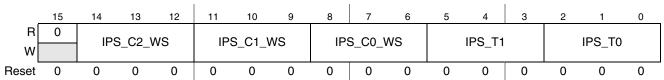


Figure 14-20. Internal Peripheral Select Register 1 (SIM_IPS1)

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Table 14-16. Internal Peripheral Select Register 1 (SIM_IPS1) Descriptions

Field	Description							
15	Reserved							
14–6 GPS_C6	IPS_C2_WS, IPS_C1_WS, IPS_C0_WS — Select the WINDOW/SAMPLE input for comparators 2, 1, and 0 respectively. Each of the three fields has the same options, as described below.							
		Field Value	Function	Peripheral				
		000	T0	General Purpose Timer 0 output				
		001	T1	General Purpose Timer 1 output				
		010	TriggerA	PDB				
		011	TriggerB	PDB				
		1XX	Logic Zero	Tied Low				
5–3	Select alternate in	nput source to feed	the Timer T1 input.					
IPS_T1		Field Value	Function	Peripheral				
		000	Package Pin	GPIO B0, B5 or D3 as defined in Section 14.2.2.11, GPIO Peripheral Select Registers (GPSn)				
		001	CMP0_OUT	Comparator 0				
		010	CMP1_OUT	Comparator 1				
		011	CMP2_OUT	Comparator 2				
		100	Reload-Sync	PWM				
	Note: If PWM_CF	is set then TMR_0	CR must also be set in	order for TMR to detect the Reload-Sy	nc signal.			
2–0 IPS_T0	Select alternate is	nput source to feed	the Timer T0 input.					
		Field Value	Function	Peripheral				
		000	Package Pin	GPIO B4 or D1 as defined in Section 14.2.2.11, GPIO Peripheral Select Registers (GPSn)				
		001	CMP0_OUT	Comparator 0				
		010	CMP1_OUT	Comparator 1				
		011	CMP2_OUT	Comparator 2				
		100	Reload-Sync	PWM				
	Note: If PWM_CI	R is set then TMR_C	CR must also be set in	order for TMR to detect the Reload-Sy	nc signal.			

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14.3 Functional Descriptions

14.3.1 Clock Generation Overview

The SIM uses master clocks from the OCCS module to produce the peripheral and system (DSC core and memory) clocks. A 3x master clock input from OCCS operates at three times the system and peripheral bus rate and therefore a maximum of 96 MHz. A 2x(_b) clock input from OCCS operates two times the system and peripheral bus rate and therefore a maximum of 64 MHz. Peripheral and system clocks are generated at a maximum of 32 MHz by dividing the 2x master clock by 2 and gating it with appropriate power mode and clock gating controls. The PWM, TMR, and SCI peripheral clocks can optionally be generated at three times the normal rate at a maximum 96 MHz. These clocks are generated by gating the 3x master clock with appropriate power mode and clock gating controls.

The OCCS configuration controls the operating frequency of the SIM master clocks. In the OCCS, either an external clock (CLKIN), a crystal oscillator, or the relaxation oscillator can be selected as the master clock source (master clock). An external clock can be operated at any frequency up to 64 MHz. The crystal oscillator can only be operated at 8 MHz. The relaxation oscillator can be operated at full speed (8 MHz), standby speed (400 kHz using ROSB), or powered down (using ROPD). An 8 MHz master clock can be multiplied to 196 MHz using the PLL and post-scaled to provide a variety of high speed clock rates. Either the post-scaled PLL output or master clock signal can be selected to produce the master clocks to the SIM. When the PLL is selected, the 3x clock is the post-scaled PLL/2 and the 2x clock is the post-scaled PLL/3. When the PLL is not selected, the 3x clock is disabled and the 2x clock is master clock.

In combination with the OCCS module, the SIM provides power modes (see next section), clock enables (PCEn registers, SDn registers, CLK_DIS, ONCE_EBL), and clock rate controls (TMR_CR, PWM_CR, SCI_CR) to provide flexible control of clocking and power use. The SIM's PCEn peripheral clock enable controls can be used to disable individual peripheral clocks when not needed. The clock rate controls enable the high speed clocking option for the general purpose timers (TMR) and the PWM, but require the PLL to be on and selected. See the OCCS manual and other peripheral manuals for further details.

14.3.2 Power-Down Modes Overview

The 56800E DSC core operates in one of the power-down modes shown in Table 14-17.

Table 14-17. Clock Operation In Power-Down Modes

Mode	System Clocks Peripheral Clocks		Description
Run	Core and memory clocks enabled.	Peripheral clocks enabled	Device is fully functional.

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Table 14-17. Clock Operation In Power-Down Modes (continued)

Mode	System Clocks Peripheral Clocks		Description
Wait	Core and memory clocks disabled.	Peripheral clocks enabled.	Core executes WAIT instruction to enter this mode. Wait mode is typically used for power-conscious applications. Possible recoveries from wait mode to run mode are: • Any interrupt. • Executing a debug mode entry command using the DSC core JTAG interface. • Any reset (POR, external, software, COP).
Stop	Master clock generation in the OCCS remains operational, but the SIM disables the generation of system and peripheral clocks.		Core executes STOP instruction to enter this mode. Possible recoveries from stop mode to run mode are: Interrupt from any peripheral configured in SD register to operate in stop mode. See Section 14.2.2.8, "Stop Disable Register (SIM_SDR)," for details. Low voltage interrupt. Executing a debug mode entry command using the DSC core JTAG interface. Any reset. See Section 14.4, "Resets" for details.

Run, wait, and stop modes provide means of enabling/disabling the peripheral and/or core clocking as a group. Stop disable controls in the SDn registers to override the default behavior of stop mode. By asserting a peripherals STOP disable bit, the peripheral clock continues to operate in stop mode. This is useful to generate interrupts that recover the part from stop mode to run mode.

On-chip peripherals (with the possible exception of the COP/watchdog timer and ADCs/PGAs) run at the IP bus clock (peripheral bus) frequency¹, which is the same as the main processor frequency in this architecture. The maximum frequency of operation is sys_clk = 32 MHz. The only exceptions are the general purpose timers PWM and SCI, which can be configured to operate at three times the system bus rate using TMR_CR, SCI_CR, and PWM_CR controls, provided the PLL is active and selected.

Run, wait, and stop modes may be combined with the low-power modes of the PMC and choice of clocks to provide a broad pallette of power control techniques. See and Chapter 15, "Power Management Controller (PMC)," for additional details.

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^{1.} The TMR and PWM modules can be operated at three times the IP bus clock frequency.

14.3.3 Stop and Wait Mode Disable Function

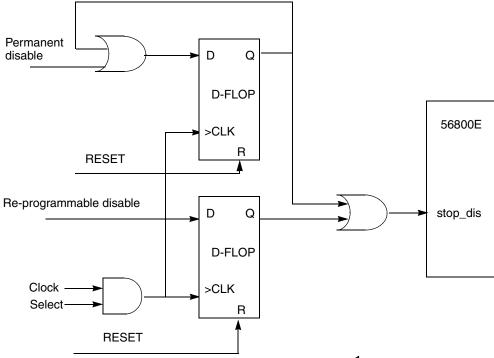


Figure 14-21. STOP Disable Circuit¹

The DSP56800E core contains both STOP and WAIT instructions. Both put the DSC core to sleep. The peripheral bus continues to run in wait mode, but in stop mode, only peripherals whose SDn control has been asserted continue to run. Entry into stop mode or wait mode does not affect the OCCS configuration and affects only the generation of system and peripheral clocks from the master clocks from the OCCS. The OCCS may be reconfigured prior to entering stop mode or wait mode, if desired, to reduce master clock frequencies and thus the power use within the OCCS.

Some applications require the 56800E STOP/WAIT instructions to be disabled. Control fields are provided in the SIM_CTRL register to disable wait mode and/or stop mode. This procedure can be on either a permanent (until reset) or temporary basis.

If the stop mode is disabled via this mechanism, the user is unable to enter partial power-down mode.

14.4 Resets

The SIM supports seven sources of reset as shown in Table 14-18 and Figure 14-22.

 Label
 Source of Reset
 Timing

 EXTR
 External Reset
 Asynchronous

 POR
 Power-On-Reset (PMC)
 Asynchronous

Table 14-18. Sources of Reset

1. WAIT disable circuit is similar

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Table 14-18. Sources of Reset (continued)

Label	Source of Reset	Timing
PPD	Recovery from Partial Power-Down Mode (PMC)	Asynchronous
COP_CPU	COP DSC core reset	Synchronous
COP_LOR	COP Loss of Reference reset	Synchronous
LVDR	Low voltage detect reset (PMC)	Synchronous
SWR	Software reset (SIM)	Synchronous

The reset generation module has three reset detectors that resolve into four primary resets (excluding test modes). These are outlined in Table 14-19. The first column lists the four primary resets that are calculated. The JTAG circuitry is reset by the power-on reset. Columns two through five indicate what reset sources trigger these signals. The last column provides additional detail.

Table 14-19. Primary System Resets

Reset Signal	POR PPD	EXTR	SWR COP_CPU COP_LOR LVDR	Comments
extended_por_b	Х	_	_	Stretched version of por_b released 64 OSC_CLK cycles after POR deasserts.
clkgen_rst_b	Х	Х	Х	Releases 32 OSC_CLK cycles after all reset sources including extend POR have released.
perip_rst_b	Х	Х	Х	Releases 32 SYS_CLK cycles after the clkgen_rst_b is released.
core_rst_b	Х	Х	Х	Releases 32 SYS_CLK cycles after perip_rst_b is released.

Figure 14-22 provides a graphic illustration of the details in Table 14-19. Note that the POR_Delay blocks use osc_clk as their time base, because other system clocks are inactive during this phase of reset.

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extended_por_b **JTAG** Power on por b reset and pulse shaper PPD Memory Delay 64 Sub-system master clock (active low) clocks clkgen rst b occs External combined_rst_b reset b in Delay 32 reset_b Peripherals perip_rst_b (active low master clock clocks pulse shaper Delay 32 sys clocks COP_CPU **DSC Core** pulse shaper LVDR (active low) SW Reset Delay 32 sys clocks pulse shaper Delay blocks assert immediately and de-assert only after the programmed number of clock cycles. core_rst_b

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Figure 14-22. Sources of Reset Functional Diagram (Test Modes Not Included)

POR resets are extended 64 master clocks to stabilize the power supply and clock source. All resets are subsequently extended for an additional 32 master clocks and 64 system clocks as the various internal reset controls are released. Given the normal relaxation oscillator rate of 8 MHz, the duration of a POR reset from power on to code running is 28 μs. An external reset generation chip may also be used. Resets may be asserted asynchronously, but they are always released internally on a rising edge of the system clock. A description of how these resets are used to initialize the clocking system and system modules is included in section Section 14.5, "Clocks".

14.5 Clocks

The memory, peripheral, and DSC core clocks all operate at the same frequency (32 MHz max) with the exception of the peripheral clocks for general-purpose timers, PWM and SCI, which have the option (using TMR_CR, SCI_CR, and PWM_CR) to operate three times faster. The SIM is responsible for stalling individual clocks as a response to holdoff requests from system bus slaves, low power modes, and other configuration parameters. The SIM has access to the following signals from the OCCS module:

- Master clock. This comes from the input clock source mux of the OCCS. It is the output of the crystal oscillator, the relaxation oscillator, or the external clock source depending on PRECS. It is not guaranteed to be at 50% duty cycle (±10% can probably be assumed for design purposes). This clock runs continuously, even during reset. It is used for reset generation.
- 3x master clock. The PLL multiplies the master clock by 24 to a maximum 192 MHz. The ZSRC field in OCCS selects the active source to be the PLL. This is divided by two and postscaled to

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System Integration Module (SIM)

- produce this maximum 96 MHz clock. It is used without further division to produce the high speed (3x system bus rate) variants of the TMRA, SCI, and PWM peripheral clocks. This clock is disabled when ZSRC is selecting master clock.
- 2x(_b). The PLL can multiply the master clock by 24 to a maximum 192 MHz. When the PLL is selected by the OCCS ZSRC field, the PLL is divided by three and postscaled to produce this maximum 64 MHz clock. When the master clock is selected by the OCCS ZSRC field, the master clock feeds the 2x master clock directly. The SIM takes this clock and divides it by two to generate all the normal (1x system bus rate) peripheral and system clocks.

The deassertion sequence of internal resets is used to coordinate the startup of the part, including the startup of the clocking system. The sequence is described in the next steps.

- 1. As power is applied, the relaxation oscillator starts to operate. When a valid operating voltage is reached, the POR reset releases.
- 2. The release of POR reset permits operation of the POR reset extender. The POR extender generates an extended POR reset, which is released 64 OSC_CLK cycles after POR reset. This provides an additional time period for the clock source and power to stabilize.
- 3. A combined reset consists of the OR of the extended POR reset and other reset sources. The entire part, except for the POR extender, is held reset as long as combined reset is asserted. The release of combined reset permits operation of the SIM_CTRL register, the synchronous reset generator, and the Clkgen reset extender.
- 4. The synchronous reset generator generates a reset to the software and COP reset logic. The COP and software reset logic is released three OSC_CLK cycles after combined reset deasserts. This provides a reasonable minimum duration to the reset for these specialized functions.
- 5. The Clkgen reset extender generates the Clkgen reset used by the clock generation logic. The Clkgen reset is released 32 OSC_CLK cycles after combined reset deasserts. This provides a window in which the SIM stabilizes the master clock inputs to the clock generator.
- 6. The release of Clkgen reset permits operation of the clock generation logic and the peripheral reset extender. The peripheral reset extender generates the peripheral reset, which is released 32 SYS_CLK cycles after Clkgen reset. This provides a window in which peripheral and core logic remain clocked but in reset, so that synchronous resets can be resolved.
- 7. The release of peripheral reset permits operation of the peripheral logic and the core reset extender. The core reset extender generates the core reset, which is released 32 SYS_CLK cycles after the peripheral reset. This provides a window in which critical peripheral startup functions such as flash security in the hfm can be implemented.
- 8. The release of Core reset permits execution of code by the DSC core and marks the end of the system startup sequence.

14.6 Interrupts

The SIM generates no interrupts.

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Chapter 15 Power Management Controller (PMC)

15.1 Overview

A sophisticated power management controller (PMC) provides regulated output voltages for consumption by both digital and analog blocks. A partial power-down mode (PPD) is provided to place the device into a state that consumes approximately 1 μ A at 3 V V_{DD}, while still preserving key state information in the RAM. In PPD mode, the I/O, RAM, PMC, and COP remain powered. The ROSC and COSC remain powered, but may be shut off if desired. All other logic and analog supplies are switched to zero volts during PPD mode.

Figure 15-1 illustrates the various power modes available on this device, along with the allowable transitions between them.

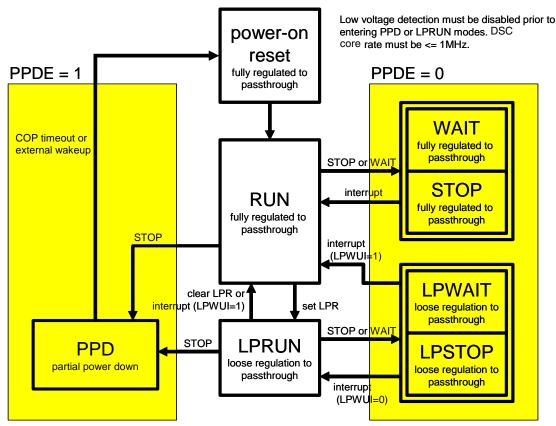


Figure 15-1. MC56F8006 Power Modes

Table 15-1 lists the various modes, PMC settings required for entry, clock settings, and switched power settings.

Table 15-1. PMC-Based DSC Core / Power Mode Selections¹

Mode of Operation	LVDE	LPR	PPDE	DSC Core and Peripheral Clocks	Switched Power
Run mode - processor and peripherals clocked normally.	х	0	х	On	On
LPrun mode with low voltage detect disabled — processor and peripherals clocked at low frequency ² . Low voltage detects are not active.	0	1	х	Low freq required	Loose Reg
Wait mode — processor clock nominally inactive, but peripherals are clocked.	х	0	х	Periph clocks on DSC core clock off	On
LPwait mode — processor clock is inactive, peripherals are clocked at low frequency and the PMC is loosely regulating. Low voltage detects must not be enabled.	0	1	x	Low freq required Periph clocks on DSC core clock off	Loose Reg
Stop — Low power modes have not been requested, low voltage detects may be enabled.	х	0	0	Off, but clock source at any frequency	On
LPstop — Low voltage detect in stop is not enabled. Clocks must be at low frequency and are gated. The regulator is in loose regulation.	0	1	0	Off Low freq clock source required	Loose Reg
Partial power-down mode	0	х	1	N/A	Off

¹ It is the responsibility of the user software to enforce LVDE restrictions shown in this table.

15.2 Features

- Separate digital (regulated) and analog (referenced to digital) supply outputs.
- Both analog and digital supply outputs are available in switched and unswitched versions. The unswitched versions are always powered. Switched versions go to zero volts during PPD mode.
- No output supply decoupling capacitors required.
- Programmable power saving modes.
- Available wakeup from PPD mode via external input or COP timeout.
- Integrated power-on reset (POR).
- Integrated out-of-regulation detection with interrupt capability.
- Integrated low voltage detect (LVD) with reset (brownout) or interrupt capability.
- Programmable LVD trip points.
- Buffered bandgap reference voltage output.
- Integrated 1 kHz oscillator.

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² 1 MHz maximum system clock frequency in LPrun, LPwait, and LPstop.

15.3 Power Management Methodologies

This device supports a broad range of power management methodologies that can be used singly, or in combination:

- The 56800E core instruction set includes WAIT and STOP instructions:
 - During wait mode, the processor clocks are disabled. Peripheral clocks continue to run.
 - During stop mode, both peripheral and DSC core clocks are normally disabled.
- Individual peripheral clocks can be enabled/disabled via the peripheral clock enable (PCE) registers in the system integration module (SIM).
- The following analog functions can be powered down when not in use:
 - Relaxation oscillator
 - Crystal oscillator
 - ADCs
 - PGAs
 - PLL
 - Comparators
 - Bandgap references
 - LVD functions
- The relaxation oscillator, crystal oscillator, comparators, and programmable gain amplifier can be programmed for low power operation.
- Frequency control: run current for CMOS logic is directly proportional to frequency of operation. The OCCS module is capable of generating a large variety of system clock frequencies in order to precisely control run time power. See Chapter 13, "On-Chip Clock Synthesis (OCCS)", for details.
- Power consumption can be reduced simply by lowering the supply voltage. This affects maximum frequency of operation.
- Use PMC_SCR[LPR] to place the PMC in low-power mode. Again, observe limitations on system frequencies.
- Use PMC_SCR[PPDE], coupled with the STOP command, to place the device in partial power-down mode.

15.4 Initiating and Recovering from Partial Power-Down Mode

During partial power-down mode, most of the logic on the chip is powered down. Output signals are latched at the value that they had when PPD mode was entered. RAM continues to be powered, and retains its contents. RESET must be configured as input-only prior to entering partial power-down mode.

The overall sequence is as follows:

- Disable the following peripherals and place corresponding output pins in a safe state: PWM, general purpose timers, SPI, SCI, I²C.
- If not done already, configure \overline{RESET} as an input-only function.

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Power Management Controller (PMC)

- Store I/O state information and any other configuration data that must be restored upon exiting PPD mode in RAM.
- If you plan to use the COP to recover from PPD mode, then:
 - Configure and enable the clock source you wish to use for the COP (crystal oscillator or 1 kHz oscillator).
 - Program the COP to time out after a desired interval based upon the clock source configured above.
- Set PMC_SCR[PPDE] and clear PMC_SCR[LVDE].
- Assert STOP to enter partial power-down mode. I/O outputs are latched, and COP, RAM, PMC, and oscillator inputs placed into safe states for PPD mode.
- PPD mode can be exited via:
 - COP timeout already configured
 - RTC wakeup
 - External wakeup signal asserted on the RESET pin
- Device reboots. The boot vector at location 0x00 0000 is used as the entry point of the program. The COP vector (0x00 0002) is not taken, even if the COP timeout is used as the mechanism for existing PPD mode.
- If PMC_SCR[PPDF] is clear, boot normally. The PPD recovery sequence stops here.
- If PMC_SCR[PPDF] is set, then the code must initiate recovery from PPD process. All registers excluding the PMC_SCR have returned to their reset state as a result of the partial power-down.
 - Program GPIO based upon I/O state information previously loaded into RAM.
 - Re-initialize clocks, low voltage detects, etc. If the RTC is running from an external oscillator, it is especially important to re-initialize OCCS registers that configure that oscillator before clearing PMC_SCR[PPDF]. Also set GPSA[GPS_A3] to allocate GPIO A3 for use as the EXTAL pin.
 - If the RTC is being used to maintain a continuous timebase, check to see if RTC_SC[RTIF] has been set. If so, increment associated software-based time variables and clear RTIF.
 - Open the I/O latches by clearing PMC_SCR[PPDF].
 - Re-initialize peripherals and continue operation.

15.5 Power Management Controller Functional Operation

15.5.1 Power-On Reset Operation

When power is initially applied to the MCU, or when the supply voltage drops below the power-on reset re-arm voltage level, V_{POR} , the POR circuit causes a reset condition. As the supply voltage rises, the LVD circuit holds the MCU in reset until the supply has risen above the LVD low threshold, V_{LVDL} (approximately 1.8 V). Both PMC_SCR[PORF] and the PMC_SCR[LVDF] are set following a POR.

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15.5.2 Low-Voltage Detect (LVD) System

This device includes a system to protect against low-voltage conditions to protect memory contents and control MCU system states during supply voltage variations. The system is comprised of a power-on reset (POR) circuit and an LVD circuit with a user-selectable trip voltage, either high (V_{LVDH}) or low (V_{LVDL}) . The LVD circuit is enabled when PMC_SCR[LVDE] bit is set and the trip voltage is selected by PMC_SCR[LVDV]. The LVD circuit must be disabled when entering LPrun or partial power-down modes.

15.5.2.1 LVD Reset Operation

The LVD can be configured to generate a reset upon detection of a low-voltage condition by setting PMC_SCR[LVDRE] to 1. The low-voltage detection threshold is determined by the PMC_SCR[LVDV] bit. After an LVD reset has occurred, the LVD system holds the MCU in reset until the supply voltage has risen above the low-voltage detection threshold. PMC_SCR[LVDF] is set following either an LVD reset or POR.

15.5.2.2 LVD Interrupt Operation

When a low voltage condition is detected and the LVD circuit is configured using PMC_SCR for interrupt operation (LVDE set, LVDIE set, and LVDRE clear), then LVDF in PMC_SCR is set and an LVD interrupt request occurs. Assuming the low voltage condition no longer exists, PMC_SCR[LVDF] can be cleared by writing a "1" to it.

There are two user-selectable trip voltages for the LVDF, one high (V_{LVDH}) and one low (V_{LVDL}) . The trip voltage is selected by PMC_SCR[LVLS].

15.5.3 Out-of-Regulation (OOR) Interrupt Operation

PMC_SCR[OORF] is an Out-of-Regulation flag that indicates to the user that the supply voltage is approaching, but is above, the LVD voltage. The OORF also has an interrupt associated with it, enabled by setting the PMC_SCR[OORIE] bit. If enabled, an OORF interrupt request occurs when PMC_SCR[OORF] is set. Assuming the out-of-regulation condition no longer exists, PMC_SCR[OORF] can be cleared by writing a 1 to it.

15.6 PMC Programmer's Model

Table 15-2. PMC Module Memory Map

Address	Register Name	Access
PMC_BASE + 0	Status and control register (PMC_SCR)	Read/Write
PMC_BASE + 1	Control register 2 (PMC_CR2)	Read/Write

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15.6.1 PMC Status and Control Register (PMC_SCR)

This register contains status and control bits for the power management controller. It supports low-voltage warning and detect functions, partial power-down mode, low-power modes, and enable of the bandgap voltage reference uses by the ADC and other modules.

PMC_SCR is not reset when exiting from partial power-down mode.

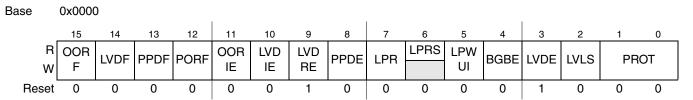


Figure 15-2. PMC Status and Control Register

Table 15-3. PMSC Register Field Descriptions

Field	Description
15 OORF	Out of Regulation Flag. Provided LVDE = 1, this status bit indicates that the external supply has dropped to the point where the internal voltage regulator is no longer in full regulation mode. This bit is "sticky." It remains set until cleared by writing a "1" to this bit. The bit can not be cleared until the supply is high enough for the regulator to be fully engaged. This bit reads as zero if LVDE = 0 and is cleared if LVDE is set to 0.
14 LVDF	Low-Voltage Detect Flag. Provided LVDE = 1, this status bit indicates that the low-voltage detection circuit has been triggered. This bit is "sticky." It remains set until cleared by writing a "1" to this bit. The bit is not cleared if the supply is still below low-voltage detection threshold. This bit is also set as a result of a power-on-reset sequence. This bit reads as zero if LVDE = 0 and is cleared if LVDE is set to 0.
13 PPDF	Partial Power-Down Flag. This bit indicates that the previous reset operation was associated with a recovery from partial power-down mode. This bit resets to zero under all other reset conditions. This bit should be cleared by writing a "1" to it. This bit must be cleared upon exiting PPD mode. Clearing this bit opens the I/O latches that were asserted when entering PPD mode.
12 PORF	Power-On Reset Flag. This bit indicates that the previous reset operation was the result of a power-on reset operation. This bit resets to zero under all other reset conditions. This bit should be cleared by writing a "1" to it. This bit is not set as a result of a recovery from the partial power-down mode.
11 OORIE	Out-of-Regulation Interrupt Enable. This bit enables hardware interrupt requests for OORF. 1 Hardware interrupt disabled (use polling). 2 Request a hardware interrupt when OORF = 1.
10 LVDIE	Low-Voltage Detect Interrupt Enable. This bit enables hardware interrupt requests for LVDF. 0 Hardware interrupt disabled (use polling). 1 Request a hardware interrupt when LVDF = 1.
9 LVDRE	Low-Voltage Detect Reset Enable. This bit enables LVDF events to generate a hardware reset (provided LVDE = 1). 0 LVDF does not generate hardware resets. 1 Force an MCU reset when LVDF = 1.
8 PPDE	Partial Power-Down Enable. This bit configures the Power Management Controller to enter partial power-down mode the next time that the STOP command is executed. O PPD mode is disabled. PPD mode is enabled.

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Table 15-3. PMSC Register Field Descriptions (continued)

Field	Description
7 LPR	Low Power Regulator Control. The LPR bit controls entry into the low-power run and low-power wait modes in which the voltage regulator is put into standby. LPR is cleared when an interrupt occurs in low-power mode and the LPWUI bit is 1. 0 Low-power run and low-power wait modes are disabled. 1 Low-power run and low-power wait modes are requested.
6 LPRS	Low-Power Regulator Status. This read-only status bit indicates that the voltage regulator has entered into standby for the low-power run or wait mode. O The voltage regulator is not currently in standby. The voltage regulator is currently in standby.
5 LPWUI	Low-Power Wakeup on Interrupt. This bit controls whether or not the voltage regulator exits standby when any active MCU interrupt occurs. O The voltage regulator remains in standby on an interrupt. The voltage regulator exits standby on an interrupt. LPR is cleared.
4 BGBE	Bandgap Buffer Enable. This bit enables an internal buffer for the bandgap voltage reference for use by the ADC module on one of its internal channels or as a voltage reference for on-chip comparators. O Bandgap buffer disabled. 1 Bandgap buffer enabled.
3 LVDE	Low-Voltage Detect Enable. This bit enables low-voltage detect logic and qualifies the operation of other bits in this register. Clearing LVDE also clears OORF and LVDF. 0 LVD logic disabled. 1 LVD logic enabled.
2 LVLS	Low-Voltage Detect Level Select. The LVDV bit selects the LVD trip point voltage (VLVD). See Table 15-4 for definition of these voltages. 0 VLVDL selected (VLVD = VLVDL). 1 VLVDH selected (VLVD = VLVDH).
1,0 PROT	Register Protection. Enables write protection of all other fields in the SCR and TRIM registers. 00 — Write protection off (default). 01 — Write protection on. 10 — Write protection off and locked until chip reset or recovery from PPD mode. 11 — Write protection on and locked until chip reset or recovery from PPD mode.

Table 15-4. LVD Trip Point Typical Values¹

LVLS	LVD Trip Point
0	V _{LVDL} = 1.86
1	V _{LVDL} = 2.33

¹ See the Data Sheet for minimum and maximum values.

15.6.2 PMC Control Register 2 (PMC_CR2)

The regulator and low power oscillator are trimmed for accuracy during manufacturing. Those trim values are stored in a protected area of flash and should be loaded (via application code) into this register during the boot sequence.

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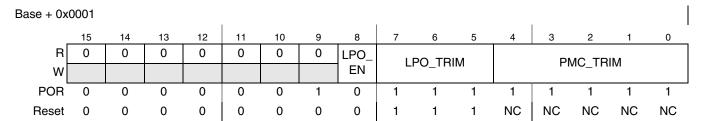


Figure 15-3. PMC Control Register 2

Table 15-5. PMSC Register Field Descriptions

Field	Description							
15–9	Reserved.							
8 LPO_EN	kHz Oscillator Enable. This bit determines whether or not the 1 kHz oscillator is enabled or not. If not enabled, the oscillator draws only leakage current. 1 kHz oscillator is enabled. 1 kHz oscillator is disabled.							
7–5 LPO_TRIM	1 kHz Oscillator Trim Bits. The PMC includes an integrated low power oscillator (LPO). The LPO is designed to have a nominal clock period of 1ms, but has a wide spread in manufacturing. These three bits are used to adjust the raw frequency closer to the 1 kHz target. Freescale records a nominal trim value for this field in flash memory during factory test. Startup code should retrieve this value from FM_OPTO and copy it to this location. The value varies from device to device, and is set during final manufacturing. Consult the device data sheet to determine accuracy of the LPO before and after trim.							
		Frequency Increment	TRIM value					
		+24.75%	100					
	+16.5% 101							
	+8.25% 110							
	Center (untrimmed, erased device) 111							
	-8.25% 000							
	-16.5% 001 -24.75% 010 -33% 011							
The user can affect the frequency of the LPO by writing to these bits; but that value does not reset.								
4–0 PMC_TRIM	Regulator Trim Bits. The regulator PMC_TRIM value for this particular device. This number changes from unit to unit. Convert this number to a trim_increment value using Table 15-7.							

A value written to this register by software is not stored in nonvolatile storage and does not persist past reset. Extreme care should be taken in writing to this register. Unpredictable results may occur for the case where V_{DD} is near any of the thresholds listed in Table 15-6.

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Changing the TRIM field has the effect of changing the POR, LVD, and regulation voltages by an amount equal to:

Eqn. 15-1

In the equation above, "nominal_voltage" is defined as one of the values in Table 15-6.

Table 15-6. PMC Nominal Voltages

Parameter	Value
V_{LVDL}	1.86 V
V_{LVDH}	2.33 V
Regulator Output	2.6 V

The "trim_increment" variable is defined in Table 15-7 as a function of the TRIM bit field value.

Table 15-7. Effects of LVD Trim Bits

TRIM<4:0>	Trim_Increment
10001	+14
10010	+13
10011	+12
10100	+11
10101	+10
10110	+9
10111	+8
11000	+7
11001	+6
11010	+5
11011	+4
11100	+3
11101	+2
11110	+1
11111	Center (erased IFR)
00000	-1
00001	-2
00010	-3
00011	-4
00100	- 5
00101	-6

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Power Management Controller (PMC)

Table 15-7. Effects of LVD Trim Bits (continued)

TRIM<4:0>	Trim_Increment
00110	-7
00111	-8
01000	-9
01001	-10
01010	-11
01011	-12
01100	-13
01101	-14
01110	-15
01111	-16
10000	-16

Chapter 16 Computer Operating Properly (COP)

16.1 Introduction

16.1.1 Overview

The computer operating properly (COP) module is used to help software recover from runaway code. The COP is a free-running down counter that, once enabled, is designed to generate a reset upon reaching zero. Software must periodically service the COP in order to reload the counter and prevent a reset.

This module is derived from the COP module used on the MC56F802x/3x DSC family, but adds:

- Programmable prescaler
- Integrated 1 kHz oscillator
- Support for switched power modes

16.1.2 References

- DSP56F801/803/805/807 16-Bit Digital Signal Processor User's Manual, Rev 2 (Document #: DSP56F801-7UM/D)
- DSPF801X Peripheral Reference Manual, Rev. 3 (Document #: MC56F800RM)

16.2 Features

The COP module design includes these distinctive features:

- Programmable prescaler
- Programmable timeout period = $(cop_prescaler*(TIMEOUT + 1))$ clock cycles, where TIMEOUT can be from 0x0000 to 0xFFFF.
- Programmable wait and stop and partial powerdown mode operation.
- COP registers do NOT reset when the device recovers from partial powerdown operation. In this instance, COP control inputs (such as chip reset) are ignored.
- COP timer is disabled while DSC is in debug mode.
- Causes loss of reference reset 128 cycles after loss of reference clock to the PLL is detected.
- Choice of clock sources for counter.
- The COP integrates a 1 kHz oscillator in support of EN60730 and IEC61508.
- Unswitched power domain.

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16.3 Partial Powerdown Operation

- The COP sits on the unswitched digital supply, and can continue operation while the SoC is in partial power down mode. The CLKSEL bits must be set to select one of the oscillator outputs, and that oscillator must be enabled. When asserted, the COP_RST_B signal causes the on-chip voltage regulator to exit partial powerdown mode (PPD) and initiate a partial-power-on-reset sequence. The PSS and TIMEOUT fields should be programmed to yield the desired wakeup time prior to entering PPD mode.
- As noted above, COP registers do NOT reset when the device recovers from partial powerdown operation. In this instance, COP control inputs (such as chip reset) are ignored.

16.4 Block Diagram

The following is the block diagram of the COP module.

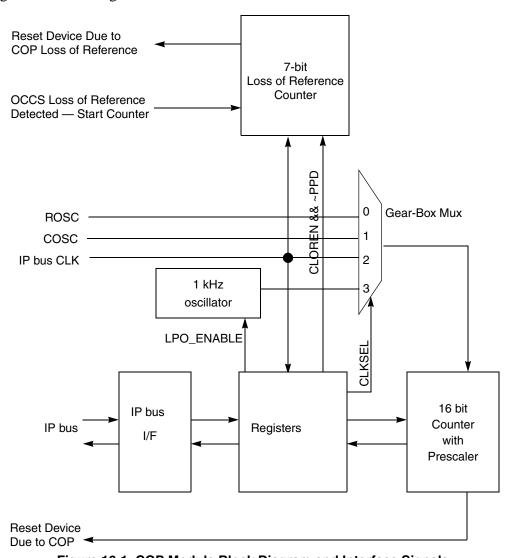


Figure 16-1. COP Module Block Diagram and Interface Signals

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16.5 Signal Description

16.5.1 Overview

The COP module primarily interfaces to the IP bus. There are no chip I/O interfaces driven directly by this module.

16.6 Memory Map and Registers

Table 16-1. COP Module Memory Map

Address	Register Name	Access
COP_BASE + 0	Control Register (COP_CTRL)	Read/Write
COP_BASE + 1	Timeout Register (COP_TOUT)	Read/Write
COP_BASE + 2	Counter Register (COP_CNTR)	Read/Write

16.6.1 Register Descriptions

16.6.1.1 COP Control Register (COP_CTRL)

Address: COP_BASE + 0

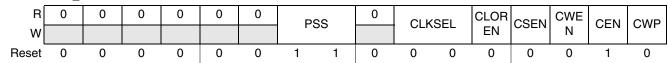


Figure 16-2. COP Control Register (COP_CTRL)

Table 16-2. COP Control Register (COP_CTRL) Descriptions

Field	Description				
15–10	Reserved				
9, 8 PSS	Prescaler Select. This two bit field determines the value of the clock divider (prescaler). You may divide the source clock by 1, 16, 256, or 1024. Generally, you use a lower prescaler value for lower frequency clock sources, but any combination of PSS and timeout may be used so long as they yield the desired timeout value. This field can be changed only when CWP is set to zero. 00 = No division: suggested setting when using 1 kHz or 32 kHz clocks 01 = Divide by 16: suggested setting when using 400 kHz ROSC clock 10 = Divide by 256: suggested setting when using 8 MHz COSC or 8 MHz ROSC source 11 = Divide by 1024: suggested setting when using 32 MHz IP bus clock				
7	Reserved				
6, 5 CLKSEL	Clock Source Select. This bit field selects the clock source for the COP counter. Some safety applications require the watchdog counter to use a different clock source than the system clock. This field can be changed only when CWP is set to zero. It also should be changed only when CEN is clear. 00 = the relaxation oscillator output (ROSC) is used to clock the counter. (default) 01 = the crystal oscillator output (COSC) is used to clock the counter. 10 = IP bus clock is used to clock the counter 11 = 1 kHz oscillator is used to clock the counter				

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Table 16-2. COP Control Register (COP_CTRL) Descriptions (continued)

Field	Description
4 CLORE N	COP Loss of Reference Enable. This bit enables the operation of the COP loss of reference counter. This bit can be changed only when CWP is set to zero. 0 = COP counter is disabled. (default) 1 = COP Loss of Reference counter is enabled.
3 CSEN	COP Stop Mode Enable. This bit controls the operation of the COP counter in stop mode. This bit can be changed only when CWP is set to zero. 0 = COP counter stops in stop mode. (default) 1 = COP counter runs in stop mode if CEN is set to one. Because partial power down (PPD) mode on the SoC is entered via a STOP command, the CSEN also controls whether or not the COP continues to operate during PPD mode.
	It is recommended that if an external wakeup signal is being used to recover from PPD (and not the COP), that the COP be explicitly disabled (CEN=0) prior to entering PPD. Otherwise, the COP starts counting again when the device reboots from PPD. This may result in a premature COP reset during the reboot sequence.
2 CWEN	COP Wait Mode Enable. This bit controls the operation of the COP counter in wait mode. This bit can be changed only when CWP is set to zero. 0 = COP counter stops in wait mode. (default) 1 = COP counter runs in wait mode if CEN is set to one.
1 CEN	COP Enable. This bit controls the operation of the COP counter. This bit can be changed only when CWP is set to zero. This bit always reads as zero when the chip is in debug mode. 0 = COP counter is disabled. 1 = COP counter is enabled. (default)
0 CWP	COP Write Protect. This bit controls the write protection feature of the COP Control register (COP_CTRL) and the COP timeout register (COP_TOUT). After it is set, this bit can be cleared only by resetting the module. 0 = COP_CTRL and COP_TOUT are readable and writable. (default) 1 = COP_CTRL and COP_TOUT are read only.

16.6.1.2 COP Timeout Register (COP_TOUT)

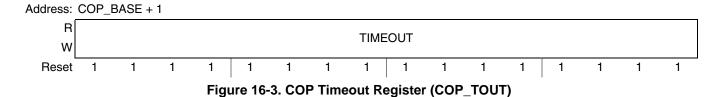


Table 16-3. COP Timeout Register (COP_TOUT) Descriptions

Field	Description
15–0 TIMEOUT	COP Timeout Period. The value in this register determines the timeout period of the COP counter. TIMEOUT should be written before the COP is enabled. After the COP has been enabled, the recommended procedure for changing TIMEOUT is to disable the COP, write to COP_TOUT, and then re-enable the COP. This ensures that the new TIMEOUT is loaded into the counter. Alternatively, the DSC core can write to COP_TOUT and then write the proper patterns to COP_CNTR to cause the counter to reload with the new TIMEOUT value. Changing TIMEOUT while the COP is enabled results in a timeout period that differs from the expected value. These bits can be changed only when CWP is set to zero.

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16.6.1.3 COP Counter Register (COP_CNTR)

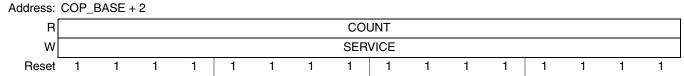


Figure 16-4. COP Counter Register (COP_CNTR)

Table 16-4. COP Counter Register (COP_CNTR) Descriptions

Field	Description
15–0 COUNT/ SERVICE	COP Count. This is the current value of the COP counter as it counts down from the timeout value to zero. A reset is issued when this count reaches zero.
	COP Service. When enabled, the COP requires that a service sequence be performed periodically in order to clear the COP counter and prevent a reset from being issued. This routine consists of writing 0x5555 to COP_CNTR followed by writing 0xAAAA before the timeout period expires. The writes to COP_CNTR must be performed in the correct order, but any number of other instructions (and writes to other registers) may be executed between the two writes.

16.7 Functional Description

16.7.1 General

When the COP is enabled, each positive edge of the prescaled clock (COSC, ROSC, peripheral, or 1 kHz oscillator) causes the counter to decrement by one. If the count reaches a value of 0x0000, then the chip is reset. For the DSC core to show that it is operating properly, it must perform a service routine prior to the count reaching 0x0000. The service routine consists of writing 0x5555 followed by 0xAAAA to COP CNTR.

16.7.2 Timeout Specifications

The COP uses a 16-bit counter that is being clocked by either COSC, ROSC or the 1 kHz oscillator, prescaled by the COP prescaler. This value is set by COP_CTRL[PSS].

Table 16-5. Minimum COP Timeout Values as a Function of Oscillator Frequency and Prescaler

	Source Clock Frequency					
Prescaler	32000 400000 8.00E+06 3.20E+07 Units					
X1	31.25	2.5	0.125	0.03125	us	
X16	500	40	2	0.5	us	
X256	8000	640	32	8	us	
X1024	32000	2560	128	32	us	

	Source Clock Frequency								
Prescaler	32000	400000	8.00E+06	3.20E+07	Units				
X1	2048	163.84	8.192	2.048	ms				
X16	32768	2621.44	131.072	32.768	ms				
X256	524288	41943.04	2097.152	524.288	ms				
X1024	2097152	167772.16	8388.608	2097.152	ms				

Table 16-5 and Table 16-6 present the range of timeout values supported as a function of oscillator frequency and COP_CTRL[PSS].

If using an 8 MHz crystal oscillator as its source, the clock to the COP counter can be scaled as low as $8 \text{ MHz}/2^{10} = 7.8125 \text{ kHz}$. The value of the COP_TOUT register can be programmed from 1 to 65535 giving a timeout period as long as 8.4 s maximum.

16.7.3 COP after Reset

CEN is set out of reset. Thus the counter is enabled by default. In addition, COP_TOUT is set to its maximum value of 0xFFFF and PRESCALER to 1024 (COP_CTRL[PSS]=11) during reset so the counter is loaded with a maximum timeout period when reset is released.

If the IP bus clock to the COP is not enabled by default after reset, then allow two clock cycles to occur after enabling it before performing a write access to the COP.

16.7.4 Wait Mode Operation

If wait mode is entered with both CEN and CWEN set to 1, then the COP counter continues to count down. If either CEN or CWEN is set to 0 when wait mode is entered, then the counter is disabled and reloads using the value in the COP_TOUT register.

16.7.5 Stop Mode Operation

If stop mode is entered with both CEN and CSEN set to 1, then the COP counter continues to count down. If either CEN or CSEN is set to 0 when stop mode is entered, then the counter is disabled and reloads using the value in the COP_TOUT register.

16.7.6 Partial Power Down Mode Operation

If partial power down mode is entered with both CEN and CSEN set to 1, then the COP counter continues to count down. If either CEN or CSEN is set to 0 when stop mode is entered, then the counter is disabled.

If enabled to run in stop, then when the COP times out, it sends COP_RST_ to the PMC to wake the part from partial power down mode. The sequence is:

Assert COP RST B

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- CEN is set to zero (COP inactive)
- PMC asserts POR
- POR deasserts (peripheral RESET continues)
- Peripheral RESET deasserts
- PMC deasserts PPD
- On deassert of safing (ram_safe deassertion), set CEN
- Chip boots
- SW restores states
- SW opens I/Os

The intent is to keep the COP inactive after it has initiated wakeup, and the PMC is still powering back up. After the supply is stable, re-enable the COP and boot.

NOTE

Care must be exercised if using both the COP and the external wakeup signal as options to wake the part from PPD. If the external wakeup initiates a reboot before the COP times out, the application is at risk of hitting the COP timeout early in the boot sequence, resetting the device a second time, and effectively losing all saved state information.

16.7.7 Debug Mode Operation

The COP counter is not allowed to count when the chip is in debug mode. In addition, the CEN bit in the COP_CTRL always reads as zero when the chip is in debug. The actual value of CEN is unaffected by debug, however, and resumes its previously set value upon exiting debug.

16.7.8 Loss of Reference Operation

When the OCCS signals the COP that a loss of the reference clock has occurred and the CLOREN bit is set, then the COP starts a 7-bit counter that runs off of the IP bus clock (which continues to be produced by the PLL for at least 1000 cycles upon losing its reference). The counter continues to count once started counting. When this counter reaches 0x7F it causes a loss of reference reset that resets the entire chip. If the software has safely shut down the chip and does not want a full reset, then the loss of reference timeout count can be delayed by servicing the COP counter in the standard manner of writing 0x5555 followed by 0xAAAA or stopped by setting CLOREN to zero.

Because the PLL is not enabled in PPD mode, this function is not applicable to that mode of operation.

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Computer Operating Properly (COP)

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Chapter 17 Real-Time Counter (RTC)

17.1 Introduction

The real-time counter (RTC) module consists of one 8-bit counter, one 8-bit comparator, several binary-based and decimal-based prescaler dividers, two clock sources, and one programmable periodic interrupt. This module can be used for time-of-day, calendar, or any task scheduling functions. It can also serve as a cyclic wakeup from low power modes without the need of external components.

17.1.1 Features

Features of the RTC module include:

- 8-bit up-counter
 - 8-bit modulo match limit
 - Software controllable periodic interrupt on match
- Three software selectable clock sources for input to prescaler with selectable binary-based and decimal-based divider values
 - 1 kHz internal low-power oscillator (LPO)
 - External crystal oscillator or COSC circuit (ERCLK)
 - System bus (IP bus up to 32 MHz) (IRCLK)

17.1.2 Modes of Operation

This section defines the operation in stop, wait, and background debug modes.

17.1.2.1 Wait Mode

The RTC continues to run in wait mode if enabled before executing the appropriate instruction. Therefore, the RTC can bring the DSC core out of wait mode if the real-time interrupt is enabled. For lowest possible current consumption, the RTC should be stopped by software if not needed as an interrupt source during wait mode.

17.1.2.2 Stop Modes

The RTC continues to run in partial power down (PPD) or LPstop mode if the RTC is enabled before executing the STOP instruction. Therefore, the RTC can bring the DSC core out of stop modes with no external components, if the real-time interrupt is enabled.

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Real-Time Counter (RTC)

The LPO clock can be used in partial power down (PPD) and LPstop modes. ERCLK and IRCLK clocks are available only in LPstop mode.

Power consumption is lower when all clock sources are disabled, but in that case, the real-time interrupt cannot wake the DSC core.

17.1.2.3 Debug Mode

The RTC suspends all counting during debug mode until the DSC returns to normal user operating mode. Counting resumes from the suspended value as long as the RTC_MOD register is not written and the RTCPS and RTCLKS bits are not altered.

17.1.3 Block Diagram

The block diagram for the RTC module is shown in Figure 17-1.

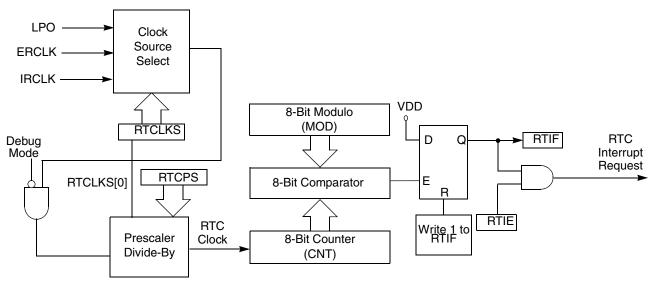


Figure 17-1. Real-Time Counter (RTC) Block Diagram

17.2 External Signal Description

The RTC does not include any off-chip signals.

17.3 Register Definitions

The RTC includes a status and control register, an 8-bit counter register, and an 8-bit modulo register.

Refer to the direct-page register summary in the memory section of this document for the absolute address assignments for all RTC registers. This section refers to registers and control bits only by their names and relative address offsets. Offsets are word offsets, and the 8-bit registers are extended to 16 bits by the addition of bits 15 to 8 on the left.

Table 17-1 is a summary of RTC registers.

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Table 17-1. RTC Register Summary

Name	7	6	5	4	3	2	1	0				
RTC_SC	R	RTIF	RTC	CLKS	RTIE	RTCPS						
1110_00	W	11111	1110	LINO	1111							
RTC_CNT	R	RTCCNT										
THO_ONT	W											
RTC_MOD	R	RTCMOD										
TTTO_MOD	W	NICWOD										

17.3.1 RTC Status and Control Register (RTC_SC)

RTC_SC contains the real-time interrupt status flag (RTIF), the clock select bits (RTCLKS), the real-time interrupt enable bit (RTIE), and the prescaler select bits (RTCPS).

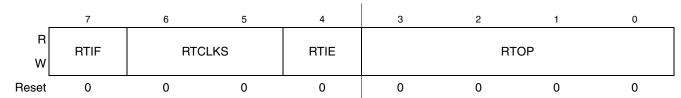


Figure 17-2. RTC Status and Control Register (RTC_SC)

Table 17-2. RTC_SC Field Descriptions

Field	Description
7 RTIF	Real-Time Interrupt Flag. This status bit indicates that the RTC counter register reached the value in the RTC modulo register. Writing a zero has no effect. Writing a one clears the bit and the real-time interrupt request. Reset clears RTIF. O RTC counter has not reached the value in the RTC modulo register. 1 RTC counter has reached the value in the RTC modulo register.
6–5 RTCLKS	Real-Time Clock Source Select. These two read/write bits select the clock source input to the RTC prescaler. Changing the clock source clears the prescaler and RTCCNT counters. When selecting a clock source, ensure that the clock source is properly enabled (if applicable) to ensure correct operation of the RTC. Reset clears RTCLKS. 00 Real-time clock source is the 1 kHz low power oscillator (LPO) 01 Real-time clock source is the external clock (ERCLK) 1x Real-time clock source is the internal clock (IRCLK)
4 RTIE	Real-Time Interrupt Enable. This read/write bit enables real-time interrupts. If RTIE is set, then an interrupt is generated when RTIF is set. Reset clears RTIE. O Real-time interrupt requests are disabled. Use software polling. Real-time interrupt requests are enabled.
3–0 RTCPS	Real-Time Clock Prescaler Select. These four read/write bits select binary-based or decimal-based divide-by values for the clock source. See Table 17-3. Changing the prescaler value clears the prescaler and RTCCNT counters. Reset clears RTCPS.

Table 17-3. RTC Prescaler Divide-By Values

DTCI KEIOI		RTCPS														
RTCLKS[0]	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
0	Off	2 ³	2 ⁵	2 ⁶	2 ⁷	2 ⁸	2 ⁹	2 ¹⁰	1	2	2 ²	10	2 ⁴	10 ²	5x10 ²	10 ³
1	Off	2 ¹⁰	2 ¹¹	2 ¹²	2 ¹³	2 ¹⁴	2 ¹⁵	2 ¹⁶	10 ³	2x10 ³	5x10 ³	10 ⁴	2x10 ⁴	5x10 ⁴	10 ⁵	2x10 ⁵

17.3.2 RTC Counter Register (RTC_CNT)

RTC_CNT is the read-only value of the current RTC count of the 8-bit counter.

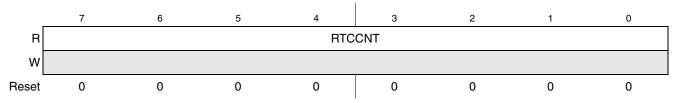


Figure 17-3. RTC Counter Register (RTC_CNT)

Table 17-4. RTC_CNT Field Descriptions

Field	Description
7–0 RTCCNT	RTC Count. These eight read-only bits contain the current value of the 8-bit counter. Writes have no effect to this register. Reset, writing to RTCMOD, or writing different values to RTCLKS and RTCPS clear the count to 0x00.

17.3.3 RTC Modulo Register (RTC_MOD)

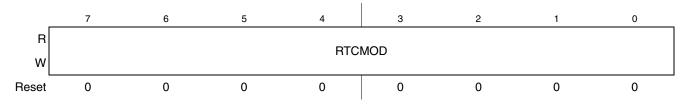


Figure 17-4. RTC Modulo Register (RTC_MOD)

Table 17-5. RTC_MOD Field Descriptions

Field	Description
7–0 RTCMOD	RTC Modulo. These eight read/write bits contain the modulo value used to reset the count to 0x00 upon a compare match and to set the RTIF status bit. A value of 0x00 sets the RTIF bit on each rising edge of the prescaler output. Writing to RTCMOD resets the prescaler and the RTCCNT counters to 0x00. Reset sets the modulo to 0x00.

17.4 Functional Description

The RTC is composed of a main 8-bit up-counter with an 8-bit modulo register, a clock source selector, and a prescaler block with binary-based and decimal-based selectable values. The module also contains software selectable interrupt logic.

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After any DSC reset, the counter is stopped and reset to 0x00, the modulus register is set to 0x00, and the prescaler is off. The 1 kHz internal oscillator clock is selected as the default clock source. To start the prescaler, write any value other than zero to the prescaler select bits (RTCPS).

Three clock sources are software selectable: the low power oscillator clock (LPO), the external clock (ERCLK), and the internal clock (IRCLK). The RTC clock select bits (RTCLKS) select the desired clock source. If a different value is written to RTCLKS, the prescaler and RTCCNT counters are reset to 0x00.

RTCPS and the RTCLKS[0] bit select the desired divide-by value. If a different value is written to RTCPS, the prescaler and RTCCNT counters are reset to 0x00. Table 17-6 shows different prescaler period values.

32 kHz Internal Clock 32 kHz Internal Clock 1 kHz Internal Clock 1 MHz External Clock **RTCPS** (RTCLKS = 01)(RTCLKS = 00)(RTCLKS = 10)(RTCLKS = 11)Off Off Off Off 0000 0001 8 ms 1.024 ms 250 μs 32 ms 0010 2.048 ms 32 ms 1 ms 64 ms 0011 64 ms 4.096 ms 2 ms 128 ms 0100 8.192 ms 4 ms 128 ms 256 ms 0101 256 ms 16.4 ms 8 ms 512 ms 0110 512 ms 32.8 ms 16 ms 1.024 s 0111 1.024 s 65.5 ms 32 ms 2.048 s 1000 1 ms 1 ms 31.25 µs 31.25 ms 1001 2 ms 2 ms 62.5 μs 62.5 ms 1010 4 ms 5 ms 125 µs 156.25 ms 1011 10 ms 10 ms 312.5 µs 312.5 ms 1100 16 ms 20 ms 0.5 ms 0.625 s1101 0.1 s50 ms 3.125 ms 1.5625 s 1110 0.5 s0.1 s 15.625 ms 3.125 s 1111 0.2 s31.25 ms 6.25 s

Table 17-6. Prescaler Period

The RTC modulo register (RTC_MOD) allows the compare value to be set to any value from 0x00 to 0xFF. When the counter is active, the counter increments at the selected rate until the count matches the modulo value. When these values match, the counter resets to 0x00 and continues counting. The real-time interrupt flag (RTIF) is set when a match occurs. The flag sets on the transition from the modulo value to 0x00. Writing to RTC_MOD resets the prescaler and the RTCCNT counters to 0x00.

The RTC allows for an interrupt to be generated when RTIF is set. To enable the real-time interrupt, set the real-time interrupt enable bit (RTIE) in RTC_SC. RTIF is cleared by writing a 1 to RTIF.

Real-Time Counter (RTC)

17.4.1 RTC Operation Example

This section shows an example of the RTC operation as the counter reaches a matching value from the modulo register.

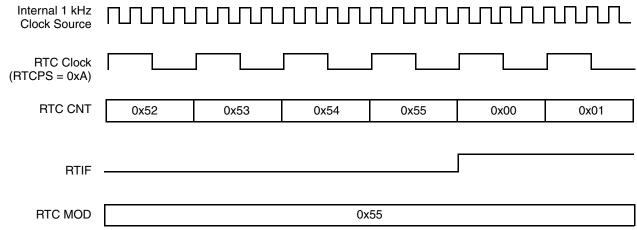


Figure 17-5. RTC Counter Overflow Example

In the example of Figure 17-5, the selected clock source is the 1 kHz internal oscillator clock source. The prescaler (RTCPS) is set to 0xA or divide-by-4. The modulo value in the RTC_MOD register is set to 0x55. When the counter, RTCCNT, reaches the modulo value of 0x55, the counter overflows to 0x00 and continues counting. The real-time interrupt flag, RTIF, sets when the counter value changes from 0x55 to 0x00. A real-time interrupt is generated when RTIF is set, if RTIE is set.

17.5 Initialization/Application Information

This section provides example code to give some basic direction to a user on how to initialize and configure the RTC module. The example software is implemented in C language.

The example below shows how to implement time of day with the RTC using the 1 kHz clock source to achieve the lowest possible power consumption. Because the 1 kHz clock source is not as accurate as a crystal, software can be added for any adjustments. For accuracy without adjustments at the expense of additional power consumption, the external clock (ERCLK) or the internal clock (IRCLK) can be selected with appropriate prescaler and modulo values.

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```
***********************
#pragma TRAP_PROC
void RTC_ISR(void)
       /* Clear the interrupt flag */
       SC.byte = SC.byte | 0x80;
       /* RTC interrupts every 1 Second */
       Seconds++;
       /* 60 seconds in a minute */
       if (Seconds > 59){
       Minutes++;
       Seconds = 0;
       /* 60 minutes in an hour */
       if (Minutes > 59){
       Hours++;
       Minutes = 0;
       /* 24 hours in a day */
       if (Hours > 23){
       Days ++;
       Hours = 0;
       }
}
```

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Real-Time Counter (RTC)

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Chapter 18 Programmable Interval Timer (PIT)

18.1 Introduction

18.1.1 Overview

The programmable interval timer module (PIT) contains a 16-bit up counter, a modulo register, and a control register. The modulo and control registers are read/writable. The counter is read only.

The modulo register is loaded with a value to count to and the prescaler is set to determine the counting rate. When enabled, the counter counts up to the modulo value and set a flag (and an interrupt request if enabled), reset to 0x0000, and resume counting.

18.1.2 Features

The PIT module design includes these distinctive features:

- 16-bit counter/timer.
- Programmable count modulo.
- Max count rate equals peripheral clock rate.
- Slave mode allows synchronization of multiple PIT count enables.

18.1.3 Modes of Operation

The PIT module design operates in only a single mode of operation: functional mode.

18.1.4 Block Diagram

The block diagram of the PIT is shown in Figure 18-1.

Programmable Interval Timer (PIT)

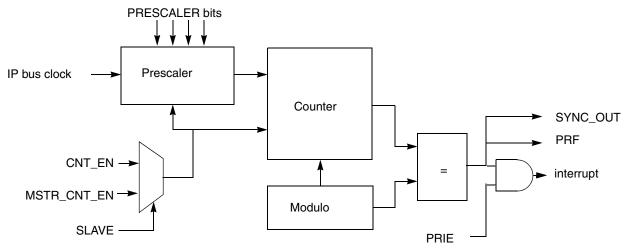


Figure 18-1. Programmable Interval Timer Block Diagram

18.2 Memory Map and Registers

18.2.1 Overview

The base address of the PIT module differs from chip to chip. All memory mapped registers described below have their location described in relation to the base address.

18.2.2 Module Memory Map

Table 18-1. Timer Memory Map without Compare Preload

Address	Register Name	Access
Base + 0x0	PIT Control Register (PIT_CTRL)	Read/Write
Base + 0x1	PIT Modulo Register (PIT_MOD)	Read/Write
Base + 0x2	PIT Counter Register (PIT_CNTR)	Read

18.2.3 Register Descriptions

The address of a register is the sum of a base address and an address offset. The base address is defined at the DSC core level and the address offset is defined at the module level. The base address given for each register is PIT_BASE.

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18.2.3.1 PIT Control Register (PIT_CTRL)

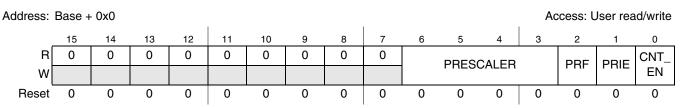


Figure 18-2. PIT Control Register (PIT_CTRL)

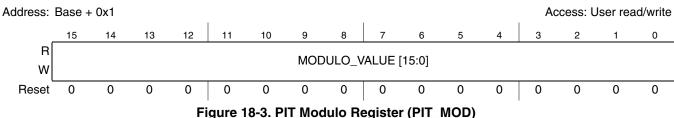
Table 18-2. Abbreviation Field Descriptions

Field	Description			
15–7	Reserved			
6–3 PRE	This field is used to	select the prescaling of the	IP bus clock to determine the counting rate of	of the PIT.
SCALER		Value	Clocking rate	
		0000	IPBus_clock	
		0001	IPBus_clk divided by 2	
		0010	IPBus_clk divided by 4	
		0011	IPBus_clk divided by 8	
		0100	IPBus_clk divided by 16	
		0101	IPBus_clk divided by 32	
		0110	IPBus_clk divided by 64	
		0111	IPBus_clk divided by 128	
		1000	IPBus_clk divided by 256	
		1001	IPBus_clk divided by 512	
		1010	IPBus_clk divided by 1024	
		1011	IPBus_clk divided by 2048	
		1100	IPBus_clk divided by 4096	
		1101	IPBus_clk divided by 8192	
		1110	IPBus_clk divided by 16384	
		1111	IPBus_clk divided by 32768	
2 PRF	register. This bit is clother. This bit can also be 1 = PIT counter has	eared by reading the PIT_0		zero to this bit position.

Table 18-2. Abbreviation Field Descriptions (continued)

Field	Description
	PIT Roll-Over Interrupt Enable. This bit enables the PIT roll-over interrupt when the PRF bit becomes set. 1 = PIT roll-over interrupt enabled. 0 = PIT roll-over interrupt disabled (default).
	Count Enable. This bit enables the PIT prescaler and counter. When this bit is clear, the counter remains at/returns to a 0x0000 value. The PRF bit is also reset when CNT_EN is clear. This field is ignored when the SLAVE bit is set and the count enable signal from the master PIT is used instead. 1 = PIT counter active. 0 = PIT counter reset (default).

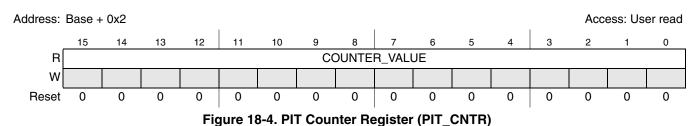
18.2.3.2 PIT Modulo Register (PIT_MOD)



rigaro to orrir modulo riogistor (rri_mob)

This read/write register stores the modulo value for the PIT counter. When the PIT counter rolls over to 0x0000 from this value, the PRF bit becomes set and the PIT counter resumes counting from 0x0000.

18.2.3.3 PIT Counter Register (PIT_CNTR)



This read only register contains the current value of the PIT counter. Clearing CNT_EN resets the counter to 0x0000. When the PIT counter rolls over the modulo value, the PRF bit becomes set and the PIT counter resumes counting from 0x0000.

18.3 Functional Description

18.3.1 General

The purpose of the PIT is to create a repeated interrupt request at a programmable time interval. The periodic rate is determined based on the peripheral clock rate, the prescaler value, and the modulo value as shown in the following equation:

interrupt rate = peripheral clock rate / ((2^prescaler) * modulo value)

Eqn. 18-1

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When using the PIT, set the prescaler and modulo values prior to setting CNT_EN. Changing prescaler or modulo settings with CNT_EN set may cause unexpected operation.

The roll-over flag is set upon rolling over the modulo value back to 0x0000. See Figure 18-5 for an example of PRF timing using a prescaler of 0x2 (IP bus clock divided by 4).

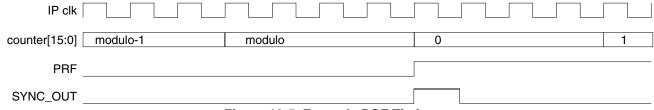


Figure 18-5. Example POF Timing

The roll-over flag can be cleared by writing a zero to the PRF bit position or by clearing CNT_EN.

18.3.2 Slave Mode

When using slave mode to synchronize several PIT modules only the CNT_EN signal is shared not the clocking for the counters. This means that each slave PIT must have their PRESCALER field and PIT_MOD registers programmed prior to setting CNT_EN in the master PIT. The following figure shows the connection between the master PIT (PIT0) and the possible slave PITs (PIT1–PITn).

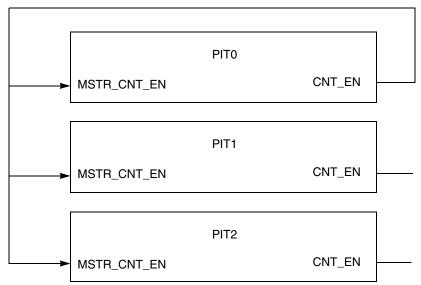


Figure 18-6. CNT EN Connection Between Multiple PITs

18.3.3 Low Power Modes

18.3.3.1 Wait Mode

If the CNT_EN bit is set prior to entering wait mode, then the PIT continues to count and can wake the chip by asserting its interrupt upon reaching the modulo value.

Programmable Interval Timer (PIT)

18.3.3.2 Stop Mode

Stop mode operation depends on whether the system integration module (SIM) is set to allow the PIT to be clocked in stop mode. If not, the PIT counter does not operate during stop mode, but does retain its current settings. If CNT_EN is set, then the counter resumes counting upon exit of stop mode assuming the exit isn't caused by a reset. If the PIT does receive clocks while the chip is in stop mode, then operation continues normally.

18.3.3.3 **Debug Mode**

If the CNT_EN bit is set prior to the chip entering debug mode, then the PIT continues to count during debug mode.

18.4 Interrupts

18.4.1 General

The PIT module can generate a single interrupt when the counter reaches the modulo value.

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Chapter 19 Flash Memory (HFM)

19.1 Introduction

19.1.1 Overview

The flash (HFM) module is a nonvolatile memory module that operates with the program and IP buses.

The programming voltage required to program and erase the flash is generated internally by on-chip charge pumps. Program and erase operations are performed by a command driven interface from the 56800E core using an internal state machine. It is not possible to read from a block while it is being programmed or erased.

19.1.2 Features

- 12 KB or 16 KB of program flash memory
- 32 MHz single cycle operation for all flash accesses.
- Automated program and erase operation
- Interrupts on command completion, command buffer empty and access error
- Fast page erase
- Single power supply program and erase
- Security feature
- Sector protection system
- The HFM supports byte and word read operations by the 56800E core
- Code integrity check using built-in data signature calculation

19.1.3 Block Diagram

An erased bit reads 1 and a programmed bit reads 0.

All registers are easily accessed to control program and erase operation. Table 19-1 shows the verified configurations described in Table 19-2

19.2 Memory Map and Registers

19.2.1 Overview

This section describes the HFM's memory map and registers.

19.2.2 Module Memory Map

Figure 19-1 shows the HFM memory map. The HFM Program flash memory array for the various configurations is shown in table Table 19-1.

Program Memory Size (Bytes)	Page Structure	Address Range
12K	8kx12	0x0800 to 0x1FFF
16K	8kx16	0x0000 to 0x1FFF

Table 19-1. Program Flash Page Structure and Address Range

The HFM configuration field has eighteen bytes, located at the top of program flash as defined in Table 19-2. The memory map for the 12K and 16K configurations is shown in Figure 19-1.

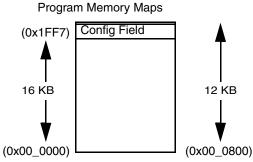


Figure 19-1. HFM Array Memory Maps

The configuration field contains data to facilitate both security and protection features. Protection refers to undesired core access while security refers to undesired external access. The configuration field is composed of 18 bytes of reserved memory space and contains information that determines the module's protection and access restriction scheme out of reset. The protection word in the configuration field is transferred into the protection register at reset. The security words in the configuration field are transferred into the security registers upon reset. A description of each value in the configuration field is given in Table 19-8

See the protection and security register descriptions for further details.

 Address
 Size (bytes)
 Description
 Word Name

 0x1FFF
 2
 Backdoor Comparison Key 3
 BACK_KEY_3_VALUE

 0x1FFE
 2
 Backdoor Comparison Key 2
 BACK_KEY_2_VALUE

Table 19-2. HFM Configuration Field

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Table 19-2. HFM Configuration Field

Address	Size (bytes)	Description	Word Name
0x1FFD	2	Backdoor Comparison Key 1	BACK_KEY_1_VALUE
0x1FFC	2	Backdoor Comparison Key 0	BACK_KEY_0_VALUE
0x1FFB	2	Not Used	Not Used
0x1FFA	2	Protection Word	PROT_VALUE
0x1FF9	2	Not Used	Not Used
0x1FF8	2	Security Word upper (See Section 19.2.3.3, "FM_SECHI-FM_SECLO — HFM Security Registers")	SECH_VALUE
0x1FF7	2	Security Word low (See Section 19.2.3.3, "FM_SECHI-FM_SECLO — HFM Security Registers")	SECL_VALUE

The HFM contains a set of control and status registers located at the HFM register base address. A summary of these registers is given in Table 19-3. In flash BIST mode, these registers are not accessible.

Table 19-3. HFM Register Address Map

Offset from Register Base Address ¹	15:8	7:0
HFM_BASE + 0x1E-0x3C	RESERVED	
HFM_BASE + 0x1D	FM_T	STSIG
HFM_BASE + 0x1C	RESE	RVED
HFM_BASE + 0x1B	FM_C	OPT1
HFM_BASE + 0x1A	RESE	RVED
HFM_BASE + 0x19	RESERVED	
HFM_BASE + 0x18	FM_DATA	
HFM_BASE + 0x17	RESERVED	
HFM_BASE + 0x16	RESERVED	
HFM_BASE + 0x15	RESERVED	RESERVED
HFM_BASE + 0x14	RESERVED	FM_CMD
HFM_BASE + 0x13	RESERVED	FM_USTAT
HFM_BASE + 0x12	RESERVED	RESERVED
HFM_BASE + 0x11	RESERVED	
HFM_BASE + 0x10	FM_PROT	
HFM_BASE+0x06-0x0F	RESE	RVED

Offset from Register Base Address ¹	15:8	7:0
HFM_BASE + 0x05	RESE	RVED
HFM_BASE + 0x04	FM_SECLO	
HFM_BASE + 0x03	FM_SECHI	
HFM_BASE + 0x02	RESERVED	RESERVED
HFM_BASE + 0x01	FM_C	CNFG
HFM_BASE + 0x00	RESERVED	FM_CLKDIV ²

¹ Absolute address is equal to the offset plus the base address.

19.2.3 Register Descriptions

19.2.3.1 FM_CLKDIV - HFM Clock Divider Register

The FM_CLKDIV register is used to control the period of the FCLK clock used for timed events in program and erase algorithms within the FI (flash interface). While the FI operates at system bus frequency, FCLK must operate in the range 150-200 kHz.. FCLK is generated by dividing the oscillator clock (MSTR_OSC in OCCS) by a prescaler and a divider.

Register address HFM_BASE + 0x00

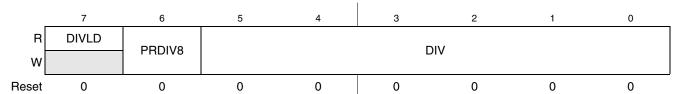


Figure 19-2. HFM Clock Divider Register (FM CLKDIV)

All bits in the FM_CLKDIV register are readable and writable in all modes except bit 7, which is a status-only bit and is not writable in any mode.

Table 19-4. HFM Clock Divider Register (FM_CLKDIV) Descriptions

Field	Description
7 DIVLD	Clock Divider Loaded. 1 = Register has been written to since the last reset. 0 = Register has not been written.

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Writes to reserved address locations have no effect and reads return zeros.

Table 19-4. HFM Clock Divider Register (FM_CLKDIV) Descriptions

Field	Description
6 PRDIV8	Enable Prescaler by 8. 1= Prescaler divides oscillator clock by 8. 0 = Prescaler divides oscillator clock by 1.
DIV 5–0	Clock Divider Bits. The divider divides the prescaler output by DIV+1. Note: DIV must not be load with all zeroes. Please use clock divider values >= 1.

The PRDIV8 and DIV fields must be set with appropriate values before programming or erasing the HFM array.. Because FCLK is re-timed into the system clock domain, the values of PRDIV8 and DIV are affected by the system bus frequency as well. Refer to the functional description of writing the FM CLKDIV register for the detailed algorithm for determining the settings for DIV and PRDIV8.

FM_CNFG - HFM Configuration Register 19.2.3.2

The FM_CNFG register is used to configure and control the operation of the HFM array.

Address: HFM_BASE + 0x01

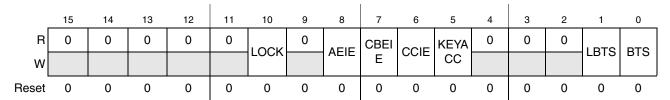


Figure 19-3. HFM Configuration Register (FM_CNFG)

Table 19-5. HFM Configuration Register (FM_CNFG) Descriptions

Field	Description
15–11	Reserved
10 LOCK	Write lock control The LOCK bit is always readable. In user mode, it is a set-once field. After it is set, it can't be cleared except by reset. In test mode, the LOCK bit is always writable. This bit provides additional security for the flash array by disabling writes to the protection register. 1 = The FM_PROT register is write-locked. 0 = The FM_PROT register is writable.
9	Reserved.
8 AEIE	Access Error Interrupt Enable. The AEIE bit is readable and writable in all modes. The AEIE bit enables an interrupt in case of an the ACCERR flag being set 1 = An interrupt is requested whenever the ACCERR flag is set. 0 = ACCERR interrupts disabled.
7 CBEIE	Command Buffer Empty Interrupt Enable. The CBEIE bit is readable and writable in all modes. The CBEIE bit enables an interrupt in case of an empty command buffer in the flash. 1 = An interrupt is requested whenever the CBEIF flag is set. 0 = Command Buffer Empty interrupts disabled.

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Table 19-5. HFM Configuration Register (FM_CNFG) Descriptions

Field	Description
6 CCIE	Command Complete Interrupt Enable. The CCIE bit is readable and writable in all modes. The CCIE bit enables an interrupt in case of all commands being completed in the Flash. 1 = An interrupt is requested whenever the CCIF flag is set. 0 = Command Complete interrupts disabled.
5 KEYACC	Enable Security Key Writing. The KEYACC bit is readable in all modes and writable only if the KEYEN bit in the FM_SECHI register is set. 1 = Writes to Flash array are interpreted as keys to open the backdoor. 0 = Flash writes are interpreted as the start of a program or erase sequence.
4–2	Reserved
1 LBTS	BTS lock control. The LBTS bit is always readable. It is a set-once field. After it is set, it cannot be cleared except by reset. This bit provides additional security for the flash array by disabling writes to the BTS bit. 1 = The BTS bit is write-locked. 0 = The BTS bit is writable.
0 BTS	Enable Branch To Self feature. 1= A read to the flash array when it is unavailable due to program/erase operations results in 0xA97F being placed on the data bus, in place of actual flash data. 0xA97F corresponds to a BRANCH to self instruction. This is a PC relative instruction, which can occur anywhere within a 56800E program sequence. All interrupts to the DSC core must be disabled prior to setting the BTS bit to one and remain disabled until BTS is cleared. Attempting an interrupt while the BTS feature is engaged corrupts the stack. 0 = An access to the flash during program/erase returns non valid data and the ACCERR flag is not set.

NOTE

The branch-to-self feature is intended to be enabled only during controlled program/erase sequences. It should be *disabled* during normal operation. Failure to do so could result in being unable to recover from or detect an illegal access. The intention is, after the program/erase is initiated, the 56800E continues to program execution, fetching these NOPs from flash. When the HFM begins its program/erase sequence, it no longer returns reads from flash, but instead returns 0xA97F, which is a branch to self command. Because the processor is currently doing no active calculations (because of the NOPs), it runs in place until the flash array is again available.

19.2.3.3 FM_SECHI-FM_SECLO - HFM Security Registers

The FM_SECHI and FM_SECLO registers are used to store the Flash Security Word defined in Table 19-2

Address: HFM_BASE + 0x03

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
R	KEYEN	SECS TAT	0	0	0	0	0	0	0	0	0	0	0	0	0	0
W																
Reset	F ¹	S ²	0	0	0	0	0	0	0	0	0	0	0	0	0	0

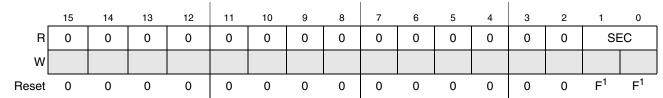
¹ Reset state loaded from flash array during reset.

Figure 19-4. FM_SECHI Security Register

Table 19-6. FM_SECHI Security Register Descriptions

Field	Description				
15 KEYEN	Enable backdoor key to security. 1 = backdoor to Flash is enabled. 0 = backdoor to Flash is disabled.				
14 SECSTAT	Flash Security Status. 1 = Flash Security is enabled. 0 = Flash Security is disabled.				
13–0	Reserved				

Address: HFM_BASE + 0x04



¹ Reset state loaded from flash array during reset operation.

Figure 19-5. FM_SECLO Security Register

² Reset state determined by security state of module

Table 19-7. FM_SECLO Security Register Descriptions

Field	Description							
15–2	Reserved.							
1–0 SEC	Memory Security Bits. The value loaded into SEC from the configuration field at reset in turn determines the of flash security at reset (SECSTAT) This table. outlines the single code that enables the security feature HFM							
		SEC[1:0] Description						
	0x2 Flash Secured							
	All other combinations Flash Unsecured							
				_				

Bits 15, 14 of FM_SECHI and bits 0-1 of FM_SECLO are readable. The FM_SECHI and FM_SECLO registers are not writable.

The FM_SECLO register is initialized at reset using SECL_VALUE from the configuration field. Likewise, the FM_SECHI register is initialized at reset using SECH_VALUE from the flash configuration field. The flash configuration field in the flash array is described in Table 19-2. The value F in the reset value in Figure 19-5. indicates bits that are copied directly from the corresponding configuration field bit.

The reset value of SECSTAT is determined by the value loaded into the SEC field at reset as described below. The value of SECSTAT can be modified at runtime as described under flash security in Section 19.3.3.

NOTE

If security is enabled then in order to perform product analysis either it must be disabled by the backdoor key or the array must be totally erased either by performing the lockout recovery sequence or by performing a mass erase followed by a read-verify.

19.2.3.4 FM_PROT – HFM Protection Register

Reset state loaded from flash array during reset

The FM_PROT register defines which flash pages or sectors are protected against program and erase.

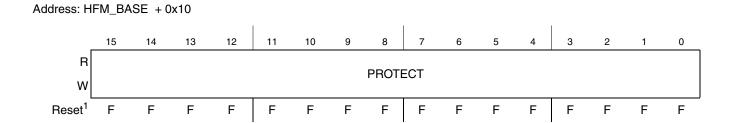


Figure 19-6. HFM Protection Register (FM PROT)

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Table 19-8. HFM Protection Register (FM_PROT) Descriptions

Field	Description
15–0 PROTECT	Each HFM array sector can be protected from program and erase by setting PROTECT[M] bit. PROTECT[M] = 1: Array sector M is protected. PROTECT[M] = 0: Array sector M is not protected.

The FM PROT register is always readable and writable only when LOCK=0.

The FM_PROT value is reset to the PROT_VALUE in the configuration field as defined in Table 19-2

HFM sector protection can be modified at runtime by writing new values to the FM_PROT register, however, this is possible only if the LOCK bit in FM_CNFG is 0. To change the flash protection loaded on reset, sector[15] of program flash must first be unprotected as just described, then the protection word in the configuration field at addresses defined in Table 19-2 must be programmed with the desired value.

On the MC56F8002 for which some sectors of the array are not implemented, the bits of the FM_PROT register corresponding to the unimplemented sectors are read-only with value 0. The other bits continue to define protection status for the implemented sectors of the flash array.

The FM_PROT register controls the protection of sixteen 1 KB sectors in a 16 KB section of program memory Figure 19-7 outlines the association between each bit in the FM_PROT register and the corresponding HFM sector within the program flash.

Protection scheme is operational only for user commands (PGM, PGERS and MASERS) launched by array writes.

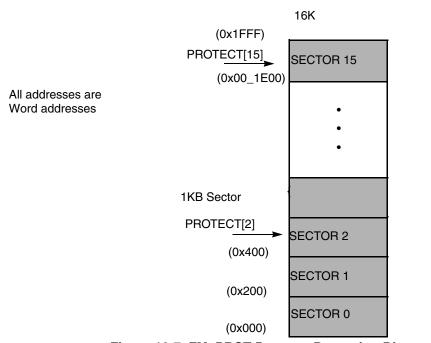


Figure 19-7. FM_PROT Program Protection Diagram

19.2.3.5 FM_USTAT – HFM User Status Register

The FM_USTAT register defines the flash state machine command status and flash array access, protection and blank verify status.

FM_USTAT register bits 7, 5, 4, and 2 are readable and writable while bits 3, 1, and 0 read zero and are not writable. Bit 6 in the FM_USTAT register is a read-only bit.

Register address HFM_BASE + 0x13

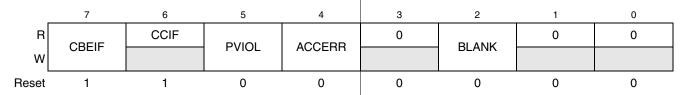


Figure 19-8. HFM User Status Register (FM_USTAT)

Table 19-9. HFM User Status Register (FM_USTAT) Descriptions

Field	Description
7 CBEIF	Command Buffer Empty Interrupt Flag. The CBEIF flag indicates that the address, data and command buffers are empty so that a new command sequence can be started. The CBEIF flag is cleared by writing a 1 this results in the FM_CMD and FM_DATA registers being transferred to the FI for launch of a command. Writing a 0 has no effect on CBEIF but can be used to abort a command sequence. The CBEIF bit can generate an interrupt if the CBEIE bit in the FM_CNFG is set. While CBEIF flag is clear the FM_CMD and FM_DATA registers are not writable. 1 = Buffers are ready to accept a new command. 0 = Buffers are full.
6 CCIF	Command Complete Interrupt Flag. The CCIF flag indicates that there are no more commands pending. The CCIF flag is set and cleared automatically upon start and completion of a command. Writing to CCIF has no effect. The CCIF bit can generate an interrupt if the CCIE bit in the FM_CNFG is set. 1 = All commands are completed. 0 = Command in progress.
5 PVIOL	Protection Violation. The PVIOL flag indicates an attempt was made to program or erase an address in a protected Flash memory area. The PVIOL flag is cleared by writing a 1. Writing a 0 has no effect on PVIOL. While the PVIOL flag is set, it is not possible to launch another command. 1 = A protection violation has occurred. 0 = No failure.
4 ACCERR	Access Error. The ACCERR flag indicates an illegal access to the HFM array or registers caused by a bad program or erase sequence. The ACCERR flag is cleared by writing a 1. Writing a 0 to ACCERR bit has no effect. While the ACCERR flag is set, it is not possible to launch another command. The ACCERR relates to HFM array writes from the 56800E core buses and is not set by writing directly to the data and address registers from the IPbuses. See Section 19.3.2.7 for details on what sets the ACCERR flag. 1 = Access error has occurred. 0 = No failure.
3	Reserved.

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Table 19-9. HFM User Status Register (FM_USTAT) Descriptions

Field	Description
2 BLANK	Flash block has been verified as erased. The BLANK flag indicates that an erase verify command (RDARY1) has checked the flash block and found it to be blank. The BLANK flag is cleared by writing a 1. Writing a 0 has no effect. 1 = Flash block verifies as erased. 0 = If an erase verify command has been requested, and the CCIF flag is set, then a zero in BLANK indicates that the block is not erased.
1, 0	Reserved.

19.2.3.6 FM_CMD – HFM Command Register

The FM_CMD register defines the flash commands used during user and test modes. All FM_CMD register bits are readable and writable except bit 7.

Register address HFM_BASE + 0x14

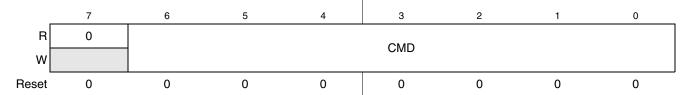


Figure 19-9. HFM Command and Buffer Register (FM_CMD)

Table 19-10. HFM Command and Buffer Register (FM_CMD) Descriptions

Field	Description
7	Reserved.
6–0 CMD	Valid commands are shown in Table 19-11. Writing a command other than those listed in Table 19-11 causes the ACCERR flag in the FM_USTAT register to set.

Table 19-11. FM_CMD Commands

Command	Name	Description
0x05	RDARY1	Erase Verify (All Ones)
0x06	RDARYM	Data Compress Flash Unit Data
0x20	PGM	Word Program
0x40	PGERS	Page Erase
0x41	MASERS	Mass Erase
0x66	RDARYMI	Data Compress Factory Stored Configuration Data

19.2.3.7 FM_DATA – HFM 16-Bit Data Buffer and Register

The FM_DATA is the 16-bit flash data register. Only read access is permitted to the FM_DATA register.

Address: HFM_BASE + 0x18

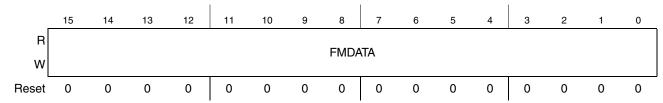
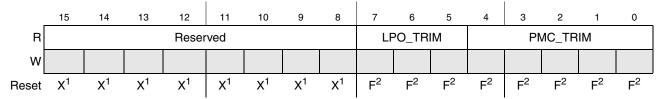


Figure 19-10. HFM Data Register (FM DATA)

FM_OPT0 - HFM IFR Option0 Register 19.2.3.8

The FM_OPT0 register is used to store trim data for the PMC and LPO that is read and used by the startup application code.

Address: HFM_BASE + 0x1A



Reset value is not specified.

Figure 19-11. FM OPT0 Register

All bits are readable. The FM OPT0 register is not writable.

Table 19-12. HFM IFR Option0 Register (FM OPT0) Descriptions

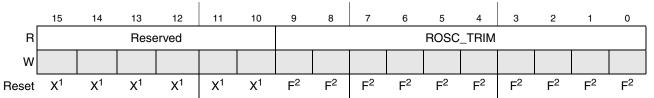
Field	Description
15–8	Reserved.
7–5 LPO_TRIM	These bits are copied into the PMC trim bits by the application startup code. See Chapter 13, "On-Chip Clock Synthesis (OCCS).
4–0 PMC_TRIM	These bits are copied into the PMC trim bits by the application startup code. See Chapter 15, "Power Management Controller (PMC).

19.2.3.9 FM_OPT1 - HFM IFR Option1 Register

The FM_OPT1 register is used to store trim data for the ROSC that is read and used by the startup application code to trim the ROSC of the OCCS.

² Reset state is loaded during reset.

Address: HFM_BASE + 0x1B



[!]Reset value is not specified.

Figure 19-12. FM_OPT1 Register

All bits are readable. The FM_OPT1 register is not writable...

The FM_OPT1 register is loaded at reset with factory-determined trim data.

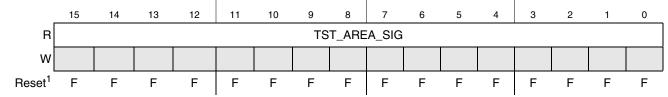
Table 19-13. HFM IFR Option1 Register (FM_OPT1) Descriptions

Field	Description
15–10	Reserved.
	These bits are copied into the OCCS ROSC trim bits by the application startup code. See Chapter 13, "On-Chip Clock Synthesis (OCCS).

19.2.3.10 FM_TSTSIG - HFM Test Array Signature

The FM_TSTSIG register is used to store the checksum for the factory-stored configuration data for the device as generated by the RDARYMI command during factory test. The value in the FM_TSTSIG register can be compared to the result of the RDARYMI through out the life of the part to confirm that factory-stored configuration data, required for proper device operation, has not been compromised.

Address: HFM_BASE + 0x1D



¹ Reset state loaded from flash array during reset.

Figure 19-13. FM_TSTSIG Register

All bits are readable. The FM TSTSIG register is not writable.

The FM_TSTSIG register is loaded at reset with the factory-supplied value.

² Reset state is loaded during reset.

19.3 Functional Description

19.3.1 General

The purpose of this section is to detail the HFM's operation. Figure 19-14 outlines all the available modes of operation.

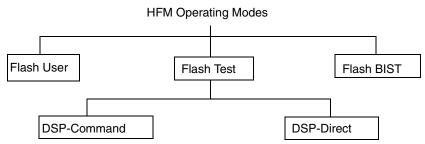


Figure 19-14. HFM modes of operation

The following operations are described in the next sub-sections:

- Array Read Operation
- Array Write Operation
- Program and Erase Operation
- Wait/Stop Mode
- Data Compress within Main Array.
- Data Compress of Flash Information Block.
- Flash BIST Mode
- Flash Security Operation

19.3.2 Flash Use

The 56800E core can perform read and write operations on HFM registers (Table 19-3) via the peripheral bus interface, perform read and write operations on the HFM memory array (Figure 19-1) via the system bus interface, and perform commands for programming, erasing, and verifying array content.

Register read and write operations are performed by using word-length (16-bit) 56800E core instructions to read/write the respective register data-space addresses.

Array read and write operations are formed by using word-length DSP program memory accesses to read/write addresses in the HFM memory array. While an array read transfers one word from the HFM memory array to the 56800E core, an array write merely registers (remembers for subsequent use, in an internally available register) the address and transfers the data value to the FM_DATA register. Modifying a word in the HFM array requires the execution of a program command.

The program command is one of several commands available. Command execution requires the execution of a specific sequence of register and array reads and writes. The execution sequence of these IO is

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monitored by a state machine and the basic algorithm is shared by all commands. Deviation from the required protocol can result in the flagging of an access error and rejection of the command.

The command execution protocol incorporates an array write followed by writing the command code to the FM_CMD register. The address and data conveyed to the HFM by this array write during the execution of the command is used differently by different commands.

19.3.2.1 Commands

Table 19-14 summarizes the valid flash commands.

Table 19-14. Flash Commands

FM_CMD CMD	Meaning	Description	Array Write Address/Data Usage	
0x05	Erase Verify	Verify that the flash array is erased. If the array is verified to be blank, the BLANK bit sets in the FM_USTAT register, Figure 19-8, upon command completion.	The registered address must be any address within the array. Data is ignored.	
0x06	Data Compress	Compress a user-specified range of words in the flash array. The resulting signature is returned in the FM_DATA register at the completion of the command.	The registered array write address specifies the starting address and data specifies the number of words to compress.	
0x20	Program	Program a 16-bit word.	The registered address and data specify the address and value to program.	
0x40	Page Erase	Erase a specific page (sector) of the flash array. A page erase is possible only when the PROTECT bit for the selected page is not set.	The registered address must be any address within the page to be erased. Data is ignored	
0x41	Mass Erase	Erase all flash memory. A mass erase is possible only when no PROTECT bits are set.	The registered address must be any address within the array. Data is ignored.	
0x66	Data Compress Test Area	Compress the flash information row (IFR) of the flash array. The resulting signature is returned in the FM_DATA register at the completion of the command. The entire IFR row 1 is compressed except the last word that contains the expected compress result. The flash information row contains proprietary data set at the factory that is required for proper operation of the device.	The registered address must be any address within the array. Data is ignored.	

19.3.2.2 Array Read Operation

A valid array read occurs whenever the program address bus (PAB) address is equal to an address within the valid range of their HFM memory space and the read/write control indicates a program read cycle. Data is returned to the core via the program data bus (PDB).. Array reads require word-length reads to program space within the address range of the array.

19.3.2.3 Array Write Operation

A valid array write operation occurs whenever the program address bus (PAB) address is equal to an address within the valid range of the HFM array and the read/write controls indicate a program write cycle. Write data is provided by the 56800E core via the write data bus (cdbw[15:0]). The action taken on a valid flash array write depends on the subsequent user command issued as part of a valid command sequence operation. Array writes require word-length writes to program space within the address range of the array.

19.3.2.4 Command Sequence Operation

This section describes how to perform a command sequence. Commands that alter HFM content (programming and erasing) must be properly timed to insure a successful update without damage. The algorithm for performing commands involves the use of an array write operation as described above as well as writes and reads of HFM registers (see Section 19.3.2.6, "Command Sequence Protocol). The algorithm is controlled by a state machine whose time base (FCLK) is derived from the chip's master clock input from the OCCS module (MSTR_OSC) using a programmable prescaler and divider controlled by fields in the FM_CLKDIV register to produce an FCLK frequency between 150 kHz and 200 kHz (see Section 19.3.2.5, "Writing the FM_CLKDIV Register). A table of commonly used PRDIV8 and FDIV values is provided (see Section Table 19-15., "PRDIV8 and FDIV Values for Various Operating Conditions). The rising edges of FCLK, are sampled in the peripheral clock domain, counted, and compared to the appropriate timing to achieve the proper duration. Buffer empty as well as command completion are signalled by flags in the HFM status register. Interrupts are generated if enabled.

NOTE

Because of the impact of clock synchronization on the accuracy of the functional timings, programming or erasing the flash memory cannot be performed while the HFM peripheral clock frequency (same as system bus frequency) is less than 1 MHz. This limitation does not apply to array reads.

While the algorithm can be used to process commands to completion one at a time, the command register as well as the address and data registers operate as a buffer and a register (2-stage FIFO), so that a new command along with the necessary data and address can be stored to the buffer while the previous command is still in progress. This technique can be applied to all commands except RDARYM and RDARYMI..

The next four sections describe:

- How to write the FM_CLKDIV register,
- Command sequence protocol,
- Errors resulting from illegal operations,
- Effects of wait/stop mode

19.3.2.5 Writing the FM_CLKDIV Register

Prior to issuing any flash command after a reset, the user is required to write the FM_CLKDIV register. This register contains factors that divide the oscillator clock (MSTR_OSC) to generate FCLK. FCLK is an internal timing clock for the HFM that must operate in the 150 kHz to 200 kHz range. Because FCLK

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is re-timed into the peripheral clock domain, the FM_CLKDIV determination involves both the oscillator and HFM peripheral clock frequencies. The HFM peripheral clock frequency is the same as the system clock frequency, which can be as high as 32 MHz.

If we define:

- FCLK as the frequency in MHz of the clock to the flash control block
- t_{Bus} as the largest period in μs of the system bus clock used during program/erase operations,

NOTE

The CodeWarrior debugger reprograms flash when SW breakpoints are used, which can occur prior to PLL activation. Hence while debugging with CodeWarrior, the value of $t_{\rm Bus}$ should typically reflect the period of the system bus when clocked by the oscillator ($t_{\rm osc}/2$) rather than the period of the system bus when clocked by the PLL (post-scaled PLL/6).

- Oscillator clock (f_{osc}) as the frequency in MHz of MSTR_OSC (MSTR_OSC is selectable in OCCS module to be either the external clock source or the output of the relaxation oscillator)
- INT(x) as taking the integer part of x (e.g. INT(4.323)=4),

then FM_CLKDIV register bits PRDIV8 and FDIV[5:0] are to be set so as to produce FLCK in the required range, above.

NOTE

Program and erase command execution time increase proportionally with the period of f_{CLK} .

Programming or erasing the flash memory with $f_{CLK} < 150~kHz$ should be avoided. Setting FM_CLKDIV to a value such that $f_{CLK} < 150~kHz$ can damage the flash memory due to overstress. Setting FM_CLKDIV to a value such that $(1/f_{CLK} - t_{Bus}/4) < 5\mu s$ can result in incomplete programming or erasure of the flash memory cells.

If the FM_CLKDIV register is written, the DIVLD bit is set automatically. If the DIVLD bit is zero, the FM_CLKDIV register has not been written since the last reset. If the FM_CLKDIV register has not been written to, the flash command loaded during a command write sequence does not execute and the ACCERR flag in the FM_USTAT register sets.

Unlike the 56F8300 Series, FM_CLKDVD's DVD is not write-protected after they're written. These bits can be modified even after their initialization.

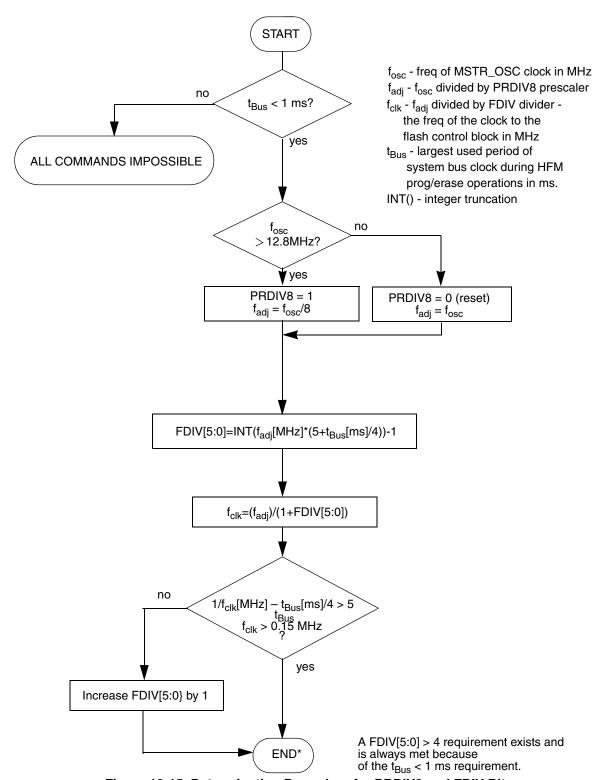


Figure 19-15. Determination Procedure for PRDIV8 and FDIV Bits

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Table 19-15. PRDIV8 and FDIV Values for Various Operating Conditions

f _{osc}	Min. System Bus Freq. Used for Program/Erase	t _{Bus}	PRDIV8	FDIV	f _{clk}
2 MHz	1 MHz	1 μs	0	10	181.8 kHz
4 MHz	2 MHz	0.5 μs	0	20	190.5 kHz
8 MHz	1 MHz	1 μs	0	41	190.5 kHz
8 MHz	2 MHz	0.5 μs	0	40	195.1 kHz
8 MHz	4 MHz	0.25 μs	0	40	195.1 kHz
8 MHz	8 MHz	0.125 μs	0	40	195.1 kHz
8 MHz	16 MHz	0.0625 μs	0	40	195.1 kHz
8 MHz	32 MHz	0.03125 μs	0	40	195.1 kHz
16 MHz	8 MHz	0.125 μs	1	10	181.8 kHz
32 MHz	16 MHz	0.0625 μs	1	20	190.5 kHz
64 MHz	32 MHz	0.03125 μs	1	40	195.1 kHz

19.3.2.6 Command Sequence Protocol

A command state machine is used to supervise the sequencing of I/O during a command sequence. To prepare for a command execution, the CBEIF flag should be tested to ensure that the registered address, data and command buffers are empty. If the CBEIF flag is set, the command sequence can be started.

The following three-step command write sequence must be strictly followed with no intermediate writes to the HFM permitted between the three steps. The command write sequence is as follows:

- 1. Perform a 16-bit array write to the desired HFM address (see Section 19.2.2, "Module Memory Map").
- 2. Write the numeric code for the command to the command buffer, FM_CMD. These commands are described in Table 19-14.
- 3. Write a 1 to the CBEIF flag to clear it, thereby launching the command. After the CBEIF flag is cleared, the CCIF flag is cleared by hardware indicating that the command was successfully launched. The hardware then sets the CBEIF flag again, indicating that the address, data, and command buffers are ready for a new command write sequence to begin.

The completion of the command operation occurs when the hardware sets the CCIF flag.

The command state machine flags errors in program- or erase-write sequences by means of the ACCERR (access error) and PVIOL (protection violation) flags in the FM_USTAT register. An erroneous command-write sequence aborts the operation and sets the appropriate flag. If set, the user must clear the ACCERR or PVIOL flags before commencing another command-write sequence.

NOTE

By writing a 0 to the CBEIF flag the command sequence can be aborted after the word write to the flash address space or after writing a command to the FM_CMD register and before the command is launched. The ACCERR flag is set on aborted commands and must be cleared before a new command is launched.

A flow chart of the entire command sequence is shown in Figure 19-16

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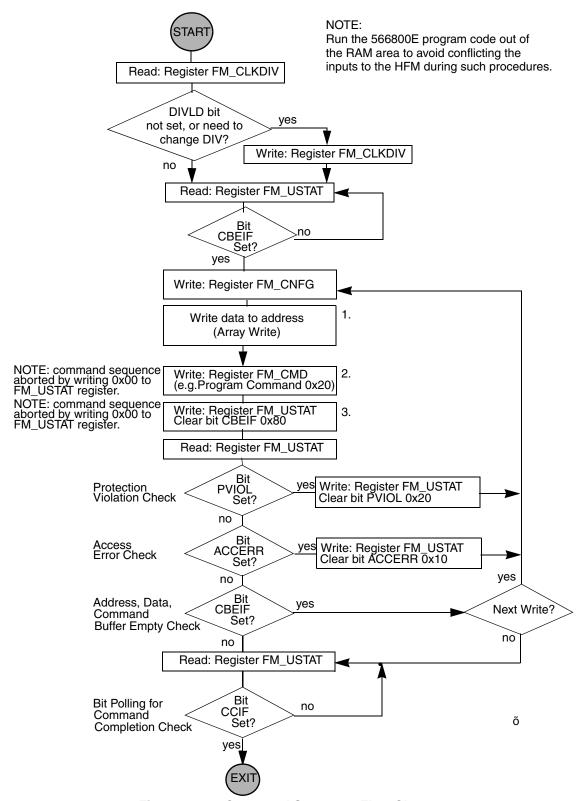


Figure 19-16. Command Sequence Flow Chart

19.3.2.7 HFM Illegal Operations

The ACCERR flag is set during the command write sequence if any of the following illegal operations are performed. Such operations cause the command sequence to immediately abort. Writes to the HFM address space refers to writes via the 56800E core buses not the IP register bus.

- Writing to the HFM address space before initializing FM_CLKDIV.
- Writing to the HFM address space while CBEIF is not set.
- Writing a second word to the HFM address space.
- Writing an invalid user command to the FM_CMD register.
- Writing to any HFM register other than FM_CMD after writing a word to the HFM address space.
- Writing a second command to the FM_CMD register before executing the previously written command.
- Writing to any HFM register other than FM_USTAT (to clear CBEIF) after writing to the command register, FM_CMD.
- The part enters stop or wait mode and a program or erase command is in progress. The command is aborted.
- Aborting a command sequence by writing a 0 to the CBEIF flag after the word write to the flash
 address space or after writing a command to the FM_CMD register and before the command is
 launched.
- Writing to the array while a data compress command (also known as a calculate signature command) is running.

The PVIOL flag is set during the command write sequence after the word write to the HFM address space if any of the following illegal operations are performed. Such operations cause the command sequence to immediately abort:

- Writing an HFM address to program in a protected area.
- Writing an HFM address to erase in a protected area.
- Writing a mass erase command to CMD while any protection is enabled for that block (see Section 19.2.3.4, "FM_PROT HFM Protection Register).

If a flash block is read during execution of an algorithm on that block (i.e., CCIF is low), the read returns non-valid data and the ACCERR flag is not set.

19.3.2.8 Data Compress (Signature) Commands RDARYM and RDARYMI

The RDARYM command compresses flash-block data into a checksum. The RDARYMI command performs a similar function for the factory configuration data stored in the device.

The data compression uses a MISR algorithm with the polynomial $p(x) = x + x^2 + x^4 + x^{15}$.

If the length passed as argument to the data compression commands (except RDARYMI) is greater than the array capacity, addresses keep wrapping (either around the block limits or the row limits, in case of the IFR) until the length count is reached. Any address can be used in the signature calculation more than once if that configuration is set.

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If the length passed as argument to data compression commands (except RDARYMI) is zero, the algorithm runs the maximum number of cycles that can be generated by the circuit counter. It happens regardless of the array maximum address, or the row limits in case of the IFR, it continues wrapping around the address limits.

19.3.2.9 Effects of Wait/Stop Mode

If a command is active (CCIF = 0) when the DSP enters wait or stop mode, the command is aborted, and the data being programmed or erased is lost. The high voltage circuitry to the flash is switched off and a pending command (CBEIF = 0) is not executed after the DSC exits wait or stop mode. The CCIF and ACCERR flags are set if a command is active when the DSC enters wait or stop mode.

When entering wait or stop mode, the HFM hardware immediately (within the next clock period) sets an ACCERR, regardless of the operation being executed at the moment, i.e., it is not necessary to finish the current operation (e.g., a command sequence) for checking the ACCERR being set.

NOTE

As active commands are immediately aborted when the device enters wait mode, it is strongly recommended that the user does not execute the WAIT instruction during program and erase execution.

19.3.3 Flash Security Operation

Flash security provides a means to protect the embedded code within the flash array from unauthorized external access. The state of flash security is reflected in the state of the SECSTAT bit in the FM_SECHI register. The value of the SECSTAT bit at reset is determined by the values in the security words stored in the flash configuration field. Thus, by appropriately programming the configuration field, the part can be forced into secure mode at reset or power-up.

Flash security prevents unauthorized external access by the JTAG/EONCE port. After flash security is set, an external user is unable to view or change embedded software and is thus unable to introduce code sequences to undo security or export code.

There are three methods of disabling flash security at run time:

- Executing a back-door-access scheme built into the application
- Pass an erase-verify check
- Execute the JTAG lockout-recovery routine to mass erase the flash

Only the first method preserves the content of flash memory.

19.3.3.1 Back Door Access

Flash security can be disabled at run-time (by a program executing on the 56800E core and running out of the RAM address space) by following the directions below. The KEYEN bit in the FM_SECHI register must be set to enable back door key access.

1. Set the KEYACC bit in the configuration (FM_CNFG) register.

- 2. Write the correct four word (64-bit) back door comparison key to the flash memory configuration field. For example, the addresses for a 16 KB block would be \$1FFC_\$1FFF. This operation must be composed of four word writes starting with the smallest address. For example, write to address \$1FFC, \$1FFD, \$1FFE, and \$1FFF (in that order) for a 16 KB block. The four write cycles can be separated by any number of other operations.
- 3. Clear the KEYACC bit.

If all four words written match the flash content in the configuration field, security is bypassed until the next reset. In the unprotected state, the 56800E core has full control of flash memory. The value of the flash security words \$1FF7–\$1FF8 is not changed by the back door method of unsecuring the device.

After the next reset sequence, the device is secured again and the same back door key is in effect, unless the configuration field is changed by program or erase. Flash security (see the bits defined as SEC in the FM_SECLO register) must be changed directly by reprogramming the flash security words in memory when the highest sector is unprotected.

The back door method of unsecuring the device has no effect on the program and erase protections defined in the protection (FM_PROT) register.

19.3.3.2 JTAG Lockout Recovery

To unsecure a secured FM:

- Mass erase the flash memory by using a sequence of JTAG commands, and then on the next reset, the part will be unsecured.
- See the device data sheet section on security features.

The JTAG lockout recovery sequence is initiated by activating input signal jtag_lockout_recovery_sec, facilitating the load of jtag_fm_data[6:0] into the FM_CLKDIV register from the JTAG register within the platform. A mass erase command write sequence is then executed. If the mass erase is successful, the next reset results in an unsecured part.

19.4 Resets

19.4.1 General

The FM module uses the early reset signal (16 clocks in advance of the 56800E core's reset signal) supplied by the SIM module to load the reset state of bit fields within the FM_PROT and FM_SECHI registers with data from the flash memory area. The early reset signal is also used to trigger the read of the security word and the enabling of chip security if it is so configured. The flash array is not accessible for any operations, from the address and data buses, during early reset. If a reset occurs while any command is in progress, that command will be immediately aborted. The state of the word being programmed or the page/block being erased is not guaranteed.

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19.5 Interrupts

19.5.1 General

The HFM module can generate an interrupt when all flash commands are completed or when the address, data and command buffers are empty.

Global Mask Local Enable **Interrupt Source** Interrupt Flag (SR) Flash Command, data and **CBEIF CBEIE** I1/I0 Bit address Buffers Empty (FM_USTAT) (FM_CNFG) I1/I0 Bit All Commands are **CCIF** CCIE Completed on Flash (FM_USTAT) (FM_CNFG) **ACCERR Generated** ACCERR AEIE I1/I0 Bit (FM_USTAT) (FM_CNFG)

Table 19-16. HFM Interrupt Sources

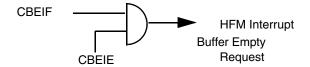
NOTE

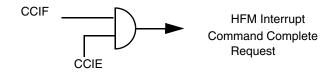
Vector addresses and their relative interrupt priority are described in Chapter 12, "Interrupt Controller (WINTC)."

19.5.2 Description of Interrupt Operation

Figure 19-17. outlines the operation of the interrupt request generated by this module. During chip integration, the HFM interrupt request line can be disconnected from the chip interrupt controller. In this case software must be used to poll the CCIF and CBEIF flags.

This system uses the CBEIE and CCIE to enable interrupt generation.





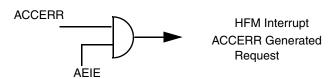


Figure 19-17. HFM Interrupt Implementation

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Chapter 20 Joint Test Action Group Port (JTAG)

20.1 Introduction

Because this device also has a 56800E core containing its own test access port (TAP), or *core TAP*, a TAP linking module (TLM) is included to manage the TAP access. Normal operation of this part will use the chip TAP as the master TAP controller, thereby disabling the 56800E TAP (core TAP) controller. This chapter discusses the master TAP only.

20.2 Features

TAP characteristics include:

- Provide a means of accessing the EOnCE module controller and circuits to control a target system
- Query the IDCODE from any TAP in the system
- Force test data onto the peripheral outputs while replacing its Boundary Scan Register (BSR) with a single bit register
- Enable/disable pullup devices on peripheral boundary scan pins

20.3 Block Diagram

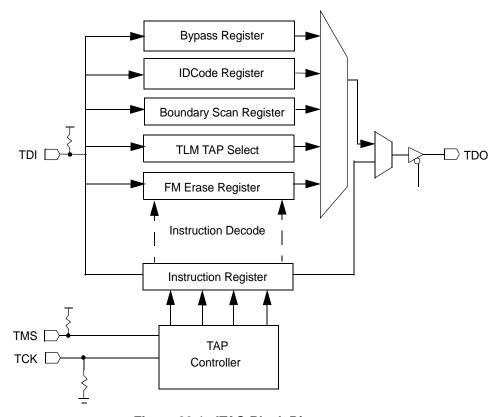


Figure 20-1. JTAG Block Diagram

20.4 Functional Description

The master TAP consists of a synchronous finite 16-bit state machine, an eight-bit instruction register, a bypass register, and an identification code register.

20.4.1 JTAG Port Architecture

The TAP controller is a simple state machine used to sequence the JTAG port through its varied operations:

- Serially shift in or out a JTAG port command
- Update and decode the JTAG port Instruction Register (IR)
- Serially input or output a data value
- Update a JTAG port or EOnCE module register

NOTE

The JTAG port supervises the shifting of data into and out of the EOnCE module through the TDI and TDO pins, respectively. In this case, the shifting is guided by the same controller used when shifting JTAG information.

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A block diagram of the JTAG port is provided in Figure 20-1. The JTAG port has four read/write registers:

- 1. Instruction Register (JTAGIR)
- 2. Chip Identification (CID) register
- 3. Bypass Register (JTAGBR)
- 4. Boundary Scan Register (BSR)

Access to the EOnCE registers is described in the 56800E Data Sheet.

20.4.2 Master TAP Instructions

The eight-bit master TAP Instruction register is in support of all JTAG functions. It is described in Table 20-1. This register includes all IEEE 1149.1 required instructions plus several additional instruction registers accommodating debug and BIST testing.

Instruction	Target Register	Opcode
BYPASS	BYPASS	11111111
IDCODE	IDCODE	0000010
	Reserved	0000011
	Reserved	00000100
TLM_SEL	TLM	00000101
Lock Out Recovery (Flash_Erase)	FLASH_ERASE	00001000

Table 20-1. Master TAP Instructions Opcode

20.4.2.1 Bypass Instruction (BYPASS)

The BYPASS instruction is a required JTAG instruction, selecting the TAP Bypass register. This register is a single stage shift register providing a serial path between the TDI and the TDO pins illustrated in Figure 20-2. This instruction enhances test efficiency by shortening the overall path between TDI and TDO when no test operation of a component is required.

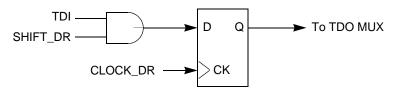


Figure 20-2. Bypass Register Diagram

20.4.2.2 IDCODE

The IDCODE instruction is an optional JTAG instruction enabling the Chip Identification (CID) register between TDI and TDO. This 32-bit register identifies the manufacturer, part, and version numbers.

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20.4.2.3 TLM_SEL

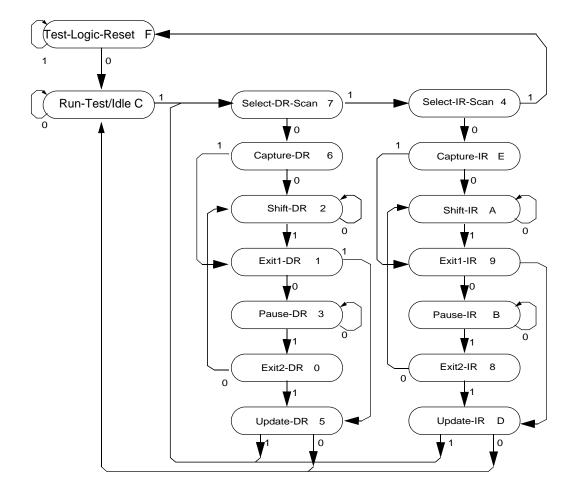
The TLM_SEL instruction is a user-defined JTAG instruction, disabling the master TAP and enabling the TAP linking module, or TLM. The TLM then selects the 56800E core TAP or the master TAP as the enabled TAP.

20.5 TAP Controller

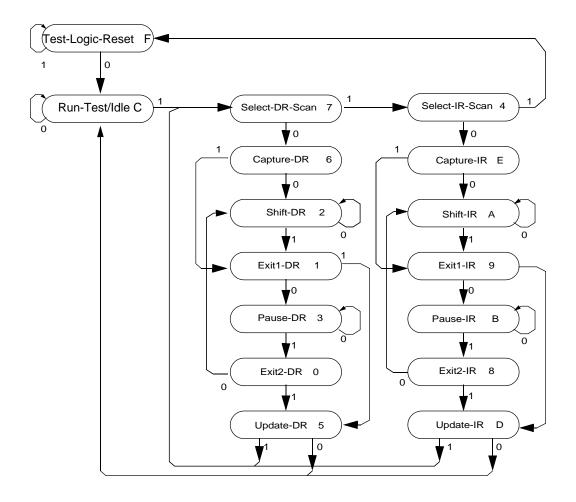
The TAP controller is a synchronous 16-bit finite state machine illustrated in Figure 20-3. The TAP controller responds to changes at the TMS and TCK pins. Transitions from one state to another occur on the rising edge of TCK. The value shown adjacent to each state transition represents the signal present on TMS at the time of a rising edge of TCK.

The TDO pin remains in the high impedance state except during the shift-DR and shift-IR TAP controller states. In shift-DR and shift-IR controller states, TDO updates on the falling edge of TCK. TDI is sampled on the rising edge of TCK.

The TAP controller executes the last instruction decoded until a new instruction is entered at the update-IR state, or test-logic-reset is entered.



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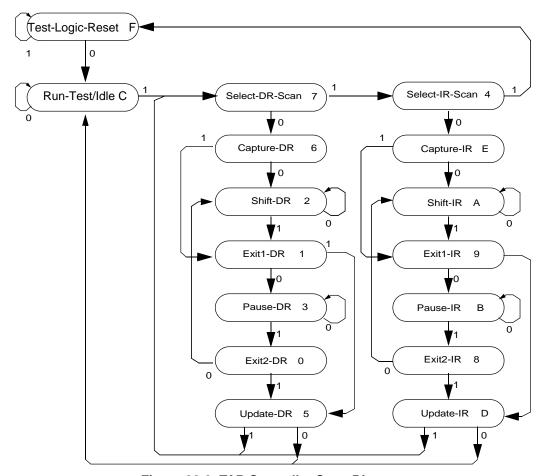


Figure 20-3. TAP Controller State Diagram

20.5.1 Operation

All state transitions of the TAP controller occur based on the value of TMS at the time of a rising edge of TCK. Actions of the instructions occur on the falling edge of TCK in each controller state illustrated in Figure 20-3.

20.5.1.1 Test Logic Reset (pstate = F)

During test-logic-reset, all JTAG test logic is disabled so the chip can operate in normal mode. This is achieved by initializing the instruction register (IR) with the IDCODE instruction. By holding TMS high for five rising edges of TCK, the device always remains in test-logic-reset no matter what state the TAP controller was in previously.

20.5.1.2 Run-Test-Idle (pstate = C)

Run-test-idle is a controller state between scan operations. When EOnCE is entered, the controller remains in run-test-idle mode as long as TMS is held low. When TMS is high and a rising edge of TCK occurs, the controller moves to the select-DR state.

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20.5.1.3 Select Data Register (pstate = 7)

The select-DR state is a temporary state. In this state, all test data registers selected by the current instruction retain their previous states. If TMS is held low and a rising edge of TCK occurs when the controller is in this state, the controller moves into the capture-DR state and a scan sequence for the selected test date register is initiated. If TMS is held high and a rising edge of TCK occurs, the controller moves to the select-IR state.

20.5.1.4 Select Instruction Register (pstate = 4)

The select-IR state is a temporary state. In this state, all test data registers selected by the current instruction retain their previous states. If TMS is held low and a rising edge of TCK occurs when the controller is in this state, the controller moves into the capture-IR state and a scan sequence for the instruction register is initiated. If TMS is held high and a rising edge of TCK occurs, the controller moves to the test-logic-reset state.

20.5.1.5 Capture Data Register (pstate = 6)

In this controller state, data may be parallel loaded into test registers selected by the current instruction on the rising edge of TCK. If a test data register selected by the current instruction does not have a parallel input, the register retains its previous value.

20.5.1.6 Shift Data Register (pstate = 2)

In this controller state, the test data register is connected between TDI and TDO. This data is then shifted one stage towards its serial output on each rising edge of TCK. The TAP controller remains in this state while TMS is held at low. When 1 is applied to TMS and a positive edge of TCK occurs, the controller will move to the exit1-DR state.

20.5.1.7 Exit1 Data Register (pstate = 1)

This is a temporary controller state. If TMS is held high, and a rising edge is applied to TCK while in this state, the controller advances to the update-DR state. This terminates the scanning process.

20.5.1.8 Pause Data Register (pstate = 3)

This controller state permits shifting of the test data register in the serial path between TDI and TDO to be temporarily halted. All test data registers selected by the current instruction retain their previous state unchanged. The controller remains in this state while TMS is held low. When TMS goes high and a rising edge is applied to TCK, the controller advances to the exit2-DR state.

20.5.1.9 Exit2 Data Register (pstate = 0)

This is a temporary controller state. If TMS is held high, and a rising edge is applied to TCK while it is in this state, the scanning process terminates and the TAP controller advances to the update-DR state. If TMS is held low and a rising edge of TCK occurs, the controller advances to the shift-DR state.

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20.5.1.10 Update Data Register (pstate = 5)

All boundary scan registers contain a two-stage data register. It isolates the shifting and capturing of data on the peripheral from what is applied to internal logic during scan mode. This register is the second stage, or parallel output, and applies a stimulus to internal logic. Data is latched on the parallel output of these test data registers from the shift register path on the falling edge of TCK in the update-DR state. On a rising edge of TCK, the controller advances to the select_dr state if TMS is held high or the run-test-idle state if TMS is held low.

20.5.1.11 Capture Instruction Register (pstate = E)

When the TAP controller is in this state and a rising edge of TCK occurs, the controller advances to the exit1-IR state if TMS is held at one, or the shift-IR state if TMS is held at zero.

20.5.1.12 Shift Instruction Register (pstate = A)

In this controller state, the shift register contained in the instruction register is connected between TDI and TDO and shifts data one stage toward its serial output on each rising edge of TCK. When the TAP controller is in this state and a rising edge of TCK occurs, the controller advances to the exit1-IR state if TMS is held at one or remains in the shift-IR state if TMS is held at zero.

20.5.1.13 Exit1 Instruction Register (pstate = 9)

This is a temporary controller state. If TMS is held high, and a rising edge is applied to TCK while in this state, the controller advances to the update-IR state. This terminates the scanning process. If TMS is held low and a rising edge of TCK occurs the controller advances to the pause-IR state.

20.5.1.14 Pause Instruction Register (pstate = B)

This controller state allows shifting of the instruction register in the serial path between TDI and TDO to be temporarily halted. All test data registers selected by the current instruction retain their previous state unchanged. The controller remains in this state while TMS is held low. When TMS goes high and a rising edge is applied to TCK, the controller advances to the exit2-IR state.

20.5.1.15 Exit2 Instruction Register (pstate = 8)

This is a temporary controller state. If TMS is held high, and a rising edge is applied to TCK while in this state, the scanning process terminates and the TAP controller advances to the update-IR state. If TMS is held low and a rising edge of TCK occurs, the controller advances to the shift-IR state.

20.5.1.16 Update Instruction Register (pstate = D)

During this state, the instruction shifted into the instruction register is latched from the shift register path on the falling edge of TCK and into the instruction latch. It becomes the current instruction. On a rising edge of TCK, the controller advances to the selector state if TMS is held high, or the run-test-idle state if TMS is held low.

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20.6 Memory Map

JTAG has no memory mapped registers.

20.7 Pin Description

The signal summaries for the JTAG are located in **Table 20-2.**

Table 20-2. JTAG Pin Description

Pin Name	Pin Description
TCK	Test Clock Input — This input pin provides the clock to synchronize the test logic and shift serial data to and from all TAP controllers and the TLM. If the EOnCE module is not being accessed using the master or 56800E core TAP controllers, the maximum TCK frequency is 1/4 the maximum frequency for the 56800E core. When accessing the EOnCE module through the 56800E core TAP controller, the maximum frequency for TCK is 1/8 the maximum frequency for the 56800E core. The TCK pin has a pulldown non-disabled resistor.
TDI	Test Data Input — This input pin provides a serial input data stream to the TAP and the TLM. It is sampled on the rising edge of TCK. TDI has an on-chip pullup resistor that can be disabled through PUPEN register in the GPIO module.
TMS	Test Mode Select Input — This input pin is used to sequence the TAP controller's TLM state machine. It is sampled on the rising edge of TCK. TMS has an on-chip pullup resistor that can be disabled through PUPEN register in the GPIO module. Note: Always tie the TMS pin to VDD through a 2.2K resistor.
TDO	Test Data Output — This three-state output pin provides a serial output data stream from the master TAP, or 56800E core TAP controller. It is driven in the shift-IR and shift-DR controller states of the TAP controller state machines. Output data changes on the falling edge of TCK.

20.8 Clocks

20.8.1 TCK

This is the sole clock used by the master TAP module. If the EOnCE module is not being accessed using the master or 56800E core TAP controllers, the maximum TCK frequency is one-quarter the maximum frequency for the 56800E core. When accessing the EOnCE module through the 56800E core TAP controller, the maximum frequency for TCK is one eighth the maximum frequency for the 56800E core.

Table 20-3. Clock Summary

Clock	Priority	Source	Characteristics
TCK	1	External	This user-provided clock shifts data and controls the state machine.

20.9 Interrupts

This module has no interrupt capabilities.

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